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PART F STATISTICAL CONCEPTS AND TECHNIQUES VOLUME 3



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Chapter 1

INTRODUCTION

Part F of the Safeguards Technical Manual is being issued in three volumes. Volume 1 was published in 1977 and revised slightly in 1979. Volume 1 discusses basic probability concepts, statistical inference, models and measurement errors, estimation of measurement variances, and calibration. These topics of general interest in a number of application areas, are presented with examples drawn from nuclear materials safeguards. The final two chapters in Volume 1 deal with problem areas unique to safeguards: calculating the variance of MUF and of D respectively.

Volume 2 continues where Volume 1 left off with a presentation of topics of specific interest to Agency safeguards. These topics include inspection planning from a design and effectiveness evaluation viewpoint, on-facility site inspection activities, variables data analysis as applied to inspection data, preparation of inspection reports with respect to statistical aspects of the inspection, and the distribution of inspection samples to more than one analytical laboratory.

Volumes 1 and 2 are written in a simplified mode with little provided in the way of statistical bases for the computational procedures set forth in somewhat of a cookbook manner. The volumes indicate how to deal with specific problems with step-by-step computational procedures, but create little understanding of the procedures themselves, their attendant assumptions and possible limitations in applications. Further, the volumes are characterized by a lack of cohesiveness or unity of purpose, consisting of a number of rather isolated procedures with little in the way of a unified development of the statistical applications to Agency safeguards.

Because of these shortcomings in Volumes 1 and 2, the need for preparation of a Volume 3 was identified. Volume 3 covers generally the same material as Volumes 1 and 2 but with much greater unity and cohesiveness. Further, the cookbook style of the previous two volumes has been replaced by one that makes use of equations and formulas as opposed to computational steps, and that also provides the bases for the statistical procedures discussed. Hopefully, this will help minimize the frequency of misapplications of the techniques.

Volume 3 stands alone in the sense that Volumes 1 and 2 need not be read before Volume 3; many examples are common to the volumes but are worked from a different perspective. Having studied Volumes 1 and 2 prior to Volume 3, however, may be helpful in reaching a quicker understanding of the Volume 3 material. Further, a greater appreciation for the material in the first two volumes should follow from studying Volume 3 which is intended to provide the motivation for the statistical procedures covered in the two volumes. Volume 3, of course, also contains more recently developed statistical techniques not present in the earlier volumes.

The 13 chapters of Volumes 1 and 2 have been rearranged and replaced by four chapters in this Volume, identified as Chapters 2-5, Chapter 2 discusses

measurement errors in considerable detail (the table of contents is given at the start of each chapter). Chapter 3 is concerned with all aspects of error propagation as it relates to safeguards. Chapters 4 and 5 deal with Agency inspections, first from the design viewpoint, and then with respect to their implementation. The final chapter, Chapter 6, identifies and discusses current developments in the statistical aspects of safeguards, in anticipation of the need to revise Volume 3 periodically to keep the material contained therein current.

Volumes 1 and 2 each contain a glossary of terms. This glossary is omitted in Volume 3 because of the rather exhaustive discussion of measurement errors in Chapter 2. This lengthy discussion effectively replaces the glossary which must be viewed as a limited attempt to summarize a lot of ideas about measurement errors with a few definitions; which is difficult to do effectively. Hence, the need for the full discussion of these ideas in Chapter 2.

Volumes 1 and 2 are somewhat deficient in the completeness of their bibliographies. In Volume 3, a more complete bibliography is included. However, only those works actually cited in Volume 3 are listed in the bibliography. This should not detract from ones ability to perform additional background research in a given topic, however, since the cited articles themselves often contain cross references to other relevant work. Further, in safeguards applications, one can locate most articles of interest in a limited number of places. These include primarily the Institute of Nuclear Materials Management (INMM) Journals and Annual Meeting Proceedings, IAEA Conference Proceedings and related Agency reports, and Proceedings of the recently instituted meetings of the European Safeguards Research and Development Association (ESARDA). Further, in the INMM journals, complete listings are often given of available publications issued at a given facility. Thus, it is a simple matter to locate most articles pertinent to a given topic.

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Chapter 2

- 3 -

MEASUREMENT ERRORS

2.1 DEFINITION OF ERRORS

Material balance accounting is an integral part of Agency safeguards. It relies heavily on measured data, which are subject to error. The inferences that are drawn on the basis of accounting data are, as a result, drawn in the presence of errors, and are hence stated in the language of statistics.

This chapter, Chapter 2 of Volume 3, Part F, is concerned with measurement errors, including error sources, error models, kinds of errors, effects of errors, and estimation of errors. Later chapters deal with the effects of errors in drawing inferences on facility performance, based both on the facility's accounting data, and also on the inspection data.

As a starting point in the discussion, it is important to define what is meant by the word, error.

ANSI Standard N15.5[2.1] provides the following definition:

Error of a Measurement--The magnitude and the sign of the difference between the measured value and the true value.

This definition is an attractive one in the context of this Volume since it speaks of a measured value as opposed to a reported or recorded value. The important distinction is that the measured value is the value that would apply to the measurement in question were there no mistakes in recording or reporting the value. The basic assumption behind drawing inferences on the basis of accounting data is that the data are free of mistakes, or defects as they will be called in later chapters. Steps are taken to provide some degree of assurance that this is, in fact, a reasonable assumption. However, whatever may be the concern on the presence of such defects in the data, it is important to keep in mind that the inferences to be drawn on the basis of the measured, quantitative data are based on the definition of an error of measurement given here.

By a simple extension of the definition, a mistake may be said to have occurred if a reported value differs by any amount from a measured value. A synonym for a measured value is an observed value, and these two expressions will be used interchangeably throughout this volume.

2.2 SOURCES OF ERROR

The definition of error given in Section 2.1 is a bit simplistic in that it implies a very simple error structure. In fact, most errors of measurement are not simply structured, and a given error of measurement often represents the combined net effect of many errors. In this section, a discussion is given of the various sources of error that might affect a given measurement. The narrative discussion of this section is followed by a parallel mathematical model presentation in later sections.

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2.2.1 Statistical Sampling Error

Consider a population of individual items, each of which has a true value of some specified characteristic associated with it. If one of these items is selected in some random fashion, then the true value associated with that item will differ from some nominal or base true value (e.g., the average of all true values over all population items) by some amount. Define a statistical sampling error as the difference: true value for randomly selected item minus base true value.

In many Agency safeguards applications, statistical sampling error need not be included when making inferences. This is because: (1) the facility itself will measure 100% of the items involved in the material balance; and (2) the inspection data are analyzed as by-difference data in which the operator's value is compared with the inspector's value for each item in question, the true value of the item in question thus not affecting this difference. That is, the statistical sampling error for the difference is zero.

The following points must, however, be kept in mind. (1) Each item may not have a unique <u>measured</u> value of the characteristic in question associated with it, although it will surely have a unique <u>true</u> value of that characteristic. The effect of this is discussed in 2.2.3.

(2) Suppose the facility does not have measured values for its items so that there is no item by item comparison of the operator's data with that of the inspector. In this event, it is necessary to make inferences about the operator's material balance solely on the basis of the inspector's data for the sampled items. Statistical sampling error must then be included, for the result found in inspection clearly depends on which sub-group of items are selected and measured. This could prove to be a major source of error in some situations.

(3) In the event of attributes inspection of the go, no-go type, the true value associated with each item is conventionally either 1, corresponding to a defect, or 0, corresponding to a non-defect. The nominal or base value for the population in question is a fraction or proportion, equal to the true total number of defects divided by the total number of items. Thus, there is a statistical sampling error committed as each item is selected. The effect of this error on the inferences drawn about the population will disappear only if all items in the population are included in the sample.

2.2.2 Bulk Measurement Error

Material accountancy is based on three measurement operations: (1) determination of the net weight or volume of an item (bulk measurement); (2) sampling of the material; (3) analysis of the sampled material for element and/or isotope concentration. In the event of NDA measurement, the bulk measurement and the sampling of the material are not performed (unless a density correction is applied on the basis of the weight or unless the NDA measurement is made on a sample of material rather than on the whole item).

It is convenient to divide the total error of a measurement into component parts, the parts corresponding to these three basic measurement operations. The bulk measurement error is defined as the magnitude and sign of the difference between an item true weight (or volume) and its measured or observed weight. With this definition, it is implied that the error is a single quantity, and as far as its effect is concerned, it is possible to regard it as such. However, in actuality, the bulk measurement error may be, and quite likely will be, the net effect of many errors associated with the bulk measurement, some of which may tend to cancel one another in their effect. See the further discussion in 2.2.5 and 2.4.

2.2.3 Material Sampling Error

Material sampling error is defined with respect to the characteristic being measured. This may be uranium concentration, U-235 concentration, plutonium concentration, etc.

Material sampling error is the magnitude and sign of the difference between the true value of the characteristic in question for the sampled material and the corresponding true value for the totality of material represented by the sample. It is important to keep in mind just what is this totality of material. To illustrate, if the characteristic in question is uranium concentration, and if the concentration is to be uniquely determined for a given container, then the sampling error is the difference between the uranium concentration for the (presumably) small sample drawn from the container, and the average concentration in that container. This may be called the "within-container sampling error." On the other hand, if a sample is drawn from a given container with the concentration to be applied to other nominally like containers, then the variability in concentration from one container to another is included in the sampling error, along with the variability within containers.

In this latter context, it is noted that material sampling error is closely related to statistical sampling error for that part of the error that occurs because of differences in concentration from item to item. Some prefer to not make a distinction between statistical and material sampling errors. Others find it convenient to do so; it is largely a matter of personal preference, but it seems convenient in the context of material accountancy to make that distinction. This is because when concentrations are uniquely determined for different containers (or groups of containers), and the value in question is the difference between the inspector's and the operator's measured concentrations, the statistical sampling error, as defined here, has no effect. On the other hand, there will still be a material sampling error, assuming that both parties did not analyze the same sample of material.

2.2.4 Analytical Measurement Error

As with material sampling error, analytical error is defined with respect to a specified characteristic. Analytical error is the magnitude and sign of the difference between the true value of the characteristic for the sampled material and the corresponding measured or observed value. Note that this error is defined with respect to the material sampled, and not to the totality of material to be characterized by that sample. It is, of course, the combined effects of sampling and analytical that is important.

In the event of measurement by NDA rather than by the bulk measurementsampling-analytical route, then the error in the NDA measurement may for convenience be labeled an analytical error (although, as pointed out in Section 2.2.2, sampling error will also be introduced if the NDA measurement is performed on a sample of material rather than on the entire item).

2.2.5 Other Errors

As was indicated in 2.2.2, a given identified error is actually the net effect of potentially many errors. For example, in the weighing operation, the error in weighing could be the combined effect of how the item was positioned on the scale, the scale type, the particular scale of that type, the operator, and the environment (temperature, humidity) to name a few obvious potential sources of error. The extent to which specific error sources are identified and studied individually depends on the circumstances. For example, if the weighing error for the operation in question has little impact on the quality of the accountancy data, then there is little need to identify each source that contributes to the error. On the other hand, if the observed weights at the measurement point in question are judged to have larger than desirable errors of measurement, studies might well be initiated to ascertain why. In conducting these studies, at least some of the potential individual measurement error sources would be identified and evaluated as to their individual effects.

Regardless of the degree to which the error structure is decomposed into individual sources, in the accountancy applications to be discussed in this volume, the principal breakdown of errors will be limited to bulk measurement, material sampling, and analytical errors, always keeping in mind the more complex underlying error structure.

2.2.6 Statistical Sampling Distributions

Each time a measurement of some kind is made, there is a corresponding measurement error associated with the observed or measured value. Obviously, one does not know the value of the error; if it were known, then the observed value could be "corrected" for the known error, leaving the true value.

Although one may not know the particular error involved in a given measurement, one must know something about the possible magnitude of the error so that some statement can be made about the true value in question. The information about the error is conveyed through its known (or estimated) probability distribution. Specifically, one might have knowledge that an error, say ε , is distributed according to the normal distribution with zero mean and variance σ_F^2 .

As has been indicated before, a given measured value is affected by many errors of measurement. By appropriately propagating errors (this topic to be covered in Chapter 3), and by applying results from mathematical statistics theory, one can describe in some defined way the effect of the combined errors on the measured value. Carrying this one step further, one can find similar results for specified functions of a number of measured values. The specified functions of interest in safeguards applications are, for example, MUF, total inventory, operator minus inspector value, etc.

Given any measured value or any specified function of measured values (called a statistic) a goal in statistical inference is to make probability statements about some parameter on the basis of the observed or measured data. To do this, one must know the probability density function of the statistic in question. The probability density function enables one to compute a probability of occurrence for each possible set of outcomes of the statistic. The function in question can be derived from statistical theory given a set of input assumptions. The resulting function is often referred to as a sampling distribution. (In statistical theory, there is a distinction between a density function and a distribution function, the latter being the integral of the former. More correctly, the statistical function in question should be called a sampling density function.)

The foregoing discussion is pertinent to the discussion on errors because a sampling distribution provides for probability statements about the size of the error that might have been committed in a given application. For example, an important statistic in safeguards applications is the material unaccounted for (MUF). Each time a MUF is calculated, an error is made because the calculated MUF will differ from the true MUF by some amount due to all the errors of measurement that were unavoidably committed when calculating the MUF. Thus, given the sampling distribution of the MUF statistic, one can make inferences about the true MUF on the basis of the calculated MUF, for even though the size and sign of the error is not known, one does have knowledge of how it behaves in a probabilistic sense. Precisely how this knowledge is derived is the subject of the next chapter.

2.3 ERROR MODELS

In the foregoing discussion, it is indicated that there are many potential sources of error that might affect an observed result. In Section 2.4 to follow, it will be shown that these errors do not all behave in the same way. Although one is interested ultimately in the net effect of all errors of different kinds as they jointly affect a result, it is often helpful, and sometimes essential, to write down an appropriate mathematical model to identify the errors and how they relate to one another. There are several reasons for doing this:

- (1) Writing the model aids in propagating the errors, i.e., in finding the net effect of the errors acting jointly.
- (2) It identifies which are the important sources of error so that corrective steps can be taken if necessary and possible.
- (3) It helps to insure that potentially important errors are not overlooked.

(4) It leads one to question the assumptions inherent in the model, and thus leads to more realistic models.

On this latter point, it should be understood that a model is a mathematical description of reality. When faced with the choice, one of course prefers simple models, even if they may depart a bit from reality. The model builder has an important task: to write the model that provides an adequate description of reality; and, at the same time to derive a model that is not too difficult to use. Proper attention must be devoted to model-building because the model may impact heavily on the results of the analysis. This very important point is sometimes overlooked.

In the next two sections, two kinds of models are considered: the additive model and non-additive model.

2.3.1 Additive Model

The additive model is the simplest model with which to work, and is also one which often provides a close approximation to reality. It is the basis for many common statistical techniques, such as the analysis of variance, and is widely employed in practice.

A very simple additive model is

 $X = \mu + \epsilon$

(eq. 2.3.1)

where, for example,

- x = observed gross weight of can of UO₂ powder, in grams
- μ = true gross weight of can
- ϵ = the error

The additive nature of the model is clear. The error, ε , selected in some as yet unspecified way, is simply added to the true weight to give the observed weight. Of course, one only has knowledge of x, and not μ or ε . On the basis of the observed X and some knowledge about the probability distribution for ε , one can make inferences about the size of μ (i.e., assign a value to μ along with some probability statement.) In another context, one might know μ (e.g., assigned value of a standard) and observe x, and use this information to make inferences about ε .

This simple additive model can be extended to include additional terms. For example, suppose that a difference between scales exists. Then, letting

 θ_i = error for scale i

the previous model might be written

 $x_{j} = \mu + \theta_{j} + \varepsilon \qquad (eq. 2.3.2)$

As this model is written, if θ , were, say, 3 grams, then the model would indicate that items weighed on this scale would consistently read high by 3 grams, not counting the additional error, ε , associated with any given reading.

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The additive model is considered further in Section 2.4.

2.3.2 Other Models

Although the additive model provides an adequate description of reality in many instances, this is not always the case. As a very simple example, even though individual errors may be described by additive models, it does not follow that a statistic of interest will have an additive model. To illustrate, keeping in mind (eq. 2.3.1,)(but letting the weights be net weights rather than gross weights), let

where

 $y = observed ratio of uranium to UO_2$

 α = true ratio

 $y = \alpha + \eta$

n = the error

Suppose now that one is interested in the observed net weight of uranium, and not UO_{2} . The model for this is found by multiplying each side of (eq. 2.3.1) by each side of (eq. 2.3.3)

 $xy = \mu \alpha + \mu \eta + \alpha \varepsilon + \varepsilon \eta$

which is no longer a simple additive model.

As an extension of this, suppose that the model for the uranium to UO, ratio is not additive as in (eq. 2.3.3), but is rather of the multiplicative form:

 $y = \alpha \eta$

as would be the case if the error, n, were expressed as a multiplier, e.g., n =1.01 would represent a 1% relative error. Then, the model for the net weight of uranium is, from (eq. 2.3.1) and (eq. 2.3.5),

> (eq. 2.3.6) $XY = \mu\alpha n + \epsilon\alpha n$

which is another non-additive model that might apply.

To summarize, although additive models are often adequate, it does not follow that they apply in all situations. One must be aware of the model before errors can be appropriately propagated and inferences drawn.

As a final comment, non-additive models may at times be appropriately transformed to result in additive models. For example, upon using logarithms, (eq. 2.3.5) may be written

 $lny = ln\alpha + lnn$

which is now additive in the logarithms.

When errors are propagated in Chapter 3, the model will be kept in mind, if not explicitly written in each instance.

(eq. 2.3.3)

(eq. 2.3.5)

(eq. 2.3.4)

(eq. 2.3.7)

2.4 KINDS OF ERRORS

It has already been noted that there are potentially many sources of error that might affect a given measured value. It is also important to note that not all error sources will behave the same way in their effects. This fact is especially important in safeguards applications, as will be noted time and time again in future chapters.

There are three broad categories or kinds of errors that will be identified. These are random errors, systematic errors or biases, and errors that fall in neither category, which are usually called short-term systematic errors in safeguards applications. The different kinds of errors are perhaps best understood in the context of an example. The example will be developed further in each of the next three sections until the three basic kinds of errors will have been discussed, along with variations on them.

2.4.1 Random Errors

The example to be developed is as follows. Six sintered UO, pellets of nominally the same composition are to be analyzed for percent uranium. Let

- x_i = measured percent uranium for pellet i
- μ = nominal (or true) percent uranium
- ρ_i = deviation from the nominal value for pellet i
- ε_i = deviation due to analytical for measurement j

For simplicity in exposition, an additive model is assumed. (The distinction to be made among the kinds of errors is independent of this assumption.) The model representing the six measured values may be written:

Consider ρ_i . Since this differs for each of the six observations in the data set, ρ_i is called a random error. Further, with reference to the discussion in Section 2.2.1, ρ_i is a statistical sampling random error. If ρ_i is regarded as a random variable with zero mean and with variance σ_ρ^2 , then σ_ρ^2 is called the statistical sampling random error variance. Note the important distinction between ρ_i and σ_ρ^2 ; ρ_i is an error while σ_ρ^2 is an error variance.

Consider ϵ_j . Since this also differs for each of the observations in the data set, ϵ_j is also a random error. More specifically, with reference to Section 2.2.4, ϵ_j is an analytical random error and, analagous with σ_ρ^2 , the quantity σ_ε^2 is called the analytical random error variance.

It is noted from (eq. 2.4.1) that since ρ and ε have the same subscripts for all six observations, it is not possible to distinguish between the sampling and analytical errors. One might wish to combine them in the model, replacing $(\rho_1 + \varepsilon_1)$ by m_1 , etc. The quantity m_1 might then be called the measurement random error, and σ_m^2 the measurement random error variance.

With respect to this last point, it is recognized by modelers that there are many potential sources of error that affect a given result, some identified and others not. It is common practice to group effects in a model especially when the effects cannot be distinguished, as in this model. If, say, duplicate analyses were performed on each pellet, then ρ_j and ε_j would not be combined; their effects are then distinguishable.

The characteristic feature of a random error in a model is that its subscript changes for each observation in the data set. The safeguards significance of random errors is that their effect on measurement uncertainty can be reduced in a relative sense by making additional measurements. A random error is said to propagate to zero in a relative sense with an increasing number of measurements. For this reason, random errors are controllable and, given sufficient resources, can be made to have little importance in many safeguards applications.

2.4.2 Systematic Errors; Biases

The model (eq. 2.4.1) is extended. Let

 Δ = deviation from the nominal due to the analytical method, for all measurements in the data set

Then write

$$x_{1} = \mu + \Delta + \rho_{1} + \varepsilon_{1}$$

$$x_{2} = \mu + \Delta + \rho_{2} + \varepsilon_{2}$$

$$x_{3} = \mu + \Delta + \rho_{3} + \varepsilon_{3}$$

$$x_{4} = \mu + \Delta + \rho_{4} + \varepsilon_{4}$$

$$x_{5} = \mu + \Delta + \rho_{5} + \varepsilon_{5}$$

$$x_{6} = \mu + \Delta + \rho_{6} + \varepsilon_{6}$$

(eq. 2.4.2)

Note that \triangle differs from ρ_i and ε_j in that there is no subscript (or, equivalently, the subscript may be the same for all members of the data set). The quantity \triangle is called a systematic error or a bias, terms which are often used interchangeably. Some users make a distinction between these two terms in the situation where the quantity \triangle is estimated in some way. The distinction made is that if observations in the data set are corrected on the basis of the estimate of \triangle , then \triangle is called a bias. However, since one cannot know \triangle precisely, but can only estimate it, it is clear that the observations cannot be completely corrected for the bias \triangle . There is a residual bias, consisting of the difference between \triangle and its estimate, and this residual bias is then called a systematic error. This distinction between bias and systematic error is not made by all modelers. The important idea to keep in mind is that whatever the \triangle quantity is called, the assumptions concerning \triangle must be stated or implied so that errors can be properly propagated corresponding to the assumed model.

In modeling, the distinction between the systematic error and the random error is that the subscript on the systematic error is the same for all members of the data set (or, equivalently, there is no subscript). If Δ is a random variable with zero mean and variance σ_{Δ}^2 , then σ_{Δ}^2 is called a systematic error variance. As a random variable, Δ is selected at random from some population just as was the random error, ρ_i or ε_i , the distinction being that, once selected, Δ is the same for all members of the data set.

In many safeguards applications, the effect of the systematic error is of dominant importance when compared with that of the random error. This is because, unlike the random error, the effect or impact of the systematic error cannot be reduced by taking additional measurements. The systematic error, as will be seen in later chapters, limits the effectiveness of safeguards from the material accounting point of view, unless steps can be taken to reduce its effect in some way. Merely making more measurements will not help.

2.4.3 Short-term Systematic Errors

The model (eq. 2.4.2) is further extended. Suppose that the six pellets are not all distributed to the same laboratory for analysis. Let

 k_k = deviation from the nominal due to the analysis being performed in laboratory k

Also suppose that within laboratory k, conditions change from one time-frame (day, shift, week, etc.) to the next so that

 $t_{m\left(k\right)}$ = deviation from the nominal due to the analysis being performed in time frame m within laboratory k

Note that in the case of $t_{m(k)}$, the subscript is written to indicate that the "time" effect is peculiar to a given laboratory. That is, time frame 1 in laboratory 1 does not correspond to time frame 1 in laboratory 2, say.

With ℓ_k and $t_m(k)$ defined, suppose that the model now becomes

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$$-13 - x_{1} = \mu + \Delta + \ell_{1} + t_{1(1)} + \rho_{1} + \epsilon_{1}$$

$$x_{2} = \mu + \Delta + \ell_{1} + t_{1(1)} + \rho_{2} + \epsilon_{2}$$

$$x_{3} = \mu + \Delta + \ell_{1} + t_{1(1)} + \rho_{3} + \epsilon_{3}$$

$$x_{4} = \mu + \Delta + \ell_{2} + t_{1(2)} + \rho_{4} + \epsilon_{4}$$

$$x_{5} = \mu + \Delta + \ell_{2} + t_{2(2)} + \rho_{5} + \epsilon_{5}$$

$$x_{6} = \mu + \Delta + \ell_{2} + t_{3(2)} + \rho_{6} + \epsilon_{6}$$
(eq. 2.4.3)

The model indicates that three of the pellets were sent to one laboratory where all three analyses were performed in the same time frame, and three were sent to a second laboratory where one analysis was performed in each of three time frames. Both laboratories used the same analytical technique and the random error variances due to analytical are assumed to be identical (indicated by use of ε_j for all six measurements).

The quantities ℓ_k and $t_{m(k)}$ differ from both the random error (ρ_i and ε_j) and the systematic error (Δ) in that for each error, the subscript is the same for some members of the data set, but not for all. Thus, ℓ_k and $t_{m(k)}$ are neither random nor systematic errors, but are some kind of intermediate type error.

In this particular application, ℓ_k may be called a laboratory error or effect, and $t_m(k)$ may be called a time effect, or a laboratory condition effect. In more general terminology, this kind of error that is intermediate to a random and a systematic error has been rather commonly referred to as a short-term systematic error in safeguards applications. In making a distinction between this and the systematic error, the latter is sometimes called a long-term systematic error.

It should be noted here that the distinction that is made between random errors, systematic errors, and short-term systematic errors is with respect to the particular set of data under discussion. For example, if the data set under consideration were to consist of only the first three observations rather than all six, then ℓ_k and $t_m(k)$ would both be (long-term) systematic errors rather than short-term systematic errors, for then the subscript would be the same for all members of the data set.

Before leaving this section on short-term systematic errors, an important side-issue comment is made with respect to the error $t_{m(k)}$. This point is made because of its importance both with respect to the interpretation of data from interlaboratory experiments (see Section 2.6.5), and also as it affects the analysis of inspection data.

For laboratory 1, since all measurements are performed in the same time frame, one cannot distinguish between the time effect and the laboratory effect. This is

an important point because one professed aim of interlaboratory experiments is to remove the effects of differences between laboratories by correcting all results to some base value, that is, by obtaining estimates of the ℓ_k 's and correcting for the laboratory effects. However, this approach does not recognize the importance of the time effect, $t_m(k)$ which is usually confounded with or indistinguishable from the laboratory effect ℓ_k . Thus, when one attempts to remove laboratory biases in this way, the results are only applicable to the given time frame that existed at the time of the interlaboratory experiment. The between-time variance, σ_t^2 , may well be a dominant effect when compared with σ_ℓ^2 , in which case it would be misleading to conclude that one can correct for differences between laboratories. Rather, in most instances, one would use interlaboratory data to obtain the combined estimate, $\sigma_\ell^2 + \sigma_\ell^2$, which becomes a systematic error variance, long term, when applied only to a given laboratory, and short term otherwise. In this instance, one usually calls this simply a between laboratory variance, it being understood that the time effect is implicitly included in that variance component. Note that for laboratory 2, the measurements are made at three different times, but this may not be the usual mode in inter-laboratory experiments.

2.5 EFFECTS OF ERRORS

Much of this Volume deals with the effects of errors on quantities of safeguards importance in a very detailed way. The discussion in this section anticipates the more detailed presentations to follow in later chapters, and is intended to provide an overview of the role played by errors of measurement. First, the effect of errors on facility MUF is discussed, and then the effect on operator and inspector comparisons is considered.

2.5.1 Effect on Facility MUF

A given facility reports a MUF at the end of each material balance period, i.e., upon completion of a physical inventory. The MUF is affected by errors of measurement. It is also affected by unmeasured inventories, unmeasured loss streams, and mistakes in the recording, transmittal, and reporting of data. It would also be affected, of course, by any thefts or diversions. As a first step in the evaluation of the facility MUF, only the effect of measurement errors is taken into account. That is, one wants to make probability statements about the true MUF on the basis of the observed MUF and its calculated standard deviation due to errors of measurement. The true MUF, which includes the effects of all factors other than the errors of measurement, may then be further evaluated, but this further evaluation may be largely non-statistical in nature.

Associated with each MUF is an actual standard deviation describing its uncertainty. There is also a calculated or reported standard deviation. It is highly unlikely that these agree exactly, although the extent to which they disagree may be difficult to characterize. The disagreement comes about because of one or more of a number of reasons:

(1) The actual input measurement error variances will not be the same as their estimated values used in the error propagation.

(2) There are approximations used in the error propagation.

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- (3) The errors may be improperly propagated, even though the approximate nature of the propagation may not lead to a serious discrepancy. Improper propagation could occur because of a large number of reasons. Some common ones being:
 - (a) Treating constant element or isotope factors as having no associated error
 - (b) Failing to account for items that are identically a part of two cancelling components of the MUF calculation (e.g., in receipts and ending inventories)
 - (c) Making arithmetic mistakes

While keeping in mind that the calculated standard deviation of MUF is not the actual standard deviation (a quantity that will not be known), nevertheless the calculated standard deviation is used in making judgements about the significance of the MUF. The inspector need not proceed on blind faith and accept the facility's calculated MUF. Experience with similar plants provides guidelines as to what is a reasonable value for the standard deviation. Any large differences between calculated and guideline values can be investigated as to cause, and the calculated value appropriately corrected if found to be in error.

Assuming that the calculated standard deviation of MUF is a reasonably correct value, a diagnostic look at the calculations will reveal what are the major sources of error. An identification can then be made of possible steps that might be taken to reduce its size. On the other hand, study may also reveal that excessive measurement effort is being made in some instances; measurement effort may well be better directed elsewhere. In short, it is worthwhile to go beyond the simple calculation of the standard deviation of MUF, and use the calculations to redirect measurement effort as judged desirable.

This diagnostic look may well reveal that the standard deviation of MUF is limited in size by systematic errors. Unfortunately, it is not a simple matter to obtain estimates of systematic error variances in all cases, nor is it possible to reduce their effects without extensive effort, if at all. (It is faulty reasoning to suppose that extensive system recalibrations will eliminate systematic errors, although it is a step in the right direction.) One conclusion that might follow is that too much effort in the facility measurement control program is being directed at obtaining current estimates of random error variances whose effects on the standard deviation of MUF may be negligible in a relative sense. This information, if put to use, may be quite important to a facility burdened by measurements made solely for safeguards purposes. The facility and the inspectorate can jointly benefit by careful study of the calculations affecting the standard deviation of MUF.

2.5.2 Effect on Inspector-Operator Comparisons

One principal aim of an Agency inspection is to make a quantitative verification of the facility MUF. This verification makes use of the \hat{D} statistic, treated

in detail in the next chapter, but which for present purposes is defined as simply the estimate of the difference between the facility MUF and the inspector's estimate of this quantity. It is based on paired comparisons between the operator's and inspector's measured values on an item-by-item basis.

As with MUF, the quantity \hat{D} is affected by errors of measurement. Unlike MUF, which is affected only by facility measurements, the uncertainty in \hat{D} is also affected by uncertainties in inspector measurements. Also, whereas the standard deviation of MUF is often limited in size by systematic errors, this may not necessarily be the case with \hat{D} because much fewer measurements are made by the inspector than by the facility. Further, only those facility measurements that are involved in the inspector comparisons affect the standard deviation of \hat{D} , so that the contribution to the random error variance of \hat{D} due to the facility measurements will be relatively much larger than their contribution to the variance of MUF.

As will be seen in Chapter 4, the random error variances will determine how many measurements the inspector will make and how he will allocate these among the various flow and inventory items. Thus, for purposes of inspection, it is necessary to have good estimates of the inspector's and the facility's random error variances.

It may be true in some applications that systematic error variances for the operator and/or the inspector are of such a size that the inspection sample sizes are limited in the sense that further measurements beyond a minimum number will have negligible effect on the variance of \hat{D} . In this limiting case, if the systematic error variances for the facility and for the inspector are roughly equivalent in size, then the variance of \hat{D} is twice the variance of MUF.

Another statistic of importance in Agency inspections is the so-called $(MUF-\hat{D})$ statistic, which is interpreted as the facility MUF adjusted for biases on the basis of the inspection data. An attractive property of $(MUF-\hat{D})$ is that it is unaffected by the operator's systematic errors. In a sense, it is the facility MUF with the operator's systematic errors replaced by the inspector's. The advantage is obvious: the inspector should be better able to evaluate and control his systematic errors than he can the operator's. This $(MUF-\hat{D})$ statistic will also be studied in detail in later chapters.

2.6 ERROR ESTIMATION

It should be apparent from the preceding sections that it is important to have valid information about measurement error variances. This information can come from a potentially large number of sources. In the balance of this chapter, methods will be given for obtaining estimates of the various measurement parameters. The techniques given are not intended to include all possible means of estimating measurement error variances, but do include those most often applied.

There are five main sub-topics: Measurements of Standards, Calibration of Measurement Systems, Measurements of Non-standard Materials, Error Estimation in the Presence of Rounding Errors, and Interlaboratory Test Data.

2.6.1 Measurements of Standards

A physical standard is an item having an assigned value associated with it for the characteristic in question. The value may be known without error, or it may have an error associated with it. In Section 2.6.1.1, the case of a single standard is considered. In 2.6.1.2, several physical standards are involved. In 2.6.1.3, measurements are made on a standard distributed over time.

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2.6.1.1 Single Standard

A given standard is measured n times under a given set of conditions. The data are to be used to estimate the measurement bias and make a decision whether or not to apply a bias correction to measurement data generated by the measurement system under the same set of conditions. Whether or not the bias correction is to be applied, the systematic error variance for the measured result is to be estimated. In the case of an uncorrected result, the mean square error is used to describe the systematic error variance. The mean square error is the expected value of the square of the difference between the measured and true values. An estimate of the random error variance for the measured result will also be given, but this estimate may be unrealistic in some instances. Better estimates of random error variances come from measurements on production items (see Section 2.6.3).

Method 2.1

<u>Notation</u>

 $\mu_o = assigned value of standard$ $<math>\sigma_o = standard$ deviation of assigned value $\bar{x} = average$ of the n measurements on the standard $s^2 = sample$ variance of these n measurements

y_i = measured value for production item j

Results

The estimated bias is

$$\hat{\theta} = (\bar{x} - \mu_0)$$
 (eq. 2.6.1)

The bias corrected result is

$$y_{j} = y_{j} - \hat{\theta}$$
 (eq. 2.6.2)

If the bias correction is applied, the estimate of the systematic error variance for the bias corrected result is

$$\sigma_0^2 + s^2/n$$
 (eq. 2.6.3)

If the bias correction is not applied, the estimate is

$$\hat{\theta}^2 = (\bar{\mathbf{x}} - \mu_0)^2$$
 (eq. 2.6.4)

which does not involve σ_0^2 , the variance of the assigned standard value. (It is noted that neither estimate is of very high quality in a statistical sense in this problem situation since they are one-degree-of-freedom estimates).

Based on statistical considerations, one would tend to apply a bias correction if the expression (2.6.3) is smaller than (2.6.4). If applied, the correction should be made at the time the measurement is made and not after the fact because of the administrative problems occurring when correcting past data.

Whether the bias correction is applied or not, the estimated random error variance for the reported result is simply s^2 .

Basis

The principle of maximum likelihood is applied [2.2]. For a full discussion of this principle as applied to this particular problem situation, see [2.3]. Reference [2.4] is also pertinent.

Examples

EXAMPLE 2.1 (a)

A plutonium standard has an assigned value of 22.12% Pu. Its uncertainty is described by the standard deviation, $\sigma_0 = 0.04\%$ Pu. Twelve analyses are made on the standard. Analyze the data to see if a bias correction should be made, and find the systematic and random error variances for the reported result (bias corrected or not). The data are listed.

$x_i = \% Pu$	$x_i = \% Pu$	$x_i = \% Pu$
22.12	22.16	22.06
22.06	22.09	22.08
22.16	22.13	22.05
22.07	22.08	22.06

The pertinent values are

μο	Ξ	22.12	x =	22.0933
σ	=	0.04	$s^2 =$	0.001552

By (eq. 2.6.1), the estimated bias is

 $\hat{\theta} = -0.0267$

If the bias correction is applied, the systematic error variance of a reported result is

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 $(0.04)^2 + (0.001552)/12 = 0.001729$

If the bias correction is not applied, then the systematic error variance is

 $(-0.0267)^2 = 0.000713$

Since this is smaller than 0.001729, the appropriate action would be to not apply the bias correction. This is because the standard value is so poorly known; there is not conclusive evidence that the measurement system is biased. Whether or not the bias correction is applied, the random error variance is 0.001552.

EXAMPLE 2.1 (b)

A standard weight is weighed at periodic intervals on a scale used to weigh fuel columns as they are loaded into rods. The scale reads net weights directly to the nearest 0.5 gram. On n = 42 weighings of the standard, the following frequency of the observed minus standard weights was found. The standard weight is to be known without error.

$(x_i - \mu_o)$ grams	Frequency
1.0	1
0.5	5
0.0	14
-0.5	19
-1.0	2
-1.5	
	42

The pertinent values are

 $(\bar{x} - \mu_0) = -0.226$ $\sigma_0 = 0$ $s^2 = 0.2220$

If the bias correction is applied, the systematic error variance is 0.2220/42 = 0.00529. If it is not applied, it is $(-0.226)^2 = 0.05108$, almost ten times as large. Based solely on statistical considerations, it would seem appropriate in this case to apply the bias correction.

In this particular application, however, it is difficult to justify correcting past data for the bias which, although statistically significant, is quite small. The problem in making the correction to past data is an administrative one, likely affecting also fuel rods already shipped. A more appropriate action in this instance would be to try and adjust the scale to eliminate or reduce the bias or, failing that, possibly to bias correct future data as they are generated.

2.6.1.2 Several Standards

There are two general types of situations in which more than one standard may be measured. In the first type of application, a given scale is to be used to measure gross and tare weights to determine the net weight for an item. The bias in the scale is to be evaluated at both the gross and tare weight ranges in order to estimate the bias for a reported net weight. In the second situation, more than one physical standard is measured but it is assumed that any bias is constant over the range covered by the standards. The standards may have different associated uncertainties, and they may be measured different numbers of times. The problem is to estimate the overall bias and to find the random and systematic error variances of the reported result on a production item, whether or not it is corrected for bias.

In what follows, Method 2.2 applies to the first situation and Method 2.3 to the second.

Method 2.2

Notation

 $\begin{array}{l} \mu_g = \mbox{assigned value of gross weight standard} \\ \mu_t = \mbox{assigned value of tare weight standard} \\ \sigma_g = \mbox{standard deviation of assigned gross weight standard value} \\ \sigma_t = \mbox{standard deviation of assigned tare weight standard value} \\ \bar{x}_g = \mbox{average of } n_g \mbox{ measurements on gross weight standard} \\ \bar{x}_t = \mbox{average of } n_t \mbox{ measurements on tare weight standard} \\ s_g^2 = \mbox{sample variance of the } n_g \mbox{ measurements} \\ s_t^2 = \mbox{sample variance of the } n_t \mbox{ measurements} \\ y_i = \mbox{measurement of the } n_t \mbox{ measurements} \\ y_i = \mbox{measurement of the } n_t \mbox{measurements} \\ \end{array}$

Results

The estimated bias in the net weight is

$$\hat{\theta} = (\bar{x}_{q} - \mu_{q}) - (\bar{x}_{t} - \mu_{t})$$
 (eq. 2.6.5)

The bias- corrected result is

$$y_{j} = y_{j} - \hat{\theta}$$
 (eq. 2.6.6)

If the bias correction is applied, the estimate of the systematic error variance for the bias corrected result is

$$\sigma_g^2 + \sigma_t^2 + s_g^2/n_g + s_t^2/n_t$$
 (eq. 2.6.7)

If the bias correction is not applied, the estimate is simply $\hat{\theta}^2$, from (eq. 2.6.5).

Based on statistical considerations, one would tend to apply a bias correction if the expression (2.6.7) is smaller than $\hat{\theta}^2$. If applied, the correction should be made at the time the measurement is made, and not after the fact.

Whether the bias correction is applied or not, the random error variance for the reported result is

 $s_g^2 + s_t^2$ (eq. 2.6.8)

Basis

The basis is the same as for Method 2.1 with a simple extension to include both the gross and tare weight standards.

Examples

EXAMPLE 2.2 (a)

A case history dealing with the estimation of scale accuracy and precision is given in reference [2.5]. Suppose that standards S and P in that reference and weighed in combination correspond to a typical gross weight while standard B is the tare weight standard. From the reference, the following information is derived.

 μ_{g} = 8878.0 g ; μ_{t} = 1591.7 g ; σ_{g} = σ_{t} = 0.97 g

Assume that weighings of these standards yield the following data:

ng	=	30	ⁿ t	=	20	
₹ _g	1	8881.3 g	^x t	=	1589.9 g	ļ
sg	=	6.2 g	s _t	=	4.9 g	

The estimated bias in the net weight is

 $\hat{\theta} = 3.3 + 1.8 = 5.1 \text{ g}$

If the bias correction is applied, the systematic error variance of the bias corrected result is

$$2(0.97)^2 + (6.2)^2/30 + (4.9)^2/20 = 4.36 g^2$$

If the bias correction is not applied, this variance is

 $(5.1)^2 = 26.01 g^2$

In this example, since 4.36 < 26.01, one would apply the bias correction on the basis of statistical considerations alone, assuming that scale adjustments could not reduce the bias to a more acceptable lower value.

Method 2.3

Notation

 $\label{eq:main_k} \begin{array}{l} m = number of standards \\ n_k = number of measurements on standard k \\ \mu_k = assigned value for standard k \\ \sigma_k = standard deviation of assigned value, standard k \\ \overline{x}_k = average of the measurements on standard k \\ s_k^2 = sample variance of these measurements \\ \end{array}$

Results

The estimated bias is the weighted average

$$\hat{\theta} = \sum_{k=1}^{m} w_k (\bar{x}_k - \mu_k) / \sum_{k=1}^{m} w_k$$
 (eq. 2.6.9)

where

$$w_k = (\sigma_k^2 + s^2/n_k)^{-1}$$
 (eq. 2.6.10)

and where s^2 is the estimated random error variance,

$$s^{2} = \sum_{k=1}^{m} (n_{k} - 1) s_{k}^{2} / (n-m)$$
 (eq. 2.6.11)

n being the total number of observations,

$$n = \sum_{k=1}^{m} n_k$$
 (eq. 2.6.12)

If the bias correction is applied, the estimate of the systematic error variance for the bias corrected result is

$$\left(\sum_{k=1}^{m} w_{k}\right)^{-1}$$
 (eq. 2.6.13)

If the bias correction is not applied, the estimate is simply $\hat{\theta}^2$, from (eq. 2.6.9).

As with Methods 2.1 and 2.2, one would tend to correct for bias if expression (2.6.13) is smaller than $\hat{\theta}^2$.

Basis

The estimate of the bias is a weighted estimate where the weights are the inverses of the variances of the estimated biases for each condition. This is a standard weighting procedure and leads to the result that the variance of the weighted average is the reciprocal of the summed weights [2.6].

Examples

EXAMPLE 2.3 (a)

Three standards are used in controlling the measurement quality of a mass spectrometer. The standard values in percent U-235 are 2.013, 3.009, and 4.949 respectively. The observations on these standards are as follows:

<u>Standard 1</u>	<u>Standard 2</u>	<u>Standard 3</u>
2.013	3.009	4.953
2.018	3.013	4.957
2.015	3.010	4.949
2.015	3.017	4.946
2.013	3.009	
2.010	3.008	
	3.013	
	3.010	
	3.011	
	3.006	

Assume that errors are constant on a relative basis. From Section 2.3.2, then, it is appropriate to transform the data to natural logarithms. The standard values in this transformed scale become:

 $\mu_1 = \ln 2.013 = 0.69963$; $\mu_2 = 1.10161$; $\mu_3 = 1.59919$

The errors in the standards are each 0.05% relative at one standard deviation.

$$\sigma_{1} = \sigma_{2} = \sigma_{3} = 0.0005$$

$$\bar{x}_1 = 0.70012$$
 $\bar{x}_2 = 1.10214$ $\bar{x}_3 = 1.59964$
 $s_1^2 = 1.7798 \times 10^{-6}$ $s_2^2 = 1.0567 \times 10^{-6}$ $s_3^2 = 0.9330 \times 10^{-6}$

Further parameter values are:

$$m = 3 \quad n_{1} = 6 \quad n_{2} = 10 \quad n_{3} = 4 \quad n = 20$$

The first step is to calculate s² from (eq. 2.6.11)
$$s^{2} = \left[(5) (1.7798) + (9) (1.0567) + (3) (0.9300) \right] \times 10^{-6} / 17$$
$$= 1.2470 \times 10^{-6}$$

The weights are, from (eq. 2.6.10),

$$w_{1} = \left[(0.0005)^{2} + 1.2470 \times 10^{-6} / 6 \right]^{-1} = 2.1842 \times 10^{6}$$
$$w_{2} = 2.6688 \times 10^{6} ; \qquad w_{3} = 1.7802 \times 10^{6}$$

$$\sum_{k=1}^{3} w_{k} = 6.6332 \times 10^{6}$$

The estimated bias is, from (eq. 2.6.9),

$$\hat{\theta} = \left[(2.1842) (0.00049) + . . . + (1.7802) (0.00045) \right] / 6.6332$$

= 0.0004954

If the bias correction is applied, the estimate of the systematic error variance for the bias corrected result is, by (2.6.13)

 $(6.6332 \times 10^6)^{-1} = 0.1508 \times 10^{-6}$

The standard deviation is 0.00039 or 0.039% relative.

If the bias correction is not applied, then the estimated error variance is

 $(0.0004954)^2 = 0.2454 \times 10^{-6}$

Since this is larger than 0.1508×10^{-6} , one would make the bias correction based on statistical considerations.

2.6.1.3 Measurements at Different Times

Thus far in the discussion, it has been assumed that the standard or standards being measured by the measurement system has been measured under a fixed set of conditions. The estimate of the bias or systematic error derived from the data apply to items measured under that same set of conditions.

In many measurement systems, the bias will not remain stable as the conditions change. Commonly, it is not possible to identify the reasons for shifting biases that may be observed in different time frames. In some cases, reasons for shifting biases may be apparent, e.g., changes in measuring instruments, operators, or environmental conditions. Whatever the explanations, in describing the total error of measurement, the effects of an overall average bias and of the degree to which it may shift from one set of conditions to another must be taken into account. In addition, the assigned value of the standard may have an associated uncertainty, and this effect must be included.

Method 2.4 to follow, then, deals with the problem in which a standard with assigned value μ_0 is measured n_i times under condition i. The data are to be used to estimate an average bias, possibly apply a bias correction to future measurements on production items, and obtain estimates of the random and systematic measurement errors, whether or not the bias correction is applied.

Method 2.4

Notation

 μ_{a} = assigned value for standard

x_{ii} = observed value for j-th measurement under condition i

 n_i = number of measurements made under condition i

- n = total number of measurements
- m = number of conditions
- σ_{α} = standard deviation of assigned value
- σ_{2}^{2} = random error variance
- σ^2 = variance among condition means (short term systematic θ error variance
- ykj = measured value for production item j measured under condition k

<u>Results</u>

Calculate the following quantities:

$$T_{i} = \sum_{j=1}^{n_{i}} x_{ij}$$
; $T = \sum_{i=1}^{m} T_{i}$

$$S_{0} = T^{2}/n \qquad S_{1} = \sum_{i=1}^{m} T_{i}^{2}/n_{i}$$

$$S_{2} = \sum_{i=1}^{m} \sum_{j=1}^{n_{i}} x_{ij}^{2} \qquad P = \left(n^{2} - \sum_{i=1}^{m} n_{i}^{2}\right)/(n(m-1))$$

$$M_{B} = (S_{1} - S_{0})/(m-1) \qquad M_{W} = (S_{2} - S_{1})/(n-m)$$

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Then, the estimated bias is

$$\hat{\theta} = (T/n - \mu_0)$$
 (eq. 2.6.14)

The bias corrected result is

$$y_{kj} = y_{kj} - \hat{\theta}$$
 (eq. 2.6.15)

The estimates of σ_ϵ^2 and σ_θ^2 are

$$\hat{\sigma}_{\varepsilon}^{2} = M_{W} \qquad (eq. 2.6.16)$$

$$\hat{\sigma}_{\theta}^{2} = (M_{B} - M_{W})/P$$
 (eq. 2.6.17)

If the bias correction is applied, the estimate of the systematic error variance for the bias corrected result, y_{kj} , is

$$\sigma_0^2 + \hat{\sigma}_\theta^2 \sum_{i=1}^m n_i^2/n^2 + \hat{\sigma}_\epsilon^2/n$$
 (eq. 2.6.18)

If the bias correction is not applied, this estimate is simply $\hat{\theta}^2,$ from (eq. 2.6.14)

<u>Basis</u>

The statistical technique that forms the basis for this method is the one way analysis of variance. The parameter estimates are derived from the analysis of variance table.

One Way ANOVA Table

Source of Variation	Degrees of Freedom	<u>Mean Square</u>	Expected Mean Square
Between conditions	m-1	м _В	$\sigma_{\epsilon}^{2} + P \sigma_{\theta}^{2}$
Within conditions	n-m	Mw	σ^2_{ε}

The analysis of variance is covered in many standard texts. See, for example, [2.7].

Examples

EXAMPLE 2.4 (a)

Mass spectrometer measurements are made at four time periods on a known standard of nominal 3.046% U-235. The standard deviation associated with this value is 0.0006% U-235. The data are as follows:

<u>Time 1</u>	<u>Time 2</u>	<u>Time 3</u>	<u>Time 4</u>
3.095 3.086 3.058 3.073	3.044 3.078 3.046 3.060 3.023 3.072	3.019 3.045 3.022	3.090 3.073 3.053 3.081

In this example, it is not necessary to transform the data to logarithms because only the one standard is used. One could, of course, perform the transformation, in which case the estimates of the standard deviations would be on a relative basis rather than an absolute basis.

The various quantities are calculated.

 $T_{1} = 12.312 \quad T_{2} = 18.323 \quad T_{3} = 9.086 \quad T_{4} = 12.297$ T = 52.018 $S_{0} = 159.168960 \quad S_{1} = 159.174242$ $S_{2} = 159.178232 \quad P = 4.157$ $M_{B} = 0.001761 \quad M_{W} = 0.000307$

Then, by (eq. 2.6.14),

 $\hat{\theta} = 0.0139$

By (eq. 2.6.16) and (eq. 2.6.17),

 $\hat{\sigma}_{2}^{2} = 0.000307$ (random error)

 $\hat{\sigma}_{A}^{2}$ = 0.000350 (short term systematic error)

If the bias correction is applied, the systematic error variance for the bias corrected result is, by (eq. 2.6.18),

 $(0.0006)^2 + (0.000350) (77)/289 + (0.000307)/17 = 0.000112$

If the bias correction is not applied, this variance becomes

 $(0.0139)^2 = 0.000193$

Since 0.000193 exceeds 0.000112, one would tend to correct for bias in this instance.

EXAMPLE 2.4 (b)

In the example just concluded, suppose that the time grouping were ignored. The data would then be analyzed by Method 2.1. The bias estimate, $\hat{\theta}$ is still 0.0139. However, the estimate of the systematic error variance would be different. For these data:

 $s^2 = 0.0005795$

n = 17

Thus, from (eq. 2.6.3), if the bias correction is applied, the estimate of the systematic error variance is

 $(0.0006)^2$ + (0.0005795)/17 = 0.00003445, compared with 0.000112 when the time grouping is taken into account as it should be. If the bias correction were not applied, the estimate of the systematic error variance would be the same as in the preceding example.

This example illustrates the importance of correctly specifying the model for the statistical analysis. The existence of the short-term systematic error in this set of data must be accounted for in the analysis.

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2.6.2 Calibration of Measurement Systems

The problem of calibration is closely related to that of measuring standards (Section 2.6.1) in that physical standards are also used in the calibration problem. In calibration, the measured response (Y) is related to the standard value (X) in some functional way, depicted by Y = f(X). The quantities Y and X may not be in the same units, e.g., X may be in grams U-235 and Y may be in count rates for an NDA counter. The calibration problem involves estimating the parameters for the function f(X) so that the relationship may be used to relate an observed response for a production item, observed on the Y scale, to an estimated value on the X scale for that item. Various statements about error variances are also made on the basis of the calibration data.

Various calibration problems are treated. First the case in which the functional relationship is linear and the variance of the measured response is constant over the range of calibration is covered.

2.6.2.1 Linear Calibration; Constant Variance

The measured response, Y, is related to the assigned value, X, by a linear relationship. At any fixed value of X, Y is normally distributed with mean value given by the linear relationship and with unknown but constant variance. The calibration data consist of n pairs of observations.

The calibration process leads to obtaining estimates of the parameters (slope, intercept, variance). The estimated calibration equation is then used for measuring production items, and random and systematic error variances are derived for the production item characteristic value corresponding to this response.

Two cases are considered. In Method 2.5, it is assumed that the intercept parameter is known. When this known value is zero, a special case, then the calibration curve passes through the origin. Method 2.6 covers the case when the value for the intercept parameter is not known.

Method 2.5

Notation

 $(y_i, x_i) = i$ -th data point; i = 1, 2, ..., n $\alpha = intercept parameter (known)$ $\beta = slope parameter (unknown)$ $y_i = \alpha + \beta x_i$, calibration equation $\sigma^2 = variance of y_i$ at given x_i Results

Calculate the following quantities:

$$S_{1} = \sum_{i=1}^{n} x_{i} \qquad S_{2} = \sum_{i=1}^{n} x_{i}y_{i} \qquad S_{3} = \sum_{i=1}^{n} x_{i}^{2}$$
$$S_{4} = \sum_{i=1}^{n} y_{i} \qquad S_{5} = \sum_{i=1}^{n} y_{i}^{2}$$

The parameter estimates are

$$\hat{\beta} = (S_2 - \alpha S_1)/S_3$$
 (eq. 2.6.19)

$$(n-1) \hat{\sigma}^2 = (S_5 - 2\alpha S_4 + n\alpha^2) - (S_2 - \alpha S_1)^2 / S_3 \qquad (eq. 2.6.20)$$

For a production item, the measured response is y_0 . The corresponding characteristic value for the item is x_0 , estimated by

$$\hat{x}_{0} = (y_{0} - \alpha)/\hat{\beta}$$
 (eq. 2.6.21)

The quantity $\hat{\beta}$, once calculated, behaves as a constant. Thus, the uncertainty in $\hat{\beta}$ affects \hat{x}_0 as a systematic error. Denoting the systematic error variance of \hat{x}_0 by $V_S(\hat{x}_0)$, it is given by

$$V_{s}(\hat{x}_{0}) = (y_{0} - \alpha)^{2} V(\hat{\beta})/\hat{\beta}^{4}$$

= $\hat{x}_{0}^{2}V(\hat{\beta})/\hat{\beta}^{2}$ (eq. 2.6.22)

where $V(\hat{\beta})$ is the variance of $\hat{\beta}$, given by

$$V(\hat{\beta}) = \hat{\sigma}^2 / S_{3}$$
 (eq. 2.6.23)

The random error variance of \hat{x}_{0} is denoted by $V_{r}(\hat{x}_{0})$

$$V_{r}(\hat{x}_{0}) = \hat{\sigma}^{2}/\hat{\beta}^{2}$$
 (eq. 2.6.24)

Consider k measured responses: y_{01} , y_{02} , ..., y_{0k} and the corresponding values calculated by (eq. 2.6.21) and denoted by \hat{x}_{01} , \hat{x}_{02} , ..., \hat{x}_{0k} . Letting \hat{x}_{ot} be the sum of these \hat{x}_{oj} values, consider the random and systematic error variances of \hat{x}_{ot} . These are

$$V_r(\hat{x}_{ot}) = k \hat{\sigma}^2 / \hat{\beta}^2$$
 (eq. 2.6.25)

and

$$V_{s}(\hat{x}_{ot}) = \hat{x}_{ot}^{2} V(\hat{\beta})/\hat{\beta}^{2}$$
 (eq. 2.6.26)

Equivalently, if \bar{x}_0 denotes the average value, i.e., \hat{x}_{ot} divided by k, then

$$V_{s}(\hat{x}_{ot}) = k^{2}\bar{x}_{0}^{2} V(\hat{\beta})/\hat{\beta}^{2}$$
 (eq. 2.6.27)

Equation 2.6.22 may be considered a special case of (eq. 2.6.27) with k=1.

Basis

The estimate given by (eq. 2.6.19) and (eq. 2.6.20) are maximum likelihood estimates [2.2]. Equivalently, $\hat{\beta}$ is derived from the principle of least squares, i.e., it is the value of β that minimizes the sum of squares:

$$Q = \sum_{i=1}^{n} (y_i - \alpha - \beta x_i)^2 \qquad (eq. 2.6.28)$$

The expressions for the variances of the quantities of interest are based on error propagation methods to be discussed in Chapter 3.

Examples

EXAMPLE 2.5 (a)

A SAM NDA instrument is calibrated for use in measuring non-fissile plutonium. Calibration data relating net count data in $CPMx10^{-3}$ to grams of non-fissile plutonium are as follows:

$x_i = g Pu$	y_i = net count rate (CPMx10 ⁻³)
104.29	141.022
208.58	286.928
312.87	420.571
406.73	545.497
417.16	557.069

Assuming a zero intercept linear model with constant variance, estimate the calibration curve. Four coupons are then counted, the counts per minute being 549,172; 319,614; 277,328; and 401,616 respectively. Estimate the total amount of plutonium in these four coupons, and find the associated random and systematic error variances. The quantities S_1-S_5 are calculated. $S_1 = 1449.63$ $S_2 = 660395.5742$ $S_3 = 491721.4159$ $S_4 = 1951.087$ $S_5 = 886987.6955$ By (eq. 2.6.19) and (eq. 2.6.20), with $\alpha = 0$ $\hat{\beta} = 1.3430$ $\hat{\sigma}^2 = 14.5057$ For the four coupons counted, from (eq. 2.6.21) $\hat{x}_{01} = 408.914$ $\hat{x}_{02} = 237.985$ $\hat{x}_{0,3} = 206.499$ $\hat{x}_{04} = 299.044$ $\hat{x}_{0t} = 1152.442 \text{ g Pu}$ From (eq. 2.6.25), (eq. 2.6.23), and (eq. 2.6.26), $V_r(\hat{x}_{ot}) = (4)(14.5057)/(1.3430)^2 = 32.170 \text{ g}^2 \text{ Pu}$ $V(\hat{\beta}) = 14.5057/491721.4159 = 29.50 \times 10^{-6}$ $V_{s}(\hat{x}_{ot}) = (1152.442)^{2}(29.50) \times 10^{-6}/(1.3430)^{2} = 21.722 \text{ g}^{2} \text{ Pu}$

EXAMPLE 2.5 (b)

In Example 2.5 (a), assume that the intercept is known to be $\alpha = 10$. Then, $\hat{\beta} = 1.3135$ $\hat{\sigma}^2 = 11.6980$ (a better fit to the data) $V_r(\hat{x}_{ot}) = 27.121 \text{ g}^2 \text{ Pu}$ $V(\hat{\beta}) = 23.79 \times 10^{-6}$ $V_s(\hat{x}_{ot}) = 18.314 \text{ g}^2 \text{ Pu}$

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Method 2.6

<u>Notation</u>

Same as for Method 2.5 except that the calibration curve is rewritten to be

 $y_i = \gamma + \beta (x_i - \bar{x})$, where

 \bar{x} = average of the n x_i values

<u>Results</u>

Calculate the quantities ${\rm S}_1 {\rm -} {\rm S}_5$ as in Method 2.5. The parameter estimates are:

$$\hat{\gamma} = S_4/n$$
 (eq. 2.6.28a)

$$\hat{\beta} = (S_2 - S_1 S_4 / n) / (S_3 - S_1^2 / n)$$
 (eq. 2.6.29)

$$(n-2) \hat{\sigma}^2 = S_5 - S_4^2 / n - (S_2 - S_1 S_4 / n)^2 / (S_3 - S_1^2 / n) \qquad (eq. 2.6.30)$$

For a measured response y_0 , the corresponding value of x_0 is estimated by

$$\hat{x}_0 = [(y_0 - \hat{\gamma})/\hat{\beta}] + \bar{x}$$
 (eq. 2.6.30a)

The variances of $\hat{\gamma}$ and $\hat{\beta}$ are given below. They have zero covariance.

$$V(\hat{\gamma}) = \hat{\sigma}^2/n$$
 (eq. 2.6.31)

$$V(\hat{\beta}) = \hat{\sigma}^2 / (S_3 - S_1^2 / n)$$
 (eq. 2.6.32)

For k measured responses, with \bar{x}_0 denoting the average value calculated from the calibration curve, the random and systematic error variances of the total, \hat{x}_{ot} , are

$$V_r(\hat{x}_{ot}) = k \hat{\sigma}^2 / \hat{\beta}^2$$
 (eq. 2.6.33)

$$V_{s}(\hat{x}_{ot}) = k^{2} [V(\hat{\gamma}) + (\bar{x}_{o} - S_{1}/n)^{2} V(\hat{\beta})] / \hat{\beta}^{2}$$
 (eq. 2.6.34)

Basis

The basis is the same as for Method 2.5.

Examples

EXAMPLE 2.6 (a)

Example 2.5 (a) is reworked assuming that the intercept value is not known. From (eq. 2.6.28a)- (eq. 2.6.34),

 $\hat{\gamma} = 390.22$, $\hat{\beta} = 1.3260$, $\hat{\sigma}^2 = 11.2712$ $V(\hat{\gamma}) = 2.2542$, $V(\hat{\beta}) = 157.78 \times 10^{-6}$ $V_{\gamma}(\hat{x}_{ot}) = 25.641 \text{ g}^2\text{Pu}$, $V_{s}(\hat{x}_{ot}) = 1.282 \text{ g}^2\text{Pu}$

Note that for this particular set of \hat{x}_{0j} values, the systematic error of the total, \hat{x}_{0t} , is much smaller for the unknown intercept than for the known intercept case. This is because (x_0-S_1/n) is very nearly zero, and is not a general result.

EXAMPLE 2.6 (b)

For the data of Example 2.2 (a), estimate the scale calibration curve assuming that the relationship is linear with unknown intercept. An observed weight on the scale is then 6616.4 grams. What is the weight corrected for bias? What are the random and systematic error variances for this corrected weight?

In the notation of Method 2.6, $x_i = 8878.0$ for the first 30 observations and $x_i = 1591.7$ for the last 20 observations. The quantities S_1-S_5 are calculated.

 $S_1 = (30)(8878.0)+(20)(1591.7) = 298,174$

 $S_2 = (8878.0)(8881.3)(30) + (1591.7)(1589.9)(20) = 2,416,058,319$

 $S_3 = (30)(8878.0)^2 + (20)(1591.7)^2 = 2,415,236,698$

 $S_4 = (30)(8881.3) + (20)(1589.9) = 298,237$

 $S_5 = (29)(6.2)^2 + (30)(8881.3)^2 + (19)(4.9)^2 + (20)(1589.9)^2$

= 2,416,881,902

From (eq. 2.6.28a) - (eq. 2.6.32),

 $\hat{\gamma} = 5964.74$ $\hat{\beta} = 1.00070$ $\hat{\sigma}^2 = 32.7271$ $V(\hat{\gamma}) = 0.65454$ $V(\hat{\beta}) = 5.1370 \times 10^{-8}$ At $y_0 = 6616.4 \text{ g}$, the bias corrected weight is $\hat{x}_0 = (6616.4 - 5964.74)/1.00070 + 5963.48$ = 6614.68 g

From (eq. 2.6.33) and (eq. 2.6.34), with k = 1, the random and systematic errors for the bias corrected result are

$$V_{r}(\hat{x}_{0}) = 32.7271/(1.00070)^{2} = 32.6813 \text{ g}^{2}$$

 $V_{s}(\hat{x}_{0}) = 0.6754 \text{ g}^{2}$

Note: It was assumed for illustrative purposes in this rework of Example 2.2 (a) that the standards were known without error. This assumption is not valid, as was pointed out in Example 2.2 (a).

2.6.2.2 Linear Calibration; Non-Constant Variance

The calibration problem is identical to that discussed in Section 2.6.2.1 except that the variance in the response variable is not constant over the calibration range. This variance, denoted by σ_i^2 at the value x_i , is a known quantity.

As was the case in Section 2.6.2.1, two situations are covered. In Method 2.7, the intercept parameter is assumed to be known, while this parameter has an unknown value in Method 2.8.

Method 2.7

Notation

The notation is identical to that in Method 2.5 except that σ^2 is replaced by σ_{i}^2 , a known quantity.

Results

Calculate the following quantities.

 $w_i = 1/\sigma_i^2$ for each observation

$$S_{1} = \sum_{i=1}^{n} w_{i}x_{i} \qquad S_{2} = \sum_{i=1}^{n} w_{i}x_{i}y_{i} \qquad S_{3} = \sum_{i=1}^{n} w_{i}x_{i}^{2}$$
$$S_{4} = \sum_{i=1}^{n} w_{i}y_{i} \qquad S_{5} = \sum_{i=1}^{n} w_{i}y_{i}^{2}$$

The estimate of β is

 $\hat{\beta} = (S_2 - \alpha S_1)/S_3$ (eq. 2.6.35)

Its variance is

 $V(\hat{\beta}) = 1/S_3$ (eq. 2.6.36)

For $\hat{x}_0 = (y_0 - \alpha)/\hat{\beta}$, y_0 being a measured response for a production item, the random and systematic error variances are

$$V_r(\hat{x}_0) = \sigma_0^2 / \hat{\beta}^2$$
 (eq. 2.6.37)
 $V_s(\hat{x}_0) = \hat{x}_0^2 V(\hat{\beta}) / \hat{\beta}^2$ (eq. 2.6.38)

and

where σ_0^2 is the known variance of y_n .

For k measured responses, with \hat{x}_{ot} being the total for the $\hat{x}_{01},\,\hat{x}_{02},\,\ldots,\,\hat{x}_{ok}$ values,

$$V_r(\hat{x}_{ot}) = \sum_{i=1}^{k} \sigma_0^2 i / \hat{\beta}^2$$
 (eq. 2.6.39)

$$V_{s}(\hat{x}_{ot}) = \hat{x}_{ot}^{2} V(\hat{\beta})/\hat{\beta}^{2}$$
 (eq. 2.6.40)

Basis

The basis is the same as that for Method 2.5 except that a weighted least squares estimate of β is found (2.8). The quantity minimized is

$$Q = \sum_{i=1}^{n} (y_i - \alpha - \beta x_i) / \sigma_i^2$$

Examples

EXAMPLE 2.7 (a)

In calibrating a uranium solid waste barrel NDA system based on gamma counting, the model Y = β X is assumed, where Y is the net counts per 100 seconds and X is the grams U-235 in standard barrels. Given the following data for which the variance σ_i^2 is also known, estimate the calibration curve. Three production barrels are then counted, the count rates per 100 seconds being 20,192; 13,919; and 42,267 respectively. Estimate the total amount of U-235 in these barrels and find the random and systematic error variances for this estimate.

y _i	σį	Wi
2853	1.65x10 ⁵	6.06x10 ⁻⁶
11611	2.34x10 ⁵	4.27x10 ⁻⁶
18072	3.03x10 ⁵	3.30x10 ⁻⁶
27554	4.43x10 ⁵	2.26x10 ⁻⁶
38649	6.91x10 ⁵	1.45x10 ⁻⁶
53464	12.50x10 ⁵	0.80x10 ⁻⁶
	y _i 2853 11611 18072 27554 38649 53464	$\begin{array}{c c} \begin{array}{c} y_{i} & & \sigma_{i}^{2} \\ \hline 2853 & 1.65 \times 10^{5} \\ 11611 & 2.34 \times 10^{5} \\ 18072 & 3.03 \times 10^{5} \\ 27554 & 4.43 \times 10^{5} \\ 38649 & 6.91 \times 10^{5} \\ 53464 & 12.50 \times 10^{5} \end{array}$

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The quantities S_1 - S_5 are calculated $S_1 = 0.00010659$ $S_2 = 2.951828$ $S_3 = 0.00110833$ $S_4 = 0.28759004$ $S_5 = 7871.2519$ For $\alpha = 0$, $\hat{\beta}$ is calculated from (eq. 2.6.35) $\hat{\beta} = 2663$ Its variance is $V(\hat{\beta}) = 902.26$ For the three production barrels, $\hat{x}_{0+} = (20192 + 13919 + 42267)/2663$ = 28.68 g U-235 By interpolation in the data table, (logarithmically on σ_i^2) $\sigma_{01}^2 = 3.30 \times 10^5$ $\sigma_{02}^2 = 2.66 \times 10^5$ $\sigma_{03}^2 = 7.99 \times 10^5$ $\sum_{i=1}^{k} \sigma_{0i}^2 = 13.95 \times 10^5$ By (eq. 2.6.39) and (eq. 2.6.40), $V_r(\hat{x}_{ot}) = 13.95 \times 10^5 / (2663)^2 = 0.1967$ $V_{s}(\hat{x}_{ot}) = 0.1047$

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Method 2.8

Notation

Same as for Method 2.7 except that the calibration curve is rewritten to be $y_i = \gamma + \beta (x_i - \bar{x})$, where \bar{x} = weighted average of the n x_i values

Results

Calculate w_i and the quantities S_1-S_5 as in Method 2.7. Also calculate S_6 , the sum of the w_i's. The parameter estimates are:

$$\hat{\gamma} = S_4 / S_6$$
 (eq. 2.6.41)

$$\hat{\beta} = (S_2 - S_1 S_4 / S_6) / (S_3 - S_1^2 / S_6)$$
 (eq. 2.6.42)

The variances are:

$$V(\hat{\gamma}) = 1/S_6$$
 (eq. 2.6.43)

$$V(\hat{\beta}) = \frac{1}{(S_3 - S_1^2/S_6)}$$
 (eq. 2.6.44)

For a measured response y_0 , the corresponding value of x_0 is estimated by

$$\hat{x}_0 = [(\hat{y}_0 - \hat{y})/\hat{\beta}] + \bar{x}$$
 (eq. 2 6.44a)

For <u>k</u> measured responses (k = 1 is a special case), with \hat{x}_{ot} being the total amount and x_{o} being \hat{x}_{ot}/k ,

$$V_r(\hat{x}_{ot}) = \sum_{i=1}^{k} \sigma_{oi}^2 / \hat{\beta}^2$$
 (eq. 2.6.45)

$$V_{s}(\hat{x}_{ot}) = k^{2} [V(\hat{\gamma}) + (\bar{x}_{o} - \bar{x})^{2} V(\hat{\beta})] / \hat{\beta}^{2}$$
 (eq. 2.6.46)

where

$$\bar{x} = S_1/S_6$$
 (eq. 2.6.47)

Basis

The basis is the same as for Method 2.7.

Examples

EXAMPLE 2.8 (a)

Rework Example 2.7 (a) given that the intercept is not zero, but is to be estimated.

The quantities ${\rm S_{1}-S_{5}}$ were calculated in Example 2.7 (a) along with the w_i. Also,

$$S_6 = \sum_{i=1}^{k} w_i = 18.14 \times 10^{-6}$$

The parameter estimates are

 $\hat{\gamma} = 15854$ $\hat{\beta} = 2618$

The variances are

 $V(\hat{\gamma}) = 55127$ $V(\hat{\beta}) = 2074.64$

For the total, \hat{x}_{ot} .

$$V_r(\hat{x}_{ot}) = 13.95 \times 10^5 / (2618)^2 = 0.2035$$

 $\hat{x}_{ot} = (76378 - 47562) / 2618 + (3)(5.8760)$
 $= 28.63 \text{ g U} - 235$
 $V_s(\hat{x}_{ot}) = 0.1090$

2.6.2.3 Single Point Calibration

A problem commonly encountered in inspection may be called a single point calibration problem and is described as follows, in terms of a specific type of example. Suppose that the percent U-235 of items is to be measured by NDA, and further suppose that the expected range of percent U-235 values is quite narrow. Assuming that no physical calibration standards are available, common practice is to make NDA measurements on a small number of randomly selected items. These items are then sampled with the samples measured by destructive analysis (e.g., mass spectrometer). The calculated average result for these samples becomes the assigned standard value.

Mathematically, this problem reduces to a linear calibration with a zero intercept with the added feature that the uncertainty in the assigned standard value is taken into account. In the event the percent U-235 (or whatever other quantity is being measured) varies over a range such that a single point calibration is not desirable, then the Method 2.5 may be applied. For Method 2.5, it is assumed that the assigned standard values are known without error, which is not strictly valid. However, for the application under discussion the uncertainty in the assigned standard value based on the destructive analysis is quite small relative to that of the NDA measurement and can safely be ignored. (If there is concern on this point, one may use statistical methods that take into account errors in both variables.)

Method 2.9 treats the single point calibration problem.

Method 2.9

Notation

- $y_i = i th$ NDA measurement on the standard
- n = number of NDA measurements on the standard
- \bar{y} = average of the n measurements

 s^2 = variance of the n measurements

 $\mu_{\rm X}$ = value assigned the standard, based on destructive analyses σ_0^2 = variance of $\mu_{\rm v}$

Results

The calibration equation is written

 $Y = \beta X$

The parameter, β , is estimated by

- .

$$\beta = y/\mu_x$$
 (eq. 2.6.48)

At a given observed value, $\boldsymbol{y}_{0},$ for a production item, the corresponding \boldsymbol{x}_{0} value is

$$\hat{x}_0 = y_0 / \hat{\beta}$$
 (eq. 2.6.49)

The random and systematic error variances of $\hat{\boldsymbol{x}}_0$ are, respectively,

$$V_r(x_0) = s^2/\beta^2$$
 (eq. 2.6.50)

$$V_{s}(\hat{x}_{0}) = (y_{0}^{2}/\hat{\beta}^{2})(\sigma_{0}^{2}/\mu_{X}^{2} + s^{2}/n\bar{y}^{2})$$
 (eq. 2.6.51)

Basis

The basis for estimating the parameter β is the same as for Method 2.5. The formulas for $V_r(\hat{x}_0)$ and $V_s(\hat{x}_0)$ are based on methods for propagating errors to be covered in Chapter 3.

Examples

EXAMPLE 2.9 (a)

NDA measurements of percent U-235 are to be made on Zr/U billets. No physical standards are available. A randomly selected billet is measured 10 times by NDA and then sectioned to provide samples for destructive analyses. Some 14 determinations are made of percent U-235 on these samples, and 21 determinations of percent uranium. The response of interest is the percent U-235 in the billet.

The average of the 14 percent U-235 measurements is 92.878% with a standard deviation on this average of 0.0091% absolute. For the 21 determinations of percent uranium, the average is 1.6882% and the associated absolute standard deviation is 0.0010%. Thus,

$$\mu_{X}$$
 = (0.92878) (1.6882) = 1.5680%

The variance, σ_0^2 , is calculated by propagation of error techniques to be discussed in Chapter 3.

 $\sigma_0^2 = (0.92878)^2 (.0010)^2 + (1.6882)^2 (0.000091)^2$

 $= 88.62 \times 10^{-8}$

The ten measurements by NDA are, in counts per unit time,

9149	9243	9219
9212	9245	9203
8923	9186	
9203	9208	

These give:

n = 10 \bar{y} = 9179.1 s² = 8846.54

Suppose a production billet is then counted to give 9031 counts. The percent U-235 for that billet is then estimated by:

 $\hat{\beta} = 9179.1/1.5680 = 5854$ $\hat{x}_{0} = 9031/5854 = 1.5427\%$ $V_{r}(\hat{x}_{0}) = 8846.54/(5854)^{2} = 0.0002581$ $V_{s}(\hat{x}_{0}) = (9031/5854)^{2} (88.62 \times 10^{-8}/(1.5680)^{2} + 8846.54/(10)(9179.1)^{2})$ = 0.00002585

2.6.2.4 SAM-2 Calibration for Percent U-235

Another problem somewhat unique to inspection activities involves the calibration of the NDA SAM-2 instrument for the measurement of percent U-235. The problem differs from calibration problems discussed previously because there are two measured responses, one corresponding to a background correction. The fact that the background correction is now not a simple subtraction as was true for other NDA applications already treated makes the problem more complicated, involving the estimation of another parameter. Method 2.10 indicates how this problem may be treated.

Method 2.10

Notation

 x_i = percent U-235 for standard, i-th measurement y_{1i} = net count rate, source plus background, for i-th measurement y_{2i} = net background count rate for i-th measurement n = number of standard measurements

$$Y_1 - \beta_1 Y_2 = \beta_2 X$$
 (calibration curve)

Results

Calculate the following quantities. All summations run from 1 to n.

$$S_{1} = \sum x_{i} y_{1i} \qquad S_{2} = \sum x_{i} y_{2i} \qquad S_{3} = \sum y_{1i} y_{2i}$$
$$S_{4} = \sum y_{1i}^{2} \qquad S_{5} = \sum y_{2i}^{2} \qquad S_{0} = \sum x_{i}^{2}$$

The parameters β_1 and β_2 are estimated by:

$$\hat{\beta}_1 = (S_0 S_3 - S_1 S_2)/S$$
 (eq. 2.6.52)

$$\hat{\beta}_2 = (S_1 S_5 - S_2 S_3)/S$$
 (eq. 2.6.53)

$$S = S_0 S_5 - S_2^2$$
 (eq. 2.6.54)

where

The variances of $\hat{\beta}_1$ and of $\hat{\beta}_2$ and the covariance between them are given by

$$V(\hat{\beta}_1) = S_0 \sigma_1^2 / S + (S_0 S_4 - S_1^2) S_0 \sigma_2^2 / S^2$$
 (eq. 2.6.55)

$$V(\hat{\beta}_2) = S_5 \sigma_1^2 / S + (S_0 S_3^2 + S_2^2 S_4 - 2S_1 S_2 S_3) \sigma_2^2 / S^2 \qquad (eq. 2.6.56)$$

$$CV(\hat{\beta}_1, \hat{\beta}_2) = S_2V(\hat{\beta}_1)/S_0$$
 (eq. 2.6.56a)

In these equation, σ_1^2 and σ_2^2 are the variances of y_{1i} and y_{2i} respectively and are estimated from replicated data as the sample variances (see example 2.10 a).

For a production item with measured responses y_{10} and y_{20} , the percent U-235 is \hat{x}_0 . Its random and systematic error variances are respectively

$$V_{r}(\hat{x}_{0}) = \sigma_{1}^{2}/\beta_{2}^{2} + (\hat{\beta}_{1}/\hat{\beta}_{2})^{2} \sigma_{2}^{2} \qquad (eq. 2.6.56b)$$

$$V_{s}(\hat{x}_{0}) = \left(y_{20}^{2} V(\hat{\beta}_{1}) + \hat{x}_{0}^{2} V(\hat{\beta}_{2}) + 2 \hat{x}_{0} y_{20} CV(\hat{\beta}_{1}, \hat{\beta}_{2})\right) / \hat{\beta}_{2}^{2} \qquad (eq. 2.6.56c)$$

where σ_1^2 and σ_2^2 are again replaced by their estimates.

Basis

The parameters β_1 and β_2 are estimated by assigning them values that minimize

$$Q = \sum_{i=1}^{n} (y_{1i} - \beta_1 y_{2i} - \beta_2 x_i)^2$$

Taking the partial derivatives of Q with respect to β_1 and $\beta_2,$ and equating to O, one obtains

$$S_3 - \beta_1 S_5 - \beta_2 S_2 = 0$$

 $S_1 - \beta_1 S_2 - \beta_2 S_0 = 0$

from which the estimating equation (eq. 2.6.52) - (eq. 2.6.54) easily follow.

To derive the expressions for $V(\hat{\beta}_1)$, $V(\hat{\beta}_2)$, $CV(\hat{\beta}_1,\hat{\beta}_2)$, $V_r(\hat{x}_0)$, and $V_S(\hat{x}_0)$, one must apply Method 3.12 to follow. The details of the derivation are not included here. They are due to Neuilly (2.29).

Examples

EXAMPLE 2.10 (a)

Calibration data for a SAM-2 instrument are tabled. An inspected item produces the count rates: $y_{10} = 90,000$ and $y_{20} = 49,200$. Estimate the percent U-235 for that item and find the random and systematic error variances of the estimate.

x = % U-235	<u>у₁(СРМ)</u>	y ₂ (CPM)
2.55	97950	49049
2.55	98008	49868
2.55	98130	49475
2.55	98218	49979
0.72	62268	46671
0.72	62569	46874
0.72	62345	47189
0.72	62802	47208

The quantities S_0-S_5 are calculated

S_0	=	28.0836	S_3	=	31,201,379,410
S_1	=	1,180,368.78	S_4	=	54,099,216,790
S_2	=	641,164.29	S_5	=	18,669,048,990

Then, by (eq. 2.6.54),

 $S = 1.1320246 \times 10^{11}$

so the estimates are

 $\hat{\beta}_1 = 1.0551$ $\hat{\beta}_2 = 17942.7$

Therefore, $x_0 = 90,000/17942.7 - [(1.0551)/(17942.7)]49,200$ = 2.123 % U-235

Next, σ_1^2 and σ_2^2 are estimated by

$$\hat{\sigma}_1^2 = \frac{1}{6} \sum_{i=1}^4 (y_{1i} - \bar{y}_1)^2 + \sum_{i=5}^8 (y_{1i} - \bar{y}_2)^2 = 36,221$$

 $\hat{\sigma}_2^2 = 122,790$

Assuming that $\sigma_1^2 = \sigma_2^2$, the estimate is the average of 36,221 and 122,790, or 79,506. This value is used in place of σ_1^2 and σ_2^2 in (eq. 2.6.55) and (eq. 2.6.56). The results are:

 $V(\hat{\beta}_1) = 4.168 \times 10^{-5}$ $V(\hat{\beta}_2) = 27732$

 $CV(\hat{\beta}_1, \hat{\beta}_2) = -0.9516$

The random error variance of \hat{x}_0 is, from (eq. 2.6.56b),

 $V_r(\hat{x}_0) = 79,506 (3.10616 + 3.45789) \times 10^{-9}$ = 5.29 × 10⁻⁴ ; $\sqrt{V_r(\hat{x}_0)} = 0.0228$

The systematic error variance is found from (eq. 2.6.56c)

 $V_{s}(\hat{x}_{0}) = (3.1339 + 3.8824 - 6.1748) \times 10^{-4}$ = 0.845 x 10⁻⁴; $\sqrt{V_{s}(x_{0})} = 0.0092$

The overall standard deviation of \hat{x}_0 is 0.0246% U-235. Since \hat{x}_0 = 2.123% U-235, this corresponds to a relative error standard deviation of 1.16%.

2.6.2.5 Several Calibration Data Sets; Linear Model

Measurement systems are recalibrated on a routine schedule because of difficulties in maintaining a stable measurement system. This is especially true for NDA measurement systems.

Assume that the calibration curve to be applied is the one based on the most recent set of data. Further assume that the calibration may shift from one time frame to another, the degree of shift being that described by prior calibrations. Then, the current set of calibration curve parameters may be regarded as being randomly selected from a population of parameters, just as prior sets of estimated parameters were also selected.

The linear model with unknown intercept and constant variance is assumed.

Method 2.11

<u>Notation</u>

Same as for Method 2.5. It is convenient to use this notation rather than the Method 2.6 notation because each data set may not have the same value for \bar{x} .

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Results

For the most recent set of data, estimate the parameters of the calibration curve by following Method 2.6. Recalculate $\hat{\alpha}$ from the equation

$$\hat{\alpha} = \hat{\gamma} - \hat{\beta} \, \bar{\mathbf{x}} \qquad (\text{eq. 2.6.57})$$

List the corresponding paired $\hat{\alpha}$, $\hat{\beta}$ values from the previous calibrations. Let the total number of calibrations, including the most recent one, be m. Given the sets $(\hat{\alpha}_i, \hat{\beta}_i)$ for i=1, 2, ..., m, compute the sample variances among the $\hat{\alpha}_i$ values, and the $\hat{\beta}_i$ values, and the sample covariance between the $\hat{\alpha}_i$ and $\hat{\beta}_i$ values. Denote these quantities by

 $s_{\hat{\alpha}}^2$, $s_{\hat{\beta}}^2$, $s_{\hat{\alpha},\hat{\beta}}$ respectively

For k measured responses (k = 1 is a special case), with \hat{x}_{ot} being the total amount and x_o being \hat{x}_{ot}/k , and with y_o being similarly defined, the random and systematic error variances are respectively

$$V_r(x_{ot}) = k\hat{\sigma}^2/\hat{\beta}^2$$
 (eq. 2.6.58)

$$V_{s}(\hat{x}_{ot}) = k^{2}\bar{x}_{o}^{2} \left\{ \frac{s_{\alpha}^{2}}{(\bar{y}_{o} - \hat{\alpha})^{2}} + \frac{s_{\hat{\beta}}^{2}}{\hat{\beta}^{2}} + \frac{2s_{\hat{\alpha},\hat{\beta}}}{\hat{\beta}(\bar{y}_{o} - \hat{\alpha})} \right\}$$
(eq. 2.6.59)

In (eq. 2.6.58), $\hat{\sigma}^2$ is calculated from (eq. 2.6.30) using the most recent data set.

Basis

The conservative assumption is made that the most recent calibration curve holds steady throughout the time frame in question. With this assumption, and assuming that the true calibration curve lies within the envelope defined by other curves for the same measurement system, the error variance describing this curve to curve variation becomes a systematic error variance. Under a less conservative assumption, one could use an average calibration curve in some sense, using the argument that the true calibration curve is fixed rather than variable, and the purpose of recalibrating is to obtain a better and better estimate of this average calibration. The true state of nature probably falls between these two extremes, but the conservative position is advocated.

As a final note, although Method 2.11 is based on the constant variance case, it may also be applied with little concern to the non-constant variance case. This

is because the curve to curve variability is probably of dominant importance, and the random error for a given curve is of little consequence. In (eq. 2.6.58), simply replace $k\hat{\sigma}^2$ as calculated from (eq. 2.6.30) by

$$\sum_{i=1}^{k} \sigma_{0i}^{2}$$
, using (eq. 2.6.39)

Examples

EXAMPLE 2.11 (a)

Suppose the data of Example 2.7 (a) represent the most recent set of calibration data. Further suppose that prior calibrations resulted in the following parameter estimates:

â	β
355	2414
730	2564
2831	2484

From Example 2.8 (a), which uses the data of Example 2.7 (a), the parameter estimates are

 $\hat{\beta} = 2618$ $\hat{\gamma} = 15854$ $\bar{x} = 1.0659 \times 10^{-4}/18.14 \times 10^{-6} = 5.876$ $\hat{\alpha} = 15854 - (2618)(5.876) = 471$, from (eq. 2.6.57)

The quantities s_{α}^2 , s_{β}^2 , and s_{α}^2 , $_{\beta}^2$ are calculated, using all four calibration curve parameter estimates.

 $s_{\hat{\alpha}}^2 = 1,361,295$ $s_{\hat{\beta}}^2 = 8024$ $s_{\hat{\alpha}},_{\hat{\beta}} = -20,423$

For the three production barrels of Examples 2.7 (a) and 2.8 (a), the reported amount of U-235 was 28.63g, as calculated in the latter example.

From (eq. 2.6.58), with $k\hat{\sigma}^2$ replaced by

$$\sum_{i=1}^{k} \sigma_{0i}^{2} = 13.95 \times 10^{5} ,$$

 $V_r(\hat{x}_{ot}) = 0.2035$, as in Example 2.8 (a). From (eq. 3.6.59),

 $V_{s}(\hat{x}_{ot}) = (28.63)^{2} \left\{ \frac{1,361,295}{(25459 - 471)^{2}} + \frac{8024}{(2618)^{2}} - \frac{40846}{(2618)} \right\}$

 $= 2.2349 g^2 U-235$

Note that this is much larger than as previously calculated because the curve to curve variation is now taken into account.

2.6.2.6 Linear Calibration; Cumulative Model

The so-called linear calibration with cumulative model is encountered in the calibration of process vessels. The vessel in question must be a straight wall tank with a minimum amount of internal piping in order for the linear model to apply. For more complex situations, a statistical expert should be consulted.

In the calibration process, the response y is the liquid level measured by some technique. Observations of the liquid level are made at values of the measured volume, x. The variable x denotes the sum of measured increments, x_i . The calibration equation is of the form

 $y = \alpha' + \beta' x$

In general terms, the error structure may be written symbolically as

$$y = \alpha' + \beta' \Sigma (x + e_y) + e_y$$
 (eq. 2.6.60)

where e_x represents the error in the measured increment x and e_y is the error in determining the liquid level y. The statistical procedure to use depends upon the relative sizes of e_x and e_y .

If there is little error in determining the weights or volumes of the liquid increments relative to the error in determining the liquid level, then the statistical procedure is that covered in 2.6.2.1. If the reverse is true, then the cumulative model applies. This terminology is properly descriptive because the error in a given x is the cumulative sum of errors in the increments of volume comprising x.

For the cumulative model, it is permissible to write the relationship in the form

 $x = \alpha + \beta_v$

(eq. 2.6.61)

and obtain estimates of α and β directly. Recall that in 2.6.2.1, it was first necessary to estimate the parameters of the equation in which y was expressed as a function of x and then use the equation in its inverse form.

For the cumulative model discussed in Method 2.12, it will be noted that only the initial and final points are used in estimating the calibration parameters. The intermediate points are used to verify that the relationship is in fact linear and to provide an estimate of the variance of a measured increment.

Method 2.12

Notation

 $(x_1, y_1) = initial point$ $(x_n, y_n) = final point$ $y_0 = measured response (after calibration)$ $x_0 = estimated liquid level corresponding to <math>y_0$ α, β are defined by (eq. 2.6.61)

Results

The estimates of β and α are

$$\hat{\beta} = (x_n - x_1) / (y_n - y_1)$$
 (eq. 2.6.62)

$$\hat{\alpha} = x_1 - \hat{\beta} y_1$$
 (eq. 2.6.63)

To calculate the variance of $\hat\beta$ and of $\hat\alpha,$ and the systematic error variance of $x_o,$ first compute

$$S = \sum_{i=2}^{n} (x_i - x_{i-1})^2 / (y_i - y_{i-1})$$
 (eq. 2.6.64)

Then,

$$V(\hat{\beta}) = \frac{(y_n - y_1)S - (x_n - x_1)^2}{(n-1) (y_n - y_1)^2}$$
(eq. 2.6.65)

$$V(\hat{\alpha}) = y_1 y_n V(\hat{\beta})$$
 (eq. 2.6.66)

$$V_{s}(x_{0}) = (y_{1}y_{n}+y_{0}^{2}-2y_{0}y_{1})V(\hat{\beta})$$
 (eq. 2.6.67)

The random error variance of $x_{\rm O}$ is zero since $y_{\rm O}$ is assumed to be measured without error in the cumulative model.

In tank calibration applications, one is often interested in transfer amounts as determined by noting the difference between two measured responses, $(y_{02}-y_{01})$. The transfer amount, $\hat{\beta}(y_{02}-y_{01})$ has a systematic error variance given by

$$V_{s}(x_{02}-x_{01}) = (y_{02}-y_{01})^{2} V(\hat{\beta})$$
 (eq. 2.6.68)

For the total of m transfers,

$$V_{s} \left[\sum_{i=1}^{m} (x_{02i} - x_{01i}) \right] = \left[\sum_{i=1}^{m} (y_{02i} - y_{01i}) \right]^{2} V(\hat{\beta})$$
 (eq. 2.6.69)

Basis

As is seen from (eq. 2.6.60), with e_y assumed to be zero for the cumulative model, the random errors for any two observations are not independent. Thus, it is inappropriate to use the methodology of 2.6.2.1 or 2.6.2.2 which require independence of observations.

As Mandel points out [2.10], one can remove this dependence by working with successive differences, or incremental additions of liquid in this application. The resulting estimates given in Method 2.12 are then weighted least squares estimates. Equivalently, one can use the original data and apply Aitkin's method of generalized least squares to obtain the estimates [2.11], as was demonstrated by Jaech [2.12].

Examples

EXAMPLE 2.12 (a)

Tank calibration data are given as follows:

<u>y (in)</u>	<u>x (1b)</u>	у	<u> </u>	у	X
33.48	5025.25	64.48	11036.05	95.37	17042.26
41.20	6525.75	72.20	12537.42	99.28	17795.36
48.95	8027.40	79.93	14038.39	104.47	18797.41
56.72	9534.40	87.62	15540.81	109.64	19798.46

Assuming that the cumulative model applies, Method 2.12 is applied. From (eq. 2.6.62) and (eq. 2.6.63),

 $\hat{\beta} = 14773.21/76.16 = 193.976$

$$\hat{\alpha} = 5025.25 - (193.976)(33.48) = -1469.07$$

From (eq. 2.6.64),

 $S = (1500.50)^2/7.72 + (1501.65)^2/7.75 + \dots + (1001.05)^2/5.17$

= 2,865,680.853

The variances of the calibration parameter estimates are given by (eq. 2.6.65) and (eq. 2.6.66).

$$V(\hat{\beta}) = \frac{(76.16)(2,865,680.853) - (14773.21)^2}{(11)(76.16)^2} = 0.0395$$
$$V(\hat{\alpha}) = (33.48)(109.64)(0.0395) = 144.99$$

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Suppose that an observed manometer reading is 98.74 inches. The estimated weight of the liquid in the tank is

$$x_0 = -1469.07 + (193.976)(98.74) = 17684.12$$
 lbs.

From (eq. 2.6.67), its variance is

$$V_{s}(x_{0}) = \left[(33.48)(109.64) + (98.74)^{2} - 2(98.74)(33.48) \right] (0.0395)$$

= 268.94 lbs²

Suppose that 5 transfers are made as follows:

	Manometer Reading			
Transfer	Before	After	Difference	
1	101.62	34.91	66.71	
2	104.29	36.18	68.11	
3	97.01	33.99	63.02	
4	88.15	35.07	53.08	
5	100.72	37.66	63.06	
	То	tal	313.98	

The estimated total weight of the transferred liquid is

(313.98)(193.976) = 60904.58 lbs.

Its variance is given by (eq. 2.6.69)

 V_{c} (transferred amount) = $(313.98)^{2}(0.0395) = 3894.06$ 1bs²

2.6.2.7 Several Calibration Data Sets; Cumulative Model

The discussion of 2.6.2.5 is applicable to this section also, the difference being that now the underlying model for any given calibration curve is the cumula-tive model rather than the independent model.

Method 2.13

Notation

Same as for Method 2.12.

Results

For the most recent set of data, estimate the parameters of the calibration curve by following Method 2.12. From the previous calibrations and including the

most recent one, list the $\hat{\alpha}$ and $\hat{\beta}$ values. Let the total number of calibrations be m. Given the sets $(\hat{\alpha}_i, \hat{\beta}_i)$ for $i = 1, 2, \ldots, m$, compute the sample variances among the $\hat{\alpha}_i$ and the $\hat{\beta}_i$ values, and the sample covariance between them. Denote these quantities respectively by

$$s^2$$
, s^2 , s , $\hat{\alpha}$, $\hat{\beta}$, $\hat{\alpha}$, $\hat{\beta}$

Then, at an observed y_0 , the variance of the corresponding x_0 (which is a systematic error variance, the random error variance being zero) is

$$V_{s}(x_{0}) = s_{\alpha}^{2} + y_{0}^{2}s_{\beta}^{2} + 2y_{0}s_{\alpha}^{2}, \hat{\beta} \qquad (eq. 2.6.70)$$

For a transfer volume,

$$V_{s}(x_{02}-x_{01}) = (y_{02}-y_{01})^{2}s_{\hat{\beta}}^{2}$$
 (eq. 2.6.71)

For the total of m transfers,

$$V_{s}\left[\sum_{i=1}^{m} (x_{02i} - x_{01i})\right] = \left[\sum_{i=1}^{m} (y_{02i} - y_{01i})\right]^{2} s_{\hat{\beta}}^{2} \qquad (eq. 2.6.72)$$

<u>Basis</u>

The basis discussion for Method 2.11 is also applicable here.

Examples

EXAMPLE 2.13 (a)

Suppose that the data of Example 2.12 (a) represent the most recent set of calibration data. Further suppose that there were two prior calibrations with the following parameter estimates:

<u> </u>	<u></u>
- 1408.77	192.792
-1505.74	194.250

Then,

$$s_{\hat{\alpha}}^2 = 2397.33$$

 $s_{\hat{\beta}}^2 = 0.60045$
 $s_{\hat{\alpha},\hat{\beta}}^2 = -37.1376$

Suppose that $y_0 = 98.74$. The corresponding x_0 value is 17684.12 lbs., from Example 2.12 (a). Its systematic error variance is given by (eq. 2.6.70)

$$V_s(x_0) = 2397.33 + (98.74)^2(0.60045) + (197.48)(-37.1376)$$

= 917.54 lbs²

2.6.2.8 Nonlinear Calibration

Thus far in the discussion of calibration equations, it has been assumed that the calibration curve is linear. In some applications, this assumption may not be valid. In NDA applications, for example, depending on the range of the calibration, the curve may depart from linearity.

Assume that, at worst, a nonlinear calibration curve may be represented by a quadratic model. The adequacy of this assumption has been demonstrated in a number of NDA applications. Further assume a constant variance, zero intercept model. For applications that do not satisfy these assumptions, qualified statistical advice should be sought. (An examination of the residuals is helpful in checking on the validity of the assumptions.)

Method 2.14

Notation

 $(y_{i}, x_{i}) = i$ -th data point; i=1, 2, ..., n α , β = parameters of the model $y_i = \alpha x_i + \beta x_i^2$ σ^2 = variance of y_i at given x_i

Results

Calculate the following quantities (all summations run from 1 to n)

$$S_{1} = \Sigma x_{1}^{2} \qquad S_{2} = \Sigma x_{1}^{3} \qquad S_{3} = \Sigma x_{1}^{4}$$
$$S_{4} = \Sigma x_{1}y_{1} \qquad S_{5} = \Sigma x_{1}^{2}y_{1} \qquad S_{6} = S_{1}S_{3} - S_{2}^{2}$$

Then, the parameter estimates are:

$$\hat{\alpha} = (S_3S_4 - S_2S_5)/S_6$$
 (eq. 2.6.73)
 $\hat{\beta} = (S_1S_5 - S_2S_4)/S_6$ (eq. 2.6.74)

$$= (S_1 S_5 - S_2 S_4) / S_6$$
 (eq. 2.6.74)

$$(n-2)\hat{\sigma}^2 = \sum_{i=1}^{n} (y_i - \hat{\alpha}x_i - \hat{\beta}x_i^2)^2$$
 (eq. 2.6.75)

For a production item, the measured response is y_0 . The corresponding x value is the solution of the equation

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$$\hat{\beta}x_0^2 + \hat{\alpha}x_0 - y_0 = 0$$

The solution is

$$x_0 = -\hat{\alpha} (1 - \sqrt{1 + 4\hat{\beta}y_0/\hat{\alpha}^2})/2\hat{\beta}$$
 (eq. 2.6.76)

The estimated variances of the estimated parameters, and the estimated covariance between them are:

$$V(\hat{\beta}) = S_1 \hat{\sigma}^2 / S_6$$
 (eq. 2.6.77)

$$V(\hat{\alpha}) = S_3 \hat{\sigma}^2 / S_6$$
 (eq. 2.6.78)

$$CV(\hat{\alpha}, \hat{\beta}) = -S_2 \hat{\sigma}^2 / S_6$$
 (eq. 2.6.79)

The systematic error variance of x_0 is denoted by $V_s(x_0)$ and is given by

$$V_{s}(x_{o}) = x_{o}^{2} \left[V(\hat{\alpha}) + x_{o}^{2} V(\hat{\beta}) + 2x_{o}^{2} C V(\hat{\alpha}, \hat{\beta}) \right] / R^{2}$$
 (eq. 2.6.80)

where

$$R = \hat{\alpha} + 2\hat{\beta}x_0$$
 (eq. 2.6.81)

The random error variance of \boldsymbol{x}_{o} is

$$V_r(x_0) = \hat{\sigma}^2 / R^2$$
 (eq. 2.6.82)

Consider k measured responses: $y_{\hat{0}_1}$, y_{02} , ..., y_{0k} and the corresponding x values: x_{01} , x_{02} , ..., x_{0k} . Letting x_{0t} be the sum of these x_{0j} values, consider the random and systematic error variances of x_{0t} . To calculate these quantities, first compute

$$S_7 = \sum_{i=1}^{k} x_{oi}/R_i$$
 $S_8 = \sum_{i=1}^{k} x_{oi}^2/R_i$ $S_9 = \sum_{i=1}^{k} 1/R_i^2$

with R_j defined in (eq. 2.6.81) for x_{oj}. Then,

$$V_{s}(x_{ot}) = S_{7}^{2} V(\hat{\alpha}) + S_{8}^{2} V(\hat{\beta}) + 2S_{7}S_{8}CV(\hat{\alpha},\hat{\beta})$$
(eq. 2.6.83)
$$V_{r}(x_{ot}) = S_{9}\hat{\sigma}^{2}$$
(eq. 2.6.84)

<u>Basis</u>

The parameter estimates are least squares estimates, i.e., are found by minimizing

$$Q = \sum_{i=1}^{n} (y_i - \alpha x_i - \beta x_i^2)^2$$

The quantity σ^2 is estimated by replacing α and β in this expression by their estimates and dividing Q by (n-2), the degrees of freedom.

The expressions for the variances of the quantities of interest are based on error propagation methods to be discussed in Chapter 3.

Examples

EXAMPLE 2.14 (a)

An NDA instrument is calibrated for use in measuring the amount of U-235 in containers of solid waste. Calibration data are as follows:

$x_i = g U - 235$	y _i = net count rate/100 sec.
1.13	2629
4.52	11455
8.03	19512
11.03	27365
16.03	38701
21.61	50136
27.33	62111
32.88	71647

The quantities are calculated.

 $S_1 = 2759.8254$ $S_2 = 72,124.22288$ $S_3 = 2,030,156.602$ $S_4 = 6,270,327.66$ $S_5 = 162,032,220.2$ $S_6 = 400,974,230.0$

By (eq. 2.6.73) and (eq. 2.6.74),

 $\hat{\alpha} = 2602$ $\hat{\beta} = -12.624$

For x_i = 1.13, 4.52, ..., 32.88, the quantities $P_i = \hat{\alpha}x_i + \hat{\beta}x_i^2$ are calculated. These are used in computing $\hat{\sigma}^2$ from (eq. 2.6.75)

xi	$P{j} = 2602 \times j - 12.624 \times j^{2}$	<u>yi-</u> Pi
1.13	2924	-295
4.52	11503	-48
8.03	20080	-568
11.03	27164	201
16.03	38466	235
21.61	50334	-198
27.33	61683	428
32.88	71906	-259

 $\hat{\sigma}^2 = \Sigma (y_i - P_i)^2 / 6 = 132,841$

The quantities V($\hat{\beta}$), V($\hat{\alpha}$), and CV($\hat{\alpha}$, $\hat{\beta}$) are calculated from (eq. 2.6.77), (eq. 2.6.78), and (eq. 2.6.79).

 $V(\hat{\beta}) = 0.91432$ $V(\hat{\alpha}) = 672.58$ $CV(\hat{\alpha}, \hat{\beta}) = -23.894$

A production item is now counted, the net count rate being 32,145 counts/ 100 sec. From (eq. 2.6.76), the corresponding amount of U-235 for that item is

> $x_0 = -2602 (1 - \sqrt{1 - 0.23975})/(-25.248)$ = 13.20 grams

Its random and systematic error variances are calculated. First, from (eq. 2.6.81),

R = 2269

Then, from (eq. 2.6.80) and (eq. 2.6.82),

 $V_s(x_0) = (13.20)^2 (672.58 + 159.31 - 630.80)/(2269)^2$ = 0.00681

 $V_{r}(x_{0}) = 132,841/(2269)^{2} = 0.02580$

Three additional production items are now counted, the estimated amounts of U-235 being 4.11, 7.69, and 19.83 g respectively. The total U-235 for the four items is x_{ot} = 44.83 g. To find the systematic and random error variances for x_{ot} , apply (eq. 2.6.83) and (eq. 2.6.84). First compute S₇, S₈, and S₉.

i	×i	Ri	×i ^{/R} i	<u> </u>	¹ /R _i ²
1 2 3 4	13.20 4.11 7.69 19.83	2269 2498 2408 2101	0.00582 0.00165 0.00319 0.00944	0.07679 0.00676 0.02456 0.18716	1.9424 x 10 ⁻⁷ 1.6026 x 10 ⁻⁷ 1.7246 x 10 ⁻⁷ 2.2654 x 10 ⁻⁷
			$S_7 = 0.02010$	S ₈ = 0.28852	$S_9 = 7.5350 \times 10^{-7}$

 $V_s(x_{ot}) = 0.27173 + 0.07611 - 0.27713 = 0.07071$ $V_r(x_{ot}) = 0.10010$

2.6.2.9 Nonlinear Calibration; Several Calibration Data Sets

The decision of 2.6.2.5 is applicable to this section also, the difference being that now the underlying model for any given calibration curve is the quadratic model with zero intercept, discussed in 2.6.2.8.

Method 2.15

Notation

Same as for Method 2.14.

Results

For the most recent set of data, estimate the parameters of the calibration curve by following Method 2.14. From the previous calibrations, and including the most recent one, list the $\hat{\alpha}$ and $\hat{\beta}$ values. Compute the sample variances of the m $\hat{\alpha}$'s and $\hat{\beta}$'s, and the sample covariance between them, calling the results $s_{\hat{\alpha}}^2$, $s_{\hat{\beta}}^2$, and $s_{\hat{\alpha}}^2$, $\hat{\beta}$ respectively. Then, at an observed y₀, the systematic error variance of the corresponding x₀ is given by (eq. 2.6.80) with:

V($\hat{\alpha}$) replaced by $s_{\hat{\alpha}}^2$ V($\hat{\beta}$) replaced by $s_{\hat{\beta}}^2$ CV($\hat{\alpha},\hat{\beta}$) replaced by $s_{\hat{\alpha}},\hat{\beta}$

The random error variance of x_0 is given by (eq. 2.6.82), using the value for $\hat{\sigma}^2$ from the most recent calibration.

For k measured responses, x_{ot} has systematic error variance given by (eq. 2.6.83), making the same replacements for V($\hat{\alpha}$), V($\hat{\beta}$), and CV($\hat{\alpha}$, $\hat{\beta}$) as just indicated. For the random error variance of x_{ot} , use (eq. 2.6.84) with the value of $\hat{\sigma}^2$ based on the most recent calibration.

Basis

The basis discussion for Method 2.11 is also applicable here.

Examples

EXAMPLE 2.15 (a)

Suppose that the data of Example 2.14 (a) represent the most recent set of calibration data. Further suppose that there were four prior calibrations with the following parameter estimates:

â	β	
2944	-22.761	
2656	-12.648	
3214	-34.792	
2573	-11.219	

Then, based on the 5 sets of values:

 $s\hat{\alpha} = 7 \ 894$ $s\hat{\beta} = 101.224$ $s_{\hat{\alpha}}, \hat{\beta} = -2755.20$

From Example 2.14 (a), at $y_0 = 32,145$ counts/100 sec., $x_0 = 13.20$ g and R = 2269. Thus, using the data from all five calibrations,

 $V_s(x_0) = (13.20)^2(75894 + 17637 - 72737)/(2269)^2$

= $0.70375 g^2$

Again using the data of Example 2.14 (a), for the four production items, $x_{ot} = 44.83$ g, and

$$V_{s}(x_{ot}) = 30.6619 + 8.4263 - 31.9562 = 7.1320 g^{2}$$

2.6.3 Measurements of Non-Standard Materials

Thus far, estimation of measurement error parameters has been based on data resulting from the measurement of physical standards. Techniques have been given for estimating error variances based on such data, and for giving guidance with respect to the need for bias correcting the data.

Although, as was repeatedly shown, analyses of standards data provide estimates of random error variances as well as systematic, the emphasis with such data is on the systematic errors. Random error variances often tend to be underestimated for physical standards for a number of reasons; it is difficult to include in the preparation of standards all the factors that might affect measurement repeatability. Usually, it is better to base estimation of random error variances on data that result from repeat measurements of production items. Techniques for doing this are covered in this section, with each technique discussed keyed to a given situation.

It is also noted that if one is willing to make certain assumptions about data structure, then systematic error variances may also be estimated from measurements made on production items. Instances in which this may be done, and techniques for doing so, are indicated as the various situations are covered.

The first topic in this section deals with the analysis of variance as applied to replicate measurement data.

2.6.3.1 Replicate Measurements; Analysis of Variance

Replicate or repeat measurements are made on the same or similar production items. The scatter in the repeat measurements is used to estimate the random error variance using a statistical technique known as the one way analysis of variance.

It is important to keep in mind just which measurement error parameter is being estimated in a given case. Depending on how the measurements are performed, for example, the random error variance being estimated may be the sum of sampling and analytical error variances, say, or it may be just the analytical error variance. This will be pointed out in the examples.

In Method 2.16, the one way analysis of variance as applied to this problem situation is discussed.

Method 2.16

Notation

 x_{ii} = observed value for j-th measurement on production item i

n; = number of measurements made on production item i

n = total number of measurements (sum of n, values)

m = number of production items measured

 σ^2 = random error variance

Results

Following Method 2.4, σ^2 is estimated by (eq. 2.6.16). That is, $\hat{\sigma}^2$ is the same calculated quantity as was σ_ϵ^2 in Method 2.4.

Basis

The basis is the same as for Method 2.4.

Examples

EXAMPLE 2.16 (a)

Five cans of UO₂ powder are weighed at random and at routine intervals on a given scale. Assume that the actual contents do not change in weight, and estimate σ^2 from the following data (weights in kg).

Can 2 Can 3 Can 4 Can 5 Can 1 22.038 22.616 21.418 19.811 24.095 22.041 22.615 21.425 19.825 24.120 19.808 24.096 21.414 22.033 22.617 24.105 22.048 22.608 19.802 19.795 24.105 22.603 22.610 24.118 19.799 24.113 Here, $n_1 = 4$ $n_2 = 6$ $n_3 = 3$ $n_4 = 6$ $n_5 = 7$ n = 26 m = 5 $T_1 = 88.160$ $T_2 = 135.669$ $T_3 = 64.257$ $T_4 = 118.840$ $T_5 = 168.752$ $S_1 = (88.160)^2/4 + \ldots + (168.752)^2/7$ = 12809.04773 $S_2 = (22.038)^2 + (22.041)^2 + \dots + (24.113)^2$ = 12809.04923Then, $\hat{\sigma}^2 = (12809.04923 - 12809.04773)/(26-5)$

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 $= 0.00007143 \text{ kg}^2$

 $= 71.43 \text{ g}^2$

2.6.3.2 Duplicate Measurements; Paired Differences

If the replicate measurements of 2.6.3.1 are, for all items, duplicate measurements (i.e., two measurements per item), then the analysis of the data is simplified. Of course, the one way analysis of variance technique of Method 2.16 may also be applied to duplicate data to give identical results, but there is no need to perform this more difficult analysis.

Method 2.17

Notation

 x_i , y_i = the two measurement results for item i k = number of items measured in duplicate d_i = the difference, $x_i - y_i$ σ^2 = the random error variance for the measurement method in question

Results

There are two estimators of σ^2 that may be used. Denote these by $\hat{\sigma}^2$ and $\tilde{\sigma}^2$ respectively.

$$\hat{\sigma}^{2} = \sum_{i=1}^{k} d_{i}^{2}/2k \qquad (eq. 2.6.85)$$

$$\tilde{\sigma}^{2} = \sum_{i=1}^{k} \frac{d_{i}^{2} - (\sum_{i=1}^{k} d_{i})^{2}/k}{2(k-1)} \qquad (eq. 2.6.86)$$

The estimator $\hat{\sigma}^2$ is preferred if there is assurance that the x_i and y_i values are not relatively biased. The estimator $\tilde{\sigma}^2$ is preferred if there is some reason to believe that such a bias might exist, e.g., if all of the initial measurements were made in one time frame and all of the repeat measurements in another.

Basis

The bases for the two estimators are very simple. The expected values of $\hat{\sigma}^2$ and $\tilde{\sigma}^2$ are both σ^2 if x_i and y_i have the same expected value for all i. If they have different expected values, then the expected value of $\tilde{\sigma}^2$ is σ^2 .

Examples

EXAMPLE 2.17 (a)

Sampled UO_2 sintered pellets were split into two parts with one sample analyzed for percent uranium by the gravimetric method and the other retained for later analysis by the same method. Over a given time period, 42 samples were thus analyzed. The difference data (d_j values) are tabled. Values are in percent uranium.

.003	.002	.028	.000
.021	.006	.008	.000
.045	.011	.009	013
.040	.015	005	002
007	.031	.005	004
.003	.020	.008	015
002	.009	.002	
.018	013	001	
012	.019	.004	
	.003 .021 .045 .040 007 .003 002 .018 012	$\begin{array}{cccccccccccccccccccccccccccccccccccc$.003 .002 .028 .021 .006 .008 .045 .011 .009 .040 .015 005 007 .031 .005 .003 .020 .008 002 .009 .002 .018 013 001 012 .019 .004

For these data,

$$\sum_{i=1}^{42} d_i = 0.269 \qquad \qquad \sum_{i=1}^{42} d_i^2 = 0.011339$$

Thus, by (eq. 2.6.85) and (eq. 2.6.86), the two estimates are:

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 $\hat{\sigma}^2 = 0.0001350$ $\tilde{\sigma}^2 = 0.0001173$

The fact that $\tilde{\sigma}^2$ is somewhat less than $\hat{\sigma}^2$ is an indication that there may be a relative bias between the two sets of measurements.

EXAMPLE 2.17 (b)

Containers of grinder sludge are resampled after having been in storage for varying lengths of time. The results in percents uranium for 15 containers are as follows.

i	y_i	d_1	[×] i	y _i	i
77.72	80.03	-2.31	77.30	78.12	-0.82
77.64	79.24	-1.60	80.00	78.76	1.24
77.88	77.68	0.20	73.95	73.92	0.03
74.98	76.82	-1.84	75.69	72.87	2.82
76.67	70.41	6.26	75.82	77.81	-1.99
76.54	78.60	-2.06	81.48	77.23	4.25
70.43	68.01	2.42	74.35	78.67	-4.32
78.41	75.95	2.46			

For these data,

$$\sum_{i=1}^{15} d_i = 4.74 \qquad \sum_{i=1}^{15} d_i^2 = 117.5092$$

By (eq. 2.6.85) and (eq. 2.6.86), the two estimates are:

 $\hat{\sigma}^2 = 3.9170$ $\tilde{\sigma}^2 = 4.1433$

In this example, σ^2 measures the combined effects of sampling and analytical errors. One could obtain separate estimates of these two errors by making replicate analyses of at least some of the samples. In this particular instance, however, sampling error is clearly dominant and so σ^2 may be interpreted as being the sampling error variance. In the previous example, the reverse was true, i.e., the sampling error may be assumed to be negligible so that σ^2 measured the analytical error.

2.6.3.3 Grubbs' Analysis; Two Measurement Methods

In the paired data analysis method just treated, the assumption is made that both measurements are made by the same measurement method or, if the methods are different, their random error variances are the same. In many safeguards applications, this assumption is not valid. Paired data occur naturally, for example, in shipper-receiver comparisons and for inspection data in which operator and inspector measurements are compared on a paired basis. In both instances, there may be little basis for assuming that the measurement error parameter values are the same for both parties; their measurement methods may in fact be quite different.

By appropriately treating the data, it is possible to obtain estimates of each of the two random error variances. The caution is made, however, that the resulting estimates may be of disappointing quality. In order for the estimates derived from this approach to be useful, it is necessary that the measurement errors be large relative to the scatter among the items being measured. There are other requirements imposed on the data set, as discussed by Jaech [2.13].

A number of statistical methods are given below. Method 2.18 gives the Grubbs' estimators and provides alternate estimators when one of the estimates is negative. In Method 2.19, an indication is given of what estimates to use when the random error of measurement is known for one of the two parties. This occurs in inspection situations, for example, when the inspector's error variance may be known based on a large body of past experience. Method 2.20 indicates how and under what conditions one can estimate systematic error variances from paired data.

Method 2.18

Notation

 $x_i =$ measured value for item i, one measurement method $y_i =$ measured value for item i, second method n = number of pairs of values $s_x^2 =$ sample variance for the x_i values $s_y^2 =$ sample variance for the y_i values $s_{xy} =$ sample covariance for the (x_i, y_i) values $\sigma_1^2 =$ random error variance, method 1 $\sigma_2^2 =$ random error variance, method 2

<u>Results</u>

The parameter estimates are

$$\hat{\sigma}_{1}^{2} = s_{x}^{2} - s_{xy}$$
 (eq. 2.6.87)

$$\hat{\sigma}_{2}^{2} = s_{y}^{2} - s_{xy}$$
 (eq. 2.6.88)

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In the event $\hat{\sigma}_2^2$ is negative, set the estimate equal to zero. The parameter ${\sigma_2}^2$ is then estimated by

$$s_x^2 + s_y^2 - 2s_{xy}$$
 (eq. 2.6.89)

Equation (eq. 2.6.89) also provides the estimate of σ_1^2 should σ_2^2 of (eq. 2.6.88) be negative.

If $s_{\chi y}^{}$ is negative, replace it by zero in estimating $\sigma_1{}^2$ and $\sigma_2{}^2.$

Basis

The method of estimation is due to Grubbs [2.14]. When one of the estimates is negative, the constrained maximum likelihood estimates apply [2.15].

Examples

EXAMPLE 2.18 (a)

Samples are taken from containers of grinder sludge and split. One subsample is analyzed by a titration method and the second by a spectrophotometric method. The analytical results are displayed below, in percent uranium.

Titration (x_i)	Spectrophotometric ((y _i)
75.44	73.96	
77.46	75.98	
72.22	74.15	
75.85	75.98	
74.28	77.44	
76.82	77.61	
74.24	70.30	
77.87	80.27	
75.32	78.75	
76.17	73.70	
73.21	77.93	
75.65	74.70	
76.93	73.38	
72.36	73.67	
79.15	76.01	
75.90	77.01	
77.03	76.71	
75.90	73.71	
	Titration(x _j) 75.44 77.46 72.22 75.85 74.28 76.82 74.24 77.87 75.32 76.17 73.21 75.65 76.93 72.36 79.15 75.90 77.03 75.90	$\begin{array}{c cccc} \hline \mbox{Titration(x_i)} & \mbox{Spectrophotometric} \\ \hline \mbox{75.44} & \mbox{73.96} \\ \hline \mbox{77.46} & \mbox{75.98} \\ \hline \mbox{72.22} & \mbox{74.15} \\ \hline \mbox{75.85} & \mbox{75.98} \\ \hline \mbox{74.28} & \mbox{77.44} \\ \hline \mbox{76.82} & \mbox{77.61} \\ \hline \mbox{74.24} & \mbox{70.30} \\ \hline \mbox{77.87} & \mbox{80.27} \\ \hline \mbox{75.32} & \mbox{78.75} \\ \hline \mbox{76.17} & \mbox{73.21} & \mbox{77.93} \\ \hline \mbox{75.65} & \mbox{74.70} \\ \hline \mbox{76.93} & \mbox{73.38} \\ \hline \mbox{72.36} & \mbox{73.67} \\ \hline \mbox{79.15} & \mbox{76.01} \\ \hline \mbox{75.90} & \mbox{77.1} \\ \hline \mbox{75.90} & \mbox{73.71} \\ \end{array}$

The sample variances and covariance are

 $s_x^2 = 3.433035$ $s_y^2 = 5.751694$ $s_{xy} = 1.317212$ By (eq. 2.6.87) and (eq. 2.6.88) $\hat{\sigma}_1^2$ = 2.115823 (titration) $\hat{\sigma}_2^2$ = 4.434482 (spectrophotometric)

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Suppose that one of the two random error variances (say σ_2^2) may be assumed known. One might decide to use this information in estimating σ_1^2 . This may not be a good decision. Method 2.19 provides a way to determine which estimate of σ_1^2 to use when σ_2^2 is known.

Method 2.19

Notation

Same as for Method 2.18. Also,

 σ_{μ}^2 = variance of characteristic from one item to the next, excluding effect of measurement errors

 $(\sigma_{\mu}^{2} \text{ is estimated by s}_{XY})$ R = $\sigma_{1}^{2}/\sigma_{2}^{2}$

Results

If knowledge about the value of σ_2^2 is ignored, then σ_1^2 is estimated by (eq. 2.6.87).

If the value of $\sigma_2{}^2$ is taken into account, then $\sigma_1{}^2$ is estimated by

$$\tilde{\sigma}_1^2 = s_x^2 + s_y^2 - 2s_{xy} - \sigma_2^2$$
 (eq. 2.6.90)

The expression in (eq. 2.6.90) is identically the same as provided by finding each paired difference, calculating the variance of the differences, and subtracting σ_2^2 .

The choice of which of the two estimators is preferred depends on two quantities; A and T, where

A =
$$(3R + 2)/(R + 1)$$
 (eq. 2.6.91)
T = $\sigma_{\mu}^{2}/\sigma_{2}^{2}$ (eq. 2.6.92)

The following rule applies:

- (1) If T<2, use $\hat{\sigma}_1^2$
- (2) If T>3, use $\tilde{\sigma}_1^2$
- (3) If $2 \le T \le 3$, use $\hat{\sigma}_1^2$ if A<T; otherwise, use $\tilde{\sigma}_1^2$
Basis

The criterion for selecting one estimator over the other is the sampling variance of each estimator. The estimator with the smaller variance is regarded as the better one. For details, see [2.16].

Examples

EXAMPLE 2.19 (a)

In Example 2.18 (a), suppose that $\sigma_2^2 = 4.00$ is a known quantity. The quantity σ_{μ}^2 is not known, but is replaced by its estimate, $s_{\chi y} = 1.317$. Then, by (eq. 2.6.92),

T = 1.317/4.00 = 0.33

Since this is less than 2, use the estimator $\hat{\sigma}_1^2$, i.e., ignore the know-ledge about the value of ${\sigma_2}^2$.

Normally, one obtains information about systematic errors by measuring standards, and not production items. However, by making certain assumptions, it is possible to obtain estimates of systematic error variances from paired data also. In a sense, such estimates may be more realistic than those based on standards data.

Two key assumptions are made:

- (1) Both measurement methods are indeed applied to the same items, i.e., the item being measured in no way changes in true value after the first measurement is made.
- (2) The systematic error or bias associated with each of the two measurement methods is a random variable with <u>zero mean</u> and variance that is called the systematic error variance for that method.

With these assumptions kept in mind, Method 2.20 is now considered.

Method 2.20

Notation

Same as for Method 2.18. Also

 \bar{x} , \bar{y} = average of the x_i and y_i measurements respectively σ_{e1}^2 = systematic error variance for method 1

 $\sigma_{s_2}^2$ = systematic error variance for method 2

Results

The sum of the two systematic error variances, σ_{S1}^2 and σ_{S2}^2 , is estimated by

$$\hat{\sigma}_{s1}^2 + \hat{\sigma}_{s2}^2 = (\bar{x} - \bar{y})^2 - (s_x^2 + s_y^2 - 2s_{xy})/n$$
 (eq. 2.6.93)

One cannot assign separate values to the two parameters unless: (1) one value is known; or (2) the two values are the same (or one is a known function of the other).

In passing, it is noted that the expression $(s_x^2 + s_y^2 - 2s_{xy})$ is the same as the variance of the $d_i = (x_i - y_i)$ values. This latter value is, of course, easier to compute.

Basis

Under the stated assumptions, the expected value of $(\bar{x} - \bar{y})^2$ is

 $\sigma_{s1}^2 + \sigma_{s2}^2 + (\sigma_1^2 + \sigma_2^2)/n$

so that $(\hat{\sigma}_{S_1}^2 + \hat{\sigma}_{S_2}^2)$ is found by equating the observed value $(\bar{x}-\bar{y})^2$ to its expected value and replacing $(\sigma_1^2 + \sigma_2^2)$ by its estimate.

If the bias for either method shifts over some time frame, and if data are collected over several time frames, then a more complex statistical analysis is performed. For an illustrative example, see [2.17].

Examples

EXAMPLE 2.20 (a)

When nitrate solution is being loaded into a recovery plant for further purification, samples are drawn from each container and analyzed for percent plutonium using two different analytical techniques. Sample data from 20 containers are given below.

Sample	i	y_i	d_i	Sample		y_i	d
1	13.11	13.00	0.11	11	13.26	13.01	0.25
2	15.14	14.90	0.24	12	11.00	11.06	-0.06
3	13.22	13.01	0.21	13	12.74	12.75	-0.01
4	13.67	13.65	0.02	14	13.69	13.69	0.00
5	10.48	10.61	-0.13	15	10.43	10.40	0.03
6	15.37	15.11	0.26	16	11.38	11.30	0.08
7	12.37	12.40	-0.03	17	12.26	12.27	-0.01
8	12.50	12.63	-0.13	18	12.89	12.70	0.19
9	11.46	11.71	-0.25	19	13.33	13.30	0.03
10	14.28	14.21	0.07	20	11.88	11.90	-0.02

In applying (eq. 2.6.93), replace $(\bar{x} - \bar{y})^2$ by its equivalent, \bar{d}^2 , and replace $(s_X^2 + s_y^2 - 2s_{Xy})$ by its equivalent, s_d^2 . The values are

 $\bar{d} = 0.0425$ $\bar{d}^2 = 0.001806$ $s_d^2 = 0.018883$

Then,

 $\hat{\sigma}_{s_1}^2 + \hat{\sigma}_{s_2}^2 = 0.001806 - 0.018883/20$ = 0.000862

Suppose σ_{S2} were known to be 0.02% Pu. Then,

 $\hat{\sigma}_{s1}^2 = 0.000862 - (.02)^2 = 0.000462$ $\hat{\sigma}_{s1}^2 = 0.021\%$ Pu

If there were no prior knowledge about either parameters, then it might be reasonable to make them equal so that each σ_{s1}^2 would be estimated by 0.000862/2 = 0.000431.

2.6.3.4 <u>Grubbs' Analysis; More Than Two Measurement Methods With Constant</u> <u>Relative Bias</u>

In the discussion of Section 2.6.3.3, it was pointed out that the estimates of the two measurement error random variances were not useful unless the measurement errors were large relative to the item to item variation. When more than two measurement methods are involved, this difficulty disappears; the quality of the estimates is then <u>not</u> a function of the relative sizes of the random errors of measurement.

Method 2.21 gives the technique for estimating random error variances for each of N measurement methods with N \geq 3. Each item is measured no more than once by each of the N methods. It is assumed that any relative biases among measurement methods are constant over all items measured. This assumption is relaxed in 2.6.3.5.

Method 2.21

<u>Notation</u>

x_{ik} = measured value for item k, method i
N = number of measurement methods
n = number of items measured

 $d_{ijk} = x_{ik} - x_{ik}$ for all pairs i, j

 v_{ij} = sample variance among the n d_{ijk} values for each i,j. There are N(N-1)/2 v_{ij} values

$$\sigma_{\mathbf{i}}^2$$
 = random error variance, method i

Results

For each method i, calculate

$$S_{i} = \sum_{j \neq i}^{\Sigma} v_{ij}$$
 (eq. 2.6.94)

Also sum all the $v_{\mbox{ij}}$ values and call this sum V. Then, σ_1^2 is estimated from

$$\hat{\sigma}_i^2 = S_i / (N-2) - V / (N-1)(N-2)$$
 (eq. 2.6.95)

Basis

The method of estimation is given in [2.14] and in [2.18]. The latter reference contains an example for N = 6 measurement methods.

Examples

EXAMPLE 2.21 (a)

Turnings from a zirconium-uranium billet are distributed among three laboratories as indicated below for analysis of percent uranium. The results are tabulated.

×_{ik} (% U)

Turn Number	lah 1	Lab 2	lah 3
1	77	81	78
2	85		90
3	80		84
4	85	81	
5	90	79	88
6		82	90
7		75	88
8	92	84	89
9	81	84	

The d _{ijk} values are	calculated		
k 1 2 3 4 5 6 7 8 9	$ \frac{d_{12k}}{-4} \\ 4 \\ \\ 4 \\ 11 \\ \\ 8 \\ -3 $	$\frac{d_{13k}}{-1}$ -5 -4 2 3	$\frac{d_{23k}}{3}$ -9 -8 -13 -5
The variances, v _{ij} ,	are		
$v_{12} = 43.70$	v ₁₃ = 1	2.50	v ₂₃ = 35.80
Then, V = 43.70	+ 12.50 + 35.80	= 92.00	
$S_1 = 43.70$	+ 12.50 = 56.20		
S ₂ = 43.70	+ 35.80 = 79.50		
$S_3 = 12.50$	+ 35.80 = 48.30		
By (eq. 2.6.95),			
$\hat{\sigma}_1^2 = 56.20$	- 92.00/2 = 10.2	20 ; $\hat{\sigma}_1$ =	3.19% U
$\hat{\sigma}_{2}^{2} = 33.50$;		
$\hat{\sigma}_{3}^{2} = 2.30$; $\hat{\sigma}_3$ = 1.52% U		

If one can make the same assumptions as were made prior to Method 2.20, then estimates of systematic error variances may also be derived from data of this type. The technique for obtaining these estimates is given by Method 2.22.

Method 2.22

Notation

Same as Method 2.21. Also,

 \bar{x}_i = average of the x_{ik} values = $\sum_{k=1}^{n} x_{ik}/n$, where n = number of measurements for each method σ_{si}^2 = systematic error variance for method i

Results

First, perform the calculations of Method 2.21 to obtain estimates of the random error variances, $\hat{\sigma}_{i}^{2}$. Then, the sum of the systematic error variances, $\sigma_{s_{i}}^{2}$, is estimated by

$$\sum_{i=1}^{N} \hat{\sigma}_{si}^{2} = Ns_{xi}^{2} - \sum_{i=1}^{N} \hat{\sigma}_{i}^{2}/n \qquad (eq. 2.6.96)$$

where $s_{\bar{x}\,i}^2$ is the sample variance among the N \bar{x}_i values.

One cannot obtain separate estimates of the systematic error variances without additional information. For example, one might be willing to assume that all systematic error variances are the same, or are related to one another in some known way.

Basis

The result in (eq. 2.6.96) is based on the fact that the expected value of $Ns_{\bar{x}\,i}^2$ is

$$\sum_{i=1}^{N} \sigma_{si}^{2} + \sum_{i=1}^{N} \sigma_{i}^{2}/n$$

so that

$$\sum_{i=1}^{N} \hat{\sigma}_{si}^2$$

is found by equating the expected value of $\text{Ns}_{X\,i}^2$ to its observed value and replacing σ_i^2 by its estimate for all i.

Examples

EXAMPLE 2.22 (a)

One cannot perform this analysis on the data of Example 2.21 (a) because it is necessary that all measurement methods measure all items in order to obtain estimates of the systematic error variance. This assumption was not necessary when using Grubbs' method to estimate random error variances.

EXAMPLE 2.22 (b)

Percent plutonium analyses on sintered pellet samples are reported for 13 samples by four laboratories. Analyze the following data to find estimates of the random error variances. Assume that all four laboratories have the same systematic error variance and obtain its estimate.

<u>Sample</u>	<u>Lab 1</u>	Lab 2	Lab 3	Lab 4
1	4.62	4.57	4.64	4.56
2	4.61	4.67	4.61	4.55
3	4.72	4.71	4.80	4.79
4	4.66	4.67	4.65	4.66
5	4.68	4.61	4.72	4.52
6	4.67	4.67	4.77	4.64
7	4.69	4.67	4.71	4.67
8	4.68	4.67	4.75	4.65
9	4.72	4.69	4.71	4.69
10	4.70	4.70	4.73	4.66
11	4.59	4.60	4.66	4.58
12	4.59	4.55	4.63	4.59
13	4.61	4.63	4.66	4.64

Method 2.21 is followed. The columns of differences, $d_{\mbox{ijk}},\mbox{ are found.}$

^d 12k	^d 13k	^d 14k	^d 23k	^d 24k	^d 34k
.05	02	.06	07	.01	.08
06	.00	.06	.06	.12	.06
.01	08	07	09	08	.01
01	.01	.00	.02	.01	01
.07	04	.16	11	.09	.20
.00	10	.03	10	.03	.13
.02	02	.02	04	.00	.04
.01	07	.03	08	.02	.10
.03	.01	.03	02	.00	.02
.00	03	.04	03	.04	.07
01	07	.01	06	.02	.08
.04	04	.00	08	04	.04
02	05	03	03	01	.02

The variances, v_{ij} are:

v ₁₂	=	0.001117	V ₂₃	=	0.002397
V ₁₃	=	0.001214	v ₂₄	=	0.002559
v _{l4}	=	0.002876	V ₃₄	=	0.003177

Then

V = 0.00117 + ... + 0.003177 = 0.013340 $S_1 = 0.001117 + 0.001214 + 0.002876 = 0.005207$ $S_2 = 0.006073$ $S_3 = 0.006788$ $S_4 = 0.008612$ From (eq. 2.6.95),

 $\hat{\sigma}_1^2 = 0.005207/2 - 0.013340/6 = 0.000380$ $\hat{\sigma}_2^2 = 0.000813$ $\hat{\sigma}_3^2 = 0.001171$ $\hat{\sigma}_4^2 = 0.002083$

Method 2.22 is now followed. The means of the four columns of data are found

$$\bar{x}_1 = 4.6569$$
 $\bar{x}_2 = 4.6469$ $\bar{x}_3 = 4.6954$ $\bar{x}_4 = 4.6308$

The sample variance among these four mean values is

 $s_{xi}^2 = 0.000754$ From (eq. 2.6.96),

$$\sum_{i=1}^{4} \hat{\sigma}_{si}^2 = 4 \hat{\sigma}_{s}^2 = (4)(0.000754) - (0.004447)/13$$

from which

 $\hat{\sigma}_{s}^{2} = 0.000668$

2.6.3.5 More Than Two Measurement Methods With Non-Constant Relative Bias

The problem under discussion is the same as that in 2.6.3.4 except for an important distinction. In the methodology of 2.6.3.4, it was assumed that any relative biases among measurement methods are constant over all the items measured. In Method 2.23 to follow, this assumption is no longer made.

Method 2.23

Notation

x_{ik}, N, and n as in Method 2.21

 s_i^2 = sample variance among the x_{ik} values, method i

- s_{ij} = sample covariance among the x_{ik} and x_{jk} values, methods i and j
- μ_k = true (but unknown) value for item k
- σ_u^2 = variance among the μ_k values

 α_i , β_i = parameters describing the relative bias among measurement methods, defined by the model

$$E(x_{ik}) = \alpha_{i} + \beta_{i} \mu_{k} \qquad (eq. 2.6.97)$$

$$\sigma_{i}^{2} = random \ error \ variance, \ method \ i$$

Arbitrarily, set β_1 = 1. This does not affect the estimate of the σ_1^2 parameters.

Results

For $i = 2, 3, \ldots, N$, calculate

$$\hat{\beta}_{j} = \begin{pmatrix} N \\ II \\ j \neq 1, j \end{pmatrix}^{1/(N-2)}$$
(eq. 2.6.98)

Calculate

$$\hat{\sigma}_{\mu}^{2} = \left(\prod_{\substack{i=3\\j < i, \neq 1}}^{N} s_{1i} s_{1j} / s_{ij} \right)^{2/(N-1)(N-2)}$$
(eq. 2.6.99)

The parameters are estimated by

$$\hat{\sigma}_{i}^{2} = s_{i}^{2} - \hat{\beta}_{i}^{2} \hat{\sigma}_{\mu}^{2}$$
, where $\hat{\beta}_{1} = 1$ (eq. 2.6.100)

Basis

Two methods of estimation have been suggested for this model [2.19], [2.20]. The latter reference forms the basis for the estimation Method 2.23. See also [2.21] and [2.22].

Examples

EXAMPLES 2.23 (a)

In Table III of [2.17], data are given corresponding to 5 NDA measurements of plutonium-bearing solid wastes. After transforming the data to natural logarithms, Method 2.21, based on the constant relative bias model, was applied, giving the following 5 estimates as reported in [2.17].

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$\hat{\sigma}_1^2 =$	0.07162	$\hat{\sigma}_{4}^{2} =$	0.00413
$\hat{\sigma}_{2}^{2} =$	0.00100	$\hat{\sigma}_{5}^{2} =$	0.04076
$\hat{\sigma}_{3}^{2} =$	0.00805		

The data are re-analyzed after removing the assumption that relative biases are constant. The transformed data are given below as natural logarithms of grams of plutonium.

		Measuremen	nt Method (Se	ee [2.17])	
<u>Container</u>		2	3	4	5
1	3.906	3,906	3.661	2.944	2.923
2	1.740	1.792	1.649	1.030	1.131
3	1.131	1.482	0.956	0.693	0.693
4	2.128	2.128	2.015	1.308	1.386
5	3.144	2.760	2.542	1.946	1.705

The appropriate variances and covariances are calculated.

$s_1^2 = 1.235259$	$s_{12} = 1.043854$	$s_{24} = 0.852077$
$s_2^2 = 0.920771$	s ₁₃ = 1.112266	$s_{25} = 0.802107$
$s_3^2 = 1.032645$	$s_{14} = 0.972217$	$s_{34} = 0.893879$
$s_4^2 = 0.789404$	s ₁₅ = 0.897719	$s_{35} = 0.847349$
$s_5^2 = 0.711128$	s ₂₃ = 0.963278	$s_{45} = 0.741087$

From (eq. 2.6.98),

$$\hat{\beta}_{2} = (s_{23}s_{24}s_{25}/s_{13}s_{14}s_{15})^{1/3} = 0.878584$$

$$\hat{\beta}_{3} = (s_{23}s_{34}s_{35}/s_{12}s_{14}s_{15})^{1/3} = 0.928645$$

$$\hat{\beta}_{4} = (s_{24}s_{34}s_{45}/s_{12}s_{13}s_{15})^{1/3} = 0.815103$$

$$\hat{\beta}_{5} = (s_{25}s_{35}s_{45}/s_{12}s_{13}s_{14})^{1/3} = 0.764160$$

From (eq. 2.6.99),

$$\hat{\sigma}_{\mu}^{2} = \left(\frac{s_{13}s_{12}}{s_{23}} \cdot \frac{s_{14}s_{12}}{s_{24}} \cdot \frac{s_{14}s_{13}}{s_{34}} \cdot \frac{s_{15}s_{12}}{s_{25}} \cdot \frac{s_{15}s_{13}}{s_{35}} \cdot \frac{s_{15}s_{14}}{s_{45}}\right)^{1/6}$$

= 1.188312

The parameter estimates are then given by (eq. 2.6.100).

$$\hat{\sigma}_1^2 = 1.235259 - (1) (1.188312) = 0.04695$$

 $\hat{\sigma}_2^2 = 0.920771 - (0.878584)^2 (1.188312) = 0.00350$
 $\hat{\sigma}_3^2 = 0.00787$
 $\hat{\sigma}_4^2 = -0.00010$ (=0)
 $\hat{\sigma}_5^2 = 0.01722$

In comparing these estimates with those based on the constant relative bias model, it is noted that the results are quite different. The model assumption is obviously quite important. With so few data points, it is difficult to determine with any confidence which model is the more appropriate one in this instance. In [2.20], expressions are given for the sampling variance of $\hat{\beta}_i$ which will permit testing whether or not the slopes differ significantly from unity, i.e., whether or not the constant relative bias model applies.

2.6.3.6 Combining Parameter Estimates from Different Experiments

Estimates of measurement error parameters will often come from a number of data sources or experiments. In application, one requires a single estimate of each parameter, one that is the "best" estimate in some sense. The problem of how to obtain such an estimate is covered by Method 2.24.

Method 2.24

Notation

There are n observed variances, where

 $v_{j} = j$ -th observed variance

The expected value of v_i is of the form

where

 θ_i = i-th measurement error parameter, i = 1, 2, ..., k

c_{ii} = known constant

For example, θ_1 may be the random error variance due to sampling and θ_2 may be the random error variance due to analytical for a given analytical method. If 12 containers are sampled with the samples all analyzed in duplicate, and if the observed variance among the 12 results is, say, 100 units², then, assuming that the containers have the same nominal value for the characteristic of interest (e.g. percent uranium), one estimating equation would be

 $\theta_1 + 0.5 \theta_2 = 100$

Assume that the v_j have different sampling variances, and hence, should be weighted differently. Further assume (for the moment) that each weight is known:

 w_j = weight associated with v_j

Results

A k by k matrix, A, is formed. This is a symmetric matrix whose element in row i and column h is

$$a_{ih} = \sum_{j=1}^{n} w_j c_{ij} c_{hj}$$
 (eq. 2.6.101)

A k by 1 column matrix, V, is formed. In row h, the element is

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$$V_{h} = \sum_{j=1}^{n} w_{j} c_{hj} v_{j}$$
 (eq. 2.6.102)

Invert A to give A^{-1} and perform the matrix multiplication

A-1V

The element in row h of $A^{-1}V$ is the estimate of the parameter θ_{h} .

Basis

The weighted least squares estimation method is used [2.23]. If an unweighted analysis is performed (i.e., if all the v_j values have about the same sampling uncertainty), let $w_j = 1$ for all i.

The method assumes that the w_j values are known. In practice, w_j will be a function of the θ 's which are, of course, not known, and hence, w_j would not be known either. An iterative estimation procedure is available in this instance [2.24]. Method 2.24 is in essence one step in this iterative procedure, for the procedure calculates weights at each stage of the estimation process based on the estimates of the parameters from the prior stage.

Examples

EXAMPLE 2.24 (a)

Several data sources provide estimates of sampling error, (θ_1) , of analytical error by titration, (θ_2) , and of analytical error by spectrophotometry, (θ_3) , in the measurement of percent uranium in UO₂ dirty powder scrap. The following equations are derived

 $\theta_1 = 2.89$ $\theta_2 = 6.28$ $\theta_3 = 4.98$ $\theta_1 + \theta_2 = 8.13$ $\theta_1 + 0.5\theta_3 = 6.70$

In the notation of this method, the c_{ij} and v_i values are tabulated

j	c _{lj}	c _{2j}	c _{3j}	vj_
1	1	0	0	2.89
2	0	1	0	6.28
3	0	0	1	4.98
4	1	1	0	8.13
5	1	0	0.5	6.70

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Assume that the \boldsymbol{v}_j are based on the following numbers of replicate measurements:

$$m_1 = 29$$
 $m_2 = 10$ $m_3 = 43$ $m_4 = 18$ $m_5 = 7$

It is well known that when sampling from a normal distribution (as will be assumed here), the sampling variance of an estimated variance is twice the square of the true variance divided by the degrees of freedom, $m_j -1$ [2.25]. Also, since the weights are the reciprocals of the sampling variances, they are

$$w_{1} = 28/2\theta_{1}^{2} \qquad w_{2} = 9/2\theta_{2}^{2} \qquad w_{3} = 42/2\theta_{3}^{2}$$
$$w_{4} = 17/2(\theta_{1}+\theta_{2})^{2} \qquad w_{5} = 6/2(\theta_{1}+0.5\theta_{3})^{2}$$

These are functions of the unknown parameter values. An iterative procedure is needed, using an arbitrary starting point. A reasonable starting point could be the estimates based on the first three equations:

$$\hat{\theta}_1 = 2.89$$
 $\hat{\theta}_2 = 6.28$ $\hat{\theta}_3 = 4.98$

The weights for the first iteration are then,

 $w_1 = 1.676$ $w_2 = 0.114$ $w_3 = 0.847$

$$w_{14} = 0.101$$
 $w_5 = 0.104$

Then, from (eq. 2.6.101),

 $a_{11} = 1.676 + 0.101 + 0.104 = 1.881$ $a_{22} = 0.114 + 0.101 = 0.215$ $a_{33} = 0.847 + 0.25 (0.104) = 0.873$ $a_{12} = 0.101$ $a_{13} = 0.5 (0.104) = 0.052$ $a_{23} = 0$

The A matrix is

$$\begin{pmatrix} 1.881 & 0.101 & 0.052 \\ 0.101 & 0.215 & 0 \\ 0.052 & 0 & 0.873 \end{pmatrix}$$

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By (eq. 2.6.102),

 $V_1 = (1.676) (2.89) + (.101)(8.13) + (.104)(6.70) = 6.362$ $V_2 = (.114)(6.28) + (.101)(8.13) = 1.537$ $V_3 = (.847)(4.98) + (.5)(.104)(6.70) = 4.566$

The V matrix is

$$V = \begin{pmatrix} 6.362 \\ 1.537 \\ 4.566 \end{pmatrix}$$

The inverse matrix, A^{-1} , is found. Procedures for finding the inverse of a matrix are found in many texts. Most computer program packages contain matrix inversion routines. Certain pocket calculators with program cards or tabs also permit rapid inversion of matrices of order 4 by 4 or smaller. The inverse of A is found to be

	/ 0.5463	-0.2566	-0.0325
A-1 =	-0.2566	4.7717	0.0153
	\-0.0325	0.0153	1.1474/

The estimates are the elements of A^{-1} V.

$$\hat{\theta}_1 = (.5463)(6.362) - (.2566)(1.537) - (.0325)(4.566) = 2.933$$

 $\hat{\theta}_2 = 5.771$
 $\hat{\theta}_3 = 5.056$

Note how these estimates compare with the inputs for this iteration. They could then be used to determine the weights for the next iteration, and the process could continue until convergence.

2.6.4 Error Estimation in the Presence of Rounding Errors

In some safeguards applications, most notably, with weighing data, the effect of rounding errors on the total error of measurement cannot be ignored. If a scale rounds to the nearest 10 grams, say, and if replicate measurements are made on the same item, it is quite likely that all recorded weights would agree exactly. If one were then to follow the procedures in 2.6.3.1 to estimate the random error variance due to weighing, the estimate would be zero, for any variability in the weighing process would be obscured by the rounding error. Clearly, it would be misleading to assert that there is zero random error. By similar reasoning, if one weighed known standards when rounding error is relatively large, the conclusion in following the procedures of 2.6.1 would be that the systematic error variance is also zero, for all recorded measurements would be in perfect agreement with the assigned standard value. Such a conclusion is also invalid. By statistical theory based on the uniform or rectangular distribution, for a measurement process in which data are rounded to the nearest u units, the systematic error standard deviation can be no smaller than $u/\sqrt{12}$ units. The same is true of the random error standard deviation for a single weighing [2.26].

If rounding error is not the sole error, but is nevertheless too large to be ignored, e.g., if the measurement data fall into 2 or 3 groups, then an iterative method of obtaining the estimates of the parameters has been developed. The methodology is beyond the scope of this Volume, but the model and estimation procedure are referenced [2.27]. The computer program based on this estimation method is in the Agency library. It is recommended that the method be used whenever measurement data are grouped in 2 or 3 cells because of rounding.

2.6.5 Interlaboratory Test Data

In many Agency safeguards applications, more than one analytical laboratory is involved in some way. Most notably, this occurs whenever interlaboratory sample exchange or "round robin" programs are instigated in order to obtain information on measurement error parameters. Another instance in which such data are generated is whenever inspection samples are sent to more than one laboratory for analysis.

In the sections to follow, the analyses of interlaboratory data are considered. In 2.6.5.1, samples of a single standard reference material are sent to a number of laboratories in a round robin exercise. In 2.6.5.2, non-standard materials are distributed to a number of laboratories for analysis. Section 2.6.5.3 considers the same problem, but it is now assumed that random errors of measurement may be laboratory dependent. The distribution of inspection samples to a number of laboratories with different specified patterns of distribution is discussed in 2.6.5.4.

2.6.5.1 Single Standard Reference Material

The purpose of an exercise in which samples of single standard reference material are sent to participating laboratories is to identify factors that contribute to the uncertainty of a measured value, and assess their importance. To accomplish this, it is necessary that detailed instructions be sent the laboratories relative to how the samples should be measured. That is, one might be interested in obtaining estimates of differences due to replicate measurements of aliquots, differences among aliquots, etc. To obtain such estimates, it is necessary that the analyses be performed according to some plan.

The statistical analysis of the data resulting from such an exercise is called a nested or hierarchal analysis of variance with the plan or experimental design called a general unbalanced nested design. To permit a simpler presentation of the analysis, it will be assumed in Method 2.25 that there are 4 identified variance components to be estimated, and the example will specify the 4 components in question. It should be readily apparent from the analysis of Method 2.25 how the procedures should be altered to account for fewer or more than 4 components. Further, the 4 variance components identified in the example can, of course, be replaced by other components. Method 2.25

Notation

 μ = true value of item being measured

A_i = deviation from μ for level i of factor A; i = 1, 2, ..., a

$${}^Bj(i) \stackrel{=}{}^{} deviation \ from \ \mu \ for \ level \ j \ of \ factor \ B \ within \ level \ i \ of \ factor \ A; \ j = 1, 2, \ \ldots, \ b_i$$

$$C_{k(i,j)}$$
 = deviation from μ for level k of factor C within level j of factor B within level i of factor A; (k = 1, 2, ..., $c_{i,j}$)

$$D_{\ell}(i,j,k) =$$
deviation from μ for level ℓ of factor D within level k of factor C within level j of factor B within level i of factor A; $(\ell = 1, 2, ..., d_{ijk})$

The extension to additional components is obvious.

$$\begin{split} Y_{ijk\ell} &= \text{given observed value related to } A_i, B_{j(i)}, \text{ etc. by the model} \\ Y_{ijk\ell} &= \mu + A_i + B_{j(i)} + C_{k(i,j)} + D_{\ell(i,j,k)} & (\text{eq. 2.6.103}) \\ A_i \text{ is selected at random from a population with zero mean and variance } \sigma_A^2 \\ B_{j(i)} \text{ is selected at random from a population with zero mean and variance } \sigma_B^2 \\ \sigma_C^2 \text{ and } \sigma_D^2 \text{ are similarly defined} \end{split}$$

Results

The problem is to obtain estimates of σ_A^2 , σ_B^2 , σ_C^2 , and σ_D^2 . Note the implicit assumption that σ_B^2 , say, is the same for all levels of factor A, i.e., there are not a values of $\sigma_B^2(i)$ to estimate, but only the one. Similar statements apply to σ_C^2 and σ_D^2 .

The statistical analysis proceeds as follows. The parameters will be estimated by solving the following four equations, starting from the last and working upward.

 $M_{A} = \hat{\sigma}_{D}^{2} + Q_{1}\hat{\sigma}_{C}^{2} + P_{1}\hat{\sigma}_{B}^{2} + R_{1}\hat{\sigma}_{A}^{2}$ $M_{B} = \hat{\sigma}_{D}^{2} + Q_{2}\hat{\sigma}_{C}^{2} + P_{2}\hat{\sigma}_{B}^{2}$ $M_{C} = \hat{\sigma}_{D}^{2} + Q_{3}\hat{\sigma}_{C}^{2}$ $M_{D} = \hat{\sigma}_{D}^{2}$ (eq. 2.6.104)

The procedures for obtaining the M's, Q's, P's, and R_1 are given below. Calculate the following quantities:

$$\begin{split} n_{ij} &= \sum_{k} d_{ijk} \qquad n_{i} = \sum_{j} n_{ij} \qquad n = \sum_{i} n_{i} \\ F_{A} &= a-1 \\ F_{B} &= \sum_{i} b_{i} - a \\ F_{C} &= \sum_{i} \sum_{j} c_{ij} - \sum_{i} b_{i} \\ F_{D} &= n - \sum_{i} \sum_{j} c_{ij} \\ T_{ijk} &= \sum_{k} y_{ijkk} \qquad T_{ij} = \sum_{k} T_{ijk} \\ T_{i} &= \sum_{k} y_{ijkk} \qquad T_{ij} = \sum_{i} T_{i} \\ S_{0} &= T^{2}/n \qquad S_{1} = \sum_{i} T_{i}^{2}/n_{i} \\ S_{2} &= \sum_{i} \sum_{j} T_{ij}^{2}/n_{ij} \qquad S_{3} = \sum_{i} \sum_{j} \sum_{k} T_{ijk}/d_{ijk} \\ S_{4} &= \sum_{i} \sum_{j} \sum_{k} \sum_{k} y_{ijkk} \\ S_{A} &= S_{1}-S_{0} \qquad S_{B} = S_{2}-S_{1} \\ S_{C} &= S_{3}-S_{2} \qquad S_{D} = S_{4}-S_{3} \end{split}$$

The M's are:

$$M_{A} = S_{A}/F_{A} \qquad M_{B} = S_{B}/F_{B}$$

$$M_{C} = S_{C}/F_{C} \qquad M_{D} = S_{D}/F_{D}$$

$$G_{i} = (^{1}/n_{i} - ^{1}/n)/F_{A}$$

$$G_{ij} = (^{1}/n_{ij} - ^{1}/n_{i})/F_{B}$$

$$G_{ijk} = (^{1}/d_{ijk} - ^{1}/n_{ij})/F_{C}$$
(eq. 2.6.105)

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The Q's are:

$$Q_{1} = \sum_{i} \sum_{j} \sum_{k} d_{ijk}^{2} G_{i}$$

$$Q_{2} = \sum_{i} \sum_{j} \sum_{k} d_{ijk}^{2} G_{ij}$$

$$Q_{3} = \sum_{i} \sum_{j} \sum_{k} d_{ijk}^{2} G_{ijk}$$
(eq. 2.6.106)

The P's are:

$$P_{1} = \sum_{i} \sum_{j} n_{ij}^{2} G_{i}$$

$$P_{2} = \sum_{i} \sum_{j} n_{ij}^{2} G_{ij}$$
(eq. 2.6.107)

Finally,

$$R_1 = \sum_i n_i^2 G_i$$
 (eq. 2.6.108)

In solving (eq. 2.6.104), M_D cannot be a negative quantity, but it may be that one or more of the estimates of σ_A^2 , σ_B^2 , and σ_C^2 may be negative. In this event, equate each such estimate to zero and obtain pooled estimates of the other parameters by appropriately combining the equations.

Basis

The distinctive feature of a nested experimental design is noted. Consider factor $B_j(i)$, for example. The j-th level of this factor only has meaning with respect to the i-th level of factor A. For example, if A and B represent laboratory and instrument effects respectively, then instrument 1 for laboratory 1 is not the same as instrument 1 for laboratory 2, say. If one were speaking of instrument <u>types</u> (or analytical methods), then the model would not be nested. It would then be called a crossed-classification and a different statistical analysis would be required.

Many textbooks treat the nested or heirarchal design, but most restrict their treatment to the case where there are equal numbers of observations at each level. For a good treatment of the general unbalanced case treated here, which is the case most likely to be encountered in practice due to "missing" observations even if the plan itself is balanced, see [2.28].

Examples

EXAMPLE 2.25 (a)

Samples of the NBS standard reference material 949/d were distributed to a number of laboratories for analysis of plutonium concentration. For those

laboratories that used a potentiomitry method, the data are tabled. Tabular entries are in percent recovery minus 100. The identified factors are:

- A : laboratories
- B : times within laboratories
- C : aliquots within times within laboratories

D : determinations within aliquots within times within laboratories

Lab Time Aliquot	1 1 .03 .10 10 08	2 1 .09 .21 .09	2 2 1 .45 .23 01	3 1 10 05 12 01 07	3 2 1 08 11 07 13 09	4 1 .02 10 04
Lab Time Aliquot	4 1 2 .00 03 04	4 2 1 08 10 .01	4 2 09 07 .01	$5\\1\\.06\\.53\\.11\\.24\\.42\\.53$	5 1 2 .26 .25 .29 .63 .35 .08	6 1 .06 .30 .57
Lab Time Aliquot	6 1 2 .23 .07 .48	6 2 1 .26 .14 .41	7 1 .09 06 10	7 1 2 .02 .04	7 2 1 042 .013 .018 .044 017	

The various quantities are calculated

$n_{11} = 4$	$n_{42} = 6$	$n_1 = 4$	n = 63
$n_{21} = 3$	n ₅₁ = 12	$n_2 = 6$	
$n_{22} = 3$	$n_{61} = 6$	$n_3 = 10$	
$n_{31} = 5$	$n_{62} = 3$	$n_4 = 12$	
$n_{32} = 5$	$n_{71} = 5$	n ₅ = 12	
$n_{41} = 6$	$n_{72} = 5$	n ₆ = 9	
		$n_7 = 10$	

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	F _A =	6	ł	B	= 12 - 7 =	5		
	F _C =	17 - 12 =	5 I	D	= 63 - 17 =	46		
T 1	111 =	05	T ₄₁₂	=	07	T ₆₁₂	=	.78
T ₂	211 =	.39	T ₄₂₁	=	17	T ₆₂₁	=	.81
T ₂	221 =	.67	T_{422}	Ξ	15	T ₇₁₁	=	07
Τg	311 =	35	T ₅₁₁	Ξ	1.89	T ₇₁₂	Ξ	.06
Τg	321 =	48	T ₅₁₂	-	1.86	T ₇₂₁	Ξ	.016
T۱	+11 =	12	T ₆₁₁	Ξ	.93			
T	ī ₁₁ =	05	Т ₃₂	=	48	Т ₆₁	=	1.71
1	21 =	.39	T ₄₁	=	19	T ₆₂	=	.81
Ţ	22 =	.67	T ₄₂	=	32	T ₇₁	=	01
Т	- 31 =	35	T ₅₁	=	3.75	T ₇₂	=	.016
	T1 =	05	T.	=	51	T ₇	=	.006
	$T_2 =$	1.06	T ₅	П	3.75			
	$T_3 =$	83	т _б	=	2.52	Т	=	5.946
	9		0					
	S=	0 561189	S.	=	2 155935	So	=	2 172618
	$S_{2} =$	2.180340	Su	=	3.009182	02		2117 2010
	• 3	2.100010	~4		0.000102			
	s _A =	1.594746	SB	=	0.016683			
	s _c =	0.007722	s _D	=	0.828842			
M's	are;	from (eq.	2.6.105)					
	M _A =	0.265791	М _В	=	0.003337			
	M _C =	0.001544	М _П	=	0.018018			
	-							

Then,

The

 $G_1 = .039021$ $G_{11} = 0$ $G_{42} = .016667$ $G_2 = .025132$ $G_{21} = .033333$ $G_{51} = 0$ $G_3 = .014021$ $G_{22} = .033333$ $G_{61} = .011111$ $G_4 = .011243$ $G_{31} = .02$ $G_{62} = .044444$ $G_5 = .011243$ $G_{32} = .02$ $G_{71} = .02$ $G_{72} = .02$ $G_6 = .015873$ $G_{41} = .016667$ $G_7 = .014021$ $G_{111} = 0$ $G_{412} = .033333$ $G_{612} = .033333$ $G_{621} = 0$ $G_{211} = 0$ $G_{421} = .033333$ $G_{422} = .033333$ $G_{711} = .026667$ $G_{221} = 0$ $G_{712} = .06$ $G_{311} = 0$ $G_{511} = .016667$ $G_{512} = .016667$ $G_{721} = 0$ $G_{321} = 0$ $G_{411} = .033333$ $G_{611} = .033333$ The Q's are; from (eq. 2.6.106), $Q_1 = 3.9534$ $Q_2 = 3.5600$ $Q_3 = 3.4800$ From (eq. 2.6.107), $P_2 = 4.6000$ $P_1 = 5.6216$ From (eq. 2.6.108), $R_1 = 8.8570$ The estimating equations (eq. 2.6.104) are $0.265791 = \hat{\sigma}_{D}^{2} + 3.9534\hat{\sigma}_{C}^{2} + 5.6216\hat{\sigma}_{B}^{2} + 8.8570\hat{\sigma}_{A}^{2}$ $0.003337 = \hat{\sigma}_{D}^{2} + 3.5600\hat{\sigma}_{C}^{2} + 4.6000\hat{\sigma}_{B}^{2}$ $0.001544 = \hat{\sigma}_{D}^{2} + 3.4800\hat{\sigma}_{C}^{2}$

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Since $M_C < M_D$, the estimate of σ_C^2 is zero. The revised estimate of σ_D^2 is found by taking a weighted average using the last two equations. The weights are F_C and F_D respectively. (These are called degrees of freedom.)

 $0.018018 = \hat{\sigma}_{\rm D}^2$

 $(5)(0.001544) = 5\hat{\sigma}_D^2$ $(46)(0.018018) = 46\hat{\sigma}_D^2$

 $0.836548 = 51\hat{\sigma}_{D}^{2} \implies \hat{\sigma}_{D}^{2} = 0.016403$

From the second equation, it is also evident that the estimate of σ_B^2 is zero. Again weighting,

 $(5)(0.003337) = 5\hat{\sigma}_{D}^{2}$ $0.836548 = 51\hat{\sigma}_{D}^{2}$ $0.853233 = 56\hat{\sigma}_{D}^{2} \implies \hat{\sigma}_{D}^{2} = 0.015236$ From the first constinue than

From the first equation, then,

$$0.265791 = \hat{\sigma}_D^2 + 8.8570\hat{\sigma}_A^2$$

so that

$$\hat{\sigma}_{A}^{2}$$
 = (0.265791 - 0.015236)/8.8570 = 0.028289

Thus, the estimates are:

 $\hat{\sigma}_{A}^{2} = 0.028289$; $\hat{\sigma}_{B}^{2} = \hat{\sigma}_{C}^{2} = 0$; $\hat{\sigma}_{D}^{2} = 0.015236$

The differences among laboratories is the dominant effect. This component, σ_A^2 , is a systematic error variance, while σ_D^2 is a random error variance.

2.6.5.2 Several Samples; Non-Standard Materials

The discussion in the previous section is now extended to accommodate the following changes:

- (1) The samples distributed for analysis are not reference standards, but are samples of production materials.
- (2) The samples are identified, i.e., sample 1 sent to laboratory 1, say, is sampled from the same population as sample 1 sent to laboratory 2.

The second change in assumptions requires a different method of statistical analysis. If the samples were not so identified, the model would still be a nested model and the Method 2.25 could be applied. The fact that the samples are identified results in a model that is partly crossed and partly nested.

To handle this case, follow Method 2.26.

Method 2.26

Notation

Same as for Method 2.25 except that the S's, F's, Q's, etc. have an additional subscript, h, to indicate the sample number. Thus, S_{hA} is the same as S_A in Method 2.25, except that it applies to sample h.

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Results

Perform the analysis of Method 2.25 for each sample. Replace the key equations, (eq. 2.6.104), by the following equivalent equations for sample h.

$$S_{hA} = F_{hA} \left(\hat{\sigma}_{D}^{2} + Q_{h1} \hat{\sigma}_{C}^{2} + P_{h1} \hat{\sigma}_{B}^{2} + R_{h1} \hat{\sigma}_{A}^{2} \right)$$

$$S_{hB} = F_{hB} \left(\hat{\sigma}_{D}^{2} + Q_{h2} \hat{\sigma}_{C}^{2} + P_{h2} \hat{\sigma}_{B}^{2} \right)$$

$$S_{hC} = F_{hC} \left(\hat{\sigma}_{D}^{2} + Q_{h3} \hat{\sigma}_{C}^{2} \right)$$

$$S_{hD} = F_{hD} \hat{\sigma}_{D}^{2}$$
(eq. 2.6.109)

Sum these over the h samples to obtain the four equations which provide the estimates of σA , σB , σC , and σD . (Note: Method 2.26 also assumes that there are the 4 variance components for simplicity in discussion; there may be more or fewer.)

Next, letting \bar{y}_h be the average of all the observations for sample h, compute the variance among these sample means, calling the variance $s_{\bar{y}}^2$. This is equated to its expected value, given using (eq. 2.6.110), and solved for σ_s^2 , the variance due to sampling of the material in question. In (eq. 2.6.110), V_h is the variance of the sample mean for sample h, and the sums indicated are for that sample.

$$V_{h} = \sigma_{s}^{2} + (\sigma_{A}^{2} \sum_{i} n_{i}^{2} + \sigma_{B}^{2} \sum_{i,j} n_{ij}^{2} + \sigma_{C}^{2} \sum_{i,j,k} d_{ijk}^{2} + \sigma_{D}^{2} n_{h})/n_{h}^{2} \qquad (eq. 2.6.110)$$

where n is the total number of observations for sample h. Then σ_{S}^2 is estimated from h

$$\hat{\sigma}_{s}^{2} = s_{y}^{2} - \sum_{h=1}^{H} (V_{h} - \sigma_{s}^{2})/H$$
 (eq. 2.6.111)

where $\sigma_A^2,~\sigma_B^2,~\sigma_C^2,$ and σ_D^2 are replaced by their estimates.

Basis

For this partly crossed and partly nested model, because of the unbalanced nature it is most straightforward to perform the analysis of Method 2.25 separately for each sample and then appropriately combine results to give the overall estimates of σ_A^2 , σ_B^2 , ..., suggested by (eq. 2.6.109).

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To estimate σ_s^2 , the error variance due to sampling of the material in question, the variance among the sample means is calculated, equated to its expected value, and the equation solved for σ_s^2 .

Examples

EXAMPLE 2.26 (a)

Two distinct and identified samples of Pu oxide are distributed to a number of laboratories for analysis of percent plutonium by a given analytical method. The data, in percent Pu minus 86 are tabled. Note, by comparison with the Example 2.25 (a), that there is now no "time" effect. As a result, there are only three levels in the nested model.

Sample 1

Lab Aliquot	$ \begin{array}{r}1\\1\\.188\\.178\\.158\\.198\end{array} $	1 	1 	2 1 .157 .847	2 2 1.007 .837	2 3 .837 .657
Lab Aliquot	3 1 .651 .611 .591	3 2 .581 .641 .581	4 1 .451 .530 .625	4 2 .545 .608 .685	4 3 .586 .702 .730	5 1 .888 .720 .814
Lab Aliquot	5 2 . 377 . 383 . 388	5 3 .661 .651 .394	6 1 .885 .645 .366	6 2 063 .625 1.094	6 3 .645 .615 .475	7 1 .515 .635 .555
Lab Aliquot	7 2 .645 .645 .615	7 3 .825 .715 .725	8 1 .677 .492 .640 .636 .645	8 2 .698 .532 .580 .526 .608	8 3 .346 .456 .466 .617 .656	

		-				
Lab Aliquot	$ \begin{array}{r}1\\1\\.318\\.138\\.388\\.158\end{array} $	1 2 .048 .228 .098 .218	$ \begin{array}{r} 1 \\ 3 \\ .128 \\ .398 \\ .198 \\ .168 \end{array} $	2 .580 .660 .610	2 2 .730 .890	2 3 .680 .110 .890
Lab Aliquot	3 1 .587 .567 .547	3 2 .507 .457 .467	3 3 .587 .587 .487	4 1 .690 .683 .793	4 2 .662 .546 .596	5 1 .570 .542 .828
Lab Aliquot	5 2 .867 .390 .782	5 3 .503 .242 .622	6 1 .380 .170 .510	6 2 .400 .610 .370	6 3 .440 .380 .450	7 _1 .478 .698 .328
Lab Aliquot	7 2 .418 .548 .488	7 3 . 158 . 318 . 458				

Since the analysis for each of the two samples is so similar to that demonstrated in Example 2.25 (a), the only difference being that now there are three levels rather than four, the calculations are not all indicated. Rather, (eq. 2.6.109) is shown for each of the two samples, and for their sum.

Sample 1: 1.127201 = 7 $(\hat{\sigma}_{C}^{2}+3.217119\hat{\sigma}_{B}^{2}+9.257067\hat{\sigma}_{A}^{2})$ 0.659001 = 15 $(\hat{\sigma}_{C}^{2}+3.266685\hat{\sigma}_{B}^{2})$ 1.325515 = 52 $\hat{\sigma}_{C}^{2}$ Sample 2: 1.506556 = 6 $(\hat{\sigma}_{C}^{2}+3.098098\hat{\sigma}_{B}^{2}+8.806384\hat{\sigma}_{A}^{2})$

 $0.308824 = 13 \ (\hat{\sigma}_{C}^{2} + 3.096190\hat{\sigma}_{B}^{2})$

 $0.950346 = 42 \ \hat{\sigma}_{C}^{2}$

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Sample 2

Summed over both samples: $2.633757 = 13\hat{\sigma}_{C}^{2} + 41.108421\hat{\sigma}_{B}^{2} + 117.637773\hat{\sigma}_{A}^{2}$ $0.967825 = 28\hat{\sigma}_{C}^{2} + 89.250745\hat{\sigma}_{B}^{2}$ $2.275861 = 94\hat{\sigma}_{C}^{2}$ Solving these: $\hat{\sigma}_{C}^{2} = 0.024211$ (Replicates) $\hat{\sigma}_{R}^{2} = 0.003248$ (Aliguots) $\hat{\sigma}_{\Lambda}^2 = 0.018578$ (Laboratories) Proceeding to find the estimate of σ_S^2 , the two sample means are $\bar{y}_1 = 0.5603$ $\bar{y}_2 = 0.4733$ $s_{\overline{v}}^2 = 0.003785$ from which From (eq. 2.6.110), $V_1 = \sigma_s^2 + 0.003000$ $V_2 = \sigma_s^2 + 0.003301$ Thus, from (eq. 2.6.111), $\hat{\sigma}_{s}^{2} = 0.003785 - 0.006301/2$ = 0.000635(Sampling)

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2.6.5.3 Laboratory-Dependent Random Error

For the case in which several samples of a given material are distributed to a number of laboratories, it may be appropriate to apply a Grubbs' analysis as described in 2.6.3.4, or the analysis described in 2.6.3.5 if the assumptions underlying the Grubbs' analysis are not valid. The main advantage of the Grubbs' analysis is that it provides estimates of the random error variance for each laboratory. It is not required that all have the same random error variances, an assumption implicit in Methods 2.25 and 2.26. Further, the estimate of the error may be more realistic than one based on observing the scatter among reported results.

2.6.5.4 Distribution of Inspection Samples to Several Laboratories

A problem of special interest to Agency safeguards is that concerned with the distribution of inspection samples to more than one laboratory. The effect of this action on statistical inference is discussed in the next chapter. In this section, the problem of analyzing the inspection data to make inferences about errors of measurement is considered.

There are, of course, any number of ways in which samples may be distributed. Three representative distribution plans are treated here. For variations on these plans, competent statistical advice should be sought.

For each plan, n items of a given material are selected for analysis, and there are L laboratories to perform the analysis. There are two reported results per sampled item so that the total number of observations is 2n for each plan. The plans under consideration are:

- Plan 1: n/L samples are sent to each of the L laboratories. Each laboratory performs duplicate analyses on each sampled item.
- Plan 2: The n samples are each split into two parts or subsamples. There are only L=2 laboratories, each of which makes single analyses on each of the n paired subsamples.
- Plan 3: Same as Plan 2 except that there are L(L-1)/2 pairs of laboratories, each pair of which are sent 2n/L(L-1) pairs of subsamples. Each laboratory makes a single analysis on each subsample.

Plan 1 will be covered by Method 2.27, Plan 2 by Method 2.28, and Plan 3 by Method 2.29. First, however, the mathematical model underlying all three plans is presented. The model is written to include components that may not be estimable with each plan, except perhaps in combination. The assumed model is:

$$x_{ijk} = \mu^{+\theta+\beta} i^{+\eta} j^{+\omega} ijk$$
 (eq. 2.6.112)

where

 x_{ijk} = measured result for lab i, sample j, analytical determination k μ = true average result for population being sampled θ = overall deviation, or bias, common to all labs β_i = deviation due to lab i n_j = deviation due to sample j ω_{ijk} = deviation for determination k, lab i, sample j

Some important points are noted from this model.

(1) It is not possible to obtain separate information about μ and θ from the inspection samples alone; only the net effect of both parameters can be studied.

(For example, the labs in total could all be biased high by, say, 0.1%, but this could not be detected unless known standards were used.)

(2) β_i , called the lab effect, should be thought of as the sum of two effects. One is the deviation for lab i averaged over all time frames, and the other is the deviation due to the particular time frame existing for the data in question. It is assumed that all inspection samples in question are analyzed in the same time frame. Thus, β_i is really the algebraic sum of the lab effect and the time-within-lab effect. It is assumed that β_i is a random variable with zero mean and variance σ_{β}^2 .

(3) η_j is a random variable with zero mean and variance σ_{η}^2 . This describes the variance between sample values, or the item to item variance.

(4) ω_{ijk} is a random variable with zero mean and variance σ_{ω}^2 , called the analytical error.

(5) As a variation on the model that is not generally identified, it is recognized that a correlation can exist between replicate analytical results. The quantity σ_{ω}^2 is intended to represent the net effect of all factors normally operating within a laboratory in a given time frame. If, for a set of observations, some conditions that are normally permitted to vary are held constant, then the resulting estimate of σ_{ω}^2 will be biased low. To accommodate this possibility in the model, write the covariance between two results within lab i as

$$E(\omega_{ijk}, \omega_{ijl}) = \rho_i \sigma_{\omega}^2 \qquad (eq. 2.6.113)$$

This representation is not wholly realistic or satisfactory, but it will serve to keep in mind at least in a semi-quantitative way what quantities are estimable with the different sample distribution plans.

Method 2.27

Under Plan 1, n/L samples are sent to each of the L laboratories with duplicate analyses performed on each sampled item.

Notation

The notation is given by (eq. 2.6.112) and following.

Results

The data are analyzed by a nested analysis of variance, but the analysis is simpler than by Method 2.25 because of the balance in the design. The estimating equations are

$$M_{1} = 2n\hat{\sigma}_{\beta}^{2}/L + 2\hat{\sigma}_{\eta}^{2} + \hat{\sigma}_{\omega}^{2} (L + \sum_{i} \rho_{i})/L$$

$$M_{2} = 2\hat{\sigma}_{\eta}^{2} + \hat{\sigma}_{\omega}^{2} (L + \sum_{i} \rho_{i})/L$$

$$M_{3} = \hat{\sigma}_{\omega}^{2} (L - \sum_{i} \rho_{i})/L$$

$$(eq. 2.6.114)$$

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The M's are calculated from the data as follows. Calculate

$$Q_{ij} = \sum_{k} x_{ijk} \qquad T_{i} = \sum_{j} Q_{ij}$$

$$T = \sum_{i} T_{i}$$

$$S_{0} = T^{2}/2n \qquad S_{1} = L \sum_{i} T_{i}^{2}/2n$$

$$S_{2} = \sum_{i} \sum_{j} Q_{ij}^{2}/2 \qquad S_{3} = \sum_{i} \sum_{j} \sum_{k} x_{ijk}^{2}$$

The M's of (eq. 2.6.114) are calculated from

$$M_{1} = (S_{1}-S_{0})/(L-1)$$
$$M_{2} = (S_{2}-S_{1})/(n-L)$$
$$M_{3} = (S_{3}-S_{2})/n$$

From the first two equations of (eq. 2.6.114), it is evident that σ_β^2 is estimated by

$$\hat{\sigma}_{B}^{2} = (M_{1} - M_{2})L/2n$$
 (eq. 2.6.115)

From the equations for M_2 and M_3 , it is also evident that σ_{ω}^2 and σ_{η}^2 can only be estimated if $\sum_i \rho_i = 0$.

If

is positive, M_3 will tend to overestimate σ_ω^2 , while σ_η^2 will tend to be underestimated. However, no matter what the size of

,

 $\sum_{i}^{\rho} i$

the sum of σ_n^2 and σ_ω^2 is estimated by $(M_2+M_3)/2$.

On the other hand, if the sampling error, $\sigma_\eta^2,$ were known to be negligibly small relative to $\sigma_\omega^2,$ then

$$\hat{\sigma}_{\omega}^2 = (M_2 + M_3)/2$$
 (eq. 2.6.116)

$$\sum_{i} \rho_{i} = L(M_{2}-M_{3})/(M_{2}+M_{3})$$
 (eq. 2.6.117)

and

If ρ_i is to be estimated separately for each laboratory, then the data may be analyzed separately for each laboratory, as the example will illustrate.

The (eq. 2.6.114) are very instructive in pointing out just what combinations of parameters are being estimated by each statistic.

Basis

Given the model of (eq. 2.6.112) and the expressions for M_1 , M_2 , and M_3 , the estimating equations (eq. 2.6.114) are found by equating the expected values of M_1 , M_2 , and M_3 to their respective observed values.

Examples

EXAMPLE 2.27 (a)

In an inspection, 24 sintered UO_2 pellets are sampled. Eight pellets are sent to each of labs 1, 2, and 3, and each lab performs duplicate analyses. The data, in percent U minus 80, are given below.

Lab 1			Lab 2	Lab 3		
Pellet	%U-80	Pellet	<u>%U-80</u>	Pellet	%U-80	
1	8.056, 7.992	9	7.939, 8.107	17	8.144, 8.122	
2	8.088, 7.999	10	7.883, 7.970	18	8.240, 8.279	
3	8.044, 8.026	11	8.005, 7.923	19	8.132, 8.054	
4	8.015, 8.117	12	8.064, 8.119	20	8.233, 8.266	
5	7.897, 7.825	13	8.001, 7.922	21	8.079, 8.127	
6	8.039, 8.099	14	7.977, 7.982	22	8.102, 8.130	
7	7.950, 7.881	15	7.881, 7.921	23	7.977, 7.837	
8	8.113, 8.068	16	7.946, 8.023	24	8.105, 8.048	

The design parameter values are

L = 3

The calculated quantities are:

$Q_{11} =$	16.048	$Q_{29} =$	16.046	$Q_{3,17} =$	16.266
$Q_{12} =$	16.087	$Q_{2,10} =$	15.853	Q _{3,18} =	16.519
$Q_{13} =$	16.070	$Q_{2,11} =$	15.928	Q _{3,19} =	16.186
$Q_{14} =$	16.132	$Q_{2,12} =$	16.183	$Q_{3,20} =$	16.499
$Q_{15} =$	15.722	$Q_{2,13} =$	15.923	$Q_{3,21} =$	16.206
$Q_{16} =$	16.138	$Q_{2,14} =$	15.959	$Q_{3,22} =$	16.232
$Q_{17} =$	15.831	$Q_{2,15} =$	15.802	$Q_{3,23} =$	15.814
$Q_{18} =$	16.181	$Q_{2,16} =$	15.969	$Q_{3,24} =$	16.153

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 $T_1 = 128.209$ $T_2 = 127.663$ $T_3 = 129.875$ T = 385.747 $S_0 = 3100.015583$ $S_1 = 3100.181554$ $S_2 = 3100.491001$ $S_3 = 3100.557383$

The M's are calculated from these S values, and the estimating equations become:

 $0.082986 = 16\sigma_{\beta}^{2} + 2\sigma_{\eta}^{2} + \sigma_{\omega}^{2} (1+\bar{\rho})$ $0.014736 = 2\sigma_{\eta}^{2} + \sigma_{\omega}^{2} (1+\bar{\rho})$ $0.002766 = \sigma_{\omega}^{2} (1-\bar{\rho})$

where

$$\bar{\rho} = (\rho_1 + \rho_2 + \rho_3)/3$$

From the first two equations,

 $\hat{\sigma}_{B}^{2}$ = (.082986 - .014736)/16 = 0.004266

If one can assume that $\bar{\rho}$ = 0, then

 $\hat{\sigma}_{\omega}^2 = 0.002766$ $\hat{\sigma}_{n}^2 = (.014736 - .002766)/2 = 0.005985$

Regardless of the value of $\bar{\rho}$, the sum of the two variance components is

$$\hat{\sigma}_{\omega}^2 + \hat{\sigma}_{\eta}^2 = (.014736 + .002766)/2 = 0.008751$$

The sampling error for percent U in uranium pellets should be very small. If σ_{η} = 0, then from the last two of the estimating equations,

$$.014736 = \sigma_{\omega}^{2}(1+\bar{\rho})$$

$$.002766 = \sigma_{\omega}^{2}(1-\bar{\rho})$$

which gives $\bar{\rho} = 0.684$ (large positive correlation)
 $\hat{\sigma}_{\omega}^{2} = 0.008751$

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The correlation coefficient is not likely to be the same for all three laboratories. The parameters ρ_1 , ρ_2 , and ρ_3 can be estimated separately for each lab by setting L=1 in Method 2.27 and using only the last two of the estimating equations (eq. 2.6.114). The summary results are, again assuming $\sigma_2^2=0$:

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Lab 1 $.013171 = \sigma_{\omega}^{2}(1+\rho_{1})$ $\hat{\sigma}_{\omega}^{2} = 0.007783$ $.002395 = \sigma_{\omega}^{2}(1-\rho_{1})$ $\hat{\rho}_{1} = 0.692$ Lab 2 $.006856 = \sigma_{\omega}^{2}(1+\rho_{2})$ $\hat{\sigma}_{\omega}^{2} = 0.005282$ $.003708 = \sigma_{\omega}^{2}(1-\rho_{2})$ $\hat{\rho}_{2} = 0.298$ Lab 3 $\hat{\sigma}_{\omega}^{2} = 0.013188$; $\hat{\rho}_{3} = 0.834$

Method 2.28

Under Plan 2, the n samples are each split into two subsamples. L=2, and each lot makes a single analysis on each of the n subsamples.

Notation

The notation is given by (eq. 2.6.112) and following.

Results

The data are analyzed by the method of Grubbs (see 2.6.3.3). In order to apply this, it is necessary that the sampling error variance, σ_{η}^2 , be small relative to the analytical error variance, σ_{ω}^2 . However, for large σ_{η}^2 , the estimate of σ_{ω}^2 is meaningful if, in fact, σ_{ω}^2 is the same for both laboratories. The correlation coefficient, ρ_i , does not enter into the analysis since replicate measurements are not made.

Compute V₁ and V₂, the sample variances among the n values for labs 1 and 2 respectively. Also compute V₁₂, the sample covariance for the n pairs of values. Then, the estimating equations are:

 $\hat{\sigma}_{n}^{2} = V_{12}$ (eq. 2.6.118)

 $\hat{\sigma}_{\omega 1}^{2} = V_{1} - V_{12}$ $\hat{\sigma}_{\omega 2}^{2} = V_{2} - V_{12}$ (eq. 2.6.119)

(Eq. 2.6.119) provides separate estimates of σ_{ω}^2 for each lab. If both labs have the same value of σ_{ω}^2 , then this is estimated by

$$\hat{\sigma}_{\omega}^2 = (V_1 + V_2 - 2V_{12})/2$$
 (eq. 2.6.120)

The variance between labs, σ_{β}^2 , is estimated by

$$\hat{\sigma}_{\beta}^2 = [(T_1 - T_2)^2/n - (\hat{\sigma}_{\omega 1}^2 + \hat{\sigma}_{\omega 2}^2)]/2n$$
 (eq. 2.6.121)

where T_i is the total of all observations for Lab i.

Basis

The basis is the same as for Methods 2.18 and 2.20.

Examples

EXAMPLE 2.28 (a)

The 24 sintered pellets of Example 2.27 (a), were each split into two parts with one part of each pellet sent to Lab 1 and the other to Lab 2. The data are tabled below, all values being in (% U-80).

Pellet	<u>Lab 1</u>	<u>Lab 2</u>	Pellet	<u>Lab 1</u>	<u>Lab 2</u>	Pellet	Lab 1	<u>Lab 2</u>
1	7.985	8.025	9	8.139	7.992	17	8.042	7.868
2	7.862	7.975	10	8.051	7.893	18	8.034	8.057
3	8.013	7.938	11	7.940	8.019	19	7.981	8.016
4	8.061	8.071	12	7.918	7.859	20	7.917	7.947
5	8.016	7.862	13	8.204	7.959	21	7.913	7.933
6	7.857	7.866	14	8.059	7.842	22	7.999	7.992
7	8.036	8.010	15	8.044	7.992	23	7.923	8.194
8	8,170	7,974	16	7,948	8.022	24	8.033	8.047

Then,

 $V_1 = 0.007823$ $V_2 = 0.006850$ $V_{12} = 0.000044$

From (eq. 2.6.118),

 $\hat{\sigma}_n^2 = 0.000044$

From (eq. 2.6.119),

 $\hat{\sigma}_{w1}^2 = 0.007779$

 $\hat{\sigma}_{\omega 2}^2 = 0.006806$

From (eq. 2.6.121), where $T_1 = 192.145$ and $T_2 = 191.353$

 $\hat{\sigma}_{B}^{2}$ = (.026136 - .014585)/48 = 0.000241

Plan 2 involves only the two laboratories. When sampling errors are not small relative to analytical errors, and when separate estimates of the analytical error variance for the laboratories are desired, the paired subsamples should be distributed to more than two labs according to the Plan 3 distribution plan.

Method 2.29

Notation

The notation is given by (eq. 2.6.112) and following.

Results

To estimate $\sigma_{\omega i}^2$, follow Method 2.21, where N of 2.21 is the same as L, and where σ_i^2 is the same as $\sigma_{\omega i}^2$.

The sampling variance, σ_{η}^2 , is estimated by

$$\hat{\sigma}_{\eta}^2 = \sum_{i=1}^{L} (s_i^2 - \hat{\sigma}_{\omega i}^2)/L$$
 (eq. 2.6.122)

where s_1^2 is the variance among the measured values of Lab i.

To estimate the between lab variance, σ_β^2 , calculate the means for each of the L(L-1)/2 columns of differences. Calling this mean \bar{x}_{ij} for Labs i and j, then σ_β^2 is estimated by

$$\hat{\sigma}_{\beta}^{2} = \sum_{i} \sum_{j} \bar{x}_{ij}^{2} / L(L-1) - (L-1) \sum_{j} \hat{\sigma}_{\omega i}^{2} / 2n$$
 (eq. 2.6.123)

<u>Basis</u>

The basis for Method 2.21 which provides the estimates of $\sigma_{\omega\,i}^2$ was given earlier, under that method.

For (eq. 2.6.122) and (eq. 2.6.123), the expected values of Σs_1^2 and of $\Sigma \Sigma \bar{x}_1 \bar{j}^2$ respectively are found and equated to the observed values of these statistics. The equations are then solved for the parameters to be estimated, σ_η^2 and σ_β^2 respectively. The quantity $\sigma_{\omega j}^2$ is replaced by its estimate for each lab i.

Examples

EXAMPLE 2.29 (a)

The 24 sintered pellets of Example 2.27 (a) were each split into two pairs. The 24 pairs were distributed among 4 labs, with each pair of labs receiving 4 pairs. The data, expressed as (% U-80) are tabled.

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<u>Pellet</u>	Lab 1	Lab 2	Pellet	<u>Lab 1</u>	Lab 4	Pellet	Lab 2	Lab 4
1	8.030	8.048	9	7.839	8.088	17	7.986	8.140
2	8.062	7.954	10	7.932	8.217	18	7.785	8.165
3	7.994	7.981	11	7.970	8.064	19	8.009	8.061
4	8.036	7.988	12	8.020	8.130	20	8.015	8.048
	Lab 1	Lab 3		Lab 2	Lab 3		Lab 3	Lab 4
5	7.931	8.096	13	7.909	8.046	21	8.137	7.981
6	8.032	7.990	14	7.934	8.069	22	7.998	8.038
7	8.187	8.033	15	7.927	8.092	23	8.108	8.120
8	8.009	8.196	16	8.009	7.999	24	8.022	8.058

Here, n = 24 and L = 4

First, follow Method 2.21. The calculated differences are not shown, but the summarizing statistics are:

$v_{12} = 0.002920$	$v_{23} = 0.006245$	
$v_{13} = 0.027197$	$v_{24} = 0.025373$	
$v_{14} = 0.009334$	$v_{34} = 0.008740$	
Then, by (eq. 2.6.94),		
$S_1 = 0.039451$	$S_3 = 0.042182$	V = 0.

$S_1 = 0.039451$	$S_3 = 0.042182$	V = 0.079809
$S_2 = 0.034538$	$S_4 = 0.043447$	

By (eq. 2.6.95),

 $\hat{\sigma}_{\omega 1}^{2} = (.039451)/2 - 0.079809/6 = 0.006424$ $\hat{\sigma}_{\omega 2}^{2} = 0.003968$ $\hat{\sigma}_{\omega 3}^{2} = 0.007790$ $\hat{\sigma}_{\omega 4}^{2} = 0.008422$

To estimate σ_{η}^2 by (eq. 2.6.122), first calculate s_{j}^2 for each lab. The results are

s ₁ ²	=	0.007146	s_3^2	H	0.003964
s ₂ 2	=	0.004768	s_4^2	=	0.004143

Thus,

$$\hat{\sigma}_{\eta}^2$$
 = (.000722 + .000800 - .003826 - .004279)/4
= -0.001646 (call it 0)

To estimate σ_{β}^2 by (eq. 2.6.123), first calculate the 6 mean differences.

 $\bar{x}_{12} = 0.03775$ $\bar{x}_{23} = -0.10675$ $\bar{x}_{13} = -0.03900$ $\bar{x}_{24} = -0.15475$ $\bar{x}_{14} = -0.18450$ $\bar{x}_{34} = 0.01700$

Then,

$$\hat{\sigma}_{\beta}^2 = (.073618)/12 - 3 (.026604)/48$$

= 0.004389
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Chapter 3

ERROR PROPAGATION

3.1 DEFINITION OF ERROR PROPAGATION

In the Safeguards Dictionary [3.1] prepared by the Brookhaven National Laboratory for the then United States Atomic Energy Commission, error propagation is defined as follows: "The determination of the value to be assigned as the uncertainty of a given quantity using mathematical formulae for the combination of measurement errors. Error propagation involves many considerations and the choice of formulae for computing the uncertainty depends upon the functional relations of the measurement parameters involved."

This definition is made with respect to safeguards applications since it speaks of combining measurement errors. Nevertheless, the definition accurately identifies error propagation as a procedure based on using mathematical formulae. It is consistent with another quote taken from an expository paper on error propagation by Birge [3.2], "The subject of the propagation of errors . . . is a purely mathematical matter, with very definite and easily ascertained conclusions." Although the practitioner might quarrel with the words "easily ascertained" there can be no quarrel with the principal point in both quotations, namely, error propagation is a <u>mathematical</u> exercise and hence leads to precise and well-defined procedures.

Although the error propagation procedures may be exact, this does not mean that the net effect of the propagated errors is exactly determined. The error propagation formulas draw a mathematically precise line from some model to the conclusions; any inexactness in an answer derived from error propagation comes not from drawing this mathematically precise line, (assuming that this line is drawn correctly), but rather from the starting point, that is, from the mathematical model. This underscores the importance of the model insofar as it corresponds to a valid description of reality.

The general error propagation problem may be formulated as follows. Let a random variable of interest (such as the MUF or material unaccounted for) be written as a specific function of a number of other random variables as in (eq. 3.1.1).

$$y = f(x_1, x_2, \dots, x_k)$$
 (eq. 3.1.1)

The precise form of this function is known in the error propagation problem, that is, the problem is not to estimate the parameters of the function (which is a statistical problem), but is rather to find the uncertainty in y as a function of the uncertainties in the x's (a mathematical problem) given that the function is well defined. In the section to follow, error propagation is considered when f is a linear function, and the more general case for the nonlinear function is treated in Section 3.3. 3.2 ERROR PROPAGATION; ADDITIVE MODEL

Error propagation for the additive or linear model is covered by Method 3.1.

Method 3.1

Notation

Let
$$x_i$$
 = value for the i-th random variable
 a_i = i-th constant; i=1, 2, ..., k
 μ_i = E(x_i) , mean of x_i
 σ_i^2 = E($x_i - \mu_i$)² , variance of x_i
 σ_{ij} = E[($x_i - \mu_i$)($x_j - \mu_j$)] , covariance between x_i and x_j
 y = value for response or dependent variable
 μ_y = E(y) , mean of y
 σ_y^2 = E($y - \mu_y$)² , variance of y

<u>Model</u>

$$y = \sum_{i=1}^{k} a_i x_i$$
 (eq. 3.2.1)

Results

$$\mu_{y} = \sum_{i=1}^{k} a_{i} \mu_{i}$$
 (eq. 3.2.2)

$$\sigma_{y}^{2} = \sum_{i=1}^{k} a_{i}^{2} \sigma_{i}^{2} + 2 \sum_{i=1}^{k-1} \sum_{j>i} a_{i}^{a} a_{j}^{\sigma} \sigma_{ij}$$
(eq. 3.2.3)

Basis

The formulas given by (eq. 3.2.2) and (eq. 3.2.3) are basic results found in most texts. See, for example, reference [3.3].

Examples

EXAMPLE 3.1 (a)

Consider a number of observations x_i, x_2, ..., x_k and calculate the sample mean or average, denoted by y

$$y = (x_1 + x_2 + \dots + x_k)/k$$

If $E(x_i) = \mu$ and $E(x_i - \mu)^2 = \sigma^2$ for all i, with $E(x_i - \mu)(x_j - \mu) = 0$ for $i \neq j$, then application of (eq. 3.2.2) and (eq. 3.2.3), with $a_i = 1/k$ for all i, gives

$$E(y) = k\mu/k = \mu$$

$$\sigma_v^2 = k\sigma^2/k^2 = \sigma^2/k$$

Note: y, the sample average or mean, is usually denoted by \bar{x} . This example shows that the mean of \bar{x} is μ and its variance is σ^2/k for the simple model considered here.

EXAMPLE 3.1 (b)

Some 19 ${\rm UF}_6$ cylinders in a shipment are weighed over a period of four days. The model for a single weighing is written:

$$x_{i(j)} = \mu_{i(j)} + \delta + \theta_{i} + \varepsilon_{i(j)}$$

where

Assume that

$$E(\delta) = E(\theta_i) = E(\varepsilon_{i(j)}) = 0$$

$$E(\delta^2) = \sigma_{\delta}^2 ; E(\theta_i^2) = \sigma_{\theta}^2 ; E(\varepsilon_{i(j)}^2) = \sigma_{\varepsilon}^2$$

$$\sigma_{\delta} = 0.6 \text{ lbs} ; \sigma_{\theta} = 1.2 \text{ lbs.} ; \sigma_{\varepsilon} = 1.6 \text{ lbs}$$

All covariances are zero.

Of the 19 cylinders, 4 are weighed on day 1, 3 on day 2, 7 on day 3, and 5 on day 4. Find the variance of the total observed weight.

Here,

$$y = \sum_{i(j)} x_{i(j)}$$
$$= \sum_{i(j)} x_{i(j)} + 19\delta + 4\theta_1 + 3\theta_2 + 7\theta_3 + 5\theta_4 + \sum_{i(j)} x_{i(j)}$$

 $\sigma_y^2 = 361\sigma_{\delta}^2 + (16+9+49+25)\sigma_{\theta}^2 + 19\sigma_{\varepsilon}^2$ = (361)(0.36) + (99)(1.44) + (19)(2.56) = 321.16 lbs² $\sigma_y = 17.9 lbs$

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3.3 GENERAL ERROR PROPAGATION; TAYLOR'S SERIES

The key equations, (eq. 3.2.2) and (eq. 3.2.3), apply only if the function indicated by (eq. 3.1.1) is linear. Although linear models are adequate approximations to reality in many applications, they cannot, of course, be expected to apply universally. In the area of safeguards applications, in fact, nonlinear models are frequently encountered, as was discussed in Section 2.3.2.

For nonlinear models, errors are propagated using an approximation based on Taylor's series. The method follows.

Method 3.2

Notation

The notation is the same as for Method 3.1, except that a_i is not defined, except in particular applications.

Mode1

In general terms, the model is schematically indicated by (eq. 3.1.1). A specific model must be written for each application.

Results

whe

The mean of y is given approximately by

$$\mu_{v} \approx f(\mu_{1}, \mu_{2}, \dots, \mu_{v})$$
 (eq. 3.3.1)

The approximation to the variance of y is

$$\sigma_y^2 \approx \sum_{i=1}^k b_i^2 \sigma_i^2 + 2 \sum_{i=1}^{k-1} \sum_{j>i} b_i b_j \sigma_{ij} \qquad (eq. 3.3.2)$$

re $b_i = \frac{\partial b}{\partial x_i}$, evaluated at μ_i for all i

Note the similarity between the forms of (eq. 3.3.2) and (eq. 3.2.3).

<u>Basis</u>

The approximations given by (eq. 3.3.1) and (eq. 3.3.2) are based on approximating the function (eq. 3.1.1) by the linear terms of a Taylor's series approximation [3.4]. This approximation is

$$f(x_1, x_2, \dots, x_k) \approx f(\mu_1, \mu_2, \dots, \mu_k) +$$

$$\sum_{i=1}^{k} \left(\frac{\partial f}{\partial x_i}\right) (x_i - \mu_i) \qquad (eq. 3.3.3)$$

Since $f(\mu_1, \mu_2, \ldots, \mu_k)$ is a constant, (eq. 3.2.3) can be applied immediately to (eq. 3.3.3), giving the result in (eq. 3.3.2). The transition from (eq. 3.3.3) to (eq. 3.3.2) is an exact one. The approximation comes about by (eq. 3.3.3) in which only the linear terms of Taylor's series are included. For most safeguards applications that are routinely encountered, this is an adequate approximation. Its adequacy depends on errors being "small" in a relative sense, e.g., smaller than 5%-10% relative. If there is concern about the adequacy of a result based on Taylor's series approximation in a given instance, statistical guidance should be sought.

Examples

EXAMPLE 3.2 (a)

In connection with Method 2.5 dealing with linear calibration, it was indicated that certain results were based on error propagations methods to be discussed in Chapter 3. With the tools now in hand, the results of interest can now be derived.

From eq. (2.6.21),

 $x_0 = (y_0 - \alpha)/\hat{\beta}$

where α is a constant, y_0 has variance estimated by $\hat{\sigma}^2$, and $\hat{\beta}$ has variance denoted by $V(\hat{\beta})$. Then, to apply (eq. 3.3.2), find the appropriate partial derivatives:

$$b_1 = \frac{\partial x_0}{\partial y_0} = \frac{1}{\hat{\beta}}$$
$$b_2 = \frac{\partial x_0}{\partial \hat{\beta}} = \frac{-(y_0 - \alpha)}{\hat{\beta}^2}$$

Therefore, from (eq. 3.3.2), and keeping in mind that the covariance between y_0 and $\hat{\beta}$ is zero, the approximate variance of x_0 is estimated by

$$V(x_0) \approx \hat{\sigma}^2/\hat{\beta}^2 + (y_0 - \alpha)^2 V(\hat{\beta})/\hat{\beta}^4$$

In Method 2.5, the first term in this expression was regarded as the random error variance, and the second term, the systematic error variance.

EXAMPLE 3.2 (b)

In Method 2.14 dealing with nonlinear calibration, (eq. 2.6.76) gave the following expression for x_0 as a function of the random variables $\hat{\alpha}$ and $\hat{\beta}$. (Treat y_0 as a constant when focussing attention on the systematic error variance.)

$$x_{0} = -\hat{\alpha}(1 - \sqrt{1 + 4\hat{\beta}y_{0}/\hat{\alpha}^{2}})/2\hat{\beta}$$
$$= [-\hat{\alpha} + (\hat{\alpha}^{2} + 4\hat{\beta}y_{0})^{1/2}]/2\hat{\beta}$$

To apply (eq. 3.3.2),

$$b_{1} = \frac{\partial x_{0}}{\partial \hat{\alpha}} = \left[-1 + \hat{\alpha} (\hat{\alpha}^{2} + 4\hat{\beta}y_{0})^{-1/2}\right]/2\hat{\beta}$$
$$= (\hat{\alpha} - R)/2\hat{\beta}R$$
$$R = (\hat{\alpha}^{2} + 4\hat{\beta}y_{0})^{1/2}$$

Also,

where

$$b_{2} = \frac{\partial x_{0}}{\partial \hat{\beta}} = \frac{2\hat{\beta}(2y_{0}R^{-1}) - (-\hat{\alpha} + R)2}{4\hat{\beta}^{2}}$$
$$= [2\hat{\beta}y_{0} + R(\hat{\alpha} - R)]/2\hat{\beta}^{2}R$$

It is noted that $\hat{\alpha}$ -R = $-2\hat{\beta}x_0$ so the expressions for b_1 and b_2 reduce to

 $b_1 = -x_0/R$ $b_2 = (y_0 - Rx_0)/\hat{\beta}R$ where $R = (\hat{\alpha}^2 + 4\hat{\beta}y_0)^{1/2} = \hat{\alpha} + 2\hat{\beta}x_0$

Then, applying (eq. 3.3.2), and letting $V(\hat{\alpha})$ and $V(\hat{\beta})$ denote the variances of $\hat{\alpha}$ and of $\hat{\beta}$ respectively, with $CV(\hat{\alpha},\hat{\beta})$ the covariance between them, the result is

$$V_{s}(x_{0}) = (x_{0}^{2}/R^{2})V(\hat{\alpha}) + [(y_{0}-Rx_{0})^{2}/\hat{\beta}^{2}R^{2}]V(\hat{\beta})$$

- 2x_{0}(y_{0}-Rx_{0})/\hat{\beta}R^{2} CV(\hat{\alpha},\hat{\beta})
But since y_{0}-Rx_{0} = \beta x_{0}^{2} + \hat{\alpha} x_{0} - \hat{\alpha} x_{0} - 2\hat{\beta} x_{0}^{2}
= $-\hat{\beta} x_{0}^{2}$,

the expression for the systematic error variance of x_0 , $v_s(x_0)$ reduces to

$$V_{c}(x_{0}) = (x_{0}^{2}/R^{2})[V(\hat{\alpha}) + x_{0}^{2}V(\hat{\beta}) + 2x_{0}CV(\hat{\alpha},\hat{\beta})]$$

which is the result, (eq. 2.6.80).

Other applications of error propagation will be encountered later in this volume.

3.4 CALCULATION OF VARIANCE OF MUF

3.4.1 Definition of MUF

The word, MUF, is an acronym for <u>material unaccounted for</u>. It is defined as the difference between the book inventory and the physical inventory. This definition may be with respect to either the element or isotope weight.

The facility MUF for a given material balance (or accounting) period is a measure of the performance of the facility with respect to its control of the nuclear materials involved. The MUF, as verified by inspection, or alternately, as adjusted on the basis of inspection results, is the key index of performance used by the Agency in its quantitative assessment of facility performance.

The MUF calculation is represented schematically by the following equation:

$$MUF = I - 0 + B - E$$
 (eq. 3.4.1)

where <u>I</u> designates inputs, <u>0</u> designates outputs (which are sometimes subdivided into product and waste streams), <u>B</u> refers to beginning inventory, and <u>E</u> to ending inventory. The three terms in (eq. 3.4.1), I, O, and B, collectively represent the book inventory, while E represents the physical inventory. Note that the physical inventory for one accounting period becomes a part of the book inventory for the subsequent period.

The definition of MUF implicity assumes that the material balance is based completely on measured data. The use of by-difference accounting results in a meaningless MUF. For example, if the contents of waste streams are calculated as the differences between the measured amounts entering a process step and those exiting the step, it is clear that the calculated MUF would be zero over that particular material balance area, i.e., it would be meaningless as a performance index.

In order to judge the significance of a given MUF, either as verified or as adjusted by the inspection results, it is necessary to calculate its variance. A MUF is affected by many factors. For example, in taking inventory, if a measured value is improperly recorded, i.e., if a mistake is made in recording the value in question, this will affect the MUF. Such a mistake will not, however, affect the variance of MUF as will be defined here, for the variance of MUF is calculated to include only the uncertainties arising from the measurement process under the assumption that this process is functioning properly. In this connection, it may be helpful to make a distinction between an observed MUF and a true MUF. The true MUF is the actual amount of material unaccounted for, excluding the effects of errors of measurement. It includes the effects of unmeasured inventories, process losses, recording mistakes, plus any diverted material. The observed MUF is a random variable whose expected value is the true MUF. In the absence of any errors of measurement, the observed MUF is identical to the true MUF. Equivalently stated, the variance of the (observed) MUF is zero in this case.

Clearly, an observed MUF together with its calculated variance are not sufficient information on which to make a judgement as to whether or not material has been diverted. Other information must be brought to bear to make such a judgement. However, it should also be clear that if the calculated variance of MUF is excessively large due to a poor measurement system, then one can never hope to carry the MUF evaluation beyond this first stage; any possible diversion would be quite obscurred by large errors of measurement and no reasonable judgement about diverted material could be made.

In the next section, it will be indicated how the variance of a given MUF can be calculated exactly by application of the error propagation formulas already given. Following that, a general approach to calculating the variance of MUF under specified rather non-restrictive assumptions will be considered.

3.4.2 Direct Application of Error Propagation Formulas

If a given calculated MUF is based on a simple model, then either Method 3.1 or Method 3.2 already given may be applied directly to calculate its variance. This is illustrated by the following example in which the variance of MUF is calculated by application of Method 3.1.

EXAMPLE 3.1 (c)

Consider the plutonium MUF in a somewhat simplified chemical reprocessing facility. The components of the material balance are identified as follows:

<u>Inputs</u> : A batch consists of a volume of material in the input accountability tank. Each volume contains nominally 10 kg Pu. Over the material balance period, there are 40 batches. The model for batch i is

 $x_{Ii} = T_{Ii} + \delta + \varepsilon_i$

where x_{ti} = measured plutonium in batch i

 T_{i} = true plutonium in batch i

 δ = systematic error for batch i

 ε_i = random error for batch i

All quantities are expressed in kilograms. The model has been simplified in that δ and ε_i each represent the combined effects of several measurement errors

(volume, sampling, analytical). Assume that δ and ϵ_i (and other measurement errors identified in what follows) have zero means with:

 $\sigma_{g} = 0.044 \text{ kg}$ $\sigma_{g} = 0.109 \text{ kg}$

Product : Product is outputted as plutonium nitrate. Each batch contains nominally 22 kg Pu, and there are 18 batches over the material balance period. For batch i, the model is

$$x_{pi} = T_{pi} + \Delta + \eta_i$$

where $X_{pi},$ $T_{pi},$ $\Delta,$ and ${}^{\eta}i$ are defined in a manner analagous to $X_{Ii},$ $T_{Ii},$ $\delta,$ and $\epsilon_i.$ Assume

$$\sigma_{\Delta} = 0.082 \text{ kg}$$
 $\sigma_{\eta} = 0.191 \text{ kg}$

Waste : Waste is batched with a nominal batch size of 0.25 kg Pu. There are 16 batches over the material balance period. The model is

$$x_{wi} = T_{wi} + \alpha + \omega_i$$
, with
 $\sigma_{\alpha} = 0.030 \text{ kg}$ $\sigma_{\omega} = 0.052 \text{ kg}$

Inventory: There are 10 batches (process vessels) in inventory. The inventory level is very low because physical inventories are taken after clean out. For beginning inventory:

$$x_{Bi} = T_{Bi} + \beta + \theta_{i}$$

and for ending inventory,

$$x_{Ei} = T_{Ei} + \beta + \gamma_i$$

Note that β appears in the model for both beginning and ending inventories and therefore will cancel in the MUF equation. The value of σ_β is hence immaterial. For θ_i and γ_i , assume

$$\sigma_{\theta} = \sigma_{\gamma} = 0.002 \text{ kg}$$

The model for MUF can then be written and Method 3.1 applied since the MUF equation is of the form (eq. 3.2.1).

$$MUF = \sum_{i=1}^{40} T_{Ii} + 40\delta + \sum_{i=1}^{40} \varepsilon_i - \sum_{i=1}^{18} T_{pi} - 18\Delta - \sum_{i=1}^{18} n_i$$
$$-\sum_{i=1}^{16} T_{Wi} - 16\alpha - \sum_{i=1}^{16} \omega_i + \sum_{i=1}^{10} T_{Bi} + 10\beta + \sum_{i=1}^{10} \theta_i$$

$$-\sum_{i=1}^{10} T_{Ei} - 10\beta - \sum_{i=1}^{10} \gamma_i$$

Then, assuming all covariances are zero, (eq. 3.2.3) is applied.

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Var (MUF) = $1600 (.044)^2 + 40(.109)^2 + 324(.082)^2 + 18(.191)^2$

 $+256(.030)^{2} + 16(.052)^{2} + 10(.002)^{2} + 10(.002)^{2}$

 $= 6.6818 \text{ kg}^2 \text{ Pu}$

Standard deviation (MUF) = 2.585 kg Pu

In this example, the standard deviations were expressed on an absolute basis, i.e., in kilograms plutonium. If they were expressed on a relative basis, multiplicative rather than additive models would have been written, and Method 3.2 applied. The answer, of course, would be the same.

3.4.3 Variance of Element MUF by General Approach

Although conceptually one can apply Method 3.1 or Method 3.2 in calculating the variance of any MUF, in practice it will often be difficult to write explicitly the model that is required to apply these methods. Even when it is possible to do so with moderate effort, as was done in the example just concluded, it may be much simpler to apply a general solution to the problem based on some simplifying assumptions set forth in the section to follow. The assumptions will rarely be 100% satisfied in practice, but (1) moderate departures from them will often have negligible effect; and (2) one can make slight alterations in the calculations to account for departures in assumptions if deemed necessary. This will be illustrated in the examples to follow.

The general approach to calculating the variance of element (and of isotope) MUF is an extension of methods documented in [3.5] and later expanded upon [3.6]. A computerized version of the calculations has been developed and is described in [3.7]. The computer code, identified as NUMSAS, is available. The program order form is reproduced as Annex 3.1.

3.4.3.1 Assumptions

The variance of element MUF is considered first. Isotope MUF will be treated in a later section.

In calculating the variance of element MUF, it is convenient to develop a hierarchy of classifications consisting of items, batches, strata, and components.

An item is a primary unit which has a weight, volume and destructive analysis or NDA measurement associated with it. A number of item collectively form a <u>batch</u>, where a batch consists of all items that are related because they have a common element concentration factor. In the event the element factor is uniquely determined for each item,

then an item and a batch are identical, i.e., there is one item in that batch. Note that this definition of batch may be different than used in accounting reports to the Agency. A number of batches collectively form a <u>stratum</u>, which consists of all batches of like material. As will be illustrated in the examples, one has a certain amount of freedom in defining a stratum in a given application; strata of similar materials may be combined into a single stratum in order to reduce the amount of calculation at the expense of bending the assumptions somewhat. Finally, strata are combined to form a component of the MUF equation. There are four MUF components, identified in the schematic (eq. 3.4.1).

With the classifications in mind, the following assumptions are made:

(1) All random, short-term systematic, and long-term systematic error standard deviations are known and are expressed on a relative basis. For example, a 0.4% relative standard deviation is expressed as 0.004. (However, see Section 3.4.3.5.)

(2) Within a given batch, the number of samples drawn and the number of analyses per sample are both constants.

(3) Within a given stratum, the number of items per batch is constant.

(4) No more than one scale or analytical method is used in a given stratum.

(5) A given element concentration factor cannot apply to more than one stratum.

Some comments on these assumptions are helpful. First, with respect to the distinction between short-term and long-term systematic errors, it is not always evident just how a given error should be classified. Whenever a given measurement system is recalibrated, this signals a change in the error structure and introduces a new short-term systematic error. However, such error shifts may also occur in a measurement system even when the system is not recalibrated. Each error source should be evaluated using the methods of Chapter 2 to properly characterize it from point of view of how often the error may shift in value. When calculating the variance of MUF, whether an error is a short-term or long-term systematic error can have significant impact on the calculated variance of MUF, and hence, it is worth the effort to properly characterize each error.

With respect to assumption (4), this assumption can be relaxed if the measurement methods in question are of the same design (e.g., same type scale). In this event, the use of several scales, say, is equivalent to the use of one scale with several shifts in the systematic error (i.e., with a short-term systematic error). See examples 3.3 (a) and 3.4 (a).

As regards assumption (5), this assumption is not generally satisfied when dealing with isotope MUF as opposed to element MUF. Should the assumption be violated for element MUF, then the methods of Section 3.4.5 for isotope MUF may be applied.

Before continuing with the general methodology, the notation to be used in the following sections is summarized.

3.4.3.2 Notation

The following notation is used.

xkqpt = total element weight in stratum k, where the element weight is found using bulk measurement method q, sampling is from material type p, and analytical technique t is used. If measurement is by NDA, regard the NDA instrument as an analytical method. "Dummy" methods can be used for the bulk and sampling measurements.

Note: It may be that within a stratum, the same systematic error does not affect all items, i.e., there is a short-term systematic error. Use parentheses to indicate the total element weight associated with "condition i" for a given measurement. For example:

xkqpt(3) = total element weight identified with condition 3 for analytical
 method t in stratum k

 $x_{kq(2)pt} = total element weight identified with condition 2 for bulk method (e.g., scale) q in stratum k.$

To continue,

- δ = a relative standard deviation; subscripts identify a specific one.
- s,g,r = first subscript on δ : s refers to a long term systematic error; g to a short term systematic error; r to a random error.
- q,p,t = second, third, and fourth subscripts on &; defined as for the subscripts on x; if the measurement method in question is a bulk method, replace p and t by dots; for example
- $\delta_{r\cdot p}$ = random error standard deviation in sampling of material type p.
 - n_{μ} = number of items per batch in stratum k.
 - m_{μ} = number of batches in stratum k.
 - r_k = number of samples drawn per batch in stratum k to estimate the batch element concentration factor.
 - c_{ν} = number of analyses per sample in stratum k
 - k = total number of strata

 $V(\dots)$ = variance of quantity within parentheses, for example,

 $V(x_{kopt})$ = variance of element weight in stratum k;

V(MUF) = variance of MUF

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With this notation in mind, Method 3.3 will now provide formulas needed to compute the random error variance of MUF.

3.4.3.3 Random Error Variance of MUF

Method 3.3

Notation

The notation is given in 3.4.3.2.

Mode1

The schematic model for MUF is given by (eq. 3.4.1). For the individual measurements, the multiplicative model is used. This is discussed in 2.3.2.

Results

For stratum k, the random error variance of the total element weight is

$$V_{r}(x_{kqpt}) = x_{kqpt}^{2}(\delta_{rq}^{2} \cdot n_{k}^{m} k^{+} \delta_{r}^{2} \cdot p_{r}^{m} k^{m} k^{+} \delta_{r}^{2} \cdot t^{c} k^{r} k^{m} k) \qquad (eq. 3.4.2)$$

To find $V_r(MUF)$, $V_r(x_{kqpt})$ is summed over all the strata.

$$V_{r}(MUF) = \sum_{k=1}^{K} V_{r}(x_{kqpt})$$
 (eq. 3.4.3)

If, in a given situation, a nominal (historical average, stoichiometric) element factor is used, then $\delta_{r.p.3.4.2}$, and $\delta_{r..t}$ are both zero for that stratum. To avoid division by zero in (eq. 9.3.4.2), r_k may be set equal to one.

Basis

The formula for $V_r(MUF)$ is derived by application of Method 3.2.

Examples

EXAMPLE 3.3 (a)

In this first example, consider a simplified material balance for a fuel fabrication facility. There are seven strata identified. There are 4 bulk measurement methods (q=1-4), 5 material types (p=1-5), and 4 analytical methods (t=1-4).

The error standard deviations are tabled.

$\delta_{r1} = 0.000658$	$\delta_{r+1} = 0.000531$	$\delta_{r-1} = 0.000433$
$\delta_{r2} = 0.000877$	$\delta_{r\cdot 2} = 0$	$\delta_{r-2} = 0.000568$
$\delta_{r_{3}} = 0*$	$\delta_{r.3.} = 0*$	$\delta_{r3} = 0.0577$

δ_{r4..} = 0.00250 δ_{r.4.} = 0.0181 δ_{r.4.} = 0.0181 δ_{r.4.} = 0.0274

*"dummy" methods

<u>Stratum 1</u> is an input stratum consisting of containers of UO_2 powder. <u>Stratum 2</u> is an output product stratum consisting of containers of sintered UO_2 pellets. <u>Stratum 3</u> is an output waste stream stratum consisting of containers of solid waste measured by NDA. <u>Stratum 4</u> is a beginning inventory stratum consisting of containers of dirty scrap. <u>Stratum 5</u> is a beginning inventory stratum consisting of containers of grinder sludge. <u>Stratum 6</u> is an ending inventory stratum containing the same kinds of material as Stratum 4. <u>Stratum 7</u> is an ending inventory stratum containing the same kinds of material as Stratum 5.

Before continuing with this example, it is important to emphasize an important point. Before any calculations of the variance of MUF are performed, data for any items that are <u>identical</u> in both a plus and minus component of the MUF equation must be deleted. For example, if an item in beginning inventory were remeasured in ending inventory, then depending as the use made of the remeasured value, this item may or may not be included in the MUF variance calculation. If the remeasured value were <u>booked</u>, then the item would be included; if it were not booked, but were only used for verification of the previously booked value, then it would not be included--it would neither affect the MUF nor its variance.

To continue with the example, it is convenient to organize the parameter values in tabular form before performing the calculations of (eq. 3.4.2). This is done below.

	1	2	3	4	5	6	7
n _k	150	47,760	1	300	200	300	200
^m k	80	1	2770	6	4	6	4
r _k	5	240	1	10	12	10	12
c _k	1	1	1	1	1	1	1
q	1	2	3	4	4	4	4
р	1	2	3	4	5	4	5
t	1	2	3	4	4	4	4
× _{kqpt} (1)	240,000	238,800	1200	7200	4000	7200	4000

Stratum (k)

(1) entries are in kg uranium

Equation (3.4.2) is now applied for each stratum.

 $V_{r}(x_{1111}) = 69.68 \text{ kg}^{2} \text{ U}$ $V_{r}(x_{2222}) = 77.58 \text{ kg}^{2} \text{ U}$ $V_{r}(x_{3333}) = 1.73 \text{ kg}^{2} \text{ U}$ $V_{r}(x_{4444}) = 931.89 \text{ kg}^{2} \text{ U}$ $V_{r}(x_{5454}) = 832.79 \text{ kg}^{2} \text{ U}$ $V_{r}(x_{6444}) = 931.89 \text{ kg}^{2} \text{ U}$ $V_{r}(x_{7454}) = 832.79 \text{ kg}^{2} \text{ U}$ $V_{r}(x_{7454}) = 832.79 \text{ kg}^{2} \text{ U}$ $V_{r}(\text{MUF}) \text{ is then computed using (eq. 3.4.3)}$ $V_{r}(\text{MUF}) = 69.68 + 77.58 + \dots + 832.79 = 3678.35 \text{ kg}^{2} \text{ U}$

EXAMPLE 3.3 (b)

This example deals with the plutonium MUF in a mixed oxide fuel fabrication plant. Except for the fact that the numbers of containers in beginning and ending inventories are not the same, the example contains no features not found in the previous example. It is included, however, because it will later serve to illustrate calculation of the short term systematic error variance.

In this facility, there are 10 strata identified (K=10). There are 5 bulk measurement methods, (q=1-5); 6 material types, (p=1-6); and 4 analytical methods, (t=1-4). The error standard deviations are listed.

$\delta_{r1} = 0.00025$	$\delta_{r \cdot 1} = 0.0001$	$\delta_{r1} = 0.0040$
$\delta_{r2} = 0.00050$	$\delta_{r \cdot 2} = 0.0080$	$\delta_{r2} = 0.0050$
$\delta_{r_3} = 0.00040$	$\delta_{r.3.} = 0.035$	$\delta_{r3} = 0.0060$
δ _{r4} = 0*	$\delta_{r \cdot 4} = 0*$	$\delta_{r4} = 0.20$
$\delta_{r5} = 0.00040$	$\delta_{r.5.} = 0.0040$	
	$\delta_{r.6.} = 0.020$	

*"dummy" methods

 $\frac{\text{Stratum 1}}{\text{stratum consisting of containers of PuO_2.} \frac{\text{Stratum 2}}{\text{stratum 3}}$ is an output stratum consisting of containers of sintered pellets. $\frac{\text{Stratum 3}}{\text{recovery.}} \frac{\text{Stratum 4}}{\text{stratum 4}}$ is an output waste stream stratum consisting of containers of solid waste measured by NDA. Stratum 5 is a beginning inventory stratum consisting of containers of mixed oxide powder. <u>Stratum 6</u> is a beginning inventory stratum containing the same kind of material as output stratum 3. <u>Stratum 7</u> is a beginning inventory stratum consisting of containers of grinder swarf. <u>Strata 8</u>, <u>9</u>, and <u>10</u> are ending inventory strata containing the same kinds of materials as strata 5, 6, and 7 respectively.

				Stratu	ım (k)					
	1	2	3	4	5	6	7	8	9	10
n _k	32	200	1	1	20	1	1	20	1	1
^m k	24	198	10	100	15	4	6	18	5	3
rk	4	5	1	1	3	1	1	3	1	1
c _k	2	1	1	1	1	1	1	1	1	1
q	1	2	3	4	5	3	3	5	3	3
р	1	2	3	4	5	3	6	5	3	6
t	1	2	3	4	3	3	2	3	3	2
× _{kqpt} (1)	1536	1485	9.0	0.4	112.5	3.6	4.5	135	4.5	2.25

The pertinent parameter values are given in the following table.

(1) entries are in kg Pu

Equation (3.4.2) is now applied for each stratum.

$$V_{r}(x_{1111}) = 0.197046 \text{ kg}^{2} \text{ Pu}$$

$$V_{r}(x_{2222}) = 0.198261 \text{ kg}^{2} \text{ Pu}$$

$$V_{r}(x_{3333}) = 0.010215 \text{ kg}^{2} \text{ Pu}$$

$$V_{r}(x_{4444}) = 0.000064 \text{ kg}^{2} \text{ Pu}$$

$$V_{r}(x_{5553}) = 0.014632 \text{ kg}^{2} \text{ Pu}$$

$$V_{r}(x_{6333}) = 0.004086 \text{ kg}^{2} \text{ Pu}$$

$$V_{r}(x_{7362}) = 0.001435 \text{ kg}^{2} \text{ Pu}$$

$$V_{r}(x_{8553}) = 0.017558 \text{ kg}^{2} \text{ Pu}$$

$$V_{r}(x_{9333}) = 0.005108 \text{ kg}^{2} \text{ Pu}$$

$$V_{r}(x_{10,362}) = 0.000717 \text{ kg}^{2} \text{ Pu}$$

 $V_r(MUF)$ is then computed using (eq. 3.4.3) $V_r(MUF) = 0.197046 + 0.198261 + \dots + 0.000717$ $= 0.449122 \text{ kg}^2 \text{ Pu}$

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EXAMPLE 3.3 (c)

In the example just considered, suppose that after the first 10 batches of P_uO_2 powder receipts were weighed, the scale was replaced by another scale of similar design. Stratum 1 could still be treated as a single stratum, even though the assumption that only one measurement method of each type were used for all items, were violated. A modification in the calculations would be required to accommodate this second scale, which may be identified by q = 6.

The 10 batches of P_uO_2 powder weighed on scale 1 corresponds to 640 kg Pu while the 14 batches weighed on scale 2 corresponds to the remaining 896 kg Pu. In calculating the random error variance of the total element weight in stratum 1, the term:

 $x_{1111}^{2} \delta_{r}^{2} \dots /n_{1}m_{1}$ or (1536)²(0.00025)²/768 = 0.000192

is replaced by

 $(640)^2(0.00025)^2/320 + (896)^2(0.00025)^2/448 = 0.000192$

The result is the same, as is easy to prove in general. For the random error variance, it doesn't matter how many measurement methods are used in a given stratum as long as they have the same measurement error standard deviations. This statement is not true for systematic error variances, as will be demonstrated later.

3.4.3.4 Systematic Error Variance of MUF

In developing the formulas needed to compute the systematic error variance of MUF, attention will first be focused on the short-term systematic errors. Method 3.4 applies.

Method 3.4

Notation

The notation is given in 3.4.3.2.

Mode1

See the discussion for the model in Method 3.3.

Results

The calculations indicated need only be performed for those measurements for which the first subscript on δ is g, i.e., for the non-zero short term systematic error variances.

For each combination of values, q(i), calculate

$$M_{q(i)} = \sum_{k=1}^{K} A_{k} x_{kq(i)pt}$$
 (eq. 3.4.4)

where $A_k = +1$ for input and beginning inventory strata and where $A_k = -1$ for output and ending inventory strata.

For each combination of values, p(i), calculate

$$M_{p(i)} = \sum_{k=1}^{K} A_k \times kqp(i)t$$
 (eq. 3.4.5)

where A_k is defined as above.

For each combination of values, t(i), calculate

$$M_{-+1(i)} = \sum_{k=1}^{K} A_k X_{kqpt(i)}$$
 (eq. 3.4.6)

where A_k is defined as above.

The short term systematic error variance of MUF is

$$V_{g}(MUF) = \sum_{q} \delta_{gq} \cdot \sum_{i} M_{q}^{2}(i) \cdot + \sum_{p} \delta_{g} \cdot p \cdot \sum_{i} M_{\cdot}^{2}p(i) \cdot + \sum_{t} \delta_{g}^{2} \cdot t \sum_{i} M_{\cdot}^{2}(i) \cdot + \sum_{t} \delta_{g}^{2} \cdot t \sum_{i} M_{\cdot}^{2} \cdot t(i)$$
(eq. 3.4.7)

Any stratum in which the element factor is a nominal factor (historical average, stoichiometric) will not have g as a first subscript on δ for the sampling or analytical errors. Hence, the calculations indicated would not be performed in such cases.

Basis

The basis for Method 3.4 is the same as for Method 3.3. The distinction is that for random error variances, one squares quantities and then sums them; for systematic error variances, one sums and then squares.

Examples

EXAMPLE 3.4(a)

In the facility described in example 3.3 (b), assume that there are short-term systematic errors associated with the analytical methods due, in part, to system

recalibrations during the one-year material balance period. Also, with reference to example 3.3 (c), the introduction of the second scale in the bulk measurement of the $P_{\rm U}O_2$ receipts can be treated by introducing a short-term systematic error; since this second scale has the same design as the first one, the effect is the same as if the first scale had simply been recalibrated.

The following error parameter values are given.

$$\delta_{g1..} = 0.00010$$
 $\delta_{g..1} = 0.0013$
 $\delta_{g..2} = 0.0016$
 $\delta_{g..3} = 0.0020$
 $\delta_{g..4} = 0.06$

From the information given in example 3.3 (c), for scale (bulk measurement method) 1,

 $X_{11(1)11} = 640 \qquad X_{11(2)11} = 896$

Then, from (eq. 3.4.4),

 $M_{1(1)} = 640$ $M_{1(2)} = 896$

For the analytical methods, assume that the following quantities of materials are associated with the various shifts in the systematic errors (all quantities in kg Pu):

<u>stratum 1</u>	$x_{1111(1)} = x_{1111(2)} = x_{1111(3)} = 512$
<u>stratum 2</u>	$x_{2222(1)} = x_{2222(2)} = x_{2222(3)} = 495$
<u>stratum 3</u>	$x_{3333(1)} = 0$, $x_{3333(2)} = 9.0$
<u>stratum 4</u>	$x_{4444(1)} = 0.16$, $x_{4444(2)} = 0.24$
<u>stratum 5</u>	$x_{5553(1)} = 112.5$, $x_{5553(2)} = 0$
<u>stratum 6</u>	$x_{6333(1)} = 3.6$, $x_{6333(2)} = 0$
stratum 7	$x_{7362(1)} = 4.5$, $x_{7362(2)} = x_{7362(3)} = 0$
stratum 8	$x_{8553(1)} = 0$, $x_{8553(2)} = 135$
stratum 9	$x_{9333(1)} = 0$, $x_{9333(2)} = 4.5$
stratum 10	$x_{10,362(1)} = x_{10,362(2)} = 0$, $x_{10,362(3)} = 2.25$

Equation 3.4.6 may then be applied for each combination of values t(i):

 $M \cdot \cdot 1(1) = M \cdot \cdot 1(2) = M \cdot \cdot 1(3) = 512$ $M \cdot \cdot 2(1) = -495 + 4.5 = -490.5$ $M \cdot \cdot 2(2) = -495$ $M \cdot \cdot 2(3) = -495 - 2.25 = -497.25$ $M \cdot \cdot 3(1) = 112.5 + 3.6 = 116.1$ $M \cdot \cdot 3(2) = -9.0 - 135 - 4.5 = -148.5$ $M \cdot \cdot 4(1) = -0.16$ $M \cdot \cdot 4(2) = -0.24$

Equation 3.4.7 is applied to find the short term systematic error variance of MUF.

		Kg ru
$V_{g}(MUF) = (0.00010)^{2}[(640)^{2} + (896)^{2}]$	=	0.012124
+ $(0.0013)^2[(512)^2 + (512)^2 + (512)^2]$	=	1.329070
+ $(0.0016)^2[(-490.5)^2 + (-495)^2 + (-497.25)^2]$	=	1.876154
+ $(0.0020)^2[(116.1)^2 + (-148.5)^2]$	=	0.142126
+ $(0.06)^2[(-0.16)^2 + (-0.24)^2]$	=	0.000300
V _g (MUF)	=	3.359774 kg ² Pu

.

ka2 Pu

Next, consider the long term systematic error variance of MUF. The calculations described in Method 3.5 follow easily from those in Method 3.4.

Method 3.5

Notation

The notation is given in 3.4.3.2.

Model

See the discussion for the model in Method 3.3.

Results

For each value of q, calculate

$$M_{q} = \sum_{k=1}^{K} A_k x_{kqpt} \qquad (eq. 3.4.8)$$

where $A_k = +1$ for input and beginning inventory strata and $A_k = -1$ for output and ending inventory strata. Note that if the calculations indicated by (eq. 3.4.4) are performed for each value of q, then M_q .. may be found by summing the $M_q(i)$.. values over i. Similar statements hold for sampling and analytical errors.

For each value of p, calculate

 $M_{p} = \sum_{k=1}^{K} A_{k} x_{kqpt}$ (eq. 3.4.9)

where A_k is defined as above.

For each value of t, calculate

$$M_{\cdot \cdot t} = \sum_{k=1}^{K} A_k x_{kqpt}$$
 (eq. 3.4.10)

where \boldsymbol{A}_k is defined as above.

The long term systematic error variance of MUF is

$$V_{s}(MUF) = \sum_{q} M_{q}^{2} \cdot \delta_{sq}^{2} \cdot t + \sum_{p} M_{p}^{2} \cdot \delta_{s}^{2} \cdot t + \sum_{t} M_{t}^{2} \cdot \delta_{s}^{2} \cdot t \quad (eq. 3.4.11)$$

For any stratum for which the element factor is a nominal factor (historical average, stoichiometric), set $\delta = 0$. The quantity $\delta_{s..t}$ must be assigned a value that is a measure of the s.p. systematic error s..t between the true average element factor for that stratum and the nominal factor. In this event, the subscript t is a dummy index. The quantity $\delta_{s..t}$ could be quite large if a stoichiometric factor is used.

If it is known that the element factor in question is obviously in error by an appreciable amount in a given direction, it would be preferable to attempt to correct the data for the bias in the factor, and reduce the value for δ accordingly to reflect the systematic error in the residual bias. See example 3.5(c).

Basis

The basis for Method 3.5 is the same as for Method 3.3.

Examples

EXAMPLE 3.5(a)

Continue with the facility of example 3.3 (a). The following error parameter values are given.

 $\delta_{s1} = 0.000439 \qquad \delta_{s1} = 0 \qquad \delta_{s1} = 0.000571$ $\delta_{s2} = 0.000175 \qquad \delta_{s2} = 0 \qquad \delta_{s2} = 0.000341$ $\delta_{s3} = 0* \qquad \delta_{s3} = 0* \qquad \delta_{s2} = 0.00462$ $\delta_{s4} = 0.00167 \qquad \delta_{s4} = 0 \qquad \delta_{s24} = 0.00896$ $\delta_{s5} = 0.00444$

*"dummy" methods

From the data table given in example 3.3 (a), the M values of (eq. 3.4.8), (eq. 3.4.9), and (eq. 3.4.10) are calculated. It is not necessary to calculate these quantities for q = 3, and p = 1, 2, 3, or 4 since the corresponding error standard deviations are all zero.

 $M_{1..} = 240,000 \quad (all units in kg U)$ $M_{2..} = -238,800$ $M_{4..} = 7200 + 4000 - 7200 - 4000 = 0$ $M_{.5.} = 4000 - 4000 = 0$ $M_{..1} = 240,000$ $M_{..2} = -238,800$ $M_{..3} = -1200$ $M_{..4} = 7200 + 4000 - 7200 - 4000 = 0$

Equation (3.4.11) is now applied to find the systematic error variance of MUF: kq^2U

$V_{s}(MUF) = (240,000)^{2}(0.000439)^{2}$	=	11100.73
+ (-238,800) ² (0.000175) ²	=	1746.40
+ (240,000) ² (0.000571) ²	=	18779.96
+ $(-238,800)^2(0.000341)^2$	=	6630.98
+ (-1200) ² (0.0462) ²	=	3073.59
	$V_{s}(MUF) =$	41,331.66 kg ² U

From example 3.3 (a) $V_r(MUF) = 3678.35 \text{ kg}^2 \text{U}$. Therefore, $V(MUF) = 45010.01 \text{ kg}^2 \text{U}$ standard deviation of MUF = 212 kg U, or 0.089% of input

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EXAMPLE 3.5 (b)

Continue with the mixed oxide fuel fabrication facility of examples 3.3 (b) and 3.4 (a). The following error parameter values are given.

$$\begin{split} \delta_{s1} &= 0.00020 \qquad \delta_{s-1} = 0 \qquad \delta_{s-1} = 0.0007 \\ \delta_{s2} &= 0.00035 \qquad \delta_{s-2} = 0.0010 \qquad \delta_{s-2} = 0.0012 \\ \delta_{s3} &= 0.00025 \qquad \delta_{s-3} = 0.015 \qquad \delta_{s-3} = 0.0015 \\ \delta_{s4} &= 0^* \qquad \delta_{s-4} = 0^* \qquad \delta_{s-4} = 0.08 \\ \delta_{s5} &= 0.00025 \qquad \delta_{s-5} = 0.0024 \\ \delta_{s-6} &= 0.008 \end{split}$$

*"dummy" method

From the data table given in example 3.3 (b), the M values of (eq. 3.4.8), (eq. 3.4.9), and (eq. 3.4.10) are calculated. For the analytical methods, the M 's are easily calculated using the results of example 3.4 (a) for which the short-term systematic error variances were calculated. All units are in kg Pu.

$$M_{1...} = 1536$$

$$M_{2...} = -1485$$

$$M_{3...} = -9.0 + 3.6 + 4.5 - 4.5 - 2.25 = -7.65$$

$$M_{5...} = 112.5 - 135 = -22.5$$

$$M_{.2.} = -1485$$

$$M_{.3.} = -9.0 + 3.6 - 4.5 = -9.9$$

$$M_{.5.} = 112.5 - 135 = -22.5$$

$$M_{.6.} = 4.5 - 2.25 = 2.25$$

$$M_{..1} = 1536$$

$$M_{..2} = -490.5 - 495 - 497.25 = -1482.75$$

$$M_{..3} = 116.1 - 148.5 = -32.4$$

$$M_{..4} = -0.4$$

Equation (3.4.11) is now applied to find the long-term systematic error variance of MUF.

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			<u>kg²Pu</u>	
$V_{s}(MUF) =$	= (1536) ² (0.00020) ²	=	0.094372	
+	- (-1485) ² (0.00035) ²	=	0.270140	
+	- (-7.65) ² (0.00025) ²	=	0.000004	
+	- (-22.5) ² (0.00025) ²	=	0.000032	
+	$(-1485)^2(0.0010)^2$	=	2.205225	
+	- (-9.9) ² (0.015) ²	=	0.022052	
+	$(-22.5)^2(0.0024)^2$	=	0.002916	
+	$-(2.25)^2(0.008)^2$	=	0.000324	
+	- (1536) ² (0.0007) ²	=	1.156055	
+	$(-1482.75)^2(0.0012)^2$	=	3.165908	
+	- (-32.4) ² (0.0015) ²	=	0.002362	
+	$(-0.4)^2(0.08)^2$	=	0.001024	
		V _s (MUF) =	6.920414	kg²Pu

From examples 3.3 (b) and 3.4 (a), the random and short term systematic error variances are given.

 $V_r(MUF) = 0.449122 \text{ kg}^2\text{Pu}$ $V_q(MUF) = 3.359774 \text{ kg}^2\text{Pu}$

Therefore, summing, the variance of MUF is

 $V(MUF) = 10.729310 \text{ kg}^2\text{Pu}$ $\sqrt{V(MUF)} = 3.276 \text{ kg Pu}, \text{ or } 0.213\% \text{ of input}$

EXAMPLE 3.5(c)

In examples 3.3(b), 3.4(a) and 3.5(b), say that in stratum 1, a nominal plutonium factor of 0.875 is used for the PuO_2 powder, and further say that X for stratum 1 is then 1542 kg Pu rather than 1536 kg Pu. In accordance with the notes that follow (eq. 3.4.2), (eq. 3.4.7) and (eq. 3.4.11), the following changes are then made in the calculations.

In example 3.3(b), set $\delta_{r,1} = \delta_{r,1} = 0$ and $r_1 = 1$. Then

 $Vr(X_{1111}) = (1542)^2 (0.00025)^2/768$

 $= 0.000194 \text{ kg}^2 \text{ Pu}$, (rather than $0.197046 \text{ kg}^2 \text{ Pu}$).

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and Vr (MUF) = $0.252270 \text{ kg}^2 \text{ Pu}$, (rather than $0.449122 \text{ kg}^2 \text{ Pu}$)

In example 3.4(a), $\delta = 0$, (rather than 0.0013). Then, in the table of calculations on Page 125, replace^{g..1} the quantity 1.329070 by zero so that:

Vq (MUF) = $2.030704 \text{ kg}^2 \text{ Pu}$ (rather than $3.359774 \text{ kg}^2 \text{ Pu}$).

In example 3.5(b), set δ = 0.0025, (rather than 0.0007). Then, in the table of calculations on Page 129, s.1 replace

 $(1536)^2 (0.0007)^2 = 1.156055$ by $(1542)^2 (0.0025)^2 = 14.861025 \text{ kg}^2 \text{ Pu}$, so that Vs (MUF) = 20.625384 kg² Pu, (rather than 6.920414 kg² Pu).

Finally,

V (MUF) = 0.000194 + 2.030704 + 20.625384

 $= 22.656282 \text{ kg}^2 \text{ Pu}$, (rather than 10.729310 kg² Pu).

To continue with this example, the value of $\delta_{s..1} = 0.0025$ is set this large because it is known that the nominal factor of s..1 = 0.0025 is biased high. One could attempt to correct the data for bias by utilizing a "more reasonable" factor of, say, 0.872, based on applicable historical data. For a factor of 0.872, the value for X for stratum 1 is 1536.71 kg² Pu. The new value for Vg (MUF) is essentially for stratum 1 is 1536.71 kg² Pu and the new value for Vg (MUF) is identically the same as before, viz., 2.030704 kg² Pu. For the 0.872 factor, assign the value 0.0012 to $\delta_{s..1}$. Then, rather than 14.861025 kg² Pu as the contribution to the systematic s..1 error variance due to the use of the nominal factor of 0.875, the contribution for the 0.872 factor is:

(1536.71)² (0.0012)² = 3.400528 kg² Pu. With this change, Vs (MUF) = 9.164887 kg² Pu, and V (MUF) = 0.000192 + 2.030704 + 9.164837 = 11.195783 kg² Pu. Before leaving this subject, it is noted that in all of the examples, common element concentration factors did not appear in different strata. Should this occur, then the methods suggested in a later section, 3.4.5, may be applied.

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3.4.3.5 Case of Constant Absolute Errors

As stated in the assumptions of 3.4.3.1, all errors have thus far been assumed to be constant on a relative basis, and δ with subscripts was used to designate such an error standard deviation. For example, $\delta_{rq} \cdot \cdot = 0.0004$ designates a relative error of 0.04% for the random error standard deviation of bulk measurement method q.

In some applications, and most notably in the case of scales, errors are more likely to be constant on an absolute basis rather than on a relative basis. The error propagation formulas given in the foregoing sections must be modified to account for this. The modifications are very simple if one keeps in mind the relationship between relative errors and absolute errors.

Letting σ with subscripts be the standard deviation in absolute units, then in stratum k, one has the relationship

$$\delta_{rq..} = \frac{n_k m_k \sigma_{rq..}}{x_{kqpt}}$$
(eq. 3.4.12)

assuming that one is speaking of a bulk measurement. Similar modifications can easily be made for sampling and analytical if needed, but here the common practice is to express all errors relatively.

With (eq. 3.4.12) in mind, then the key equations may be modified as follows:

In (eq. 3.4.2), replace the first term by

 ${}^{n}k {}^{m}k {}^{\sigma}{}^{2}rq \cdot \cdot$

for all strata in which errors are expressed in σ units rather than in δ units. Effectively, this replaces amounts by numbers of weighing.

In (eq. 3.4.4), for the methods for which errors are expressed in absolute units, multiply $x_{ko(i)pt}$ by

 $^{n}k ^{m}k^{/x}kq(i)pt$

This is the same as replacing $x_{kq(i)pt}$ by the <u>number</u> of weighings (or measurements) performed under condition i.

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A similar change is made in (eq. 3.4.8). For the methods in question, multiply \mathbf{x}_{kopt} by

ⁿk ^mk^{/x}kqpt

Example

The examples for the mixed oxide fuel fabrication plant (see examples 3.3 (b), 3.4 (a), and 3.5 (b)) are reconsidered given that for bulk measurement method 1, the error standard deviations are expressed in absolute units rather than relatively. The error standard deviations in question are:

 $\sigma_{r1} = 0.0005 \text{ kg}$ (0.5 g) $\sigma_{g1} = 0.0002 \text{ kg}$ (0.2 g) $\sigma_{s1} = 0.0004 \text{ kg}$ (0.4 g)

Then, with the other input data unchanged, upon application of the modified (eq. 3.4.2),

 $V_r(x_{1111}) = 768(.0005)^2 + (1536)^2[(.0001)^2/96 + (.004)^2/192] = 0.197046$, (as before)

Turning to example 3.4 (a), the values for $M_{1(1)}$. and $M_{1(2)}$. become respectively

 $M_{1(1)}$ = (640)(768)/1536 = 320 (number of weighings) $M_{1(2)}$ = (896)(768)/1536 = 448 (number of weighings)

Then, the first term of (eq. 3.4.7) becomes, for q = 1,

 $(0.0002)^{2}[(320)^{2} + (448)^{2}] = 0.012124 \text{ kg}^{2}$, (as before)

From example 3.5 (b),

 $M_{11} = (1536)(768)/1536 = 768$ weighings

From the first term of (eq. 3.4.11), for q = 1, one gets

 $(.004)^2(768)^2 = 0.094372 \text{ kg}^2$

It is noted that in this example the results, of course, are unchanged. This is because the scale in question is used in only one stratum. If a scale were used in different strata in which the average weight per item differs, then this would affect the results. The cumulative MUF is the sum of individual MUF's over a number of material balance periods. The cumulative MUF has the same model structure as the MUF for a given material balance period, i.e., the MUF components are still the inputs, outputs, beginning and ending inventories. Therefore, the variance of the cumulative MUF is calculated using the same methods as are used for the MUF over a single balance period. In this connection, note that if one were interested in calculating the variance of the cumulative MUF over, say, a three year period, then only the inventories at the beginning and end of this three year period affect the MUF, and hence its variance. It doesn't matter how many physical inventories there are during this period of time; the three year MUF is completely independent of such intermediate inventories.

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In a parallel situation, if one were interested in calculating the MUF and its variance over a number of combined material balance areas (or facilities), then the remarks in the foregoing paragraph still apply. The summation is now over space rather than over time. Thus, if the MUF for a state were to be calculated, this quantity, and hence its variance, is affected only by inputs to and outputs from the state, and the beginning and ending inventories in that state. Clearly, transfers among facilities within the state do not affect the MUF, just as transfers among locations within a facility do not affect the facility MUF. The problem is not one of calculating a state MUF or its variance; in concept this is a simple exercise, or at least, no more complicated than that of calculating similar quantities for a facility. The problem is rather one of implementation, since all facilities within the state would have to be inventoried simultaneously. One could back off from this requirement by maintaining records of facility transfers between inventory times, but to be effective, inventories would have to be reasonably close to being simultaneous in time.

The foregoing discussion suggests the related questions as to how frequently one should take inventory to close a material balance and compute a MUF, and how finely one should divide a material balance area into sub-areas. Here is an instance in which one's intuition is perhaps challenged by the facts, for it has been proven that from point of view of maximizing the probability of detecting the removal of material from a given material balance area over a fixed time interval, one should neither subdivide the material balance area into smaller sub-areas, nor should one subdivide the time interval to close the material balance more frequently [3.8]. There are, of course, criteria to consider other than the detection probability. It is clear that the role of more frequent material balance closings (more frequent inventories) is to detect removals of material more quickly. Correspondingly, subdivision of material balance areas into sub-areas will serve to localize the removals. It is unfortunate that these two important kinds of criteria, detection probability and identification of removals in time and space work at cross-purposes; clearly, some balance is needed. See also references [3.9] - [3.11].

3.4.5 Variance of Isotope MUF by General Approach

In the foregoing sections, the variance of element MUF was treated. The isotope MUF for a facility may also be calculated, and so it is necessary to provide methods for calculating its variance.

Before providing such methods, it is worthwhile to note that for facilities other than enrichment plants, primary emphasis should logically be devoted to controlling the element MUF. If adequate control is maintained on the element MUF, then, except for mistakes in booking isotope values, there is no way the isotope MUF could be out of control. Since, on a percentage of throughput basis, the uncertainty in the isotope MUF cannot be smaller than the uncertainty in the element MUF, it follows that the element MUF is the quantity of primary concern. This fact was pointed out, and quantified results were found for a light water reactor fuel fabrication facility in a paper by Nilson, Schneider, and Jaech [3.12]. The authors pointed out that the variance of isotope MUF can easily be twice that of the variance of element MUF on a percentage of throughput basis. In the type of facility they treated, from a materials control viewpoint, the isotope MUF provides no information beyond that provided by the element MUF. (The authors do point out, however, that to guard against substitution diversion strategies, isotope measurements must, of course, be made. The question is not whether or not such measurements need be made, but rather, how the resulting data are to be factored into the decision framework.)

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The variance of the isotope MUF is, as implied in the preceding paragraphs, made up of two types of sources of variance. First, any uncertainties in measuring bulks and element concentrations will also result in an uncertainty in the isotope value since the isotope is normally calculated as the product of bulk, element concentration, and isotope concentration. The exception is with NDA measurements in which the isotope is measured directly and the element is calculated from that measurement. Such items normally comprise a small part of the material balance. That part of the variance of the isotope MUF that is due to errors in the measurements of bulk and element concentration is covered in Section 3.4.5.1.

Secondly, errors occur in the measurement of isotope concentration. Here, booking practices play an important role. If a block of material is inputted to a facility at a given measured isotope concentration value, and if nothing in the process changes that concentration, then the output would be at the same concentration as the input. To assure that the concentration remains unchanged, measurements are also made of the output. But in the situation just described, these measurements should be treated as <u>verification</u> measurements and should not be booked unless they provide evidence that the isotope concentration had indeed changed. If such verification type measurements are booked, then they introduce an artifical MUF in the isotope value and also affect the variance of the isotope MUF. This will be illustrated in the example of Section 3.4.5.2 in which section the method is provided for calculating that contribution to the variance of isotope MUF due to uncertainties in the measurements of isotope concentrations.

3.4.5.1 <u>Variance of Isotope MUF Due to Measurement Errors in Bulk and Element</u> Measurements

Method 3.6

Notation

The notation is given in 3.4.3.2 except that x now refers to an isotope weight rather than an element weight.

Mode1

See the discussion for the model in Method 3.3. For isotope weight, the multiplicative model is still used, since the isotope amount is found by multiplying the element amount by the isotope concentration factor when the amount of isotope is found by the bulk, sampling, analytical measurement route.

Results

Follow methods 3.3, 3.4, and 3.5 after replacing all element weights by isotope weights in the calculations. Before performing these calculations, delete all strata in which the amount of isotope is measured directly by NDA. This step is necessary because for such strata, the uncertainty in the measurement of the element in no way affects the uncertainty in the measurement of the isotope; rather, the situation is reversed.

Basis

The basis for Method 3.6 is the same as for Method 3.3.

Examples

EXAMPLE 3.6(a)

In Example 3.3 (a), the uranium is at six different enrichments. (This example is continued as Example 3.5 (a)). The pertinent data are tabled.

Stratum	Enrichment of Uranium
1	40 batches at 3.25% U-235 30 batches at 2.67% U-235 10 batches at 1.52% U-235
2	22,900 items at 3.25% U-235 16,720 items at 2.67% U-235 5,900 items at 1.52% U-235 2,240 items at 2.87% U-235
3	The U-235 is measured directly by NDA. Delete this stratum
4	5 batches at 3.12% U-235 1 batch at 2.58% U-235
5	All batches at 2.58% U-235
6	3 batches at 3.25% U-235 2 batches at 2.67% U-235 300 kgs U at 1.52% U-235 900 kgs U at 2.87% U-235
7	1 batch at 3.25% U-235 1 batch at 2.67% U-235 500 kgs U at 1.52% U-235 1500 kgs U at 2.87% U-235

kgs U-235. From Example 3.3 (a): $x_{1111} = (120,000)(0.0325) + (90,000)(0.0267) + (30,000)(0.0152)$ = 6759.00 $x_{2222} = 6723.21$ $x_{6444} = 211.47$ $x_{44444} = 218.16$ $x_{7454} = 109.85$ $x_{5454} = 103.20$ From Example 3.5 (a): $M_{1.1} = 6759.00$ $M_{1.1} = 6759.00$ $M_{2..} = -6723.21$ $M_{..2} = -6723.21$ $M_{\mu ...} = 0.04$ $M_{...4} = 0.04$ $M_{-5} = -6.65$ From Example 3.3 (a), to find $V_r(MUF)$: $V_r(x_{1111}) = 0.0553 \text{ kg}^2 \text{ U-235}$ $V_r(x_{2222}) = 0.0615 \text{ kg}^2 \text{ U-}235$ $V_{r}(x_{4444}) = 0.8556 \text{ kg}^2 \text{ U-235}$ $V_{r}(x_{5454}) = 0.5543 \text{ kg}^2 \text{ U-235}$ $V_r(x_{6444}) = 0.8039 \text{ kg}^2 \text{ U-235}$ $V_{r}(x_{7454}) = 0.6280 \text{ kg}^2 \text{ U-}235$ Then, $V_{r}(MUF) = 2.9586 \text{ kg}^2 \text{ U-}235$ From Example 3.5 (a), to find $V_{s}(MUF)$: kg²U-235 $(6759.00)^2(0.000439)^2$ 8.8043 = $+ (-6723.21)^2(0.000175)^2$ 1.3843 = + $(0.04)^2(0.00167)^2$ 0.0000 = $+ (-6.65)^2(0.00444)^2$

+ $(-6.65)^2(0.00444)^2$ = 0.0009 + $(6759.00)^2(0.000571)^2$ = 14.8949

Using the notation of the two cited examples, these data are converted to

+	$(-6723.21)^2(0.000341)^2$	=	5.2561
+	$(0.04)^2(0.00896)^2$	=	0.0000

 $V_{c}(MUF) = 30.3405 \text{ kg}^{2}U-235$

The variance in the U-235 isotope MUF due to errors of measurement for bulk and uranium concentrations is the sum,

 $2.9586 + 30.3405 = 33.2991 \text{ kg}^2\text{U}-235$

To this must now be added the uncertainties due to the measurement of U-235 concentrations in strata 1, 2, and 4-7, and due to the measurement of the amount of U-235 in stratum 3. The procedure for incorporating these uncertainties is in Method 3.7.

3.4.5.2 <u>Variance of Isotope MUF Due to Measurement Errors in Isotope Measurements</u> <u>Method 3.7</u>

Notation

- S_i = algebraic sum of isotope weights for isotope factor i. In the algebraic sum, amounts in input and beginning inventory strata have a plus sign while those in output and ending inventory strata have a minus sign.
 - G = total number of isotope factors
- r_* = number of samples drawn to establish isotope factor i
- c_i* = number of isotopic analyses per sample
- 6*, with subscripts = a relative standard deviation associated with an isotopic measurement. The subscripts are defined as in Section 3.4.3.2. The only errors assumed to be non-zero are:
- $\delta_{r.n.}^{*}$ = random error in sampling for isotope
- δ_{r-t}^{\star} = random error in isotopic analysis
- $\delta_{s,t}^{*}$ = long term systematic error in isotopic analysis

 T_{+} = sum of S_{i} values based on analytical method t

- $V_r^*(MUF)$ = random error variance in MUF due to random errors in isotope measurements

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Mode1

See the discussion for the model in Method 3.6.

Results

$$V_{r}^{*}(MUF) = \sum_{i=1}^{G} S_{i}^{2}(\delta_{r \cdot p}^{*} / r_{i}^{*} + \delta_{r \cdot \cdot t}^{*2} / r_{i}^{*} c_{i}^{*}) \qquad (eq. 3.4.13)$$

$$V_{s}^{*}(MUF) = \sum_{t} T_{t}^{2} \delta_{s}^{*} \cdot t$$
 (eq. 3.4.14)

<u>Basis</u>

The basis for this method is the same as for Method 3.3.

Examples

EXAMPLE 3.7 (a)

Example 3.6 (a) is continued. The following values are given for the parameters. (The nominal factor applies to the NDA measurements in stratum 3.)

<u>Factor (i)</u>	*	(c <u>*</u>	p	<u>t</u>
0.0325	5		2	1	1
0.0267	3		2	1	1
0.0152	2		2	1	1
0.0287	14		1	2	2
0.0312	5		2	1	1
0.0258	4		2	1	1
Nominal	2770		1	-	3
$\delta_{r+1}^{\star} = 0.0005$	⁶ *•2•	=	0.000)5	
$\delta_{r \cdot \cdot 1}^{\star} = 0.0015$	δ * 1	=	0.000)8	
$\delta_{r-2}^{*} = 0.0022$	δ * S ••2	=	0.001	LO	
$\delta_{r-3}^{*} = 0.07$	۶ *• •3	=	0.04		

Equations (eq. 3.4.13) and (eq. 3.4.14) may now be applied, but first, the S_i and T_t values must be calculated. The data are from Example 3.6 (a).

 $S_{1} = 0.0325 (120,000 - 114,500 - 3600 - 1000) = 29.25$ $S_{2} = 80.10 \qquad S_{5} = 187.20$ $S_{3} = -4.56 \qquad S_{6} = 134.16$ $S_{4} = -390.32 \qquad S_{7} = -36.00$ $T_{1} = 29.25 + 80.10 - 4.56 + 187.20 + 134.16 = 426.15$ $T_{2} = -390.32$ $T_{3} = -36.00$ From (eq. 3.4.13), $V_{r}^{*}(MUF) = (29.25)^{2}[(0.0005)^{2}/5 + (0.0015)^{2}/10] + \cdots$

= 0.0766 kg²U-235

From (eq. 3.4.14),

 $V_{c}^{*}(MUF) = (426.15)^{2}(0.0008)^{2} + \cdots$

 $= 2.3422 \text{ kg}^2 \text{U} - 235$

Using the results from Examples 3.6 (a) and the above, the total variance of the isotope MUF is $V^{*}(MUF)$:

 $V*(MUF) = 33.2991 + 0.0766 + 2.3422 = 35.7179 \text{ kg}^2\text{U}-235$

standard deviation = 5.976 kg U-235

To continue with this example, suppose now that booking practices are changed such that measurements of outputs are not regarded as verification measurements but are actually booked. Redefine the factors as follows:

Stratum	Factors	Description
1	0.03250 0.02670 0.01520	Measurement of input; the shipper's values are booked
2	0.03257 0.02668 0.01521 0.02870	Measurement of output, based on facility mea- surements

3-34
4,5	0.03122 0.02576	Measurements of beginning inventory, based on facility measurements
6,7	0.03257 0.02668 0.01521 0.02870	Measurements of ending in- ventory, based on facility measurements

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The revised table of factors then appears as follows:

Factor (i)	ri*	<u>c;*</u>	p	<u>t</u>
0.03250	5	2	1	1
0.02670	3	2	1	1
0.01520	2	2	1	1
0.03257	25	1	3	2
0.02668	15	1	3	2
0.01521	10	1	3	2
0.02870	14	1	2	2
0.03122	20	1	3	2
0.02576	12	1	3	2
Nominal	2770	1	-	3

The errors remain the same. One additional error is included, the random error in sampling from material type 3 (sintered pellets). Assume that $\delta_{r,3}^* = 0.0005$.

The S_i and T_t values are recalculated. There are now 10 S_i values.

 $S_{1} = (0.03250)(120,000) = 3900.00$ $S_{2} = (0.02670)(90,000) = 2403.00$ $S_{3} = (0.01520)(30,000) = 456.00$ $S_{4} = (0.03257)(-114,500 - 3600 - 1000) = -3879.09$ $S_{5} = (0.02668)(-83,600 - 2400 - 1000) = -2321.16$ $S_{6} = (0.01521)(-29,500 - 300 - 500) = -460.86$ $S_{7} = (0.02870)(-11,200 - 900 - 1500) = -390.32$ $S_{8} = (0.03122)(6000) = 187.32$ $S_{9} = (0.02576)(1200 + 4000) = 133.95$ $S_{10} = -36.00$

 $T_{1} = 3900.00 + 2403.00 + 456.00 = 6759.00$ $T_{2} = -3879.09 + \dots + 133.95 = -6730.16$ $T_{3} = -36.00$ From (eq. 3.4.13), $V_{r}^{*}(MUF) = (3900.00)^{2}[(0.0005)^{2}/5 + (0.0015)^{2}/10] + \dots$ $= 12.0465 \text{ kg}^{2}\text{U}-235$ From (eq. 3.4.14),

 $V_{s}^{*}(MUF) = (6759.00)^{2}(0.0008)^{2} + (-6730.16)^{2}(0.0010)^{2} + (0.04)^{2}(-36.00)^{2}$ = 76.6065 kg²U-235

The total variance of the isotope MUF is then

V*(MUF) = 33.2991 + 12.0465 + 76.6065

 $= 121.9522 \text{ kg}^2\text{U}-235$

and the standard deviation is 11.043 kg U-235. Note that this is over twice as large as the corresponding value when the measurements of output are not booked but serve only to verify the inputs. The importance of booking practices is clearly demonstrated by this example.

3.4.6 Effects of Other Factors on MUF and its Variance

In the discussion of Section 3.4.1, it was pointed out that MUF is affected by factors other than errors of measurement. It is emphasized that the variance of MUF, calculated by the procedures in the preceding sections, includes only the effects of measurement errors, and it is implicitly assumed that any measurement system on which such errors are based is functioning properly during the material balance period in question. Thus, there are some limitations as to what conclusions can be drawn about diversion of nuclear materials on the basis of only the MUF and its variance. That is, it does not necessarily follow that if an observed MUF differs significantly from zero based on a hypothesis test and using the variance of MUF as calculated in the preceding sections, this is evidence of diversion. Before such a conclusion is drawn, the possible effects of other factors on MUF and its variance should be taken into consideration. How this may be done objectively is a difficult problem.

Consider the factors that may affect MUF and/or its variance. These are such factors as unmeasured or hidden inventories, improperly modeled measurement biases, misstatements on error variances, and improperly recorded data. Unmeasured inventories will increase the size of MUF but will not affect its calculated variance. Improperly modeled measurement biases may affect both the MUF and its

variance, depending upon the nature of the improper modeling. For example, if biases exist but are not corrected for, or if the corrections do not properly reflect the actual biases, then obviously this will affect the value for MUF. Such conditions are, of course, presumed to exist since no measurement system can be free of bias. This is why systematic error variances are a part of the variance of MUF calculations; to reflect these biases. However, it may be difficult to model a system properly. For example, the sampling system for a liquid waste stream may select representative samples the majority of time, but process upsets may perturb the system on occasion so that the sample does not reflect the contents of the waste stream during such events. To continue, misstatements on the sizes of measurement error variances, either under or overstatements, will clearly affect the variance of MUF. Finally, mistakes committed in the recording of data will affect the MUF, but not the calculated variance. Such mistakes are realistically impossible to eliminate completely, and are quite difficult if not impossible to model properly. Their collective effects make it very difficult to distinguish between material diversions and losses that may be explained by innocent causes.

The problems pointed out in the preceding paragraphs are simple to pose but difficult to solve. The function of inspection is to instill confidence in the facility MUF and its variance. In Chapter 4, detailed inspection plans are provided to that end. Further, facility inspection can address itself to other problems just discussed; for example, an assessment can be made of the magnitude of unmeasured inventories, and these can be taken into account in the final MUF evaluation. Even detailed and well conducted facility inspections cannot, however, provide a complete solution.

One approach that has received some attention starts with the premise that there is a tolerable level of lack of material control that will not be included in the standard MUF-LEMUF analysis. This tolerable level is then modeled in some way. Such modeling may be done synthetically, by identifying the various factors that might contribute to MUF and/or its variance, assigning tolerable ranges of values to such factors, and then combining their effects, either analytically or possibly through simulation methods. This does not provide a simple solution; it is difficult to be objective and realistic in this modeling process.

Another approach is to evaluate past MUF data from typical plants considered to have an acceptable level of control. Future MUF performance may then be judged against this past acceptable performance. It is difficult to be objective with this approach also. There is no simple solution to the problem of MUF evaluation; objectivity can only proceed so far in the evaluation process, and semi-objective evaluation must complete any given evaluation, aided by whatever modeling is available. It is relatively straightforward to reach a decision as to whether or not a loss of material is larger than can be explained by errors of measurement; it is quite a different problem to distinguish between losses due to innocent causes, and those due to material diversion.

3.5 CALCULATION OF VARIANCE OF D, THE DIFFERENCE STATISTIC

It has been pointed out that the primary role of inspection from an accounting viewpoint is to instill confidence in the reported MUF and its variance. In performing this function, the so-called D statistic, or the difference statistic, is of prime importance. The quantity \hat{D} is an estimate of the bias in the facility MUF. In actuality, it estimates a relative bias between the facility and the inspection agency, which is interpreted as a bias in the facility MUF when the assumption is made that the agency inspection measurements are unbiased.

The \hat{D} statistic, as defined explicity in the next section, has intuitive appeal in the sense that it seems to be a logical way to compare inspector data with operator data. Beyond this, the importance of this statistic has been demonstrated based on theoretical considerations. In reference [3.13], it is shown that if all items in a given stratum are biased (or falsified) by the same amount, then \hat{D} is an optimal statistic from point of view of maximizing the probability of detecting this bias. The more general case in which items may be biased by variable amounts has also been studied, but an exact solution has not been found for this case. However, in view of the aforementioned important result for the constant bias case, it seems reasonable to base quantitative verification on the \hat{D} statistic for the more general case also; one would not expect to find significant departures from optimality, if any.

In Section 3.5.1, the \hat{D} statistic is defined. The variance of \hat{D} is computed directly by error propagation methods in 3.5.2. In 3.5.3, a general approach to calculating the variance of \hat{D} under specified rather non-restrictive assumptions will be presented.

3.5.1 Definition of \hat{D}

A stratum is defined as in 3.4.3.1. Within each stratum, the inspector obtains measured values for a sampled number of items and compares his results on an item by item basis with those of the facility. The inspector may not obtain a completely independently measured value for each sampled item; he may use average concentration factors to apply to a number of items, just as the facility does.

For each item measured by the inspector, let the difference: facility value minus inspector value, be calculated. Then, average these differences in each stratum, letting \bar{d}_k be the average difference in stratum k. This difference is in terms of either element weight or isotope weight. The difference is then extrapolated to apply to the total weight of element or isotope in stratum k.

$$\hat{D}_{k} = N_{k} \bar{d}_{k}$$
 (eq. 3.5.1)

where N_k is the number of items in stratum k.

To determine the net effect of the biases in all strata on MUF, the D statistic is defined as

 $\hat{D} = \sum_{k} A_{i} \hat{D}_{k}$ (eq. 3.5.2)

where $A_i = +1$ for input and beginning inventory strata, and where $A_i = -1$ for output and ending inventory strata. With \hat{D} defined in this way, a positive value of \hat{D} means that MUF is biased on the high side while a negative value means that MUF is biased low (see the discussion in Section 3.6).

In order to make probability statements about \hat{D} , i.e., in order to determine whether or not an observed \hat{D} provides evidence that the bias in the facility MUF is different from zero, it is necessary to calculate its variance. This is done by methods discussed and exemplified in the sections to follow.

3.5.2 Variance of \hat{D} by Direct Application of Error Propagation Formulas

If a given calculated \hat{D} is based on a simple model that may be written explicitly, then either Method 3.1 or Method 3.2 already given may be applied directly to calculate its variance. This is illustrated by the following example in which the variance of MUF is calculated by Method 3.2. The example is concerned with a shipper-receiver difference analysis for a single stratum rather than with a facility-inspection comparison. Mathematically, the two problems are equivalent.

EXAMPLE 3.2 (c)

Shipper-receiver data for a receipt of 22 cylinders of low enriched ${\sf UF}_6$ are displayed below.

	Net We UFa(eight lbs)	Perc	ent U	Percent	<u>U-235</u>	U-235	(1bs)
Cylinder	S	R	S	R	<u> </u>	<u> </u>	S	R
1	4853	4850	67.61	67.590	3.288	3.300	107.88	108.18
2	4855	4851					107.93	108.20
3	4852	4848					107.86	108.13
4	4846	4843	4	\downarrow	Ļ	4	107.73	108.02
5	4817	4818	67.60	67.605	2.394	2.397	77.96	78.08
6	4838	4835	¥	¥	¥	\downarrow	78.30	78.35
7	4506	4504	67.61	67.60	2.832	2.820	86.28	85.86
8	4504	4506					86.24	85.90
9	4503	4496					86.22	85.71
10	4504	4503					86.24	85.84
11	4504	4503	\downarrow	\downarrow	\downarrow	\downarrow	86.24	85.84
12	4502	4502	67.60	67.610	2.821	2.833	85.85	86.23
13	4503	4503		1			85.87	86.25
14	4498	4499					85.78	86.17
15	4513	4515	↓	\downarrow	4	↓	86.06	86.48
16	4854	4851	67.58	67.585	3.282	3.294	107.66	108.00
17	4853	4850					107.64	107.97
18	4854	4854		ĺ	1		107.66	108.06
19	4849	4848	Ļ	\downarrow	¥	ł	107.55	107.93
20	4856	4855	67.60	67.595	3.286	3.300	107.87	108.30
21	4853	4850					107.80	108.19
22	4853	4851		<u> </u>	↓	<u>↓</u>	107.80	108.21

The quantity \bar{d}_k is the average of the differences in the values for the last two columns. Since N_k is 22, i.e., since every item in this stratum was measured, the quantity \bar{D}_k given by (eq. 3.5.1) is simply the total of the 22 differences. This is -3.48 pounds U-235.

The data layout in the table suggest the following model. The notation is unique to this example.

	Shipper Values							
x ₁ =	μι	^δ x	^θ x :	^ү х	ε <mark>x</mark> l	ω _{X1}	^v x ¹	
x ₄ =	μ_4	δx	θx	γ_{X}	ε x4	ωX1	ν _{X1}	
x ₅ =	μ5	^δ x	^θ x	^ү х	ε x 5	^ω x2	ν x 2	
•			•			۰	•	
•		•	•			•	٠	
x ₁₃ =	μ13	°х	θx	γx	ε x 13	^ω x4	ν _{X4}	
•			•			•	•	
•			•			•	•	
• Xoo =	100	8	• A	Ŷ	ç	•	•	
~22	<u> ~22</u>	ΫХ	Ϋ́Х	'X	χ 22	2 ~X 6	`X 6	

where

x_i = observed amount of U-235 in pounds for shipper

- μ_i = true amount of U-235 in pounds
- δ_{x} = shipper's systematic error in weighing
- θ_{x} = shipper's systematic error in analysis for uranium concentrate
- γ_{x} = shipper's systematic error in analysis for U-235 concentration
- ε_{xi} = shipper's random error in weighing
- ω_{xi} = shipper's random error in analysis for uranium concentrate
- v_{Xj} = shipper's random error in analysis for U-235 concentration

For the receiver, the notation is similar except that y replaces x throughout. It is assumed that each error is a random variable with mean equal to one and standard deviations given below. All errors are assumed to be independently distributed.

Standard Deviations

Random Variable	Standard Devi	ation
δ _x	0.0001	(i.e., 0.01% relative)
θχ	0.0004	
Ϋ́X	0.0006	
εxi	0.0001	
ωxi	0.0002	
vxi	0.0010	
v		

$$\begin{array}{cccc} - 143 & - \\ & & & & \\ \delta_{y} & & & & \\ \theta_{y} & & & & \\ 0.0007 \\ \gamma_{y} & & & & \\ \delta_{yi} & & & & \\ \delta_{yi} & & & & \\ \delta_{yj} & & & & \\ 0.0005 \\ & & & \\ \psi_{yj} & & & & \\ 0.00025 \end{array}$$

The quantity $\hat{D}_1\,,$ or \hat{D} in this instance, is of the form:

$$\hat{D} = \mu_{1} \left(\delta_{X} \theta_{X} \gamma_{X} \varepsilon_{X1} \omega_{X1} \nu_{X1} - \delta_{y} \theta_{y} \gamma_{y} \varepsilon_{y1} \omega_{y1} \nu_{y1} \right)$$

$$+ \cdots$$

$$+ \mu_{4} \left(\delta_{X} \theta_{X} \gamma_{X} \varepsilon_{X4} \omega_{X1} \nu_{X1} - \delta_{y} \theta_{y} \gamma_{y} \varepsilon_{y4} \omega_{y1} \nu_{y1} \right)$$

$$+ \mu_{5} \left(\delta_{X} \theta_{X} \gamma_{X} \varepsilon_{X5} \omega_{X2} \nu_{X2} - \delta_{y} \theta_{y} \gamma_{y} \varepsilon_{y5} \omega_{y2} \nu_{y2} \right)$$

$$+ \cdots$$

$$+ \mu_{13} \left(\delta_{X} \theta_{X} \gamma_{X} \varepsilon_{X1} \omega_{X4} \nu_{X4} - \delta_{y} \theta_{y} \gamma_{y} \varepsilon_{y1} \omega_{y4} \nu_{y4} \right)$$

$$+ \cdots$$

$$+ \mu_{22} \left(\delta_{X} \theta_{X} \gamma_{X} \varepsilon_{X2} \omega_{X6} \nu_{X6} - \delta_{y} \theta_{y} \gamma_{y} \varepsilon_{y2} \omega_{y6} \nu_{y6} \right)$$

Following Method 3.2, a number of partial derivatives, evaluated at the mean values of the random variables, must be calculated. These are

$$\frac{\partial \hat{D}}{\partial \delta_{X}} = \frac{\partial \hat{D}}{\partial \theta_{X}} = \frac{\partial \hat{D}}{\partial \gamma_{X}} = \sum_{i=1}^{22} \mu_{i}$$

$$\frac{\partial \hat{D}}{\partial \delta_{y}} = \frac{\partial \hat{D}}{\partial \theta_{y}} = \frac{\partial \hat{D}}{\mu \gamma_{y}} = -\sum_{i=1}^{22} \mu_{i}$$

$$\frac{\partial \hat{D}}{\partial \epsilon_{xi}} = \mu_{i} , \quad i = 1, 2, \dots, 22$$

$$\frac{\partial \hat{D}}{\partial \epsilon_{yi}} = -\mu_{i} , \quad i=1, 2, \dots, 22$$

$$\frac{\partial \hat{D}}{\partial \omega_{\chi 1}} = \frac{\partial \hat{D}}{\partial \nu_{\chi 1}} = \mu_1 + \mu_2 + \mu_3 + \mu_4$$

$$\frac{\partial \hat{D}}{\partial \omega_{x2}} = \frac{\partial \hat{D}}{\partial \nu_{x2}} = \mu_5 + \mu_6$$
, etc.

Various sums involving the μ_i are needed. The quantity μ_i is unknown and must be replaced by an estimate. For convenience, estimate μ_i by x_i . (It will make very little difference in propagating the errors whether one estimates μ_i by x_i , or by the mean $(y_i + x_i)/2$. Use the simplest value, x_i (or y_i).) Then

$$x_{1} + x_{2} + x_{3} + x_{4} = 431.40$$

$$x_{5} + x_{6} = 156.26$$

$$x_{7} + x_{8} + \dots + x_{11} = 431.22$$

$$x_{12} + x_{13} + x_{14} + x_{15} = 343.56$$

$$x_{16} + x_{17} + x_{18} + x_{19} = 430.51$$

$$x_{20} + x_{21} + x_{22} = 323.47$$

$$\sum_{i=1}^{22} x_{i} = 2116.42$$

(Eq. 3.3.2) of Method 3.2 may now be applied to find the variance of \hat{D} . In the calculations displayed below, the terms having a common coefficient, (b_1^2 in the referenced equation), are combined. 1bs² U-235

(2116.42) ² (1+16+36+25+49+64) x10 ⁻⁸	=	8.5553
$(107.88^2+107.93^2+\cdots+107.80^2)(1+25) \times 10^{-8}$	=	0.0537
$(431.40^2+156.26^2+\cdots+323.47^2)(4+100+16+625)$	$x10^{-8} =$	5.9934
	Var Ô =	14.6024
	σ _Ô =	3.82 1bs U-235

Even for this rather simple model and small set of data, the calculations by the direct approach can quickly become burdensome. The question arises whether some simplifying assumptions can be made without greatly affecting the results. For example, in the second and third lines of the calculations displayed in the example, suppose average values were squared and then multiplied by the number of terms. The second line becomes:

 $22(96.20)^{2}(1+25) \times 10^{-8} = 0.0529$ (compared with 0.0539)

This third line becomes

 $6(352.74)^2(4+100+16+625) \times 10^{-8} = 5.5618$ (compared with 5.9934)

With these simplifying assumptions, $\sigma_{\hat{D}}$ would be 3.76 lbs U-235 rather than 3.82 lbs U-235, which is not a difference of major impact.

This example, and others of a similar nature, suggests that, as for the variance of MUF, a general approach for calculating the variance of \hat{D} based on simplifying assumptions can also be developed. This is the subject of the next section.

3.5.3 Variance of D by General Approach

General formulas will be developed to permit simple calculation of the variance of D. These formulas will be based on assumptions set forth in Section 3.5.3.1 As was true for the calculation of the variance of MUF by general formulas, the assumptions will rarely if ever be completely valid in given applications. However, experience has shown that this is not a great difficulty, since in many cases, even moderate departures from the assumptions have very little effect (as was illustrated by the example just presented). Further, if one has concern about the validity of the general formulas in a given instance, they can readily be altered as appropriate to accommodate a different set of circumstances.

3.5.3.1 Assumptions

The assumptions about the facility data were set forth in Section 3.4.3.1. (Again, the variance of \hat{D} for element weight is considered here; see Section 3.5.4 for isotope weight.) The additional assumptions relative to the inspection are as follows:

(1) For samples of items within a stratum, the inspector also makes measurements. He need not necessarily make the same type of measurement as the facility, e.g., he may use nondestructive assay methods to a much greater extent than does the facility operator.

(2) The inspector and the facility use the same material sampling procedures, and hence, systematic errors in sampling will cancel. The effect of changing this assumption on the calculations should be quite obvious.

(3) When there are batches within a stratum, the inspector may first sample batches at random and then measure the same number of items in each batch sampled.

(4) The inspector may utilize a number of laboratories to analyze the samples, but for a given stratum, all use the same analytical method. This idea is carried further in the next section.

The notation is an extension to that given earlier in Section 3.4.3.2. The quantity y_{kqpt} is defined as was x_{kqpt} , except that y refers to an inspector value. The measurement methods q, p, t refer to <u>his</u> methods.

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Note: As was the case with the facility operator, it may be that within a stratum, the same systematic error does not affect all items, i.e., there is a short term systematic error. Use parentheses to indicate the total element weight associated with "condition i" for a given measurement.

Since, under assumption (3) of the previous paragraph, the inspector may utilize a number of laboratories, this concept is extended to accommodate this possibility. Specifically,

y_{kqpt(i(j))} = total element weight in stratum k as determined by the inspector using the indicated measurement methods, and for those items measured under condition j within laboratory i.

If need be, this idea can be extended further using additional classifications that may be either crossed or nested. However, the extension just indicated should be adequate to cover the great majority of applications.

To continue with the notation, δ with subscripts still denotes a relative standard deviation. The first subscript of r, s, or g is defined as in 3.4.3.2. If the first subscript is h, this refers to a short term systematic error within another such error, i.e., to a condition or time effect within a laboratory. Subscripts 2, 3, and 4 are defined as in 3.4.3.2. A fifth subscript is either x to refer to an operator standard deviation or y to refer to one for the inspector. Further, let u_k , w_k , v_k , and a_k denote inspector parameters associated with stratum k:

 u_{μ} = number of batches sampled by the inspector

- wk = number of items per sampled batch for which the inspector makes bulk measurements
- $v_k =$ number of samples drawn by the inspector per sampled batch to determine the element factor

 $a_{\mu} \approx$ number of analyses performed by the inspector per sample

With this notation in mind, Method 3.8 will now provide formulas needed to compute the random error variance of \hat{D} .

3.5.3.3 Random Error Variance of D

Method 3.8

Notation

The notation is given in Sections 3.4.3.2 and 3.5.3.2.

Model

The statistic \hat{D} is defined in (eq. 3.5.2). The model for a given term in the indicated sum is exemplified by the model discussed in example 3.2 (c).

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Results

For stratum k, the random error variance of $\hat{\mathsf{D}}_k$ due to measurement errors committed by the facility is

$$V_{rx}(\hat{D}_k) = x_{kqpt}^2 \left[\delta_{rq}^2 \cdot x'^{u_k w_k} + \delta_{r \cdot p \cdot x}^2 / u_k r_k + \delta_{r \cdot \tau x}^2 / c_k u_k r_k \right] (eq. 3.5.3)$$

That due to the inspector is

$$V_{ry}(\hat{D}_k) = y_{kqpt}^2 \left[\delta_{rq}^2 \cdot y'^{\mu} k^{w} k + \delta_{r}^2 \cdot p \cdot y'^{\mu} k^{v} k^{+} \delta_{r}^2 \cdot t y'^{a} k^{\mu} k^{v} k^{-}\right] \quad (eq. 3.5.4)$$

The variance of \hat{D}_{ν} is

$$V_r(\hat{D}_k) = V_{rx}(\hat{D}_k) + V_{ry}(\hat{D}_k)$$
 (eq. 3.5.5)

The variance of \hat{D} is then found by summing $V_r(\hat{D}_k)$ over the strata.

$$V_r(\hat{D}) = \sum_{k=1}^{K} V_r(\hat{D}_k)$$
 (eq. 3.5.6)

Basis

The formula for $V_r(\hat{D})$ is found by application of Methods 3.1 and 3.2. The key equations, (eq. 3.5.3) and (eq. 3.5.4) are simple to remember if it is kept in mind that the divisor for each variance component is the number of measurement operations affecting that component. For example, in (eq. 3.5.3), the divisor on $\delta^2_{rq..X}$ is the number of batches sampled by the inspector, u_k , times the number of items weighed per sampled batch by the inspector. Since these items are compared on a one by one basis with the corresponding facility measurements, only those items weighed (i.e., bulk measured) by the inspector affect \hat{D}_k . All other items in that stratum that are weighed by the facility do not affect \hat{D}_k , and hence, the number of such weighings is not in the divisor. Similar reasoning holds for the second term. Only the number of batches sampled by the inspector times the number of \hat{D}_k are included. This is the number of batches sampled by the inspector.

Examples

EXAMPLE 3.8 (a)

The facility of examples 3.3 (a) and 3.5 (a) is inspected. The matrix below sets forth the pertinent parameter values for the inspector. The facility data are given in example 3.3 (a). For purposes of error propagation, assume that $x_{kqpt} = y_{kqpt}$.

	1	2	3	4	5	6	7
q	1	1	2	1	1	1	1
р	1	2	3	4	5	4	5
t	1	2	3	4	4	4	4
u _k	12	1	10	6	4	6	4
Wk	3	100	1	3	4	3	4
v _k	2	24	1	2	3	2	3
ak	2	2	1	2	2	2	2

S	tr	a	tı	ur	n	k

The error standard deviations for the inspector are as follows:

 $\delta_{r1 \cdots y} = 0.000658 \qquad \delta_{r \cdots 1 \cdot y} = 0.000531 \qquad \delta_{r \cdots 1 y} = 0.000433$ $\delta_{r2 \cdots y} = 0 \qquad \delta_{r \cdots 2 \cdot y} = 0 \qquad \delta_{r \cdots 2 \cdot y} = 0.000822$ $\delta_{r \cdots 3 \cdot y} = 0 \qquad \delta_{r \cdots 3 \cdot y} = 0.0923$ $\delta_{r \cdots 4 \cdot y} = 0.0181 \qquad \delta_{r \cdots 4 \cdot y} = 0.0198$ $\delta_{r \cdots 5 \cdot y} = 0.0418$

Equation 3.5.3 is now applied for each stratum

$$V_{rx}(\hat{D}_{1}) = 1143 \text{ kg}^{2}\text{U}$$

$$V_{rx}(\hat{D}_{2}) = 515 \text{ kg}^{2}\text{U}$$

$$V_{rx}(\hat{D}_{3}) = 479 \text{ kg}^{2}\text{U}$$

$$V_{rx}(\hat{D}_{4}) = V_{rx}(\hat{D}_{6}) = 950 \text{ kg}^{2}\text{U}$$

$$V_{rx}(\hat{D}_{5}) = V_{rx}(\hat{D}_{7}) = 839 \text{ kg}^{2}\text{U}$$

Equation 3.5.4 is now applied for each stratum

$$V_{ry}(\hat{D}_{1}) = 1594 \text{ kg}^{2}\text{U}$$

$$V_{ry}(\hat{D}_{2}) = 1050 \text{ kg}^{2}\text{U}$$

$$V_{ry}(\hat{D}_{3}) = 1227 \text{ kg}^{2}\text{U}$$

$$V_{ry}(\hat{D}_{4}) = V_{ry}(\hat{D}_{6}) = 2263 \text{ kg}^{2}\text{U}$$

$$V_{ry}(\hat{D}_{5}) = V_{ry}(\hat{D}_{7}) = 2591 \text{ kg}^{2}\text{U}$$

The random error variance of D, given by (eq. 3.5.6), is found by summing all the above values.

 $V_{r}(\hat{D}) = 19,294 \text{ kg}^2 \text{U}$

EXAMPLE 3.8 (b)

The facility of examples 3.3 (b), 3.3 (c), 3.4 (a), and 3.5 (b) is inspected. This is a mixed oxide fuel fabrication facility. The matrix below sets forth the pertinent parameter values for the inspector. The pertinent facility data are in example 3.3 (b). For purposes of error propagation, assume that $x_{kqpt} = y_{kqpt}$.

Stratum k										
	1	2	3	4	5	6	7	8	9	10
q	1	2	2	3	1	1	1	2	2	2
р	1	2	3	4	5	3	6	5	3	6
t	1	2	3	4	3	3	2	3	3	2
u _k	16	40	4	8	6	2	2	4	2	1
Wk	6	12	1	1	5	1	1	7	1	1
٧k	3	5	1	1	2	1	1	2	1	1
ak	2	2	2	1	2	2	2	2	2	2

The error standard deviations for the inspector are as follows.

$$\begin{split} \delta_{r1 \cdot \cdot y} &= 0.00050 \qquad \delta_{r \cdot 1 \cdot y} = 0.0001 \qquad \delta_{r \cdot \cdot 1 y} = 0.0050 \\ \delta_{r2 \cdot \cdot y} &= 0.00075 \qquad \delta_{r \cdot 2 \cdot y} = 0.0080 \qquad \delta_{r \cdot 2 y} = 0.0070 \\ \delta_{r3 \cdot \cdot y} &= 0 \qquad \delta_{r \cdot 3 \cdot y} = 0.035 \qquad \delta_{r \cdot 3 y} = 0.010 \\ \delta_{r \cdot 4 \cdot y} &= 0 \qquad \delta_{r \cdot 4 \cdot y} = 0.0040 \\ \delta_{r \cdot 5 \cdot y} &= 0.0040 \\ \delta_{r \cdot 6 \cdot y} &= 0.020 \end{split}$$

Equation 3.5.3 is now applied for each stratum, as is (eq. 3.5.4) for the inspector. All quantities are in kg^2 plutonium.

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$V_{rx}(\hat{D}_1) = 0.296817$	$V_{ry}(\hat{D}_1) = 0.621036$
$V_{rx}(\hat{D}_2) = 0.982474$	$V_{ry}(\hat{D}_2) = 0.978395$
$V_{rx}(\hat{D}_3) = 0.025538$	$V_{ry}(\hat{D}_3) = 0.025830$
$V_{rx}(\hat{D}_{4}) = 0.000800$	$V_{ry}(\hat{D}_{4}) = 0.003200$
$V_{rx}(\hat{D}_5) = 0.036630$	$V_{ry}(\hat{D}_5) = 0.069715$
$V_{rx}(\hat{D}_6) = 0.008172$	$V_{ry}(\hat{D}_6) = 0.008264$
$V_{rx}(\hat{D}_7) = 0.004305$	$V_{ry}(\hat{D}_7) = 0.004301$
$V_{rx}(\hat{D}_8) = 0.079079$	$V_{ry}(\hat{D}_8) = 0.150722$
$V_{rx}(\hat{D}_9) = 0.012769$	$V_{ry}(\hat{D}_9) = 0.012915$
$V_{rx}(\hat{D}_{10}) = 0.002152$	$V_{rv}(\hat{D}_{10}) = 0.002152$

The random error variance of $\hat{D},$ given by (eq. 3.5.6), is found by summing all the above values.

 $V_r(\hat{D}) = 3.325266 \text{ kg}^2 \text{ plutonium}$

3.5.3.4 Systematic Error Variance of D

In developing the formulas needed to compute the systematic error variance of \hat{D} , attention will first be directed at the short term systematic error. Method 3.9 applies.

Method 3.9

Notation

The notation is given in Sections 3.4.3.2 and 3.5.3.2.

Mode1

See the discussion for the model in Method 3.8.

The calculations indicated need only be performed for those measurements for which the first subscript on δ is g or h, i.e., for the non-zero short term systematic error variances.

For each combination of values q(i), calculate

$$M_{q(i)} \cdot x = \sum_{k=1}^{K} A_{k} x_{kq(i)pt}$$
 (eq. 3.5.7)

where $A_k = +1$ for input and beginning inventory strata and where $A_k = -1$ for output and ending inventory strata.

For each combination of values t(i), calculate

$$M_{\cdot \cdot t(i)x} = \sum_{k=1}^{K} A_k x_{kqpt(i)}$$
 (eq. 3.5.8)

where the A_k are defined as for (eq. 3.5.7).

The contribution to the short term systematic error variance of $\hat{\mathsf{D}}$ due to facility measurements is

$$V_{gx}(\hat{D}) = \sum_{q} \delta_{gq}^{2} \cdots x \sum_{i} M_{q}^{2}(i) \cdots x$$

+
$$\sum_{t} \delta_{g}^{2} \cdots tx \sum_{i} M^{2} \cdots t(i) x \qquad (eq. 3.5.9)$$

For the inspector, for each combination of values q(i), calculate

$$M_{q(i)} = \sum_{k=1}^{K} A_{k} y_{kq(i)}$$
 (eq. 3.5.10)

with the A_k defined as for (eq. 3.5.7).

For each combination of values t(i(j)), calculate

$$M_{\cdot \cdot t(i(j))y} = \sum_{k=1}^{K} A_k y_{kqpt(i(j))}$$
 (eq. 3.5.11)

with $A_{\rm k}$ defined as above. Finally, for each combination t(i), calculate from (eq. 3.5.11),

$$M_{\cdot\cdot t(i)y} = \sum_{j} M_{\cdot\cdot t(i(j))y}$$
 (eq. 3.5.12)

The contribution to the short term systematic error variance of $\hat{\mathsf{D}}$ due to inspector measurements is

$$V_{gy}(\hat{D}) = \sum_{q} \delta_{gq}^{2} \cdots y \sum_{i} M_{q(i)}^{2} \cdots y + \sum_{t} \delta_{h}^{2} \cdots ty \sum_{i,j} M_{\cdot}^{2} \cdots t(i(j))y$$
$$+ \sum_{t} \delta_{g}^{2} \cdots ty \sum_{i} M_{\cdot}^{2} \cdots t(i)y \qquad (eq. 3.5.13)$$

The total short term systematic error variance of \hat{D} is

$$V_{g}(\hat{D}) = V_{gx}(\hat{D}) + V_{gy}(\hat{D})$$
 (eq. 3.5.14)

Basis

The basis for Method 3.9 is the same as for Method 3.8. The distinction is that for random error variances, one first squares quantities and then sums them; for systematic error variances, one sums and then squares.

It is implicitly assumed in this method that both the inspector and the facility apply the same material sampling procedures and hence commit the same systematic errors. For the \hat{D} statistic, these errors would then cancel. This is why, in the method, there are no expressions for $M_{.p(i).x}$ and $M_{.p(i).y}$. Should this assumption not be valid, the equations used to compute these two quantities are essentially the same as (eq. 3.5.7) and (eq. 3.5.10), with obvious modifications. The equations (eq. 3.5.9) and (eq. 3.5.13) would each contain the additional set of terms.

Examples

EXAMPLE 3.9 (a)

The low enriched uranium fuel fabrication facility of example 3.8 (a) is continued. Say that there are no short term systematic errors for either the facility or the inspector except for those occurring because the inspector distributes the inspection samples to four laboratories. The values for the error parameters are:

 $\delta_{g \cdot \cdot 1y} = 0.000544$ $\delta_{g \cdot \cdot 2y} = 0.000522$ $\delta_{g \cdot \cdot 4y} = 0.00711$

The allocation of samples to the various laboratories is given by the following table. The tabular entries are the amounts of uranium, in kilograms, represented by the samples sent to the laboratories, i.e., they are $y_{kqpt(i)}$ values.

Laboratory (1)	
--------------	----	--

Stratum	Ak	<u>t</u>	1	2	3	4
1	1	1	120,000	120,000	0	0
2	-1	2	79,600	79,600	79,600	0
4	1	4	7,200	0	0	0
5	1	4	1,000	1,000	1,000	1,000
6	-1	4	3,600	3,600	0	0
7	-1	4	2,000	2,000	0	0

The quantities $M_{\cdot,t}(i)_y$ are calculated from (eq. 3.5.12). First, (eq. 3.5.11) must be applied, where j = 1 in all cases. Since j = 1, $M_{\cdot,t}(i(j))_y$ and $M_{\cdot,t}(i)_y$ are equivalent, and so the latter quantity is calculated from (eq. 3.5.11).

 $M_{\cdot\cdot1(1)y} = 120,000 \qquad M_{\cdot\cdot1(2)y} = 120,000$ $M_{\cdot\cdot2(1)y} = M_{\cdot\cdot2(2)y} = M_{\cdot\cdot2(3)y} = -79,600$ $M_{\cdot\cdot4(1)y} = 7200 + 1000 - 3600 - 2000 = 2600$ $M_{\cdot\cdot4(2)y} = 1000 - 3600 - 2000 = -4600$ $M_{\cdot\cdot4(3)y} = M_{\cdot\cdot4(4)y} = 1000$ Then, (eq. 3.5.13) is applied. $V_{gy}(\hat{D}) = (0.000544)^{2}[(120,000)^{2} + (120,000)^{2}]$ $+ (0.000522)^{2}[3(-79,600)^{2}]$ $+ (0.00711)^{2}[(2600)^{2} + (-4600)^{2} + 2(1000)^{2}]$ $= 15,215 \text{ kg}^{2}\text{U}$

Finally, from (eq. 3.5.14), the total short term systematic error variance of $\hat{\text{D}}$ is

 $V_{\rm q}(\hat{\rm D}) = 15,215 \ {\rm kg}^2 {\rm U}$

This contribution to the total error is a result of distributing the samples to different laboratories. Had only one laboratory been utilized, the corresponding value would have been

$$V_{gy}(\hat{D}) = (0.000544)^2 (240,000)^2 + (0.000522)^2 (-238,800)^2$$

= 32,584 kg²U

EXAMPLE 3.9 (b)

Continue with the mixed oxide fuel fabrication facility of example 3.8 (b). For the facility measurements, the information on the short term systematic errors was given in example 3.4 (a). The value calculated for $V_g(MUF)$ in that example is identical with $V_{gx}(\hat{D})$, viz,

 $V_{qx}(\hat{D}) = 3.359774 \text{ kg}^2\text{Pu}$

This result is true in general as long as the inspector does not commit the same systematic errors. Since it is assumed in Method 3.9 that the facility and the inspector commit the same systematic errors in sampling, but not in analytical, and since the only short term systematic errors assumed to exist in this example are those due to analytical, the result that $V_g(MUF) = V_{gx}(D)$ holds in this example.

Turning to the inspector measurements, assume that he distributes the samples to only one laboratory, but that the short term systematic error standard deviations for analytical measurements, including NDA measurements, are as follows:

> $\delta_{g \cdot \cdot 1y} = 0.0016$ $\delta_{g \cdot \cdot 2y} = 0.0020$ $\delta_{g \cdot \cdot 3y} = 0.0025$ $\delta_{g \cdot \cdot 4y} = 0.12$

The table below gives the amounts associated with each measurement error shift by stratum and by measurement method, i.e., the tabled values are $y_{kqpt(i)}$ values, in k_q Pu.

			Short Term Measurement Error (i)				
Stratum	Ak	<u>t</u>	1	_2	_3		
1	1	1	768	768	-		
2	-1	2	288	765	432		
3	-1	3	-	9.0	-		
4	-1	4	0.4	-	-		
5	1	3	112.5	-	-		
6	1	3	3.6	-	-		
7	1	2	4.5	-	-		
8	-1	3	-	135	-		
9	-1	3	-	4.5	-		
10	-1	2	-	-	2. 25		

Since only the one laboratory is involved in this example, the quantities M..t(i)y are calculated as in the previous example. Physically, these values now represent total amounts of plutonium associated with each measurement error rather than with each laboratory; the error propagation is identical.

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$$M_{\cdot\cdot1(1)y} = M_{\cdot\cdot1(2)y} = 768$$

$$M_{\cdot2(1)y} = -288 + 4.5 = -283.5$$

$$M_{\cdot2(2)y} = -765$$

$$M_{\cdot2(3)y} = -432 - 2.25 = -434.25$$

$$M_{\cdot\cdot3(1)y} = 112.5 + 3.6 = 116.1$$

$$M_{\cdot\cdot3(2)y} = -9.0 - 135 - 4.5 = -148.5$$

$$M_{\cdot\cdot4(1)y} = -0.4$$
Then, (eq. 3.5.13) is applied.
$$V_{gy}(\hat{D}) = (0.0016)^{2}[2(768)^{2}] + (0.0020)^{2}[(-283.5)^{2} + (-765)^{2}]$$

+
$$(-434.25)^2$$
] + $(0.0025)^2$ [(116.1)² + $(-148.5)^2$]

+
$$(0.12)^2(-0.4)^2$$

Finally, from (eq. 3.5.14), the total short term systematic error variance of \hat{D} is

$$V_{g}(\hat{D}) = 3.359774 + 6.660956 = 10.020730 \text{ kg}^2 \text{ Pu}$$

EXAMPLE 3.9 (c)

In the example just completed, assume that the samples of $P_{\rm U}O_2$ drawn from stratum 1 are distributed to three laboratories and that within each laboratory, they are analyzed under two sets of conditions (shift in short-term systematic error). Then, the value for $\delta_{\rm g\cdot\cdot1y}$ of 0.0016 given in the previous example becomes $\delta_{\rm h\cdot\cdot1y}$ since $\delta_{\rm g\cdot\cdot1y}$ must now represent the laboratory effect for analytical method 1. Suppose that

$$\delta_{g \cdot \cdot 1y} = 0.0008$$

and recalculate $V_{qy}(\hat{D})$.

For application in (eq. 3.5.11) and following, the following input values are used:

$$y_{1111(1(1))} = y_{1111(1(2))} = 256$$
$$y_{1111(2(1))} = y_{1111(2(2))} = 256$$
$$y_{1111(3(1))} = y_{1111(3(2))} = 256$$

Applying (eq. 3.5.11), the y values just given are identically the same as the M values of (eq. 3.5.11). From (eq. 3.5.12),

M
..t(1)y = M ..t(2)y = M ..t(3)y = 512

Then, from (eq. 3.5.13),

$$V_{gy}(\hat{D}) = (0.0016)^2 [6(256)^2] + (0.0008)^2 [3(512)^2] + C$$

= 1.509949 kg² Pu + C

The remaining terms are represented by C. From the previous example,

$$C = 6.660956 - (0.0016)^{2} [2(768)^{2}] = 3.641057$$

Therefore,

and

 $V_{gy}(\hat{D}) = 5.151006 \text{ kg}^2 \text{ Pu}$ $V_{g}(\hat{D}) = 8.510780 \text{ kg}^2 \text{ Pu}$

Note that the reduction in size from the previous example occurs because now there are six sets of analytical conditions rather than three, causing more of an averaging effect.

Next, consider the long term systematic error variance of \hat{D} . The calculations described in Method 3.10 follow easily from those in Method 3.9.

Method 3.10

Notation

The notation is given in Sections 3.4.3.2 and 3.5.3.2.

Mode1

See the discussion for the model of Method 3.8.

Results

First, consider the systematic errors for the facility measurements. For each value of q, calculate

$$M_{q \cdot \cdot x} = \sum_{k=1}^{K} A_k x_{kqpt}$$
 (eq. 3.5.15)

where $A_k = +1$ for input and beginning inventory strata and $A_k = -1$ for output and ending inventory strata. Note that if the calculations indicated by (eq. 3.5.7) are performed for each value of q, then $M_{q \cdot \cdot X}$ may be found by summing the $M_{q(j) \cdot \cdot X}$ values over i. Similar statements hold for equations to follow.

For each value of t, calculate

...

$$M_{\cdot \cdot tx} = \sum_{k=1}^{K} A_k x_{kqpt}$$
 (eq. 3.5.16)

with the A_k defined as above.

The long term systematic error variance of D due to facility measurements is

$$V_{sx}(\hat{D}) = \sum_{q} M_{q \cdot \cdot x}^{2} \delta_{sq \cdot \cdot x}^{2} + \sum_{t} M_{\cdot \cdot tx}^{2} \delta_{s \cdot \cdot tx}^{2} \qquad (eq. 3.5.17)$$

For the inspector measurements, for each value of q, calculate

$$M_{q \cdot \cdot y} = \sum_{k=1}^{K} A_k y_{kqpt}$$
 (eq. 3.5.18)

and for each value of t, calculate

$$M_{\cdot \cdot ty} = \sum_{k=1}^{K} A_k y_{kqpt}$$
 (eq. 3.5.19)

where $A_{\textbf{k}}$ is again defined as above. The long-term systematic error variance of \hat{D} due to inspector measurements is

$$V_{sy}(\hat{D}) = \sum_{q} M_{q}^{2} \cdot y \delta_{sq}^{2} \cdot y + \sum_{t} M_{\cdot}^{2} \cdot ty \delta_{s..ty}^{2}$$
 (eq. 3.5.20)

Finally, the total systematic error variance of D is

$$V_{s}(\hat{D}) = V_{sx}(\hat{D}) + V_{sy}(\hat{D})$$
 (eq. 3.5.21)

<u>Basis</u>

See the discussion for the basis in Method 3.9.

Examples

EXAMPLE 3.10 (a)

Continue with the example of 3.9 (a). For the facility measurements, the information on the long-term systematic errors was given in example 3.5 (a). The value calculated for $V_S(MUF)$ in that example was 41,332 kg²U. In this particular example, $V_S(MUF)$ and $V_{SX}(\hat{D})$ have identical values because although $V_S(MUF)$ includes the effects of systematic errors in sampling while $V_{SX}(\hat{D})$ does not (under the assumption that the inspector commits the same systematic errors in sampling as does the facility), in this particular example, the contribution to $V_S(MUF)$ from this error source was zero. Therefore,

 $V_{sv}(\hat{D}) = 41,332 \text{ kg}^2 U$

For the inspector measurements, the error parameter values are:

 $\delta_{s_1 \cdots y} = 0.000439$ $\delta_{s \cdots 1y} = 0.000172$ $\delta_{s \cdots 2y} = 0.000165$ $\delta_{s \cdots 3y} = 0.0692$ $\delta_{s \cdots 4y} = 0.00225$

The values for $M_{q\cdot\cdot y}$ and $M_{\cdot\cdot ty}$ are calculated from (eq. 3.5.18) and (eq. 3.5.19).

 $M_{1} \cdot y = 240,000 - 238,800 = 1200$ $M_{1} \cdot y = 240,000$ $M_{1} \cdot y = -238,800$ $M_{1} \cdot y = -238,800$ $M_{1} \cdot y = -1200$ $M_{1} \cdot y = 0$ (Eq. 3.5.20) is applied. $V_{3} \cdot y(\hat{D}) = (1200)^{2}(0.000439)^{2} + (240,000)^{2}(0.000172)^{2}$

+
$$(-238,800)^2(0.000165)^2$$
 + $(-1200)^2(0.0692)^2$

$$= 10,152 \text{ kg}^2 \text{U}$$

The total systematic error variance of \hat{D} is given by (eq. 3.5.21).

 $V_{c}(\hat{D}) = 41,332 + 10,152 = 51,484 \text{ kg}^2\text{U}$

The results from examples 3.8 (a), (random error) 3.9 (a), (short term systematic error), and this example are now combined to give the total variance of D.

 $V(\hat{D}) = V_r(\hat{D}) + V_g(\hat{D}) + V_s(\hat{D})$ = 19,294 + 15,215 + 51,484 = 85,993 kg²U

EXAMPLE 3.10 (b)

Continue with the example of 3.9 (b). For the facility measurements, the information on the long term systematic error variance was given in example 3.5 (b). The value calculated for $V_{\rm S}({\rm MUF})$ in that example was 6.920414 kg²Pu.

Unlike the example just completed, $V_{S}(MUF)$ and $V_{SX}(\hat{D})$ are not the same value in the current example. This is so because $V_{S}(MUF)$ includes systematic errors in sampling while $V_{SX}(\hat{D})$ does not, it being assumed that the facility and the inspector commit the same systematic sampling errors. From example 3.5 (b), that part of $V_{S}(MUF)$ due to sampling is

 $(-1485)^2(0.0010)^2 + (-9.9)^2(0.015)^2 + (-22.5)^2(0.0024)^2 + (2.25)^2(0.008)^2$

= 2.230517 kg²Pu

Therefore,

 $V_{sx}(\hat{D}) = 6.920414 - 2.230517$

= 4.689897 kg²Pu

For the inspector measurements, the error parameter values are:

$\delta_{s_1 \cdots y} = 0.00030$	$\delta_{s \cdot \cdot 1y} = 0.0012$
δ _{s2••y} = 0.00050	$\delta_{s \cdot \cdot 2y} = 0.0015$
	⁶ s···3y = 0.0020
	$\delta_{s \cdots 4y} = 0.15$

The values for M_{q} ...y and $M_{..ty}$ are calculated from (eq. 3.5.18) and (eq. 3.5.19). From the data matrices of examples 3.3 (b) and 3.8 (b),

$$M_{1 \cdots y} = 1536 + 112.5 + 3.6 + 4.5 = 1656.6$$

$$M_{2 \cdots y} = -1485 -9.0 -135 -4.5 -2.25 = -1635.75$$
From example 3.9 (b),

$$M_{\cdots 1y} = 2(768) = 1536$$

$$M_{\cdots 2y} = -283.5 -765 -434.25 = -1482.75$$

$$M_{\cdots 3y} = 116.1 -148.5 = -32.4$$

$$M_{\cdots 4y} = -0.4$$
Then, (eq. 3.5.20) is applied.

$$V_{sy}(\hat{D}) = (1656.6)^{2}(0.00030)^{2} + (-1635.75)^{2}(0.00050)^{2}$$

$$+ (1536)^{2}(0.0012)^{2} + (-1482.75)^{2}(0.0015)^{2}$$

$$+ (-32.4)^{2}(0.0020)^{2} + (-0.4)^{2}(0.15)^{2}$$

$$= 9.267826 \text{ kg}^{2}\text{Pu}$$

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The total systematic error variance of D is given by (eq. 3.5.21).

 $V_{s}(\hat{D}) = 4.689897 + 9.267826$ = 13.957723 kg²Pu

The results from examples 3.8 (b), (random error), 3.9 (b), (short-term systematic error, with all samples sent to the same laboratory), and this example are now combined to give the total variance of \hat{D} .

V(D) = 3.325266 + 10.020730 + 13.957723 = 27.303719 kg²Pu

3.5.4 Variance of D for Isotope

If the variance of \hat{D} is to be calculated for isotope weight rather than for element weight, then the additional uncertainty associated with the determination of the isotope factors must be included. Before considering the methods for performing these calculations, the discussion in Section 3.4.5 should be reread. This discussion places in perspective the preferred role for measurements of isotope in certain kinds of facilities.

Two methods are given for performing the calculation. Method 3.11 gives the procedures to follow when calculating the variance of isotope \hat{D} caused by uncertainties in the measurement of bulk and in the sampling and analytical measurements

for element. Method 3.12 provides the additional calculations needed to factor in the uncertainty due to isotope measurements. In application, of course, both methods must be followed.

Method 3.11

Notation

The notation is given in Section 3.5.3.2 except that the element weights are now isotope weights.

Mode1

See the discussion for the model of Method 3.8. For isotope weight, the multiplicative model is still used, since the amount of isotope is found by multiplying the amount of element by the isotope concentration factor when the amount of isotope is found by the bulk, sampling, analytical measurement route as opposed to by nondestructive assay.

Results

First, delete from the calculations all strata in which the amount of isotope is determined directly by nondestructive assay, i.e., in which the amount of isotope is not derived from the amount of element by application of a measured isotope concentration factor. If there are strata for which measurements of the amount of isotope are found by bulk-sampling-analytical by one party and by nondestructive assay by the other, delete from the calculations only those that apply to the party using nondestructive assay.

After making the appropriate data deletions, follow Methods 3.8, 3.9, and 3.10, replacing all element weights by isotope weights in the calculations. This may be done by determining the weighted average enrichment per stratum for all the material in the stratum (i.e., not for just those items inspected). Then, in the case of the random error variance, multiply the previously calculated $V_{rX}(\hat{D}_k)$ and $V_{ry}(\hat{D}_k)$ values by the squares of these average enrichments, expressed as fractions rather than as percentages. In the case of the short-term and long-term systematic error variances, the weighted average enrichment fractions must be multiplied by the stratum totals (and by the sub-stratum totals in the case of short term errors) to express these totals in amounts of isotope before finding the sums associated with each systematic error.

Basis

The basis for Method 3.11 is essentially the same as for Method 3.8.

It is implicitly assumed in this method that the weighted average enrichments for the items inspected are the same as for the uninspected items in each stratum (or substratum). More exactly, the coefficient that converts relative error variances to absolute amounts in the error propagation should be the square of the product of the total number of items in the stratum and the average amount of isotope per item inspected. Thus, only if the average amount per item inspected is the same as the average amount per uninspected item will the propagation formulas be correct in the strict sense. This assumption is necessary because the \hat{D} statistic that is in common usage in Agency inspection is implicitly based on a

model in which errors are constant on an absolute basis, whereas the error structure generally assumed in measurements of this type is one in which errors are constant on a relative basis. (To be consistent, it would be more appropriate to work with <u>ratios</u> of facility to inspector measurements rather than with differences, but the advantages that would follow from this change in procedure are outweighed by the problems in introducing the ratio statistic to replace the familiar difference statistic.) The problem is quite academic and only becomes important if a given stratum contains material with widely varying enrichments and if the inspection con-

centrates on certain enrichments in the stratum that are, in total, not representative.

Examples

EXAMPLE 3.11 (a)

Data relative to the inspection of the previously discussed low enriched fuel fabrication plant are given in examples 3.8 (a), 3.9 (a), and 3.10 (a). Material enrichments for the plant are given in example 3.6 (a).

Assume that the inspector obtains quantitive measures of U-235 concentrations using the stabilized assay meter (SAM-2) except in stratum 3, the solid waste output stratum. In stratum 3, nondestructive assay measurements are made directly of the amount of U-235. Since the same is true of the facility measurements, stratum 3 is deleted in the calculations to follow.

Following Method 3.11, the first step is to calculate the average enrichment for all strata but stratum 3. From the data tables of examples 3.3 (a) and 3.6 (a), these weighted enrichments are, by stratum:

Stratum

1	6759.00/240,000 = 0.02816
2	6723.21/238,800 = 0.02815
4	218.16/7200 = 0.03030
5	103.20/4000 = 0.02580
6	211.47/7200 = 0.02937
7	109.85/4000 = 0.02746

Then, the random error variances are (see example 3.8 (a)):

$$V_{r}(\hat{D}_{1}) = (0.02816)^{2}(1143 + 1594) = \frac{\text{kg}^{2}\text{U}-235}{2.1704}$$

$$V_{r}(\hat{D}_{2}) = (0.02815)^{2}(515 + 1050) = 1.2401$$

$$V_{r}(\hat{D}_{4}) = (0.03030)^{2}(950 + 2263) = 2.9498$$

$$V_{r}(\hat{D}_{5}) = (0.02580)^{2}(839 + 2591) = 2.2831$$

$$V_{r}(\hat{D}_{6}) = (0.02937)^{2}(950 + 2263) = 2.7715$$

$$V_r(\hat{D}_7) = (0.02746)^2(839 + 2591) = 2.5864$$

Summing, $V_r(\hat{D}) = 14.0013 \text{ kg}^2\text{U}-235.$

Next, the short term systematic error variance of \hat{D} for isotope is calculated, following example 3.9 (a). In the cited example, the data table indicated the amounts of uranium represented by the samples distributed to the four laboratories. By applying the weighted average enrichment per stratum to that table, these amounts are converted to kilograms of U-235.

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			Laboratory (i)							
Stratum	Ak	<u>t</u>	1	2	3	4				
1	1	1	3379.20	3379.20	-	-				
2	-1	2	2240.74	2240.74	2240.74	-				
4	1	4	218.16	-	-	-				
5	1	4	25.80	25.80	25.80	25.80				
6	-1	4	105.73	105.73	-	-				
7	-1	4	54.92	54.92	-	-				

The quantities $M_{\cdot \cdot t(i)y}$ are calculated as in example 3.9 (a).

$$M_{\cdot\cdot1(1)y} = M_{\cdot\cdot2(2)y} = 3379.20$$

$$M_{\cdot\cdot2(1)y} = M_{\cdot\cdot2(2)y} = M_{\cdot\cdot2(3)y} = 2240.74$$

$$M_{\cdot\cdot4(1)y} = 218.16 + 25.80 - 105.73 - 54.92 = 83.31$$

$$M_{\cdot\cdot4(2)y} = 25.80 - 105.73 - 54.92 = -134.85$$

$$M_{\cdot\cdot4(3)y} = M_{\cdot\cdot4(4)y} = 25.80$$
Then, (eq. 3.5.13) is applied.
$$V_{gy}(\hat{D}) = (0.000544)^{2} [2(3379.20)^{2}] + (0.000522)^{2} [3(2240.74)^{2}]$$

$$+ (0.00711)^{2} [(83.31)^{2} + (-134.85)^{2} + 2(25.80)^{2}]$$

$$= 12.2004 \text{ kg}^{2} \text{ U} - 235$$

Since, in this example, there is no contribution to the short term systematic error variance from the facility measurements

$$V_{g}(\hat{D}) = V_{gy}(\hat{D}) = 12.2004 \text{ kg}^2 \text{ U-}235$$

Finally, the long term systematic error variance is calculated following Method 3.10. The calculations of example 3.10 (a) illustrate Method 3.10 for uranium, and these are now repeated for U-235.

First, consider the contribution to this error variance from the facility measurements. Following the same argument as presented in the first paragraph of the example 3.10 (a) discussion, and with reference to the calculations of example 3.6 (a), the result is

$$V_{sx}(\hat{D}) = V_{s}(MUF) = 30.3405 \text{ kg}^2\text{U}-235$$

For the inspector measurements, the values for $M_{\rm q} \cdot \cdot y$ and $M \cdot \cdot ty$ are calculated as in example 3.10 (a).

since scale 1 is used in all strata.

$$M_{\cdot \cdot 1y} = 6759.00$$

$$M_{\cdot \cdot 2y} = -6723.21$$

$$M_{\cdot \cdot 4y} = 218.16 + 103.20 - 211.47 - 109.85 = 0.04$$

Note that M_{*} is not calculated since the stratum 3 measurements have been deleted. Then, from (eq. 3.5.20),

$$V_{sy}(\hat{D}) = (35.83)^2(0.000439)^2 + (6759.00)^2(0.000172)^2 + (-6723.21)^2(0.000165)^2 + (0.04)^2(0.00225)^2 = 2.5824 kg^2U-235$$

The total systematic error variance of \hat{D} is given by (eq. 3.5.21)

$$V_{s}(\hat{D}) = 30.3405 + 2.5824 = 32.9229 \text{ kg}^2\text{U}-235$$

The random, short term systematic, and long term systematic error variances are now added to give the total variance of \hat{D} due to uncertainties in the measurement of bulk and of element concentrations:

Method 3.11, as exemplified in example 3.11 (a) just completed, gives the variance of \hat{D} in isotope weight that is caused by uncertainties in the measurement of bulk and in the sampling and analytical measurement for element. Thus, the result in example 3.11 (a), viz, $V_t(D) = 59.1246$ kg U-235, does not include the effects of errors in measuring the isotope that are committed by either the facility or the inspector. Procedures for including these errors are detailed in Method 3.12

Method 3.12

Notation

The notation is an extension to that given earlier in Method 3.7. For the error standard deviations, a slight change is made in the notation to distinguish between facility and inspector errors. Specifically, the following errors are defined.

δ* r.n.	=	random	erro	or s	stanc	lard	devia	ation	in	samp	ling	for	isotope,
1 •p•		assumed	l to	be	the	same	for	the	faci	ility	and	the	inspector

- δ^*_{r} = random error standard deviation in isotopic analysis for the facility's analytical method t
- $\delta_{s \cdot \cdot tx}^{*}$ = systematic error standard deviation in isotopic analysis for the facility's analytical method t
- $\delta^*_{r \cdot \cdot ty}$ = random error standard deviation in isotopic analysis for the inspector's analytical method t
- $\delta_{s \cdot \cdot ty}^{*}$ = systematic error standard deviation in isotopic analysis for the inspector's analytical method t

Additional parameters relating to the inspector's measurement are defined:

- v_i^* = number of samples drawn by the inspector to verify the facility's isotopic concentration factor i
- a^{*} = number of isotopic analyses per sample performed by the inspector

Model

See the discussion for the model in Method 3.11.

Results

For facility measurements, the random and systematic error contributions to the variance of \hat{D} due to measurements of isotopic concentrations are denoted by $V_{rx}(\hat{D})$ and $V_{SX}(\hat{D})$ respectively. They are calculated by:

$$V_{rx}^{*}(\hat{D}) = \sum_{i=1}^{G} S_{i}^{2} \left(\delta_{r \cdot p}^{*2} / r_{i}^{*} + \delta_{r \cdot \cdot tx}^{*2} / r_{i}^{*} c_{i}^{*} \right) \qquad (eq. 3.5.22)$$

$$V_{sx}^{\star 2}$$
 (\hat{D}) = $\sum_{t} T_{tx}^{2} \delta_{s \cdot \cdot tx}^{\star 2}$ (eq. 3.5.23)

These equations are identical to those for $V_r^*(MUF)$ and $V_s^*(MUF)$ given by (eq. 3.4.13) and (eq. 3.4.14) respectively. An additional subscript is added to $\delta_{r}^* \cdot \cdot t$, $\delta_{s}^* \cdot \cdot t$, and T_t in the cited equations to designate that these parameters relate to facility measurements, but the numerical calculations are identical.

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For the inspector, the random error is

$$V_{ry}^{*}(\hat{D}) = \sum_{i=1}^{G} S_{i}^{2} \left(\delta_{r \cdot p}^{*2} / v_{i}^{*} + \delta_{r \cdot \cdot ty}^{*2} / v_{i}^{*} a_{i}^{*} \right)$$
(eq. 3.5.24)

To compute the systematic error, first calculate

T_{ty} = sum of S_i values based on the inspector's isotopic analytical method t

$$V_{sy}^{*}(\hat{D}) = \sum_{t} T_{ty}^{2} \delta_{s \cdot \cdot ty}^{*2}$$
 (eq. 3.5.25)

The total variance of \hat{D} due to isotopic measurements is

$$V_{t}^{*}(\hat{D}) = V_{rx}^{*}(\hat{D}) + V_{sx}^{*}(\hat{D}) + V_{ry}^{*}(\hat{D}) + V_{sy}^{*}(\hat{D})$$
 (eq. 3.5.26)

To compute the total variance of the isotope D due to all sources of error, the results of Methods 3.11 and 3.12 are combined. That is, find the sum

$$V^{*}(\hat{D}) = V(\hat{D}) + V_{t}^{*}(\hat{D})$$
 (eq. 3.5.27)

<u>Basis</u>

The basis for this method is essentially the same as for Method 3.8.

Some important assumptions on which the computational equations are based should be emphasized. First, since $\delta_{\mathbf{r}}^* \cdot \mathbf{p} \cdot \mathbf{has}$ no x or y subscript, it is implicitly assumed that both parties use the same sampling equipment. Further, it is assumed that systematic errors in sampling for isotope are zero. Finally, no provision is made for calculating a short term systematic error variance for isotope measurements; such errors are assumed to be zero.

If any of these assumptions should be invalid in a given application, the additional calculations required should be apparent from similar applications detailed by the methods of this chapter.

Examples

EXAMPLE 3.12 (a)

Continue with example 3.11 (a). Additional information relative to the inspector's measurements is required.

In stratum 1, of the 12 batches inspected, 6 have 3.25% enrichment, 4 have 2.67%, and 2 have 1.52%. To measure the enrichment, the inspector uses the stabilized assay meter (SAM-2) on 5 items per sampled batch.

In stratum 2, SAM-2 measurements are made on 50 items. Twenty of these are at 3.25% U-235, 15 at 2.67%, 5 at 1.52%, and 10 at 2.87%.

In stratum 3, the inspector measures the amount of U-235 directly on the 10 items. In stratum 4, all 6 batches are measured with SAM-2 measurements made on 3 items per batch. In stratum 5, all batches are again measured with SAM-2 measurements made on 4 items per batch. No measurements are made of enrichment in strata 6 and 7.

The inspector's error standard deviations are

 $\delta^{*}_{r \cdot \cdot 1y} = 0.01$ $\delta^{*}_{r \cdot \cdot 2y} = 0.10$ $\delta^{*}_{s \cdot \cdot 1y} = 0.004$ $\delta^{*}_{s \cdot \cdot 2y} = 0.06$

where the subscript 1 refers to the SAM-2 and the subscript 2 to the nondestructive assay instrument used in measuring the solid waste in stratum 3.

The pertinent data for the facility are given in example 3.7 (a), and use is made of some of the results calculated in that example.

In applying (eq. 3.5.22) to calculate V_{rX}^{*} (\hat{D}) and (eq. 3.5.23) to calculate V_{SX}^{*} (\hat{D}), it was noted that these equal $V_{r}^{*}(MUF)$ and $V_{S}^{*}(MUF)$ respectively, quantities which were already calculated for this facility in example 3.7 (a).

 $V_{rx}^{*}(\hat{D}) = 0.0766 \text{ kg}^2 \text{ U-235}$ $V_{sx}^{*}(\hat{D}) = 2.3422 \text{ kg}^2 \text{ U-235}$

For the inspector measurements, a_i^* of (eq. 3.5.23) equals one for all i, while values for v_i^* are derived from the information given about the inspector's measurements per stratum

i	Factor	Vi*
1	0.0325	30 + 20 = 50
2	0.0267	20 + 15 = 35
3	0.0152	10 + 5 = 15
4	0.0287	10
5	0.0312	15
6	0.0258	3 + 16 = 19
7	Nominal	10

From (eq. 3.5.24), $V_{rv}^{\star}(\hat{D}) = (29.25)^2[(0.0005)^2 + (0.01)^2]/50$ + $(80.10)^{2}$ [(0.0005)² + (0.01)²]/35 + $(-4.56)^{2}[(0.0005)^{2} + (0.01)^{2}]/15 + (-390.32)^{2}[(0.0005)^{2} + (0.01)^{2}]/10$ + $(187.20)^{2}[(0.0005)^{2} + (0.01)^{2}]/15 + (134.16)^{2}[(0.0005)^{2} + (0.01)^{2}]/19$ $+ (-36.00)^2(0.10)^2/10$ $= 3.1727 \text{ kg}^2 \text{U} - 235$ To calculate $V_{Sy}^{*}(\hat{D})$ from (eq. 3.5.25), it is first necessary to compute T_{ty} for t = 1 (SAM-2) and t = 2 (NDA for solid waste). $T_{11} = 29.25 + 80.10 - 4.56 + 187.20 + 134.16 - 390.32 = 35.83$ $T_{2V} = -36.00$ V_{Sv}^{\star} (\hat{D}) = (35.83)²(0.004)² + (-36.00)²(0.06)² $= 4.6861 \text{ kg}^2 \text{U} - 235$ From (eq. 3.4.15), V_{+}^{\star} (\hat{D}) = 0.0766 + 2.3422 + 3.1727 + 4.6861 $= 10.2776 \text{ kg}^2 \text{U} - 235$ The total variance of the isotope \hat{D} is found using (eq. 3.5.27) and the

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The total variance of the isotope D is found using (eq. 3.5.27) and the results from this current example and from example 3.12 (a).

 $V^{*}(\hat{D}) = 59.1246 + 10.2776 = 69.4022 \text{ kg}^2\text{U}-235$

3.6 THE (MUF-D) STATISTIC

3.6.1 Application of $(MUF-\hat{D})$

There are two statistics, or quantities, that are used to evaluate the material balance data for a given facility. The first is the facility MUF, the amount of material that is unaccounted for based on the facility's measurements of inputs, outputs, and inventories. Methods for calculating the variance of MUF are given in Section 3.4. The second statistic is the so-called difference statistic, or D statistic, which measures the relative bias between the facility and inspection

measurements, or better stated, between the values recorded by the facility and the corresponding values based on measurements made by the inspector. Methods for calculating the variance of \hat{D} are given in Section 3.5.

In making inferences based on the observed or reported values for MUF and \hat{D} , one is faced with a choice as to how to proceed. On the one hand, a significance test can be made of the bias between the facility and inspector values by using the \hat{D} statistic. If the test outcome is that there is no evidence of bias, then one may accept the facility's stated MUF and test it for significance, making no further use of \hat{D} . The other approach is to correct the facility MUF for bias using the \hat{D} statistic. The quantity, \hat{D} , is defined in such a way that if \hat{D} is positive, the MUF is overstated while if \hat{D} is negative, MUF is understated. This suggests that (MUF- \hat{D}) is the statistic which may be regarded as the inspector's estimate of the facility MUF.

In the next chapter, in Section 4.6, comparisons are made of the two evaluation approaches: (1) first test for the significance of \hat{D} and, if not significant, then test for the significance of MUF; (2) test for the significance of (MUF- \hat{D}). These comparisons are made for specific examples, and on the basis of these examples it is inferred that (MUF- \hat{D}) is the preferred statistic if, in fact, the criterion for selection of a statistic is based on the probability of detection.

The fact that the probability of detection is larger for (MUF- \hat{D}) than for the \hat{D} and MUF tests applied separately, to be illustrated in the examples of Section 4.6, has, in fact, been shown to be true in general [3.14]. This fact is consistent by analogy with the earlier reported finding discussed in Section 3.4.4 in which the statistical advantages of making a single test of diversion without making subdivisions by time or by space was pointed out. Thus, the (MUF- \hat{D}) statistic, being a global statistic in the same sense that the overall MUF is (i.e., the MUF over the total finite time period and over the total material balance area) would be expected to have the same advantage as the MUF global statistic.

For other studies in which comparisons are made of $(MUF-\hat{D})$ with D and MUF applied separately, see [3.15] and [3.16].

Consider now the calculation of the variance of (MUF- $\hat{\rm D}$), a quantity needed in the chapter to follow.

3.6.2 Variance of (MUF-D)

Having calculated the variance of MUF and of \hat{D} separately by the methods of Sections 3.4 and 3.5, it is a simple matter to calculate the variance of (MUF- \hat{D}). This calculation is given by Method 3.13.

Method 3.13

Notation

The notation is consistent with that in previous sections. Specifically,

V(MUF) = variance of element MUF V*(MUF) = variance of isotope MUF

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 $V(\hat{D}) = variance of element \hat{D}$

 $V^*(\hat{D})$ = variance of isotope \hat{D}

Additional notation includes:

 $V(MUF-\hat{D}) = variance of element (MUF-\hat{D})$

 $V*(MUF-\hat{D}) = variance of isotope (MUF-\hat{D})$

 V_0 = that part of the variance of element MUF due to systematic errors that are common to both the facility and the inspector V_0^* = defined as V_0 , but for isotope MUF

One additional quantity is needed. This is the covariance between MUF and $\hat{\boldsymbol{D}},$ denoted by

cov (MUF, \hat{D}) for element cov* (MUF, \hat{D}) for isotope

Mode1

A simple additive model will be used to provide the bases for the results. In this model, all errors of a given type, (i.e., random or systematic) are combined and represented by a single error. In this exposition, short-term systematic errors are not included, for simplicity. For the same reason, a very simple material balance involving only two strata (an input and an output stratum) is considered. Further, the items within a stratum are presumed to be so ordered such that the first n_i items out of the total of N_i items are the ones inspected. None of these simplifying assumptions affect the validity of the results.

The model is written as follows. For inputs, the facility measurement of item i is

$$x_{i} = X_{i} + \theta_{i} + \Delta_{i} + \varepsilon_{i}$$
 (eq. 3.6.1)

and for outputs it is

$$x_{2i} = X_{2i} + \theta_2 + \Delta_2 + \epsilon_{2i}$$
 (eq. 3.6.2)

In stratum 1, i runs from 1 to N₁ and in stratum 2, i runs from 1 to N₂. The small x's represent observed values and the large X's represent true values. The quantities θ_1 , Δ_1 , θ_2 , and Δ_2 are systematic errors, while ε_{1i} and ε_{2i} are random errors. All errors are presumed to be distributed with zero means and variances denoted by $\sigma_{\theta^1}^2$, $\sigma_{\Delta^1}^2$, ..., $\sigma_{\varepsilon^2}^2$ respectively.

The corresponding inspector values are

$$y_{1i} = X_{1i} + \theta_1 + \psi_1 + \eta_{1i}$$
 (eq. 3.6.3)

and

$$y_{2i} = X_{2i} + \theta_2 + \psi_2 + \eta_{2i}$$
 (eq. 3.6.4)

Note that θ_1 and θ_2 are the same as for the facility measurements, i.e., they represent those systematic errors that are committed by both parties. In (eq. 3.6.3), i runs from 1 to n_1 while in (eq. 3.6.4), i runs from 1 to n_2 . The small y's represent inspector measurements.

Results

For element,

- $V(MUF-\hat{D}) = V(\hat{D}) V(MUF) + 2 V_0$ (eq. 3.6.5)
- $cov(MUF, \hat{D}) = V(MUF) V_0$ (eq. 3.6.6)

For isotope,

 $V*(MUF-\hat{D}) = V*(\hat{D}) - V*(MUF) + 2 V_0^*$ (eq. 3.6.7) $cov*(MUF,\hat{D}) = V*(MUF) - V_0^*$ (eq. 3.6.8)

Basis

Equations (eq. 3.6.1) - (eq. 3.6.4) form the basis for the results. They are written in general terms to apply to either element or isotope so that by deriving (eq. 3.6.5) and (eq. 3.6.6) for element, the corresponding equations for isotope will follow.

The approach is to write the model for MUF, for \hat{D} , and for (MUF- \hat{D}) using the model equations, find the variance of these quantities by error propagation, and demonstrate that the variances are related as indicated by (eq. 3.6.5). If (eq. 3.6.5) is shown to be true, (eq. 3.6.6) will follow easily, as will be shown.

First, consider MUF.

$$MUF = \sum_{i=1}^{N_1} x_{1i} - \sum_{i=1}^{N_2} x_{2i}$$

= $\sum_{i=1}^{N_1} x_{1i} + N_1 \theta_1 + N_1 \Delta_1 + \sum_{i=1}^{N_1} \epsilon_{1i}$
- $\sum_{i=1}^{N_2} x_{2i} - N_2 \theta_2 - N_2 \Delta_2 - \sum_{i=1}^{N_2} \epsilon_{2i}$ (eq. 3.6.9)

The variance of MUF is

$$V(MUF) = N_1^2 \sigma_{\theta_1}^2 + N_1^2 \sigma_{\Delta_1}^2 + N_1 \sigma_{\varepsilon_1}^2 + N_2^2 \sigma_{\theta_2}^2 + N_2^2 \sigma_{\Delta_2}^2 + N_2 \sigma_{\varepsilon_2}^2$$
(eq. 3.6.10)

Consider $\hat{D} = N_1 \bar{d}_1 - N_2 \bar{d}_2$

where

$$\overline{d}_{1} = \sum_{i=1}^{n_{1}} X_{1i} / n_{1}^{} + \theta_{1} + \Delta_{1} + \sum_{i=1}^{n_{1}} \varepsilon_{1i} / n_{1}$$

$$- \sum_{i=1}^{n_{1}} X_{1i} / n_{1} - \theta_{1} - \psi_{1} - \sum_{i=1}^{n_{1}} n_{1i} / n_{1}$$

$$= \Delta_{1} - \psi_{1} + \sum_{i=1}^{n_{1}} \varepsilon_{1i} / n_{1} - \sum_{i=1}^{n_{1}} n_{1i} / n_{1}$$

$$(eq. 3.6.11)$$

Similarly,

$$\bar{d}_2 = \Delta_2 - \psi_2 + \sum_{i=1}^{n_2} \epsilon_{2i} / n_2 - \sum_{i=1}^{n_2} \eta_{2i} / n_2$$
 (eq. 3.6.12)

The variance of \hat{D} follows immediately:

$$V(\hat{D}) = N_1^2 \sigma_{\Delta_1}^2 + N_1^2 \sigma_{\psi_1}^2 + N_1^2 \sigma_{\varepsilon_1}^2 / n_1 + N_1^2 \sigma_{\eta_1}^2 / n_1 + N_2^2 \sigma_{\Delta_2}^2 + N_2^2 \sigma_{\psi_2}^2 + N_2^2 \sigma_{\varepsilon_2}^2 / n_2 + N_2^2 \sigma_{\eta_2}^2 / n_2$$
(eq. 3.6.13)

From (eq. 3.6.9), (eq. 3.6.11), and (eq. 3.6.12), and including only the error terms, $\ensuremath{\mathsf{E}}$

$$(MUF-\hat{D}) = N_1\theta_1 + N_1\psi_1 - N_2\theta_2 - N_2\psi_2$$

$$+ \sum_{i=n_1+1}^{N_1} \varepsilon_{1i} + (1 - \frac{N_1}{n_1})\sum_{i=1}^{n_1} \varepsilon_{1i} - \sum_{i=n_2+1}^{N_2} \varepsilon_{2i} - (1 - \frac{N_2}{n_2})\sum_{i=1}^{n_2} \varepsilon_{2i}$$

$$+ \frac{N_1}{n_1}\sum_{i=1}^{n_1} n_{1i} - \frac{N_2}{n_2}\sum_{i=1}^{n_2} n_{2i}$$

$$(eq. 3.6.14)$$

$$V(MUF-\hat{D}) = N_1^2\sigma_{\theta_1}^2 + N_1^2\sigma_{\psi_1}^2 + N_2^2\sigma_{\theta_2}^2 + N_2^2\sigma_{\psi_2}^2$$

$$+ N_1(\frac{N_1}{n_1} - 1)\sigma_{\varepsilon_1}^2 + N_2(\frac{N_2}{n_2} - 1)\sigma_{\varepsilon_2}^2 + \frac{N_1^2}{n_1}\sigma_{\eta_1}^2 + \frac{N_2^2}{n_2}\sigma_{\eta_2}^2$$

$$(eq. 3.6.15)$$

Finally, from (eq. 3.6.10), (eq. 3.6.13), and (eq. 3.6.15), and noting that $V_0 = N_1^2 \sigma_{\theta_1}^2 + N_2^2 \sigma_{\theta_2}^2$, that the truth of (eq. 3.6.5) is demonstrated. That is

$$V(\hat{D}) - V(MUF) + 2V_0 = N_1^2 \sigma_{\psi_1}^2 + N_2^2 \sigma_{\psi_2}^2 + N_1^2 \sigma_{\theta_1}^2 + N_2^2 \sigma_{\theta_2}^2 + N_1^2 \sigma_{\theta_1}^2 + N_2^2 \sigma_{\theta_2}^2 + N_1(\frac{N_1}{n_1} - 1) \sigma_{\varepsilon_1}^2 + N_2(\frac{N_2}{n_2} - 1) \sigma_{\varepsilon_2}^2 + \frac{N_1^2}{n_1} \sigma_{\eta_1}^2 + \frac{N_2^2}{n_2} \sigma_{\eta_2}^2 ,$$

which is the expression for $V\left(\text{MUF-}\hat{D}\right),$ completing the proof.
The result of (eq. 3.6.6) then follows immediately. Write

$$V(MUF-\hat{D}) = V(MUF) + V(\hat{D}) - 2 \operatorname{cov}(MUF, \hat{D})$$

and equate this to the right hand side of (eq. 3.6.5). Solving for $cov(MUF, \hat{D})$ yields the solution given by (eq. 3.6.6).

Before leaving this section, it is noted that the key result, (eq. 3.6.5), is also contained in reference [3.17] for a general model that also included short term systematic errors. In the reference, make the equivalence

$$\hat{T}_{p} = (MUF-\hat{D})$$

 $\hat{T}_{t} = MUF$
 $\hat{T}_{t}-\hat{T}_{p} = \hat{D}$

With this equivalence in notation, (eq. 3.6.5) follows immediately from equations (10), (20), (23), and (24) of [3.17], keeping in mind that A_1 of [3.17] corresponds to V_0 of this section. The result (eq. 3.6.5) is also contained in reference [3.18], except that it is assumed in that reference that the facility and the inspector do not commit common systematic errors, so that $V_0 = 0$.

Examples

EXAMPLE 3.13 (a)

Consider the low enriched uranium fuel fabrication facility discussed in previous examples in this chapter. The following results were found:

from examp	ole 3.5 (a)	V(MUF) = 45,010 kg ² U
from examp	ole 3.10 (a)	V(D̂) = 85,993 kg²U
and		$V_0 = 0$

(The result that $V_0 = 0$ follows from the fact that although both the facility and the inspector use the same sampling technique there was zero contribution to V(MUF) due to systematic errors in sampling.)

From (eq. 3.6.5), V(MUF-D) = 85,993 - 45,010 = 40,983 kg²U From (eq. 3.6.6),

 $cov(MUF, \hat{D}) = 45,010 \text{ kg}^2\text{U}$

Note that this size covariance indicates that the correlation coefficient between MUF and D is

```
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             \rho = 45,010/\sqrt{(45,010)(85,993)}
               = 0.72
 For isotope,
      from example 3.7 (a), V^*(MUF) = 35.7179 \text{ kg}^2 \text{U}-235
                                             V^{*}(\hat{D}) = 69.4022 \text{ kg}^2 \text{U} - 235
      from example 3.12 (a),
                                               V_0 * = 0
      and
 From (eq. 3.6.7),
  V*(MUF-\hat{D}) = 69.4022 - 35.7179 = 33.6843 \text{ kg}^2\text{U}-235
 From (eq. 3.6.8),
cov*(MUF, \hat{D}) = 35.7179 \text{ kg}^2\text{U}-235
 The correlation coefficient is
            \rho = 35.7179 / \sqrt{(35.7179)(69.4022)}
               = 0.72 , as for uranium.
```

```
EXAMPLE 3.13 (b)
```

Consider the mixed oxide fuel fabrication facility discussed in previous examples in this chapter. The following results were found:

```
from example 3.5 (b), V(MUF) = 10.729310 \text{ kg}^2\text{Pu}

from example 3.10 (b), V(\hat{D}) = 27.303719 \text{ kg}^2\text{Pu}

and V_0 = 2.230517 \text{ kg}^2\text{Pu}

From (eq. 3.6.5),

V(MUF-\hat{D}) = 27.303719 - 10.729310 + 2(2.230517)

= 21.035443 \text{ kg}^2\text{Pu}

From (eq. 3.6.6)

\text{cov}(MUF,\hat{D}) = 10.729310 - 2.230517

= 8.498793 \text{ kg}^2\text{Pu}

The correlation coefficient is

\rho = 8.498793 / \sqrt{(10.729310)(27.303719)}

= 0.50
```

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PROGRAM ORDER FORM

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Chapter 4

DESIGN OF INSPECTION PLANS

4.1 PURPOSE OF INSPECTION

Stated very simply and in somewhat general terms, the purpose of Agency inspection is to provide assurance that the material balance data for a facility properly reflect the state of material control that exists in that facility, and further, that the state of control is satisfactory, i.e., it provides no indication of unaccounted for losses of material. In order to provide objectivity, quantitative criteria are established, and statements about the inspection activities are framed in terms of these criteria.

Inspection plans are to be derived to apply to a given facility and for a given material balance period. The inspection plan is not restricted to include only those activities that take place to verify amounts of material in inventory at a given time; the plan must also include provisions for monitoring flow streams, i.e., inputs to and outputs from the facility.

This discussion on inspection activities is limited to those activities that bear on material accountancy. There are other activities that take place during an inspection, e.g., checking on containment and surveillance devices, but such activities, while certainly of importance in helping to provide assurance that the material balance data are acceptable when evaluated against the criteria, are not considered to be a part of those activities aimed directly at providing this assurance in quantitative terms.

In planning for inspection, it is assumed that the facility accounting data may misrepresent the actual amounts of material in discrete items. Although such data misrepresentations may clearly occur because of innocent reasons, e.g., because of mistakes in recording the measured data, it is assumed for planning purposes that data misrepresentations occur intentionally in order to mask diversion. This assumption is made in order to provide assurance that the inspection is effective and credible against all possible combinations of understatements and overstatements of material. To be effective and credible, the inspection must guard against the worst possible set of circumstances; this worst possible set corresponds to actions that would be taken by a diverter attempting to conceal diversion through data falsification. More is said to this point in later sections.

It is noted here that the assumed existence of an adversary, the diverter, is the basis for game-theoretic developments of inspector strategies. Throughout this chapter, reference will be made to results derived from game-theoretic considerations, and they will be compared with results found using other approaches, which also assume the existence of an adversary. Generally speaking, there is close agreement in results among the different approaches to the inspection problem. This is a comfortable result, and permits some freedom for inspection planners to choose among the various approaches to inspection planning that are proposed. For a rather complete treatment of the game theoretic approach to safeguards problems, see Avenhaus [4.1].

4.1.1 Response of Accountancy Statistics to Diversion Scenarios

Before proceeding further, it is worthwhile to discuss different diversion scenarios and how the accountancy measures available to the inspector: MUF, \hat{D} , and (MUF- \hat{D}) react to these scenarios. It is perhaps most enlightening to consider

this problem in the context of a specific example. In this example, errors of measurement are ignored, total inspection and a perfect material balance are assumed, i.e., in the absence of diversion, the MUF would be zero. (In the presence of measurement errors and random sampling corresponding to less than total inspection, the results of the following discussion are interpreted for the expectations of the statistics.)

For the example facility material balance, assume the following:

BI = 1000 units (beginning inventory)

R = 500 units (receipts)

S = 800 units (shipments plus waste streams)

EI = 700 units (ending inventory)

MUF = BI + R - S - EI = 0 units

Some representative diversion scenarios are now constructed, and the responses of the test statistics to these scenarios are noted.

Scenario 1

100 units are moved from BI <u>after</u> having been verified by the inspector. The facility is therefore short 100 units at the end of the balance period, i.e., there are actually only 600 units in EI.

Strategy 1

Do not falsify EI, i.e., book the true 600 unit value for ending inventory. Then, the $\overline{\text{MUF}}$ being the booked amount gives MUF = 1000 + 500 - 800 - 600 = 100. The \hat{D}_k statistics for k = 1, 2, 3, and 4 are all zero since the actual amounts agree with the book amounts. Thus

 $\hat{D} = 0$ MUF- $\hat{D} = 100$ units, reflecting 100 units diverted into MUF and 0 units diverted through data falsification.

Strategy 2

Falsify the EI, i.e., book the EI as 700 units even though there are only 600 units present. Then,

Strategy 3

Partially falsify the records to hide the diversion. Overstate the shipments by 20 units and the ending inventory by 30 units. Then,

Scenario 2

Although the true BI is 1000 units, this is booked as 900 units. The 100 units are then removed from the process so that at the end, the EI is actually 600 units.

Strategy 1

Do not falsify the EI, i.e., book the 600 value. MUF = 900 + 500 - 800 - 600 = 0 $\hat{D}_1 = 900 - 1000 = -100$ $\hat{D}_2 = \hat{D}_3 = \hat{D}_4 = 0$ $\hat{D} = -100$ $MUF-\hat{D} = 0 - (-100) = 100 \text{ units, reflecting 0 units diverted into MUF}$ and 100 units diverted through data falsification.

Strategy 2

Being concerned that the inspector will detect the understatement in the beginning inventory, also understate the ending inventory somewhat so that a detected discrepancy could be explained as a measurement bias. Specifically, book 560 units in EI.

MUF = 900 + 500 - 800 - 560 = 40 $\hat{D}_1 = 900 - 1000 = -100$ $\hat{D}_2 = \hat{D}_3 = 0$ $\hat{D}_4 = 560 - 600 = -40$ $\hat{D} = -100 - (-40) = -60$ $ME - \hat{D} = 40 - (-60) = -100 \text{ units} \text{ nof}$

 $MUF-\hat{D} = 40 - (-60) = 100$ units, reflecting 40 units diverted into MUF and 60 units diverted through data falsification. These examples should make it clear that the (MUF-D) statistic reacts to the total amount diverted, no matter what diversion strategy is employed. This is always true, no matter which diversion scenarios may be constructed. In this connection, data falsification can be said to occur only if the material in question is inspectable, i.e., available to the inspector for verification. Thus, with scenario 1, for example, it is not an admissible strategy to remove the 100 units from beginning inventory before it is offered for inspection. Clearly, such a diversion would not be detected within the closed loop of the facility material balance in question. Material not made available for inspection is clearly not safeguarded. Also, if material is diverted into MUF, i.e., simply removed from the process and then shipped to a clandestine facility, such a shipment is not a declared shipment and hence, the fact that there is a discrepancy between the amount shipped and the amount booked is in perfect agreement with the amount presented for inspection.

Since the diverter may not restrict his strategies to the "admissible" ones as defined here, for complete protection other statistics would also need to be included, such as shipper-receiver differences. For a complete discussion, see Reference [4.2].

4.2 INSPECTION ACTIVITIES

Inspection activities, while perhaps quite varied in a number of respects, e.g., measurement complexity, cost, accuracy, etc. may be broadly classified as falling into one of two categories--attributes or variables inspection. In attributes inspection, the item inspected is classified as being either acceptable or not acceptable (i.e., a defect) on the basis of the measurement. Attributes inspection has nothing to do with the quality of the measurement, but rather, with the end use to which the measurement is put. Variables inspection, on the other hand, assigns a measured value to each item inspected, and the measured values for a group of items are combined in some way to provide a statistic, or a function of the observations, used in the evaluation in some predetermined way. As was the case with attributes inspection, the quality of the measurement in question is not the feature that determines that an inspection measurement is variable in nature, but rather, it is the end use to which the measurement is put.

The definitions of attributes and variables inspection in the widely referenced U.S. Military Standards are quoted here to close out this discussion.

- From [4.3]: "Inspection by attributes is inspection whereby either the unit of product is classified simply as defective or nondefective, or the number of defects in the unit of product is counted, with respect to a given requirement or set of requirements."
- From [4.4]: "Inspection by variables is inspection wherein a specified quality characteristic on a unit of product is measured on a continuous scale, such as pounds, inches, feet per second, etc., and a measurement is recorded."

A more detailed discussion of inspection activities as they relate to this field of application follows.

4.2.1 Attributes Inspection Activities

The specific attributes inspection activities that may be performed in a given inspection depend on the circumstances of that inspection. Some activities,

although attributes in nature, are performed on 100% of the items and hence are not a part of the statistical planning or evaluation function. They are included in the discussion to follow for completeness.

In broad terms, the inspection activities discussed in this chapter fall in one of two categories. One category consists of records examination and the other relates to inspection of measurements data. Within each category there is a further subdivision of possible inspections. Those that might be a part of attributes inspection are discussed below.

In connection with the records examination, consider the following activities:

1) Inspection to detect recording and/or calculational mistakes in the stratum subtotals and in combining stratum subtotals to calculate the MUF. This would normally be a 100% inspection effort.

2) Reconciliation of data for receipts, shipments, and inventories as stated in the records with those submitted in reports to the Agency. This is a post-inspection activity and should be a 100% inspection with discrepancies noted and corrected.

3) Inspection to detect recording and/or calculational mistakes for individual items, including checking for proper application of the source data. This will normally be done on a sampling basis, and is part of the statistical attributes inspection.

Activities of types 1-3 are a part of the records examination. In addition, two activities related to the verification of amounts of nuclear material are a part of attributes inspection.

4) Counting of items to verify that the numbers of items located agree with the number listed on the facility records. This could be a 100% inspection, or it could be a part of the statistical attributes inspection, combined with activities 3 and 5.

5) Inspection with an attributes tester to detect discrepancies, or defects, that are larger than can be explained by the combined errors of measurement for the facility and for the inspector's attributes tester.

Some further discussion of this activity is helpful. Consider the attributes tester. This is a measurement device of some sort that will classify an inspected item as being either a defect or not a defect. The definition of an item defect is different from a planning viewpoint than it is from an implementation viewpoint. For planning purposes, a defect is defined in Section 4.3.1. From an implementation viewpoint, a defect is defined in Chapter 5. The fact that different criteria for defining a defect are used should not really be a bothersome point; in planning, it is important to establish criteria such that the amount of inspection performed is sufficient to provide protection against the best diversion strategies that might be used by a diverter. (This point was made previously in Section 4.1).

Measurement devices used as the attributes tester may not even be testers in the true sense of the word. For example, the attributes test may consist of tipping a container to verify that the actual weight does not differ greatly from that listed by the facility. The stabilized assay meter (SAM) may also be regarded as an attributes tester since it verifies that the item contains uranium of roughly the proper enrichment.

In summary, statistical attributes inspection might consist of randomly selecting items from the facility listing, locating those items, checking the calculations from the source data for those items, and performing attributes measurements such as tipping the containers and/or measuring with an NDA instrument such as the SAM. In any particular inspection, and for a given stratum in that inspection, the definition of an attributes test will, of course, have to be explicitly set forth in implementation. This is not necessary in planning, however. It is only required that some type of attributes inspection be anticipated.

4.2.2 Variables Inspection Activities

Variables inspection presupposes the existence of a variables measuring instrument, or a variables tester. Unlike attributes inspection, it is necessary to have in mind the specific tester to be used in each stratum at the planning stage, because the measurement error variances affect the planning. A variables tester may actually consist of a number of distinct measurement operations such as weighing, material sampling, and chemical analysis, or possibly, NDA analysis of the sample.

For planning purposes, variables inspection consists of two types of activities, both of which are related to the inspection of measurement data (as opposed to records examination). To continue with the list of inspection activities begun in the previous section, activities 6 and 7 defined below comprise the variable inspection.

6) Inspection to detect defects that are sufficiently small so as to escape detection with the attributes tester. This inspection activity is referred to as variables inspection in the attributes mode. As was the case with attributes inspection, the definition of a defect used in planning, given in Section 4.3.2.1, differs from that used in implementation, given in Chapter 5, and for the same reason. Interestingly enough, for planning purposes, it will be seen that the definition of a defect is related to the measurement error of the <u>attributes</u> tester. This means that, as stated above, although it is not necessary to specify the attributes tester when planning for attributes inspection, it is at least necessary to have some idea of its measurement error in order to plan for the variables inspection in the attributes mode.

7) Inspection to detect small defects or biases that may exist in all or some items in the given strata. This inspection activity is aimed at developing data for the difference statistic, \hat{D} , discussed in detail in Chapter 3.

For a discussion of how activities 6 and 7, both relating to variables inspection, are united in the planning stage, see Section 4.3.2.

4.3 CRITERIA FOR INSPECTION PLAN DESIGN

Having outlined the types of inspection activities for both the attributes and the variables inspection, the criteria used in planning the inspection are now considered. First these criteria are discussed for attributes inspection.

4.3.1 Attributes Inspection Criteria

In determining the number of items to be inspected, attention is focussed first on a single stratum. Essential to the inspection design is some quantity M.

M = goal amount of element (or isotope) established by external considerations and supplied as an input to the planning.

The attributes inspection criterion is stated very simply. If an amount, M, is missing from the stratum in question, this fact should be detected with (high) probability, $(1-\beta)$. The parameter β is also an input parameter.

Several comments are relevant. First, the definition of "detected" is considered. In order to minimize the amount of inspection that must be performed, a zero-acceptance number plan is used. This means that if even a single defect is found among the items inspected, this constitutes "detection". The action to follow in the event of this detection is yet another matter that must be defined. One action might be to 100% inspect the stratum in question on an attributes basis, correcting all records for the defective items. This is generally not possible, and some other action might be required, such as giving the facility the opportunity to improve the data base prior to another inspection to follow soon. A third possibility, and, in fact, the action most likely to be taken is that the effects on MUF of the detected discrepancy will be evaluated in some way. Section 5.1.3 describes a procedure to calculate the confidence interval for the number of defects in a stratum population. Section 5.1.2.1 describes a procedure to calculate the quantitative effect of defects on MUF. Whatever the follow-up action, detection is clearly and objectively defined here, and such a definition is all that is needed in planning.

Next, consider the definition of a defect. It is clearly to a diverter's benefit to falsify the smallest number of items necessary in order to accumulate the goal amount of M units. Thus, he would choose to falsify each item falsified by the maximum amount possible. Assume that this maximum amount corresponds to the nominal or average amount of element (or isotope) per item, denoted by \bar{x}_k , and expressed in the same units as M. Thus, the number of items that would have to be falsified in order to accumulate M units (i.e., the number of "defects") is M/\bar{x}_k in stratum k. With this in mind, the criterion for attributes inspection stated above may now be restated in its equivalent form, as follows:

If the number of gross or large defects in stratum k is M/\bar{x}_k , choose the sample size, n_{ak} , large enough such that at least one of these defects will appear in the items inspected with probability $(1-\beta)$.

At this point in the discussion, a possibly worrisome point should be brought up. The inspection is designed to detect M units if all M units are missing in stratum k. In actual fact, the adversary would likely not attempt to remove all M units by this mechanism, i.e., by large data falsifications restricted to a single stratum. Clearly, if some amount less than M is diverted from stratum k in this fashion, then the probability of detection in that stratum is some amount smaller than the desired value, $(1-\beta)$. This is a valid point of concern and touches on the general problem of how the diverter would choose to divert M units by various means so as to escape detection. This general problem is treated in detail in later sections (see Sections 4.4.1.2 and 4.6). At this point in the discussion, one need only accept the fact that the inspection criterion as stated is appropriate; its appropriateness will be demonstrated later.

4.3.2 Variables Inspection Criteria

With variables inspection, there are two kinds of criteria. One set is relevant to variables inspection in the attributes mode and the other to variables inspection in the variables mode. The inspection sample size for stratum k will be derived based on each set of criteria. In implementing the plan, the larger of the two sample sizes will be used in each stratum. This means that the actual protection afforded by the plan, i.e., the plan's ability to detect the goal amount, M, will be least as large as that calculated based on the design criteria as applied separately in the attributes and variables mode. This point is discussed further in Section 4.6.

Before presenting inspection criteria for variables inspection in each of its two modes, it is helpful to discuss briefly why the two separate sample sizes must be calculated. The reason is that an inspection plan must counter the best strategy of a diverter. Specifically, it may well happen that if variables inspection in a variables mode is all that's planned for, then the sample size in a given stratum may be too small to counter the strategy in which a diverter falsifies not all items by a small amount, but rather, a selected smaller number of items by an amount just small enough to escape detection by attributes inspection with the attributes tester. The argument used by the diverter is that if any such defected item is included among the items inspected by variables inspection, it is sure to be labelled a defect; however, chances are that the item would not be included among the items to be inspected were variables inspection only planned to develop data for the D statistic. To combat that argument, variables inspection sample sizes must also be large enough to detect these medium sized defects, those sufficiently small so as not to be detected by the attributes tester, but much larger than would be needed to accumulate M units by small defects were all items in the stratum to be falsified.

It is remarked that rather than defining these two categories of defects (medium and small), one could treat both categories of defects simultaneously on a continuous scale. This is done by defining two quantities for a given stratum, one being the number of items to be falsified by the diverter, and the other being the size of the falsification per item. In a game theoretical sense, then, the diverter chooses these two quantities in some optimum way while the inspector also chooses his best strategy to combat the diverter. Limited calculations indicate that the two different approaches to the problem lead to basically the same results from an inspection planning viewpoint [4.1].

Attention is now directed at presenting criteria for variables inspection, first in the attributes mode.

4.3.2.1 Criteria for Variables Inspection in Attributes Mode

The discussion in Section 4.3.1 on attributes inspection criteria is relevant to variables inspection in the attributes mode also. The only difference is in the definition of a defect. As with attributes inspection, it is in the best interest of a diverter to falsify any item selected for falsification by the largest amount feasible. In the case of attributes inspection, this amount was \bar{x}_k ; in the case of variables inspection, it is $\gamma_k \bar{x}_k$, where γ_k is some number less than 1.

The parameter γ_k is an input design parameter. It describes the ability of the attributes tester to detect a given degree of falsification. Specifically, γ_k may be defined by the following statement: if a discrepancy exceed $\gamma_k \bar{x}_k$ in size, it will be labelled a gross defect in the attributes tester inspection with probability one; if it is smaller than $\gamma_k \bar{x}_k$, it will be detected with probability zero.

In defining γ_k in this fashion, there is no need to define a measurement error as such associated with the attributes tester. For example, if the attributes test involves tipping a container to see if it contains about the recorded amount of gross weight, it is difficult to assign a measurement error to this operation. However, the argument can be made that if the item contains say less than half its recorded amount, then this would be detected by the tipping operation. In this event, γ_k would be assigned the value 0.5.

In the event the attributes tester produces a quantitative response or reading, then γ_k may be defined in terms of the measurement error standard deviation of the difference between the facility and the inspection measurements. Often, this reduces to the measurement error standard deviation for the inspector measurement, which will likely be the dominant error in attributes inspection. If the error standard deviation of this difference is denoted by δ_k on a relative basis, then γ_k might be defined to be, say, $4\delta_k$. For example, a 5% relative error standard deviation results in a value for γ_k of 0.20.

When there is some doubt as to the value of γ_k in a given application, it is always preferable to err on the high side. By erring in this direction, the resulting inspection sample size will be larger than needed, i.e., the error will be on the conservative side. This is one reason that the definition $\gamma_k = 4\delta_k$ is used; even though it is quite likely that a discrepancy smaller than $\gamma_k x_k$ would be detected by the attributes tester, the probability of this event is implicitly assumed to be zero in order to be sure that the sample size for variables inspection in the attributes mode is conservatively large.

With these thoughts in mind, the criterion for variables inspection in the attributes mode may now be stated as follows:

If the number of medium defects in stratum k is $M/\gamma_k \bar{x}_k$, choose the sample size, n_{V^1k} , large enough such that at least one of these defects will appear in the items inspected with probability $(1-\beta)$.

4.3.2.2 Criteria for Variables Inspection in Variables Mode, Using D

It was mentioned earlier that the data collected from the variables inspection are used to calculate \hat{D} , the difference statistic defined explicitly in Section 3.5.1. This fact implies that the criteria for the variables inspection sample sizes, when variables inspection is in the variables mode, is related in some way to this \hat{D} statistic.

The design criteria in this application are again related to the goal amount, M. In general terms, a sufficient number of items must be inspected such that if the mean value of \hat{D} is -M, this fact is detected using the \hat{D} statistic with probability (1- β). (Note: The mean of \hat{D} carries the minus sign, -M, because a negative value for \hat{D} benefits the diverter, as \hat{D} has been defined.) A number of comments must be made on this general criterion. First, the precise definition of "detected" must be given. This is related to the probability of a "false alarm", i.e., of claiming detection when in fact the true mean of \hat{D} is zero. This probability should be small. It is an input value in planning, and is labelled $\alpha.$

Secondly, it is noted that, unlike attributes inspection, the sample size for variables inspection in the variables mode is calculated over all strata, and not for a particular stratum. In finding this total sample size, it is implicitly assumed that the items to be inspected are allocated among the strata in some optimum fashion. Specifically, in this discussion, they are allocated to result in a minimum variance for \hat{D} for a fixed total sample size. Other bases for optimum allocation could be factored in, such as the cost of analysis and the attractiveness of the material from a diversion standpoint, but this is not done formally here [4.5].

As a third comment, it is noted that it may not be possible to meet the criterion as stated because the variance of \hat{D} is limited by the systematic error variance. The random part of the variance of \hat{D} will continue to decrease with increased inspection sample sizes; the systematic part will not. Further, even in the case that the design criterion can be met, the effect on $(1-\beta)$ of measuring additional items beyond a certain point may not be worth the effort. Therefore, the emphasis in this chapter will not be so much on determining a specific variables inspection sample size, but rather, in examining the relationship between sample size and $(1-\beta)$ as an aid in choosing the sample size.

Fourthly, it is recognized that the variance of \hat{D} under the hypothesis that there is no diversion through small data falsifications may be smaller than that under the alternative hypothesis that some material may be thus diverted. This is because under the alternative hypothesis, the diverter will likely choose to not falsify all items by the same amount. Thus a statistical sampling error will be introduced because the variance of \hat{D} will depend on which items were selected to be inspected. (See eq. (3.38) of [4.1] for an exact expression for this variance under a specified model.) The parameter C_0^2 is introduced to relate the variance of \hat{D} under the null hypothesis to its variance under the alternative hypothesis during the planning stage. Specifically, for planning purposes, it is assumed that the random error variance of \hat{D} under the alternative hypothesis is C_0^2 times the corresponding variance under the null hypothesis.

As a final comment, it has been noted previously that measurements made with a variables tester may well consist of a number of measurement operations, e.g., a weighing, a sampling, and an analytical measurement. For simplicity, it is assumed in this chapter that the sample size in question is taken to be the number of items sampled to determine the element concentration factor. In calculating the random error variance of \hat{D} in planning, the number of items to be weighed is set equal to the number of items to be sampled. The number of analytical determinations to be made per sampled item may be arbitrarily inputted.

4.3.2.3 Criteria for Variables Inspection in Variables Mode, Using (MUF-D)

In Section 3.6, the (MUF- \hat{D}) statistic was introduced. It was pointed out that (MUF- \hat{D}) may be regarded as the inspector's estimate of the facility MUF. Further it was suggested that the separate tests on \hat{D} and MUF could be combined into one test using (MUF- \hat{D}).

Clearly, the variance of MUF is independent of inspection sample sizes. In the Section 4.3.2.2 just preceding this one, criteria for determining the variable inspection sample sizes using the \hat{D} statistic were given. The aim here was to detect M units through use of \hat{D} . If the (preferred) test statistic, (MUF- \hat{D}), is used in the evaluation phase, then it might be logical that (MUF- \hat{D}) also be the statistic used in inspection planning, rather than \hat{D} . This latter statistic is aimed only at detection of diverted amounts through small data falsifications; the (MUF- \hat{D}) statistic responds to the combination of two strategies of diversion, one through small data falsifications, and the other through diversion into MUF. Diversion into MUF means that material is simply removed from the process with no attempts made to alter any records.

When planning is with respect to $(MUF-\hat{D})$ rather than to \hat{D} , then the criteria discussed in the preceding Section 4.3.2.2 still apply, the only difference being that $(MUF-\hat{D})$ replaces \hat{D} as the test statistic.

4.4 SELECTION OF INSPECTION SAMPLE SIZES

The methods for deriving the inspection sample sizes may now be given. First, the attributes inspection sample sizes are considered.

4.4.1 Attributes Inspection Sample Sizes

In Section 4.4.1.1, the method for determining the attributes inspection sample size in stratum k is given. In Section 4.4.1.2, it is demonstrated that this procedure provides protection against all diverter strategies in which M units are diverted through large data falsifications but allocated among the various strata.

4.4.1.1 Attributes Inspection Sample Size in Given Stratum

Method 4.1

Notation

The notation is given in Section 4.3.1 in part. It is repeated here for convenience, and some additional notation is included.

- M = goal amount of element (or isotope)
- N_{ν} = number of items in stratum k
- n_{ak} = number of items to be inspected in stratum k
 - β = probability of failing to detect the amount M, if this amount is missing from the stratum
- \bar{x}_k = average amount of element (or isotope) per item in stratum k expressed in the same units as M

Model

The random variable is the number of defects found in a sample of n_{ak} items selected at random from a population of N_k items containing a given number of defects. It is well known that this random variable follows a hypergeometric density function [4.6].

Results

The required sample size, n_{ak} , is given by

$$n_{ak} = N_k (1 - \beta^{\bar{x}_k/M})$$
 (eq. 4.4.1)

The result should always be rounded up to the next integer.

Basis

A zero acceptance plan is used to minimize the amount of inspection required. The sample size, n_{ak} , is the solution of the equation:

Prob (0 defects | M/\bar{x}_k defects in the population) = β

Using the hypergeometric model, this equation is written

$$\frac{\begin{pmatrix} M/\bar{x}_{k} \\ 0 \end{pmatrix} \begin{pmatrix} N_{k} - M/\bar{x}_{k} \\ n_{ak} \end{pmatrix}}{\begin{pmatrix} N_{k} \\ n_{ak} \end{pmatrix}} = \beta \qquad (eq. 4.4.2)$$

It is shown in [4.7] that an approximate solution to (eq. 4.4.2) is

$$n_{ak} = 0.5 (1 - \beta \bar{x}_k/M) (2N_k - M/\bar{x}_k + 1)$$
 (eq. 4.4.3)

When $(M/\bar{x}_{k} - 7)$ is small relative to N_k, it may be deleted from (eq. 4.4.3), and (eq. 4.4.1) follows immediately. When $(M/\bar{x}_{k} - 1)$ is not insignificant relative to N_k, the use of (eq. 4.4.1) will result in a conservatively large sample size.

However, it follows from (eq. 4.4.2) that detection is certain ($\beta = 0$) if $n_{\perp} > N_{\perp} - M/\bar{x}_{\perp}$ - i.e., if the sample size is greater than the number of non-defective items in the population so that the sample size never need exceed $N_{\perp} - M/\bar{x}_{\perp} + 1$. Also if cost of sampling is an important factor more precise approximation in (eq. 4.4.3) may be warranted.

Note: When computing β for given N_k, M, \bar{x}_k , and n_k the approximation of (eq. 4.4.1) may seriously overestimate^k β unless the condition that (M/ \bar{x}_k - 1) is small compared to N_k is satisfied, thus indicating a lower probability of detection than that actually achieved. If the condition is not clearly met the use of (eq. 4.4.3) is to be preferred for calculating β when $n_{ak} \leq N_k - M/\bar{x}_k$. If $n_{ak} > N_k - M/\bar{x}_k$, β is identically 0.

EXAMPLE 4.1 (a)

Let the stratum to be inspected be the feed stratum in the low enriched uranium fabrication plant of Example 3.3 (a). From the data of that example,

$$\begin{split} N_{1} &= 12000 \\ \overline{x}_{1} &= 20 \ \text{kg U} \end{split}$$
 Say that the input design parameter values are
$$\begin{split} M &= 1500 \ \text{kg U} \\ \beta &= 0.05 \end{split}$$
Then, using (eq. 4.4.1),
$$\begin{split} n_{a1} &= 12000(1 - 0.05^{1/75}) \\ &= 469.87 = 470 \ \text{items} \end{split}$$

EXAMPLE 4.1 (b)

Let the stratum to be inspected be stratum 8 of the mixed oxide fuel fabrication facility of Example 3.3 (b). This is the ending inventory stratum of mixed oxide powder items. From the cited example,

 $N_8 = 360$ $\bar{x}_8 = 0.375$ kg Pu Say that the input design parameter values are M = 8 kg Pu $\beta = 0.05$ Then, from (eq. 4.4.1), $n_{a8} = 360 (1-0.05^{0.375/8})$ = 47.16 = 48 items

4.4.1.2 Attributes Inspection Sample Sizes Over All Strata

As was mentioned in Section 4.3.1, a diverter would likely not divert all M units from a given stratum and, as a result, the probability of detecting an amount less than M diverted from a given stratum will be less than $(1-\beta)$. Assume, initially, that the diverter diverts the goal amount M through gross data falsifications only, but that he diverts an amount M_k from stratum k so that the sum of M_k over the k strata is M. (This assumption is relaxed later to permit the accumulation of the goal amount through a combination of strategies in which not all of it need be diverted through gross data falsifications.) What is then the probability of detecting this diversion?

To answer this question, "detection" must be defined. In the case of a single stratum, the diversion was detected if one or more defects appeared in the sampled items. To extend this definition over all the strata, detection will be said to occur if at least one such defect is found in one or more strata.

Let
$$\beta_k$$
 = probability of finding 0 defects in the sample of n_{ak}
items in stratum k

The overall probability of nondetection is simply the product of the β_k values over all the strata. The n_{ak} in this definition of β_k is given by (eq. 4.4.1).

The expression for β_k is found. The solution to (eq. 4.4.1) with β_k replacing β and M_k replacing M provides this expression.

$$\beta_k = (1 - n_{ak}/N_k)^{M_k/\bar{x}_k}$$
 (eq. 4.4.4)

But with n_{ak} given by (eq. 4.4.1), the expression $(1 - n_{ak}/N_k)$ may be replaced by $k_{B\bar{x}}/M_{A\bar{x}}$

so (eq. 4.4.4) becomes

$$\beta_k = \beta^M k^{/M}$$
 (eq. 4.4.5)

The product of the β_k values is then

$$\prod_{k} \beta_{k} = \beta^{\Sigma M}_{k} k^{/M} = \beta \qquad (eq. 4.4.6)$$

This gives the probability of nondetection, which is exactly the design value for a given stratum. Thus, even though the probability of detection is not $(1-\beta)$ in any given stratum (unless $M_k = M$ for that stratum), the overall probability of detection will be $(1-\beta)$, given that detection consists of finding at least one defect in at least one stratum.

This result may be more clearly understood if a numerical example is considered. Again consider the facility of Example 3.3 (a) and, following Method 4.1, find the sample size for each of the seven strata. Use M = 1500 kg U. The sampling plan information is given in the table below.

<u>Stratum (k</u>)	Nk	⊼ _k (kg U)	n _{ak}
1	12000	20	470
2	47760	5	475
3	2770	0.4332	3
4	1800	4	15
5	800	5	8
6	1800	4	15
7	800	5	8

The sample sizes, n_{ak} , are calculated from (eq. 4.4.1) for $\beta = 0.05$ with all results rounded up to the nearest integer.

Now, consider three (of the infinitely large number) diversion strategies by which 1500 kg U can be diverted through gross data falsification. These are listed below, with entries in kg U.

	M _k (kg U)					
Stratum	Strategy 1	Strategy 2	Strategy 3			
1	600	400	760			
2	600	1000	220			
3	120	0	0			
4	80	0	280			
5	0	0	40			
6	0	100	0			
7	100	0	200			
Total	1500	1500	1500			

From (eq. 4.4.4), β_k is calculated for each stratum, and for each strategy. The β_k values are displayed in the following table.

	β _k = Probabili	ty of Nondetection	in Stratum k
Stratum	Strategy 1	Strategy 2	Strategy 3
1	0.3016	0.4497	0.2191
2	0.3014	0.1355	0.6442
3	0.7407	1.0000	1.0000
4	0.8459	1.0000	0.5567
5	1.0000	1.0000	0.9044
6	1.0000	0.8112	1.0000
7	0.7778	1.0000	0.6050
Product =	0.0443	0.0494	0.0430

The key result is that even though the probability of nondetection in any one stratum is quite large, yet the overall probability of nondetection is at or below the design value of 0.05.

4.4.1.3 Game Theoretic Results

One may approach the problem using game-theoretic considerations as a starting point. This is a logical and appealing framework on which to develop an inspection strategy because of the presumed conflict between the adversary (the diverter) and the inspector (see Section 4.1).

The minimax problem is treated in reference [4.1]. Briefly stated, the diverter chooses a strategy of deciding which items to falsify that will maximize the probability of non-detection (i.e., minimize the probability of detection). The inspector then selects his sample sizes, subject to cost constraints, that will minimize this maximum probability of non-detection.

The minimax results are compared with those described in the preceding sections, i.e., with results based on the criterion that the sample size in a given stratum is that required to detect M units in that stratum. First, consider the case in which the cost of inspection is the same in all strata. Then, using the notation of the preceding sections, the minimax solution (value for n_j^0 on page 58 of [4.1]) is

$$n_{ak} = \frac{N_k \bar{x}_k \bar{k}^n_{ak}}{\sum_{k} N_k \bar{x}_k}$$
(eq. 4.4.7)

where $\frac{\Sigma}{k}$ n_{ak} is the total sample size, so chosen to provide a probability of detection of 1- β . Specifically, it is the solution of the equation

$$\beta = (1 - M/\sum_{k=1}^{\infty} k_{k} \bar{x}_{k})^{\sum_{k=1}^{\infty} a_{k}}$$
(eq. 4.4.8)

The solution is

$$\sum_{k} n_{ak} = \frac{\ell n\beta}{\ell_n (1 - M/\sum_{k=1}^{N} k \bar{x}_k)}$$
(eq. 4.4.9)

Thus, n_{ak} of (eq. 4.4.7) may be rewritten

$$n_{ak} = \frac{N_k \bar{x}_k \ell n\beta}{\binom{\Sigma}{k} k \bar{x}_k \ell n (1 - M / \frac{\Sigma}{k} N k \bar{x}_k)}$$
(eq. 4.4.10)

Let us compare this game-theoretic result with the earlier result of (eq. 4.4.1), which appears on the surface to be quite different.

First, note that since M would normally be much smaller than $\tilde{k}^{\Sigma N} k^{\bar{X}} k$, the total amount available for possible diversion, the denominator of (eq. 4.4.10) simply reduce to -M, using the result that for small a, $\ell n(1-a)$ is approximately equal to -a. Thus, (eq. 4.4.10) may be rewritten

$$n_{ak} = -N_k \bar{x}_k \ell n \beta / M$$
 (eq. 4.4.11)

Note further that since N_k is common to both (eq. 4.4.1) and (eq. 4.4.11), it remains to determine if

 $(1-\beta^{\overline{x}}k^{/M})$ and - $\overline{x}_k^{\ell n\beta}/M$

are approximately equal to establish that the two formulas for ${\sf n}_{a\,k}$ give the same results. To demonstrate this approximate equality, expand

 $_{\rm B}\bar{x}_{\rm k}/{\rm M}$

in a Maclaurin's series, retaining only the first order term, and with \bar{x}_k/M as the variable. Thus, approximately,

$$\beta^{\overline{x}}k^{/M} = \beta^{0} + \beta^{0}\ell n\beta\left(\frac{\overline{x}_{k}}{M}\right) = 1 + \ell n \beta(\overline{x}_{k}/M) \qquad (eq. 4.4.12)$$

Thus,

$$(1-\beta^{\bar{x}}k^{/M}) = -\bar{x}_k \ln \beta/M$$

thereby establishing the identity. The conclusion is that for all practical purposes, (eq. 4.4.1) and (eq. 4.4.10), giving expressions for n_{ak} that appear to be quite different, and that are based on totally different solution paths are, in fact, equivalent.

For those readers who prefer numerical demonstrations of equivalence rather than mathematical ones, the example of Section 4.4.1.2 is reworked using (eq. 4.4.10) rather than (eq. 4.4.1). For this example,

$$\sum_{k}^{\Sigma} N_{k} \overline{x}_{k} = 502,400$$

$$n_{ak} = \frac{N_{k} \overline{x}_{k} \ell n (0.05)}{(502,400) \ell n (1-.002986)} = 0.001994 N_{k} \overline{x}_{k}$$

$$n_{a1} = 479 (470) \qquad n_{a4} = n_{a6} = 15 (15)$$

$$n_{a2} = 477 (475) \qquad n_{a5} = n_{a7} = 15 (15)$$

$$n_{a3} = 3 (3)$$

Note the very close agreement with the results found by application of (eq. 4.4.1), which are given in the parentheses.

Thus far in the development, it has been assumed that the cost of inspection per sample is the same in all strata. The approximate minimax solution has also been found for the case in which the cost of inspection may differ from one stratum to the next. Letting $\boldsymbol{\epsilon}_k$ be the effort per measurement in stratum k, the sample size in stratum k is given by

$$n_{ak} = \frac{N_{k}\bar{x}_{k}}{\sum_{k} \varepsilon_{k}} \frac{\sum_{k} \varepsilon_{k}}{N_{k}} \frac{n_{ak}}{\bar{x}_{k}}$$
(eq. 4.4.13)

where

$$\sum_{k} \varepsilon_{k} n_{ak} = -(\sum_{k} \varepsilon_{k} N_{k} \overline{x}_{k}) \ell n \beta / M \qquad (eq. 4.4.14)$$

These equations follow from (3.42 a) of [4.1]. It is seen that the formulas for n_{ak} may be rewritten:

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$$n_{ak} = -N_k \bar{x}_k \ell n\beta / M \qquad (eq. 4.4.15)$$

This is identical to (eq. 4.4.11) for the case in which inspection cost is constant. Hence, from point of view of planning, once M and β are fixed, and for given N_k and \bar{x}_k , the cost of inspection plays no role.

In summarizing these results, the conclusion is that the game theoretic minimax approach to the problem produces sample sizes in very good agreement with those found using the criterion that M units diverted in each stratum are to be detected. The minimax approach does provide additional information, namely, it does specify optimum strategies for the diverter, but this is not of interest to the inspector. Either the (eq. 4.4.1) formula or the (eq. 4.4.11) formula may be applied when finding n_{ak} ; there is little to choose between them from point of view of simplicity of application.

4.4.2 Variables Inspection Sample Size

The discussion in Section 4.3.2 should be reviewed as background. This provides the motivation for determining the two sample sizes for variables inspection, one sample size relating to variables inspection in the attributes mode, and the other to variables inspection in the variables mode.

4.4.2.1 Variables Inspection Sample Size--Attributes Mode

The procedure for finding the variables inspection sample size in stratum k, when the variables inspection is in the attributes mode, is given by Method 4.2.

Method 4.2

Notation

The quantities M, N_k, β , and \bar{x}_k are defined as in Method 1. The quantity γ_k was defined in Section 4.3.2.1 by the following statement: if a discrepancy exceeds $\gamma_k \bar{x}_k$ in size, it is sure to be labelled a gross defect in the attributes tester inspection; if it is smaller than $\gamma_k \bar{x}_k$, it will not be detected. The last quantity to be defined is

nv1k = number of items to be inspected in stratum k with variables inspection in the attributes mode

Model

Same as for Method 4.1.

Results

The required sample size is given by

$$n_{v_1k} = N_k \left(1 - \beta^{\gamma_k \bar{x}_k/M}\right)$$
 (eq. 4.4.16)

The result should always be rounded up to the next integer.

Basis

The basis is the same as for Method 4.1, with $\gamma_k \bar{x}_k$ replacing \bar{x}_k .

Examples

EXAMPLE 4.2 (a)

Let the stratum to be inspected be the feed stratum in the low enriched uranium fabrication plant of Example 3.3 (a). For attributes inspection, it was found in Example 4.1 (a) that the sample size was 470 items with M = 1500 kg U and β = 0.05. For variables inspection in the attributes mode, find the sample size if γ_1 = 0.20.

Recalling that N₁ = 12000 and \bar{x}_1 = 20 kg U, the solution is given by (eq. 4.4.16).

 $n_{V_{11}} = 12000 (1-0.05^{1/375})$ = 95.48 = 96 items

EXAMPLE 4.2 (b)

Let the stratum to be inspected be stratum 8 of the mixed oxide fuel fabrication facility of Example 3.3 (b). For attributes inspection, it was found in Example 4.1 (b) that the sample size was 48 items with M = 8 kg Pu and β = 0.05. For variables inspection in the attributes mode, find the sample size if γ_8 = 0.04.

Recalling that N_8 = 360 and \bar{x}_8 = 0.375 kg Pu, the solution is given by (eq. 4.4.7).

N_{V18} = 360 (1-0.05^{0.015/8}) = 2.02 = 3 items

This example provides the opportunity to indicate a course of action to follow when n_{vlk} is very small, as here. In some applications, n_{vlk} may well be less than 1 which, when rounded up, gives an effective sample of size 1. Since variables data are to be used for a number of purposes, it seems advisable to set a lower limit on its size, recognizing that a single paired comparison certainly provides limited information. In striking a balance between inspection resources and data requirements, a reasonable minimum sample size for the number of variables measurements per strata would normally be about three; this minimum is recommended as a working minimum (subject, of course, to specific circumstances).

As was the case with attributes inspection, the sample size for variables inspection in the attributes mode in stratum k will detect an amount M with probability $(1-\beta)$. If an amount smaller than M units were diverted through medium falsification in stratum k, then the detection probability will clearly be less than $(1-\beta)$ in that particular stratum. However, by an argument very similar to that given in Section 4.4.1.2, if detection involves finding at least one defect in at least one stratum, then no matter how the M units are allocated among the strata, the overall probability of detection will be $(1-\beta)$.

An extension to this result will be given in Section 4.5.2 where the probability of finding at least one gross or medium defect in at least one stratum for attributes and/or variables inspection in the attributes mode is calculated. The goal quantity M, or more generally, the amount diverted through gross and medium data falsifications, which may be less than M, may be allocated arbitrarily among the strata, and into either gross or medium falsifications.

4.4.2.2 Variables Inspection Sample Size--Variables Mode

Sections 4.3.2.2 and 4.3.2.3 should be reviewed. The sample size for variables inspection in the variables mode will utilize either the \hat{D} statistic or the (MUF- \hat{D}) statistic for planning purposes. Method 4.3 provides the equations needed to compute the sample size.

Method 4.3

Notation

Much of the notation needed for this method has been defined in prior sections. It is repeated here to facilitate application of the method.

- $V_g(\hat{D})$ = short term systematic error variance of \hat{D} defined by (eq. 3.5.14)
- $V_{s}(\hat{D})$ = long term systematic error variance of \hat{D} defined by (eq. 3.5.21)
- $V_{s1}(\hat{D}_k)$ = random error variance of \hat{D}_k due to the facility sampling and analytical errors, computed for those strata in which the number of items measured by the inspector exceeds the number of batches. In this event, the error, although random in origin, behaves like a systematic error.
- $V_{r1}(\hat{D}_k)$ = random error variance of \hat{D}_k per item due to facility sampling and analytical errors, computed for those strata for which $V_{s1}(\hat{D}_k)$ is not computed.
- $V_{r2}(\hat{D}_k)$ = random error variance of \hat{D}_k per item due to the facility bulk measurement
- $V_{r3}(\hat{D}_k)$ = random error variance of \hat{D}_k per item due to the inspector's sampling and analytical errors.

 σ_s^2 = The sum of the components of the variance of \hat{D} whose values do not decrease with additional inspector measurements (i.e., systematic errors) s_k^2 = random error variance of \hat{D}_k per item measured by the inspector $V_r(\hat{D})/H_0$ = random error variance of \hat{D} under the hypothesis that nothing has been diverted and obscured by small data falsifications $V_r(\hat{D})$ [H₁ = random error variance of \hat{D} under the alternative that small data falsifications have been introduced to mask diversion C_0^2 = variance inflation factor relating $V_{\mu}(\hat{D})|H_1$ to $V_{\mu}(\hat{D})|H_0$ θ = ratio of $V_r(\hat{D}) | H_0$ to σ_s^2 (Note: θ is inversely proportional to the total sample size) V(MUF) = variance of element MUF V_0 = that part of the variance of element MUF due to systematic errors that are common to both the facility and the inspector STAT = test statistic, either \hat{D} or (MUF- \hat{D}) α = significance level of test β = probability of failing to detect an amount M diverted and masked by small data falsifications M = goal quantity in amount of element t_{α} = defined such that the area under the standardized normal curve t_{α} to ∞ is α t_{β} = defined such that the area under the standardized normal curve from t_{ρ} to ∞ is β u_{ν} = number of batches sampled by the inspector w_k = number of items per sampled batch for which the inspector makes bulk measurements v_k = number of samples drawn by the inspector per sampled batch to determine the element factor $a_k = number of analyses performed by the inspector per sample in$ stratum k m_{ν} = number of batches in stratum k r_k = number of sample drawn by the facility per batch to determine the element factor c_{ν} = number of analyses performed by the facility per sample in stratum k

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Mode1

It is assumed that the test statistic, either D or (MUF-D), is normally distributed. For each statistic, the mean is zero under the hypothesis of no diversion, and M under the alternative hypothesis. Also, for each statistic, the random error variance under the alternative hypothesis is assumed to be larger than under the null hypothesis.

Results

The quantities σ_s^2 and s_k must be calculated. To calculate σ_s^2 , the first step is to calculate $V_g(\hat{D})$ and $V_s(\hat{D})$ from (eq. 3.5.14) and (eq. 3.5.21) respectively. Next, $V_{s1}(\hat{D}_k)$ is computed for each stratum for which the number of items to be measured by the inspector exceeds the number of batches. It is assumed that the inspector allocates his samples evenly among batches, or as near evenly as possible (i.e., he may sample one additional item from certain batches in order to achieve his required total number of samples). In some instances, it may not be known a priori whether or not $V_{s1}(\hat{D}_k)$ should be calculated for a certain stratum. One could, of course, iterate to a solution, but the impact of including a given stratum in this calculation when it should not be included, or vice-versa, will usually not be very large, and iteration should normally not be required. The quantity $V_{s1}(\hat{D}_k)$ is calculated from:

$$V_{s_1}(\hat{D}_k) = x_{kqpt}^2 \left(\delta_{r \cdot p \cdot x}^2 / m_k r_k + \delta_{r \cdot \cdot tx}^2 / c_k m_k r_k \right)$$
 (eq. 4.4.17)

Then, σ_{S}^2 is given by

$$\sigma_{s}^{2} = V_{g}(\hat{D}) + V_{s}(\hat{D}) + \sum_{k=1}^{K} V_{s_{1}}(\hat{D}_{k})$$
 (eq. 4.4.18)

To calculate s_k , the first step is to calculate $V_{r1}(\hat{D}_k)$ for all strata for which $V_{s1}(\hat{D}_k)$ was not computed.

$$V_{r_1}(\hat{D}_k) = x_{kqpt}^2 (\delta_{r \cdot p \cdot x}^2 / r_k + \delta_{r \cdot \cdot tx}^2 / c_k r_k)$$
 (eq. 4.4.19)

Next, for each stratum, $V_{r_2}(\hat{D}_k)$ is computed.

$$V_{r_2}(\hat{D}_k) = x_{kqpt}^2 \delta_{rq}^2 \cdot x$$
 (eq. 4.4.20)

Similarly,

$$V_{r_3}(\hat{D}_k) = y_{kqpt}^2 (\delta_{rq \cdot y}^2 + \delta_{r \cdot p \cdot y}^2 + \delta_{r \cdot ty}^2 / a_k)$$
 (eq. 4.4.21)

Then, s_k^2 is computed for each stratum

$$s_k^2 = V_{r_1}(\hat{D}_k) + V_{r_2}(\hat{D}_k) + V_{r_3}(\hat{D}_k)$$
 (eq. 4.4.22)

The quantities V(MUF) and V₀ are computed using Methods 3.3, 3.4, and 3.5, keeping in mind the systematic errors that are common to both the facility and the inspector when computing V₀. Then calculate k_2

$$k_{2} = \frac{V(MUF) - 2V_{0}}{\sigma_{s}^{2}}$$
 (eq. 4.4.23)

With M known, compute

$$m = M/\sigma_s$$
 (eq. 4.4.24)

The quantities α and β (and hence, t_{α} and t_{β}) are chosen, as is C_0^2 , the variance inflation factor. Finally, a decision is made as to the choice of the test statistic to be used in planning, i.e., either \hat{D} or (MUF- \hat{D}). Define

The quantity $\boldsymbol{\theta}$, which is inversely proportional to the sample size, is then calculated.

$$\theta = (A-B)/C$$
 (eq. 4.4.26)

where

$$A = [(C_0^2 + 1)at_{\alpha}^2 t_{\beta}^2 + m^2 t_{\alpha}^2 + C_0^2 m^2 t_{\beta}^2 - at_{\alpha}^4 - C_0^2 at_{\beta}^4]$$
(eq. 4.4.27)

$$B = 2mt_{\alpha}t_{\beta} \sqrt{a(C_{0}^{2}-1)(C_{0}^{2}t_{\beta}^{2}-t_{\alpha}^{2})+C_{0}^{2}m^{2}}$$
 (eq. 4.4.28)

$$C = (t_{\alpha}^2 - C_0^2 t_{\beta}^2)^2 \qquad (eq. 4.4.29)$$

Two special cases are considered. First, if $C_0^2 = 1$, then

$$\theta = m^2 / (t_{\alpha} + t_{\beta})^2 - a$$
 (eq. 4.4.30)

If

$$C = 0, \text{ i.e., if } C_0^2 = (t_{\alpha}/t_{\beta})^2 \text{ , then}$$

$$\theta = \frac{a^2(t_{\alpha}^2 - t_{\beta}^2)^2 - 2am^2(t_{\alpha}^2 + t_{\beta}^2) + m^4}{4m^2 t_{\alpha}^2}$$
(eq. 4.4.31)

Having computed $\boldsymbol{\theta}$, the total sample size, $\boldsymbol{n}_{\boldsymbol{V}_2},$ is found by

$$n_{v_2} = (\sum_{k=1}^{K} s_k)^2 / \theta \sigma_s^2$$
 (eq. 4.4.32)

In stratum k, the sample size is

$$n_{v2k} = n_{v2} s_k / \sum_{k=1}^{K} s_k$$
 (eq. 4.4.33)

<u>Note 1</u>: The quantity θ as computed by (eq. 4.4.26), (eq. 4.4.30), or (eq. 4.4.31) may be negative. This means that the input value for β is unattainable because of the limitations due to the systematic error. A larger value of β must then be selected and θ recomputed.

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Note 2: The number of items inspected in stratum k, n_{V2k} , is interpreted to be the total number of weighings or, equivalently, the total number of samples drawn to estimate element concentration factors. That is,

$$n_{v_{2k}} = u_{k}v_{k} = u_{k}w_{k}$$
 (eq. 4.4.34)

It is quite unlikely that v_k and w_k will be integers, unless m_k , the number of batches, is either equal to one or to the total number of items in the stratum. Thus, for some strata, it is more correct to write

 $n_{v2k} = \sum_{i=1}^{m_k} v_{ki} = \sum_{i=1}^{m_k} w_{ki}$ (eq. 4.4.35)

where v_{kj} is the number of samples drawn by the inspector in batch i of stratum k, and w_{kj} is similarly defined for bulk measurements. For any two such batches, i and j, the quantities v_{kj} and v_{kj} would not normally differ by more than one, nor would wki and w_{kj} .

Note 3: The results given by this method are quite general in nature. If certain parameter values are fixed, then simpler graphical solutions for θ are obtained. Specifically, commonly used values are

$$\alpha = 0.05$$
 $C_0^2 = 4$ $a = 1$ (i.e., use \hat{D} statistic)

For these values of the parameters, the figures in Annexes 4.1 (a) and 4.1 (b) show the relationship between θ (or more exactly, $1/\theta$), and β (or, more exactly, $1-\beta$). Having selected a value for θ corresponding to the desired, or feasibly attainable value for β , the corresponding sample sizes are again given by (eq. 4.4.32) and (eq. 4.4.33).

A comment is in order on the value assigned C_0^2 . Commonly, the value $C_0^2 = 4$ has been used in planning. This means that the random error variance of \hat{D} under the alternative hypothesis of diversion is four times that under the null hypothesis of no diversion. The variance is inflated when not all items are falsified, or when the items that are falsified (which may be all the items) are falsified by varying amounts. For the first case, an expression for the variance of \hat{D} under H is given by equation (3.38) in [4.1], and a similar expression, modified to reflect the different amounts by which items are falsified, would describe the second diversion strategy. Examination of the cited equation (3.38) would indicate that $C_0^2 = 4$ is a reasonable upper bound; this corresponds to falsifying items by an

amount equal to about 3.5 times the random error standard deviation for each item element weight. Since the value of 4 represents an upper bound, it is conservative for planning purposes in that the sample sizes determined for this value of C_0^2 will tend to err on the high side. (Also see Section 6.3 of this Manual.)

Basis

The sample size is selected using amount of element as the variable rather than amount of isotope. First, let the test statistic be \hat{D} rather than (MUF- \hat{D}). The variance of \hat{D} under the hypothesis of no diversion is

$$V(\hat{D}) |H_0 = \sigma_s^2 + V_r(\hat{D}) |H_0$$
 (eq. 4.4.36)

where

 $V_{r}(\hat{D})|H_{0} = \Theta \sigma_{s}^{2}$ (eq. 4.4.37)

defines the quantity θ .

Under the alternative hypothesis, ${\rm H}_1,$ the variance of \hat{D} is

$$V(\hat{D})|H_1 = \sigma_s^2 + C_0^2 \theta \sigma_s^2$$
 (eq. 4.4.38)

The quantity $V_r(\hat{D})|H_0$ is a function of the total sample size and also of the allocation of this total sample size among the K strata. From (eq. 3.5.6), and recognizing that $V_r(\hat{D})|H_0$ is the same as $V_r(\hat{D})$,

$$V_{r}(\hat{D})|_{H_{0}} = \sum_{k=1}^{K} V_{r}(\hat{D}_{k})$$
 (eq. 4.4.39)

where $V_r(\hat{D}_k)$ may be written in the form:

$$V_{r}(\hat{D}_{k}) = x_{kqpt} \left(\delta_{rq \cdot \cdot x}^{2} / n_{v2k} + \delta_{r \cdot p \cdot x}^{2} / DIV + \delta_{r \cdot \cdot tx}^{2} / c_{k}^{DIV} \right)$$

+ $y_{kqpt}^{2} \left(\delta_{rq \cdot \cdot y}^{2} / n_{v2k} + \delta_{r \cdot p \cdot y}^{2} / n_{v2k} + \delta_{r \cdot \cdot ty}^{2} / a_{k}^{2} n_{v2k} \right) (eq. 4.4.40)$

where

DIV = min
$$(n_{v^2k}, m_k r_k)$$
 (eq. 4.4.41)

and where a_k is a known input value (i.e., the number of analyses per sample performed by the inspector is known)

From (eq. 4.4.19) - (eq. 4.4.23), it is seen that $V_{\rm r}(\hat{D})|{\rm H}_0$ may be written in the form

$$V_{r}(\hat{D})|H_{0} = \sum_{k=1}^{K} s_{k}^{2}/n_{v_{2}k}$$
 (eq. 4.4.42)

keeping in mind that $V_{r_1}(\hat{D}_k)$ is included in the definition of s_k only for those strata where DIV of (eq. 4.4.41) is n_{V_2k} .

In allocating the samples among the strata, this allocation should be performed so as to minimize $V_r(\hat{D})|H_0$. This is seen from (eq. 4.4.48) to follow in which the aim is to maximize t_β . In this equation, θ is directly proportional to $V_r(\hat{D})|H_0$. When all items are falsified by the same amount, the variance inflation factor, C_0^2 , is one, and t_β is clearly maximized as θ is minimized. At values of C_0^2 greater than one, t_β is maximized as θ is minimized as long as β <0.50, which is the region of interest. For values of β >0.50, it would benefit the inspector to have a large variance of \hat{D} , but this region of β is of little practical importance.

Minimization of $V_r(\hat{D})|H_0$ is a standard minimization problem, and it is easily shown that the n_{V_2k} should be chosen by the equation:

$$n_{v2k} = n_{v2} s_k / \sum_{k=1}^{K} s_k$$
 (eq. 4.4.43)

(This result is derived in [4.8] where it is also shown how other criteria for optimization may be included.)

From (eq. 4.4.42) and (eq. 4.4.43), along with (eq. 4.4.37), the key relationship between n_{V2} and θ , given by (eq. 4.4.32), follows easily. If some other optimization criterion were imposed, then the relationship between θ and n_{V2} would have to be altered accordingly, but the equations to follow, which lead to the solution for θ , would remain unchanged.

The value for θ is selected such that the goal amount, M, is detected with probability $(1-\beta)$ under the alternative. Further, the significance level of the test is set at α . Before writing down the equations that lead to the solution for θ , it should be noted that as \hat{D} is defined, large <u>negative</u> values of \hat{D} are evidences of diversion, and not large positive values. It is convenient to replace \hat{D} by its negative counterpart, \hat{D} , such that large positive values of \hat{D} lead to rejection of the null hypothesis of no diversion. Thus, define

$$\hat{D}^{-} = -\hat{D}$$
 (eq. 4.4.44)

It is obvious that the variance of \hat{D} will, of course, be the same as the variance of \hat{D} . The two equations to solve for θ and the critical value, D_0 , are

Prob
$$(\hat{D}^{\prime} > D_0 | E(\hat{D}^{\prime}) = 0) = \alpha$$
 (eq. 4.4.45)

and

Prob
$$(\hat{D}^{-} > D_0 | E(D^{-}) = M) = 1 - \beta$$
 (eq. 4.4.46)

From (eq. 4.4.45), (eq. 4.4.36), and (eq. 4.4.37),

$$D_0 = t_{\alpha}\sigma_s \sqrt{1+\theta}$$
 (eq. 4.4.47)

where t α is defined in the <u>Notation</u> section. From (eq. 4.4.46), (eq. 4.4.38), and (eq. 4.4.47),

$$\frac{t_{\alpha}\sigma_{s}\sqrt{1+\theta}-M}{\sigma_{s}\sqrt{1+C_{0}^{2}\theta}} = -t_{\beta}$$
 (eq. 4.4.48)

or, replacing M/σ_S by m, solve the following equation for $\theta.$

$$t_{\alpha} \sqrt{1+\theta} - m = -t_{\beta} \sqrt{1+C_{0}^{2}\theta}$$
 (eq. 4.4.49)

Before indicating the solution to this equation, note the effect of replacing the test statistic \hat{D} by (MUF- \hat{D}) while keeping all other parameters fixed. In this event, from (eq. 3.6.5), the variance of the test statistic, (MUF- \hat{D}), under the null hypothesis is

$$V(MUF-\hat{D})|H_0 = \sigma_s^2(1+\theta-k_2)$$
 (eq. 4.4.50)

while its variance under the alternative hypothesis is

 $a = 1 - k_2$

$$V(MUF-\hat{D})|H_1 = \sigma_s^2(1+C_0^2\theta-k_2)$$
 (eq. 4.4.51)

with k_2 defined by (eq. 4.4.53). It follows immediately that for (MUF- \hat{D}) as the test statistic, (eq. 4.4.49) becomes

$$t_{\alpha} \sqrt{a+\theta} -m = -t_{\beta} \sqrt{a+C_0^2 \theta} \qquad (eq. 4.4.52)$$

(eq. 4.4.53)

where

Thus, in general terms, (eq. 4.4.52) may be solved for θ_1 where a = 1 if the sample size is based on detecting M units with the \hat{D} statistic, and a = $1-k_2$ if the (MUF- \hat{D}) statistic is used. It is shown in [4.9] that the solution to (eq. 4.4.52) is given by the key results: (eq. 4.4.26), (eq. 4.4.30), and (eq. 4.4.31).

Examples

EXAMPLE 4.3 (a)

Consider the low enriched uranium facility of Examples 3.3 (a) and 3.5 (a). Follow Method 4.3 to determine the variables inspection sample size when inspection is in the variables mode. Set M = 1500 kg U, and assume that duplicate analyses are performed in all strata but stratum 3. The inspection samples are distributed to a single laboratory as indicated in Example 3.9 (a). From that example, and from Example 3.10 (a),

$$V_{g}(\hat{D}) = 32,584 \text{ kg}^{2}\text{U}$$

 $V_{s}(\hat{D}) = 51,484 \text{ kg}^{2}\text{U}$

The quantities $V_{s1}(\hat{D}_k)$ are then computed using (eq. 4.4.17) for those strata for which the numbers of items to be measured by the inspector exceed the numbers of batches. These strata include strata 2, 4, 5, 6, and 7.

$$V_{s1}(\hat{D}_2) = (238,800)^2 [(0.000568)^2/240] = 77$$

$$V_{s1}(\hat{D}_4) = V_{s1}(\hat{D}_6)$$

$$= (7200)^2 [(0.0181)^2/60 + (0.0274)^2/60] = 932$$

$$V_{s_1}(\hat{D}_5) = V_{s_1}(\hat{D}_7)$$

= $(4000)^2[(0.0418)^2/48 + (0.0274)^2/48] = 833$

From (eq. 4.4.18),

~

$$\sigma_s^2 = 32,584+51,484+77+2(932)+2(833) = 87,675 \text{ kg}^2 \text{U}$$

Next, $V_{r_1}(\hat{D}_1)$ and $V_{r_1}(\hat{D}_3)$ are calculated from (eq. 4.4.19).

$$V_{r1}(\hat{D}_1) = (240,000)^2 [(0.000531)^2/5 + (0.000433)^2/5] = 5408$$

 $V_{r1}(\hat{D}_3) = (1200)^2 (0.0577)^2 = 4794$

For each stratum, $V_{r2}(\hat{D}_k)$ and $V_{r3}(\hat{D}_k)$ are found using (eq. 4.4.20) and (eq. 4.4.21), and assuming that $x_{kqpt} = y_{kqpt}$ for all k.

$$Vr_2(D_1) = (240,000)^2(0.000658)^2 = 24,939$$

$$V_{r_2}(\hat{D}_2) = (238.800)^2 (0.000877)^2 = 43,860$$

$$V_{r2}(\hat{D}_3) = 0$$

$$V_{r_2}(\hat{D}_4) = V_{r_2}(D_6) = (7200)^2(0.00250)^2 = 324$$

$$v_{r2}(D_5) = v_{r2}(D_7) = (4000)^2 (0.00250)^2 = 100$$

$$V_{r_3}(\tilde{D}_1) = (240,000)^2 [(0.000658)^2 + (.000531)^2 + (0.000433)^2/2] = 46,579$$

$$V_{r_3}(\hat{D}_2) = (238,800)^2[(0.000658)^2 + (0.000822)^2/2] = 43,956$$

$$V_{r_3}(\hat{D}_3) = (1200)^2 (0.0923)^2 = 12,268$$

$$V_{r_3}(\hat{D}_4) = V_{r_3}(\hat{D}_6) = (7200)^2 [(0.000658)^2 + (0.0181)^2 + (0.0198)^2/2] = 27,167$$

$$V_{r_3}(\hat{D}_5) = V_{r_3}(\hat{D}_7) = (4000)^2 [(0.000658)^2 + (0.0418)^2 + (0.0198)^2/2] = 31,099$$

The quantity ${\rm s}_k$ is now computed for each stratum using (eq. 4.4.22).

 $s_{1}^{2} = 5,408 + 24,939 + 46,579 = 76,926$; $s_{1} = 277$ $s_{2}^{2} = 43,860 + 43,956 = 87,816$; $s_{2} = 296$ $s_{3}^{2} = 4,794 + 12,268 = 17,062$; $s_{3} = 131$ $s_{4}^{2} = s_{6}^{2} = 324 + 27,167 = 27,491$; $s_{4} = s_{6} = 166$ $s_{5}^{2} = s_{7}^{2} = 100 + 31,099 = 31,199$; $s_{5} = s_{7} = 177$ 7 $\sum_{k=1}^{7} s_{k} = 1390$

Suppose that the following criteria are set:

$$\alpha = 0.05 \quad (\text{significance level}) \\ c_0^2 = 4 \qquad (\text{variance inflation factor}) \\ a = 1 \qquad (\hat{D} \text{ statistic used in planning}) \\ \text{Then, following Note 3, the graphical solution for } \theta \text{ is found. Here},$$

$$M/\sigma_{c} = 1500/296 = 5.07$$

Set $\beta = 0.05$, or $1-\beta = 0.95$. From Annex 4.1 (b),

The total sample size is then given by (eq. 4.4.32).

$$n_{V_2} = (1390)^2 (1.75) / (87,675)$$

= 39

In each stratum, the sample size is given by (eq. 4.4.33).

$$n_{v21} = (39)(277)/1390 = 8$$

$$n_{v22} = (39)(296)/1390 = 8$$

$$n_{v23} = 4$$

$$n_{v24} = n_{v26} = 5$$

$$n_{v25} = n_{v27} = 5$$

Total = 40

To illustrate application of the more general methodology suppose now that the (MUF- \hat{D}) statistic is to be used in planning, and that $\beta = 0.025$ with all other parameters the same. It is necessary to calculate k_2 from (eq. 4.4.23) to obtain the value for a from (eq. 4.4.25). From Example 3.5 (a),

 $V(MUF) = 45,010 \text{ kg}^2 \text{U}$

From Example 3.10 (a), $V_0 = 0$ since, although both the facility and the inspector commit the same systematic errors in sampling, the contribution to the variance of MUF due to these sources of error was zero in this example. Thus,

 $k_2 = 45,010/87,675 = 0.5134$ $a = 1-k_2 = 0.4866$

The quantity θ is now calculated from (eq. 4.4.26), but first, A, B, and C are found using (eq. 4.4.27), (eq. 4.4.28), and (eq. 4.4.29).

 $A = [(5)(0.4866)(1.645)^{2}(1.960)^{2}+(5.07)^{2}(1.645)^{2}+(4)(5.07)^{2}(1.960)^{2} -(0.4866)(1.645)^{4}-(4)(0.4866)(1.960)^{4}] = 457.5541$

$$B = (2)(5.07)(1.645)(1.960) \sqrt{(0.4866)(3)[(4)(1.960)^2 - (1.645)^2] + (4)(5.07)^2} = 360.0746$$
$$C = [(1.645)^2 - (4)(1.960)^2]^2 = 160.2851$$

$$\theta = \frac{457.5541 - 360.0746}{160.2851} = 0.6082$$

The total sample size in this instance is

 $n_{VO} = (1390)^2 / (0.6082)(87,675) = 37$

Finally, suppose that the variance inflation factor, C_0^2 , were set equal to 1 rather than 4. Then, θ is given directly by (eq. 4.4.30).

 $\theta = (5.07)^2 / (1.645 + 1.960)^2 - 0.4866$ = 1.4913 ,

and the sample size is 15 rather than 37.

EXAMPLE 4.3 (b)

Consider the mixed oxide fuel fabrication facility first introduced in Example 3.3 (b) and considered in a number of examples following that one. Set M = 8 kg Pu, and assume that duplicate analyses are performed in all strata but stratum 4. Further assume that the inspection samples are distributed to only one laboratory, and that the short term systematic error structure is as indicated in Example 3.9 (b). Find the inspection sample size for two cases:
Case 1	$\alpha = 0.05$	$\beta = 0.05$	$C_0^2 = 4$
Use	D̂ statistic		
<u>Case 2</u>	α = 0.025	$\beta = 0.20$	$C_0^2 = 4$
Use	(MUF-D̂) statistic		

The quantities $V_{\rm g}(\hat{D})$ and $V_{\rm S}(\hat{D})$ were calculated in Examples 3.9 (b) and 3.10 (b) respectively.

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 $V_{g}(\hat{D}) = 10.020730 \text{ kg}^{2}\text{Pu}$ $V_{s}(\hat{D}) = 13.957723 \text{ kg}^{2}\text{Pu}$

The quantities $V_{s1}(\hat{D}_k)$ are then computed using (eq. 4.4.17) for those strata for which the numbers of items to be measured by the inspector exceed the numbers of batches. These strata likely include strata 1, 3, 6, 7, 9, and 10

 $V_{s1}(\hat{D}_1) = (1536)^2[(0.0001)^2/96+(0.0040)^2/192] = 0.196854$

$$V_{s_1}(\hat{D}_3) = (9.0)^2[(0.035)^2/10+(0.0060)^2/10] = 0.010214$$

$$V_{s1}(\hat{D}_6) = (3.6)^2[(0.035)^2/4+(0.0060)^2/4] = 0.004086$$

$$V_{S1}(\hat{D}_7) = (4.5)^2 [(0.020)^2/6 + (0.0050)^2/6] = 0.001434$$
$$V_{S1}(\hat{D}_7) = (4.5)^2 [(0.035)^2/5 + (0.0060)^2/5] = 0.005107$$

$$v_{s1}(v_9) = (4.3)^{-1} [(0.033)^{-1} 3^{-1} (0.0000)^{-1} 3^{-1}] = 0.003107$$

$$V_{s_1}(D_{10}) = (2.25)^2[(0.020)^2/3 + (0.0050)^2/3] = 0.000717$$

From (eq. 4.4.18),

$$\sigma_s^2 = 10.020730+13.957723+\dots+0.000717 = 24.196865$$

Next, $V_{r_1}(\hat{D}_2)$, $V_{r_1}(\hat{D}_4)$, $V_{r_1}(\hat{D}_5)$, and $V_{r_1}(\hat{D}_8)$ are calculated using (eq. 4.4.19).

$$V_{r_1}(\hat{D}_2) = (1485)^2 [(0.0080)^2 / 5 + (0.0050)^2 / 5] = 39.253005$$

$$V_{r_1}(D_4) = (0.4)^2 (0.20)^2 = 0.006400$$

$$V_{\gamma_1}(\hat{D}_5) = (112.5)^2[(0.0040)^2/3+(0.0060)^2/3] = 0.219375$$

$$V_{r_1}(\hat{D}_8) = (135)^2[(0.0040)^2/3+(0.0060)^2/3] = 0.315900$$

For each stratum, $V_{r2}(\hat{D}_k)$ and $V_{r3}(\hat{D}_k)$ are found using (eq. 4.4.20) and (eq. 4.4.21), and assuming that $x_{kqpt} = y_{kqpt}$ for all k.

$$V_{r2}(\hat{D}_1) = (1536)^2 (0.00025)^2 = 0.147456$$

$$V_{r_2}(\hat{D}_2) = (1485)^2 (0.00050)^2 = 0.551306$$

$$V_{r_2}(\hat{D}_3) = (9.0)^2 (0.00040)^2 = 0.000013$$

$$V_{r_2}(\hat{D}_4) = (0.4)^2 (0) = 0$$

$$V_{r2}(\hat{D}_5) = (112.5)^2 (0.00040)^2 = 0.002025$$

$$V_{r2}(\hat{D}_6) = (3.6)^2 (0.00040)^2 = 0.000002$$

$$V_{r2}(\hat{D}_7) = (4.5)^2 (0.00040)^2 = 0.000003$$

$$V_{r2}(\hat{D}_8) = (135)^2 (0.00040)^2 = 0.002916$$

$$V_{r_2}(\hat{D}_9) = (4.5)^2 (0.00040)^2 = 0.000003$$

$$V_{r2}(\hat{D}_{10}) = (2.25)^2 (0.00040)^2 = 0.000001$$

$$V_{r3}(\hat{D}_1) = (1536)^2 [(0.00050)^2 + (0.0001)^2 + (0.0050)^2/2] = 30.104617$$
$$V_{r3}(\hat{D}_2) = (1485)^2 [(0.00075)^2 + (0.0080)^2 + (0.0070)^2/2] = 196.402852$$

$$V_{r3}(\hat{D}_3) = (9.0)^2 [(0.00075)^2 + (0.035)^2 + (0.010)^2/2] = 0.103321$$

$$V_{r3}(\hat{D}_{4}) = (0.4)^{2}(.40)^{2} = 0.025600$$

$$V_{r_3}(\hat{D}_6) = (3.6)^2 [(0.00050)^2 + (0.035)^2 + (0.010)^2/2] = 0.0388477$$

$$V_{r_3}(\hat{D}_6) = (3.6)^2 [(0.00050)^2 + (0.035)^2 + (0.010)^2/2] = 0.016527$$

$$V_{r3}(\hat{D}_7) = (4.5)^2 [(0.00050)^2 + (0.020)^2 + (0.0070)^2/2] = 0.008601$$

$$V_{r3}(\hat{D}_8) = (135)^2[(0.00075)^2 + (.0040)^2 + (0.010)^2/2] = 1.213102$$

$$V_{r3}(\hat{D}_9) = (4.5)^2 [(0.00075)^2 + (0.035)^2 + (0.010)^2/2] = 0.025830$$

$$V_{\gamma 3}(\hat{D}_{10}) = (2.25)^2 [(0.00075)^2 + (0.020)^2 + (0.0070)^2/2] = 0.002152$$

The quantity s_k^2 is now computed for each stratum using (eq. 4.4.22).

$$s_{1}^{2} = 0.147456 + 30.104617 = 30.252073; s_{1} = 5.500$$

$$s_{2}^{2} = 39.253005 + 0.551306 + 196.402852 = 236.207163; s_{2} = 15.369$$

$$s_{3}^{2} = 0.000013 + 0.103321 = 0.103334; s_{3} = 0.321$$

$$s_{4}^{2} = 0.006400 + 0.025600 = 0.032000; s_{4} = 0.179$$

$$s_{5}^{2} = 0.219375 + 0.002025 + 0.838477 = 1.059877; s_{5} = 1.030$$

$$s_{6}^{2} = 0.000002 + 0.016527 = 0.016529; s_{6} = 0.129$$

$$s_{7}^{2} = 0.000003 + 0.008601 = 0.008604; s_{7} = 0.093$$

$s_8^2 = 0.315900 + 0.002916 + 1.213102$	= 1.531918; s ₈ = 1.238
$s_9^2 = 0.000003 + 0.025830$	= 0.025833; s ₉ = 0.161
$s_{10}^2 = 0.000001 + 0.002152$	= 0.002153; s ₁₀ = 0.046

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$${}^{10}_{\Sigma} {}_{s_k} = 24.066$$

For the Case 1 criteria, Note 3 of the method may be followed to provide the graphical solution for θ , noting that

 $M/\sigma_{\rm s} = 8/4.919 = 1.626$

From Annex 4.1 (a), it is evident that it is impossible in this example to meet the β = 0.05 criterion. Even with very large sample sizes, the β value for M/σ_s = 1.626 is about 0.50. Somewhat arbitrarily set $1/\theta$ = 10 which yields a β value slightly smaller than 0.50. For $1/\theta$ = 10, the total sample size is given by (eq. 4.4.32).

$$n_{v^2} = (24.066)^2(10)/(24.196865) = 240$$

In each stratum, the sample size is given by (eq. 4.4.33).

$n_{v^{21}} =$	(240)(5.500)/24.066	=	55
n _{v22} =	(240)(15.369)/24.066	=	153
n _{v23}		=	3
n _{v24}		=	2
n _{v25}		=	10
n _{v26}		=	1
n _{v27}		=	1
n _{v28}		=	12
n _{v29}		=	2
n _{v2,10}		=	1
	Total	=	240

(Note that there are 5 strata with less than 3 samples. Refer back to the comments following Example 4.2 (b) relative to minimum numbers of samples per stratum.)

This completes the calculations for Case 1. For Case 2, it is first necessary to assign values to V(MUF) and V_0. From Examples 3.5 (b) and 3.10 (b) respectively,

 $V(MUF) = 10.729310 \text{ kg}^2\text{Pu}$ $V_0 = 2.230517 \text{ kg}^2\text{Pu}$

Then, from (eq. 4.4.23),

 $k_2 = [10.729310 - 2(2.230517)]/24.196865$

= 0.2591

and, from (eq. 4.4.25),

a = 0.7409

The quantity θ is then calculated from (eq. 4.4.26) and following, where

m = 1.626 t_{α} = 1.960 c_0^2 = 4 t_{β} = 0.842

 $A = [(5)(0.7409)(1.960)^{2}(0.842)^{2} + (1.626)^{2}(1.960)^{2} + (4)(1.626)^{2}(0.842)^{2} - (0.7409)(1.960)^{4} - (4)(0.7409)(0.842)^{4}] = 15.320064$

 $B = (2)(1.626)(1.960)(0.842) \sqrt{(0.7409)(3)[(4)(0.842)^2 - (1.960)^2] + 4(1.626)^2} = 15.498965$

Since B<A for this value of β , a larger value of β must be inputted to provide a positive value for θ . Trial and error calculations show that β must exceed 0.50. At β = 0.55 (or 1- β = 0.45), t_{β} = -0.126. The revised values for A and B are

A = -0.384323 B = -1.185220 Also, C = $[(1.960)^2 - 4(-0.126)^2]^2$ = 14.274009

and

 θ = (-0.384323+1.185220)/14.274009 = 0.0561 At this value for θ , the required sample size is

 $n_{V2} = (24.066)^2 / (0.0561) (24.196865) = 427$

4.5 EVALUATION OF INSPECTION PLAN--INDIVIDUAL TESTS

In this section and in Section 4.6 to follow, methods are given for evaluating the inspection plan along with the accountability measures taken by the facility. Evaluation is measured by the probability that the statistical test in question will return a significant result as a function of the amount of material unaccounted for by the mechanism to which the test is designed to be responsive.

In applying the statistical tests in question, a distinction is made between principal and supplemental tests, as discussed in the next section.

4.5.1 Distinction Between Principal and Supplemental Tests

As will be discussed in Section 4.6, of chief concern or interest to the inspection planner is the overall probability of detection of a specified goal amount. Detection occurs if at least one of the statistical tests in question returns a positive response. The statistical tests that are applied collectively in calculating this overall probability of detection are called <u>principal</u> tests. One important characteristic of the principal tests is that, taken as a group, there is control over the value for α , the significance level (false alarm probatility) associated with the collection of statistical tests to be applied.

There are two combinations of tests that are identified as principal tests. These are as follows.

Combination 1:

- 1) The tests for gross defects performed with the attributes tester. There are K such tests.
- 2) The tests for medium defects performed with the variables tester used in the attributes made. There are K such tests.
- 3) The test for the significance of (MUF- \hat{D}), the facility MUF adjusted for the bias (small defects) that is estimated by the \hat{D} statistic.

Combination 2:

- 1) Same as above.
- 2) Same as above.
- 3) The test for the significance of \hat{D} , the measure of facility bias as it affects the MUF.
- 4) The test for the significance of the facility MUF.

These principal tests are discussed separately in Sections 4.5.2, 4.5.4, 4.5.5, and 4.5.6. The tests that comprise Combination 1 are then considered collectively in Section 4.6.1 while those that comprise Combination 2 are treated in Section 4.6.2.

In addition to these principal tests, the data analyst (inspector) would want to perform other statistical tests when analyzing the data for a given facility over a given material balance period (see Section 4.1.1). These other tests are referred to as <u>supplemental</u> tests to distinguish them from the principal tests. Examples of supplemental tests that may be applied include:

- 1) Tests for the significance of \hat{D}_k , the measure of facility bias in stratum k.
- 2) Tests for the significance of shipper-receiver differences.
- 3) Miscellaneous tests on distributional properties, such as outlier tests and tests for normality.
- 4) Tests for randomness of small calculational mistakes.
- 5) Tests for randomness of data over time and other data groupings, including CUSUM plots and analyses of variance.

This listing is not intended to be all inclusive, but rather to portray the kinds of supplemental tests that the data analyst may apply. The statistical tests are described in Chapter 5. In this chapter, Chapter 4, the emphasis is not on the test itself, but rather on its ability to detect a specified missing amount of material. Not all of the supplemental tests identified above may be evaluated in this fashion because for some tests, it is difficult to specify an alternative hypothesis that relates directly and in a meaningful way to a missing amount of material. Tests 1 and 2, the tests on \hat{D}_k and on the shipper-receiver difference can be so evaluated, and are discussed in Section 4.5.3.

As the above listing suggests, and as will become more evident in Chapter 5, a large number of statistical tests might be performed in the course of evaluating inspection and material balance data for a given facility. With so many tests, it would be expected that a few would give positive signals due to chance alone, and one should not become unduly concerned when this occurs. The important emphasis should be placed on the principal tests, using either Combination of tests 1 or 2 identified above. For these principal tests, the false alarm rate, α , can be controlled as mentioned earlier. The functions of the supplemental tests are essentially twofold: to provide some degree of assurance that the assumptions underlying the application of the primary tests are valid; and to isolate causes of significant results returned by the primary tests.

4.5.2 Attributes Inspection Tests

Two attributes inspection tests are performed in each stratum, one using the attributes tester to check for gross defects, and one using the variables tester in the attributes mode to check for medium defects. For the K strata, there are a total of 2K attributes tests. There is no problem in performing each test since the existence of one or more defects in any stratum corresponds to detection, i.e., to rejection of the null hypothesis that no defects (gross on medium in size as the case may be) exist. Further, there is no concern with controlling the false alarm rate either since α is zero for each attributes test (clearly, if there are no defects in the population there is zero probability that any will be found in the sample.)

Consider the power of the attributes test taken as a whole, i.e., consider the probability that one or more of the tests will lead to rejection of the hypothesis through observing one or more defects. This is called the probability of detection. In calculating the probability of detection, it is simpler to find its complement, the probability of nondetection. Nondetection implies that no defects are found in any of the strata. To calculate the nondetection probability, define

 h_k = amount of element falsified as gross defects in stratum k

 g_{k} = amount of element falsified as medium defects in stratum k

Summed over all strata, the total amount falsified (i.e., diverted and obscured through data falsification) is

$$\sum_{k=1}^{K} (h_k + g_k) = a_2 M$$
 (eq. 4.5.1)

where

The sample sizes for attributes inspection using the attributes tester and the variables tester in the attributes mode, n_{ak} and n_{v1k} respectively, are given by (eq. 4.4.1) and (eq. 4.4.16). Let p_{ak} be the probability of not finding a defect in stratum k with the attributes tester, and let p_{vk} be similarly defined for the variables tester. Then, letting $\beta_k = \beta$ for all strata and for both testers, from (eq. 4.4.5),

$$p_{ak} = \beta^{h} k^{/M}$$

$$p_{vk} = \beta^{gk/M}$$

$$(eq. 4.5.2)$$

Since the tests are independent, over all strata, the probability of non-detection, denoted by \mathbb{Q}_2 is

$$Q_2 = \prod_k p_{ak} p_{vk}$$
 (eq. 4.5.3)
= β^{a_2}

where the last step is a consequence of (eq. 4.5.1).

 $0 \leq a_2 \leq 1$

This result indicates that no matter how the a_2M units of element are distributed among the strata and between gross and medium defects, the overall probability of nondetection is β^{a_2} , where the sample size in each stratum and for each tester is based on the same value for β .

It is important to note that if β is not the same for all strata-tester combinations, then the <u>largest</u> value for β must be used in (eq. 4.5.3). This is so because the optimum strategy of the diverter is to falsify the data in the strata with the largest β values. To illustrate the importance of this point, suppose that $a_2 = 0.6$ (60% of the goal amount M is diverted and obscured through

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gross and/or medium defects) and that $\beta = 0.05$ for all strata-tester combinations. Then, by (eq. 4.5.3), the non-detection probability is

 $Q_2 = (0.05)^{0.6} = 0.1657$, (detection probability = 0.8343).

Suppose, however, that constraints on the inspection require that $\beta = 0.50$, say, for the attributes tester in a given stratum. Then, assuming that the stratum in question is sufficiently large to permit diversion of the entire amount, a_2^M , from this stratum, the nondetection probability is

 $Q_2 = (0.50)^{0.6} = 0.6598$, (detection probability = 0.3402).

This small detection probability occurs in spite of the fact that $\beta = 0.05$ for all other strata-tester combinations. The example illustrates the need to cover all strata with comparable intensity of inspection (i.e., to achieve the same value for β).

4.5.3 Tests on \hat{D}_k and Shipper/Receiver Difference Tests

From a mathematical viewpoint, there is no distinction between a test on \hat{D}_k (defined by (eq. 3.5.1)), and a shipper/receiver difference test. In both cases, measurements for one party are compared with measurements for the second party. Thus, it is permissible to discuss the \hat{D}_k test and have this discussion apply to the shipper/receiver test as well.

Before giving the method for finding the probability that the \hat{D}_k test will detect a given amount of material diverted from stratum k through small data falsifications, two points must be made. First, in Section 4.4.2.2, the concept of the variance inflation factor, C_0^2 , was introduced. That is, the random error variance of \hat{D} under the alternative hypothesis was assumed to be C_0^2 times the corresponding variance under the null hypothesis. A similar inflation factor would apply to \hat{D}_k , the \hat{D} statistic for an individual stratum. For planning purposes, it is reasonable to assign a conservatively large value to C_0^2 in order to assure that the corresponding sample size is conservative on the high side. From an evaluation viewpoint, however, it is more reasonable that the inflation factor be a function of the amount diverted. An assumed empirical relationship between the variance inflation factor and the amount diverted under the alternative model is used in the method to follow.

As a second point, the facility value minus the inspector value is the basis for the \hat{D}_k statistic. If the stratum in question is either an input or a beginning inventory stratum, then it is to the diverter's advantage to introduce falsifications that will result in a <u>negative</u> value for \hat{D}_k , i.e., the mean of \hat{D}_k under the alternative would be a negative value. On the other hand, if the stratum in question is either an output or an ending inventory stratum, then a <u>positive</u> value of \hat{D}_k would benefit the diverter. To avoid repetition, and to provide consistency with the development in Section 4.5.4 to follow, assume that the stratum in question is an output stratum so that the mean of \hat{D}_k under the alternative is positive. (It would be a simple matter to apply Method 4.4 to an input or a beginning inventory stratum; simply change the sign of \hat{D}_k , or, equivalently, redefine \hat{D}_k to be based on inspector minus facility values for such a stratum).

Method 4.4 is now given. This provides the equations needed to calculate the probability of nondetection and its complement, the probability of detection, for a specified alternative.

Method 4.4

Notation

The notation is consistent with that given in Methods 4.3, and 3.8-3.10. In addition,

- C_1^2 = variance inflation factor under the alternative hypothesis of diversion through small data falsifications
- $a_1M = total$ amount of element thus diverted
- Q₁ = probability of nondetection of the amount a₁M diverted through small data falsifications in stratum k

Model

The random variable, \hat{D}_k , is assumed to be normally distributed with variance $V(\hat{D}_k)|H_0$ under the null hypothesis of no diversion (i.e., when $E(\hat{D}_k) = 0$) and with variance $V(\hat{D}_k)|H_1$ under the alternative hypothesis, i.e., when $E(\hat{D}_k) = a_1M$.

Results

The quantities $V_r(\hat{D}_k)$, $V_g(\hat{D}_k)$, and $V_s(\hat{D}_k)$ are calculated using Methods 3.8, 3.9, and 3.10 respectively. In applying Methods 3.9 and 3.10, which relate to \hat{D} rather than \hat{D}_k , include only the single stratum in question. Then

$$V(\hat{D}_{k})|H_{0} = V_{r}(\hat{D}_{k}) + V_{g}(\hat{D}_{k}) + V_{s}(\hat{D}_{k})$$
 (eq. 4.5.4)

$$V(\hat{D}_{k})|H_{1} = C_{1}^{2}V_{r}(\hat{D}_{k}) + V_{g}(\hat{D}_{k}) + V_{s}(\hat{D}_{k})$$
(eq. 4.5.5)

where

and

$$C_1^2 = \min \left[4, 1 + a_1 M / \sqrt{V_g(\hat{D}_k) + V_s(\hat{D}_k)} \right]$$
 (eq. 4.5.6)

Next, compute

$$t_{1} = \frac{t_{\alpha} \sqrt{V(\hat{D}_{k}) | H_{0} - a_{1}M}}{\sqrt{V(\hat{D}_{k}) | H_{1}}}$$
 (eq. 4.5.7)

 Q_1 is then the area under the standardized nominal curve from --- to t_1 , i.e., Q_1 is defined by

$$Q_1 = \frac{1}{\sqrt{2\pi}} \int_{-\infty}^{t_1} e^{-z^2/2} dz \qquad (eq. 4.5.8)$$

Basis

The formula for the variance inflation factor, C_1^2 , in (eq. 4.5.6) is an assumed relationship. It is felt that a more exact relationship could be derived under certain reasonable assumptions with regards to diversion strategies, but the (eq. 4.5.6) model is regarded as being an adequate one and a preferred one because of its simplicity (see Section 6.3 in this regard).

The null hypothesis, $H_0:E(\hat{D}_k) = 0$, is rejected if \hat{D}_k is too large, i.e., if it exceeds some critical value D_{k0} , where D_{k0} is chosen such that it is exceeded with probability α when H_0 is true. Thus, D_{k0} is defined by

Prob $(\hat{D}_k > D_{k0}) | H_0 = \alpha$, which reduces to

$$D_{k^0} = t_{\alpha} \sqrt{V(\hat{D}_k) | H_0}$$

Under the alternative, find the probability of nondetection:

$$Q_{1} = \operatorname{Prob} \left[\hat{D}_{k} < t_{\alpha} \sqrt{V(\hat{D}_{k}) | H_{0}} \right] | H_{1} =$$

$$\operatorname{Prob} \left(Z < \frac{t_{\alpha} \sqrt{V(\hat{D}_{k}) | H_{0}} - a_{1}M}{\sqrt{V(\hat{D}_{k}) | H_{1}}} \right) \qquad (eq. \ 4.5.9)$$

where z is normally distributed with zero mean and unit standard deviation. This is the basis for (eq. 4.5.7).

Examples

EXAMPLE 4.4 (a)

Consider the input UO₂ powder stratum for the facility of example 3.8 (a) and find the probability of detecting 400 kg uranium if diverted in this stratum through small falsifications. Set $\alpha = 0.01$.

From example 3.8 (a), $V_r(\hat{D}_1) = 1143 + 1594 = 2737 \text{ kg}^2 \text{U}$ From example 3.9 (a), $V_g(\hat{D}_1) = (0.000544)^2(2)(120,000)^2$ $= 8,523 \text{ kg}^2 \text{U}$

From example 3.10 (a), and with reference to the earlier example 3.5 (a),

 $- 219 - V_{s}(\hat{D}_{1}) = 11100.73 + 18779.96 + (240,000)^{2}(0.000439)^{2} + (240,000)^{2}(0.000172)^{2} = 42,685 \text{ kg}^{2}\text{U}$ By (eq. 4.5.4), $V(\hat{D}_{1})|H_{0} = 53,945 \text{ kg}^{2}\text{U}$ By (eq. 4.5.6), $C_{1}^{2} = \min (4, 1 + 400/\sqrt{51208}) = 3.7676$, so that, from (eq. 4.5.5), $V(\hat{D}_{1})|H_{1} = 61,520 \text{ kg}^{2}\text{U}$ By (eq. 4.5.7), $t_{1} = \frac{2.326\sqrt{53,945} - 400}{\sqrt{61,520}} = 0.5654$

The nondetection probability, ${\rm Q}_1$, is the area under the standardized normal curve from $-\infty$ to 0.5654, or

 $Q_1 = 0.7141$

so the probability of detection is $1-Q_1 = 0.2859$.

4.5.4 Test on D

The test on \hat{D} is very similar to that on \hat{D}_k . As with \hat{D}_k , it is assumed that the variance inflation factor, C_1^2 , is a function of the amount diverted through small data falsifications, i.e., of $E(\hat{D})$ under the alternative. As explained in Section 4.4.2.2, in order to work with positive values of the test statistic under the alternative, it is convenient to replace \hat{D} as defined in (eq. 3.5.2) by its negative counterpart, \hat{D}^2 . In what follows, then, \hat{D}^2 of (eq. 4.4.44) is the test statistic.

Method 4.5 is now given. This provides the equations needed to calculate the probability of nondetection and its complement, the probability of detection, for a specified alternative.

Method 4.5

Notation

The notation is consistent with that given in Method 4.3. The variance inflation factor, C_1^2 , has the same interpretation as in Method 4.4. In addition, a_3 = fractional amount diverted through small data falsification

- $a_{3}M$ = total amount of element thus diverted
- Q_3 = probability of nondetection of the amount a_3M diverted through small data falsifications

Model

The discussion for Method 4.4 applies, with \hat{D}_k replaced by \hat{D}' and a_1 replaced by a_3 . For the \hat{D}' statistic, the emphasis is on the variance of \hat{D}' as determined in the planning stage, i.e., by following Method 4.3 to determine θ and hence, the sample size. If the evaluation is rather to be performed with actual sample sizes used in implementation, and assuming that these may differ appreciably from those developed in the planning stages, then Method 4.4 may be applied with slight modification: replace \hat{D}_k by \hat{D} , a_1 by a_3 , t_1 by t_3 , and Q_1 by Q_3 .

Results

Following Method 4.3, calculate $\sigma_{\rm S}^2$ from (eq. 4.4.18) and θ from (eq. 4.4.26), (eq. 4.4.30), or (eq. 4.4.31). Then, compute

$$t_{3} = \frac{t_{\alpha} \sqrt{1 + \theta} - a_{3}m}{\sqrt{1 + C_{1}^{2}\theta}}$$
 (eq. 4.5.10)
m = M/\sigma_{s}, and where

where

$$C_1^2 = \min(4, 1 + a_3m)$$
 (eq. 4.5.11)

 Q_3 is then the area under the standardized normal curve from ---- to $t_3,$ i.e., Q_3 is defined by

$$Q_3 = \frac{1}{\sqrt{2\pi}} \int_{-\infty}^{t_3} e^{-z^2/2} dz$$
 (eq. 4.5.12)

Basis

The basis for Method 4.5 is developed in the Method 4.3 basis. The key equation, (eq. 4.5.10), follows directly from (eq. 4.4.49) with t_{β} replaced by t₃ and C₀² replaced by C₁².

Examples

EXAMPLE 4.5 (a)

Consider the low enriched uranium fuel fabrication facility of example 4.3 (a). Find the probability that the difference statistic, \hat{D} , will detect 400 kg U diverted, with the diversion obscured by small data falsifications. Use $\alpha = 0.05$.

From the cited example,

$$\sigma_{\rm S} = \sqrt{87,675} = 296 \text{ kg U}$$

 $\theta = (1.75)^{-1} = 0.571$
 $a_{3}m = 400/296 = 1.351$

Then, from (eq. 4.5.10), since $C_1^2 = 2.351$ from (eq. 4.5.11),

$$t_3 = \frac{1.645 \sqrt{1.571} - 1.351}{\sqrt{2.342}} = 0.464$$

and

 $Q_3 = 0.679$, nondetection probability 1- $Q_3 = 0.321$, probability of detection

EXAMPLE 4.5 (b)

Consider the mixed oxide fuel fabrication facility of example 4.3 (b). Using the Case 2 criteria in that example, find the probability that the \hat{D} statistic will detect 5 kg Pu diverted, with the diversion obscured by small data falsifications. From the cited example,

 σ_s = 4.919 kg Pu ; θ = 0.0561 ; a_3m = 5/4.919 = 1.016 From (eq. 4.5.11), C_1^2 = 2.106, so, applying (eq. 4.5.10),

> $t_3 = \frac{1.960 \sqrt{1.0561} - 1.016}{\sqrt{1.1131}} = 0.946$ Q₃ = 0.828 , nondetection probability 1-Q₃ = 0.172 , probability of detection

EXAMPLE 4.5 (c)

For the same mixed oxide fuel fabrication facility in the previous example, suppose the inspection plan is as indicated in example 3.8 (b), and rework the example 4.5 (b).

In applying Method 4.5 to solve this problem, the development of Method 4.4 is followed, with \hat{D}_k replaced by \hat{D} , a_1 by a_3 , t_1 by t_3 , and Q_1 by Q_3 . From example 3.8 (b),

 $V_{r}(\hat{D}) = 3.325266 \text{ kg}^{2}\text{Pu}$ From example 3.9 (b), $V_{g}(\hat{D}) = 10.020730 \text{ kg}^{2}\text{Pu}$ From example 3.10 (b), $V_{s}(\hat{D}) = 13.957723 \text{ kg}^{2}\text{Pu}$ By (eq. 4.5.4), appropriately modified, $V(\hat{D}^{-})|H_{0} = 27.303719 \text{ kg}^{2}\text{Pu}$

By (eq. 4.5.6), appropriately modified,

$$C_{1}^{2} = \min(4, 1 + 5) \sqrt{23.978453}$$

= 2.021

so that, from the modified (eq. 4.5.5),

$$V(\hat{D}^{-})|H_1 = 30.698816$$

Then,

$$t_{3} = \frac{1.960 \sqrt{27.303719} - 5}{\sqrt{30.698816}} = 0.946$$

$$Q_{3} = 0.828$$

$$1-Q_{3} = 0.172$$

Note that the answers are precisely the same (to three decimals) as in the previous example. In the previous example, the total sample size was 427; in example 3.3 (b), the number of samples was 287 and the number of weighings was 653. The fact that the detection probabilities agree to within 3 decimals is a bit fortuitous, but close agreement would be expected because of the dominance of systematic errors in this example.

4.5.5 Test on MUF

Although the inspector has no direct control over the size of the variance of MUF, this quantity has an impact on the ability to detect diversion, especially as it affects the variance of (MUF-D) as considered in the next section. The test on MUF is considered in Method 4.6.

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Method 4.6

Notation

The notation is given in section 3.4.3.2. In addition,

 a_4 = fractional amount of element diverted into MUF

 $a_{\mu}M$ = total amount of element thus diverted

 Q_4 = probability of nondetection of the amount a_4M diverted into MUF

Mode1

The quantity MUF is assumed to be a random variable which is normally distributed with variance V(MUF). Under the null hypothesis, the mean of MUF is zero, while it is a_4M under the alternative.

Results

Compute
$$t_4 = t_{\alpha} - a_4 M / \sqrt{V(MUF)}$$
 (eq. 4.5.13)

 \mathbb{Q}_4 is the area under the standardized normal curve from ---- to t_4, i.e., \mathbb{Q}_4 is defined by

$$Q_{4} = \frac{1}{\sqrt{2\pi}} \int_{-\infty}^{t_{4}} e^{-z^{2}/2} dz$$
 (eq. 4.5.14)

Basis

The null hypothesis that E(MUF) = 0 is rejected if MUF exceeds some critical value M_0 , where M_0 is chosen such that it is exceeded with probability α when H_0 is true. Thus, M_0 is defined by

Prob $(MUF > M_0) | (E(MUF) = 0) = \alpha$, which reduces to

$$M_0 = t_{\alpha} \sqrt{V(MUF)}$$

Under the alternative, $E(MUF) = a_4M$. Find the probability of nondetection:

$$Q_4 = Prob (MUF < t_{\alpha} \sqrt{V(MUF)} | (E(MUF) = a_4M)$$

= Prob (
$$z < t_{\alpha} - a_{4}M/\sqrt{V(MUF)}$$
) (eq. 4.5.15)

where z is normally distributed with zero mean and unit standard deviation. This is the basis for (eq. 4.5.15).

Examples

EXAMPLE 4.6 (a)

Consider the mixed oxide fuel fabrication facility of examples 3.3 (b), 3.4 (a), and 3.5 (b), find the probability that the MUF test would detect a diverted amount of 3 kg Pu if α = 0.05.

From example 3.5 (b), $V(MUF) = 10.729310 \text{ kg}^2\text{Pu}$ Therefore, by (eq. 4.5.13), $t_4 = 1.645 - 3/\sqrt{10.729310}$ = 0.729 $Q_4 = 0.767$, nondetection probability $1-Q_4 = 0.233$, probability of detection

4.5.6 Test on $(MUF-\hat{D})$

Consider the (MUF- \hat{D}) statistic introduced in Section 3.6 and discussed further in Sections 4.3.2.3 and 4.4.2.2. The detection probability employing (MUF- \hat{D}) as the test statistic is covered by Method 4.7. This statistic is responsive to the combination of diversions employing two strategies: diversion into MUF and diversion obscured by small data falsifications.

Method 4.7

Notation

The notation is given in Method 3.13. In addition,

 Q_5 = probability of nondetection of the amount $(a_3+a_4)M$ diverted into MUF and small data falsifications $(a_3 \text{ and } a_4 \text{ are defined} in Methods 4.5 and 4.6 respectively)$

Mode1

The random variable, (MUF- \hat{D}), is assumed to be normally distributed with mean zero and variance V(MUF- \hat{D})|H₀ under the null hypothesis, and with mean (a_3+a_4)M and variance V(MUF- \hat{D})|H₁ under the alternative.

Two approaches to finding the detection probability for the (MUF-D) statistic are used. First, it is assumed that the inspection sample sizes are those developed in the planning stage, i.e., following Method 4.3. In the second approach, actual sample sizes used in the inspection are utilized, the assumption being that they may differ appreciably from the planned sample sizes.

Results

First approach--

Following Method 4.3, a number of quantities must be calculated. These include:

 σ_s^2 using (eq. 4.4.18) V(MUF) and V₀ using Methods 3.3, 3.4, and 3.5 k₂ using (eq. 4.4.23) a = 1-k₂ θ using (eq. 4.4.26), (eq. 4.4.30), or (eq. 4.4.31)

Then, compute

 $m = M/\sigma_s$

$$t_{5} = \frac{t_{\alpha} \sqrt{a+\theta} - (a_{3} + a_{4})m}{\sqrt{a+C_{1}^{2}\theta}}$$
 (eq. 4.5.16)

where

and where $C_1^2 = \min(4, 1+a_3m)$, as given by (eq. 4.5.11).

 ${\tt Q}_5$ is the area under the standardized normal curve from – $_\infty to$ $t_5,$ i.e., ${\tt Q}_5$ is defined by

$$Q_5 = \frac{1}{\sqrt{2\pi}} \int_{-\infty}^{t_5} e^{-z^2/2} dz$$
 (eq. 4.5.17)

Second approach--

Compute the quantities V_n(\hat{D}), V_g(\hat{D}), and V_s(\hat{D}) using Methods 3.8, 3.9, and 3.10 respectively. Compute V(\hat{D})|H₀ and V(\hat{D})|H₁ using (eq. 4.5.4) and (eq. 4.5.5) with \hat{D}_k replaced by \hat{D} , and with C_1^2 defined by (eq. 4.5.6), again with \hat{D}_k replaced by \hat{D} . The quantities V(MUF- \hat{D})|H₀ and V(MUF- \hat{D})|H₁ are then calculated using (eq. 3.6.5), first with V(\hat{D})|H₀ in place of V(\hat{D}), and then using V(\hat{D})|H₁. The quantity t₅ is then computed from the formula:

$$t_{5} = \frac{t_{\alpha} \sqrt{V(MUF - \hat{D}) | H_{0}} - (a_{3} + a_{4})M}{\sqrt{V(MUF - \hat{D}) | H_{1}}}$$
(eq. 4.5.18)

<u>Basis</u>

The basis for the first approach is developed in the Method 4.3 basis. The key equation, (eq. 4.5.16), follows directly from (eq. 4.4.52) with t_{β} replaced by t_5 and C_0^2 replaced by C_1^2 .

For the second approach, refer to the Basis for Method 4.4, replacing \hat{D}_{K} by (MUF- \hat{D}) and a_1 by (a_3+a_4) .

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Examples

EXAMPLE 4.7 (a)

Consider the low enriched uranium fuel fabrication facility of example 4.3 (a), and treated again in example 4.5 (a). Find the probability that the (MUF-D) test will detect a diversion of 400 kg U obscured by small data falsifications and one of 500 kg U diverted into MUF. Use $\alpha = 0.05$.

The first approach is used since the test is to be evaluated based on planned sample sizes. From example 4.5 (a), values were given for σ_s^2 and θ . Also, from example 3.4 (a), which pertains to this same facility,

$$V(MUF) = 45,010 \text{ kg}^2 U$$

 $V_0 = 0$

Then, from (eq. 4.4.23),

and

 $k_2 = 45,010/87,675 = 0.513$

On applying (eq. 4.5.16),

 $t_5 = \frac{1.645 \sqrt{0.487 + 0.571} - 900/296}{\sqrt{0.487 + (2.351)(0.571)}} = -0.997$ Q₅ = 0.159 , nondetection probability 1-Q₅ = 0.841 , probability of detection

EXAMPLE 4.7 (b)

In the example just concluded, suppose again that 900 kg U total were diverted through the same two diversion strategies, but that the split were different, with 100 kg U obscured by small data falsifications and 800 kg U diverted into MUF. All the calculations in the preceding example remain unchanged except that the value for C_1^2 in the denominator of the expression for t_5 differs. In the preceding example, C_1^2 was 2.351 since a_3m was 1.351 for $a_3M = 400$ kg. If $a_3M = 100$ kg U, then a_3m is 100/296 = 0.338 and C_1^2 is 1.338. Thus,

$$t_5 = \frac{1.645 \sqrt{1.058} - 900/296}{\sqrt{0.487 + (1.338)(0.571)}} = -1.206$$

 $Q_5 = 0.114$, nondetection probability

 $1-Q_5 = 0.886$, probability of detection

Since the diverter would like to maximize Q_5 , or minimize $1-Q_5$, he would prefer the diversion strategy of example 4.7 (a) to that of 4.7 (b). This concept of best diversion strategies is fully treated in Section 4.6.

EXAMPLE 4.7 (c)

Consider the mixed oxide fuel fabrication facility of example 4.5 (c). Find the probability that the (MUF- \hat{D}) test will detect a total diversion of 6.5 kg Pu if 5 kg Pu is obscured by small data falsifications and 1.5 kg Pu is diverted into MUF. Use α = 0.025.

The second approach of Method 4.7 is used since the test is to be evaluated based on actual sample sizes, rather than on planned sample sizes.

From the cited example, values were given for $V(\hat{D})|H_0$ and $V(\hat{D})|H_1$.

 $V(\hat{D})|H_0 = 27.303719 \text{ kg}^2\text{Pu}$

 $V(\hat{D})|H_1 = 30.698816 \text{ kg}^2\text{Pu}$

This value for $V(\hat{D})|H_1$ is the appropriate one to use since, in the cited example, $a_3M = 5$ kg Pu as in this example. Were the amount of diversion through small data falsifications different from 5 kg Pu, then $V(\hat{D})|H_1$ would have to be recalculated since it is a function of C_1^2 , and hence, of a_3M .

To continue, values for V(MUF) and V_0 for this facility were given in example 3.13 (b).

 $V(MUF) = 10.729310 \text{ kg}^2\text{Pu}$ $V_0 = 2.230517 \text{ kg}^2\text{Pu}$

Thus,

 $V(MUF-\hat{D}) | H_0 = 27.303719 - 10.729310 + 2(2.230517)$ = 21.035443 kg²Pu $V(MUF-\hat{D}) | H_1 = 30.698816 - 10.729310 + 2(2.230517)$

 $= 24.430540 \text{ kg}^2\text{Pu}$

From (eq. 4.5.18),

$$t_5 = \frac{1.960 \sqrt{21.035443} - 6.5}{\sqrt{24.430540}} = 0.504$$

- 228 - $Q_5 = 0.693$, nondetection probability 1- $Q_5 = 0.307$, probability of detection

4.6 OVERALL PROBABILITY OF DETECTION OF GOAL AMOUNT

As was mentioned in Section 4.5.1, in evaluating his inspection plan, the inspector is primarily interested in determining how his plan, together with measurements performed by the facility, will react to diversion strategies used by the diverter. Although he may perform the evaluations presented in Sections 4.5.2 - 4.5.6 in this connection, either before the inspection or after the fact, this leaves unanswered the question as to how he can combine the resulting information to arrive at an overall assessment of the inspection plan. This section will address this question.

Two combinations of principal statistical tests are considered. First, in Section 4.6.1, test Combination 1 identified in Section 4.5.1 is considered. This includes the combination of attributes tests and of the test using (MUF- \hat{D}). In Section 4.6.2, test Combination 2 that employs the attributes tests, the test on \hat{D} , and the test on MUF, is discussed.

In evaluating the test combinations in each instance, the measure used is the overall probability of detecting the goal amount diverted. Detection means that a positive signal, or significant result, is returned with at least one of the tests. In application, it is simpler to calculate the probability of nondetection, the detection probability then being the complement of this quantity.

The detection probability is quite obviously a function of the diversion strategy, i.e., of how the goal amount is apportioned among the various diversion possibilities. Again responding to the assumption that the plan is to combat an intelligent adversary bent on diversion, the inspector is chiefly interested in calculating the probability of nondetection corresponding to the best adversary strategy. For test Combination 1, this probability. Clearly, the inspector will prefer to apply the combination of tests that yields the smallest value for the nondetection probability, i.e., the largest probability of detection. In making this decision, of course, he recognizes that should the adversary not employ his best strategy, the inspector may be better off using the other test combination; however, his probability of nondetection and the case of test Combination 1 or Q_{max} in the case of Combination 2.

4.6.1 Attributes and (MUF-D) Tests

In this section, the probability of nondetection is calculated for test Combination 1 as identified in Section 4.5.1. The discussions in Sections 4.5.2 and 4.5.6 form the basis for Method 4.8 to follow.

Method 4.8

Notation

See the notation in Section 4.5.2 and for Method 4.7 in Section 4.5.6. In addition,

Q = probability of nondetection for test Combination 1

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Q_{max} = maximum value for Q; that value of Q corresponding to the best strategy of the diverter

Mode1

See the discussion in Section 4.5.2 and the model discussion for Method 4.7.

Results

The joint probability of nondetection is

 $Q = \beta^{a_2} Q_5$ (eq. 4.6.1)

 Q_5 is a function of a_3 and a_4 . The quantities a_2 , a_3 , and a_4 sum to 1. Q_5 is given by (eq. 4.5.17) and (eq. 4.5.16) or (eq. 4.5.18) for given a_3 and a_4 .

Use a trial and error approach to find Q_{max} . Vary a_2 in increments from 0 to 1 (steps of 0.1 are adequate). At a given value of a_2 , calculate Q_5 , where (a_3+a_4) is equal to $(1-a_2)$.

In calculating C_1^2 , use the following rule to select the value for a_3 :

If t_5 is negative, choose $a_3 = 1-a_2$ (rule 4.6.1) If t_5 is positive, choose $a_3 = 0$

 Q_{max} is easily determined, either from the table of Q versus a_2 values, with a_2 rounded to the nearest tenth, or from a plot of the tabled data, which permits choosing a value of a_2 between tabled values.

Basis

Equation 4.6.1 follows from the fact that the tests on the attributes and the (MUF-D) test are independent. Rule 4.6.1 applies because that value of a_3 should be chosen to give the largest value to Q_5 . If t_5 is negative, Q_5 is maximized when t_5 is as close to zero as possible, i.e., when the denominator of t_5 is made as large as possible. This occurs when $a_3=1-a_2$. If t_5 is positive, Q_5 is maximized when t_5 is made as large as large as possible. This occurs when $a_3=0$.

Examples

EXAMPLE 4.8 (a)

In following up on the low enriched uranium fuel fabrication facility of example 4.7 (a), set M = 1500 kg U and find the value of Q_{max} . Assume that $\beta = 0.05$ for the attributes tests and that $\alpha = 0.05$ for the (MUF-D) test.

From example 4.7 (a),

$$t_{5} = \frac{1.6920 - 1500(a_{3}+a_{4})/296}{\sqrt{0.487+0.571C_{1}^{2}}}$$
$$= \frac{1.6920 - 5.0676(a_{3}+a_{4})}{\sqrt{0.487+0.571C_{1}^{2}}}$$

The table below gives the value for Q as a function of a_2 . The column headed "NUM" is the sign of the numerator in the expression for t_5 , which dictates the value for a_3 .

<u>a</u> 2	β ^{a2}	NUM	<u>a</u> 3	$\underline{C_1^2}$	t_5	Q ₅	Q
0	1.0000	NEG	1	4	-2.028	0.0213	0.0213
0.1	0.7411	NEG	0.9	4	-1.723	0.0424	0.0314
0.2	0.5493	NEG	0.8	4	-1.419	0.0779	0.0428
0.3	0.4071	NEG	0.7	4	-1.115	0.1324	0.0539
0.4	0.3017	NEG	0.6	4	-0.810	0.2090	0.0631
0.5	0.2236	NEG	0.5	3.53	-0.532	0.2974	0.0665
0.6	0.1657	NEG	0.4	3.03	-0.225	0.4110	0.0681
0.7	0.1228	POS	0	1	0.167	0.5663	0.0695
0.8	0.0910	POS	0	1	0.660	0.7454	0.0678
0.9	0.0675	POS	0	1	1.152	0.8753	0.0591
1.0	0.0500	POS	0	1	1.645	0.9500	0.0475

For a rounded to the nearest tenth, Q_{max} is 0.0695. Thus, the maximum probability of nondetection, 0.0695, occurs at $a_2 = 0.7$, $a_3 = 0$, $a_4 = 0.3$, or when 1050 kg U is diverted into large and medium data falsifications, and 450 kg U is diverted into MUF.

EXAMPLE 4.8 (b)

In following up on the mixed oxide fuel fabrication facility of example 4.7 (c), set M = 8 kg Pu and find the value of Q_{max} . Assume that β = 0.20 for the attributes tests and that α = 0.025 for the (MUF-D) test. (Note: This large value for β is reasonable because of the inability of the variables measurements to detect the goal amount of M = 8 kg Pu. The value for Q_{max} will be independent of the β value for the attributes testing up to fairly large values of β .)

For example 4.7 (c) and the earlier example 4.5 (c),

$$t_5 = \frac{1.960 \sqrt{21.035443} - 8(a_3 + a_4)}{\sqrt{23.978453} - 10.729310 + 2(2.230517) + 3.325266C_1^2}}$$
$$= \frac{8.9894 - 8(a_3 + a_4)}{\sqrt{17.7102} + 3.325266C_1^2}$$

The table below gives Q values as a function of a .

a 2	β ^{a2}	NUM	<u>a 3</u>	$\underline{C_1^2}$	<u>t 5</u>	Q5	Q
0	1.0000	POS	0	1	0.216	0.5855	0.5855
0.1	0.8513	POS	0	1	0.390	0.6517	0.5548
0.2	0.7248	POS	0	1	0.565	0.7140	0.5175
0.3	0.6170	POS	0	1	0.730	0.7673	0.4734
0.4	0.5253	POS	0	1	0.913	0.8194	0.4304
0.5	0.4472	POS	0	1	1.088	0.8617	0.3854
0.6	0.3807	POS	0	1	1.262	0.8965	0.3413
0.7	0.3241	POS	0	1	1.437	0.9246	0.2997
0.8	0.2759	POS	0	1	1.611	0.9464	0.2611
0.9	0.2349	POS	0	1	1.786	0.9630	0.2262
1.0	0.200	POS	0	1	1.960	0.9750	0.1950

 Q_{max} is 0.5855, occurring at $a_4 = 0$, i.e., when all 8 kg Pu is diverted into MUF($a_4=1$). Clearly, the adversary would be unwise were he to divert into large and medium data falsifications in this example since the inspector can control his β error in the attributes inspection. The ability of the inspector to detect the goal amount is limited by systematic errors of measurement that affect the \hat{D} and MUF statistics, and hence, the (MUF- \hat{D}) statistic.

Note that at $a_2 = 0.1$, Q would be larger than the value at $a_2 = 0$ if

$0.6517 \beta^{0.1} > 0.5855$

This inequality holds if $\beta > 0.343$, which means that the β value for attributes inspection could be increased to 0.343, with the attendent reduced inspection sample sizes, before the intelligent adversary would choose to divert even a portion of the goal amount into large and/or medium data falsifications. Stated from a different perspective, Q_{max} will be 0.5855 for all values of the attributes inspection, β , less than 0.343.

4.6.2 Attributes, \hat{D} , and MUF Tests

In this section, the probability of nondetection is calculated for the test Combination 2 as identified in Section 4.5.1. With reference to Sections 4.5.2, 4.5.4, and 4.5.5, the probability of nondetection for the attributes, \hat{D} , and MUF tests is not $\beta^{a2}Q_{3}Q_{4}$ as might be expected because \hat{D} and MUF are correlated. This correlation must be taken into account when performing the calculations. This is not simply an academic point; failure to take into account the correlation may lend to totally erroneous conclusions.

The procedures for calculating the probability of nondetection using test Combination 2 are now given by Method 4.9.

Method 4.9

See the notation in Section 4.5.2 and for Methods 4.5, 4.6, and 4.7. In addition,

$$Q^{-}$$
 = probability of nondetection for test Combination 2

$$\rho$$
 = correlation coefficient between D⁻ and MUF

Model

See the discussion in Section 4.5.2 and the model discussions for Methods 4.5 and 4.6. Further, it is assumed that D^2 and MUF are jointly distributed as the bivariate normal with correlation coefficient ρ .

Results

The probability of nondetection is

- -

$$Q^{\prime} = \beta^{d^2} L(t_3, t_4, \rho)$$
 (eq. 4.6.2)

where

$$\rho = \frac{-(k_2 + k_3)}{\sqrt{(1+C_1^2\theta)(k_2+2k_3)}}$$
(eq. 4.6.3)
$$k_3 = V_0/\sigma_s^2$$
(eq. 4.6.4)

where

and where k_2 is given by (eq. 4.4.23)

The expression for ρ given by (eq. 4.6.3) applies if the evaluation is being performed based on sample sizes developed during the planning stage. If implementation sample sizes are used, then the more general expression for ρ applies.

$$\rho = \frac{-V(MUF) + V_0}{\sqrt{[V(\hat{D})|H_1][V(MUF)]}}$$
(eq. 4.6.5)

To continue with (eq. 4.6.2), $L(t_3, t_4, \rho)$ is the probability that two random variables, distributed as a bivariate normal distribution, are jointly less than t_3 and t_4 respectively, where ρ is the correlation coefficient. This probability may be found by table look-up or by computer calculations. Both approaches are considered.

Before proceeding further, it is necessary to remark on the choices for t_{α} used in the equations for t_3 , (eq. 4.5.10) and for t_4 , (eq. 4.5.13). If one were to assume independence between MUF and \hat{D} , and if α were the overall significance level, then α_3 and α_4 would satisfy the relationship

$$1 - \alpha = (1 - \alpha_3)(1 - \alpha_4)$$
 (eq. 4.6.6)

Further, if $\alpha_3 = \alpha_4$, = α_0 , then α_0 is the solution of the equation

$$(1-\alpha_0)^2 = 1-\alpha$$
,

the solution being

$$\alpha_0 = 1 - \sqrt{1 - \alpha}$$
 (eq. 4.6.7)

Thus, for $\alpha = 0.05$, α_0 would be 0.0253 and $t_3 = t_4 = 1.955$.

However, the assumptions leading to the result (eq. 4.6.7) are not valid; MUF and \hat{D} are correlated because both statistics are calculated from operator data. Further, there is no real basis for equating α_3 to α_4 . The problem of selecting values for α_3 and α_4 in this situation was considered by Avenhaus and Beedgen [4.10]. In a minimax sense, optimal values for α_3 and α_4 were calculated for the special but common case in which $\alpha = 0.05$, and as a function of ρ . Minimax means that the inspector chooses values for α_3 and α_4 that minimize the probability of nondetection given that the diverter had first chosen the strategy that maximizes this probability. The results are given as Figure 1 in [4.10] and reproduced here as Annex 4.4. (In the Annex 4.4 plot, the notation of [4.10] is altered to correspond to the present notation.) Thus, one may use the Annex 4.4 figure to select the values for α_3 and α_4 . Graphical interpolation is adequate for purposes of evaluating inspection plans.

For values of α other than 0.05, the Annex 4.4 plot may also be used as a good approximation simply by a change of scale. Thus, for $\alpha = 0.025$, simply divide α_3 and α_4 in Annex 4.4 by 2; for $\alpha = 0.01$, divide by 5; etc. This is a good approximation because it is shown in [4.11] that the shapes of the curves in Annex 4.4 for $\alpha = 0.01$ and for $\alpha = 0.05$ are very nearly identical.

Approach 1: Table look-up

 Δ_3

Approach 1 is based on reference [4.12]. The probability $L(t_3, t_4, \rho)$ is given by

$$L(t_3, t_4, \rho) = 0.5 (Q_3 + Q_4) - T(t_3, \Delta_3) - T(t_4, \Delta_4) - H$$
 (eq. 4.6.8)

where

$$= \frac{t_4 - \rho t_3}{t_3 \sqrt{1 - \rho^2}}$$
 (eq. 4.6.9)

$$\Delta_{i_{4}} = \frac{t_{3} - \rho t_{4}}{t_{4} \sqrt{1 - \rho^{2}}}$$
 (eq. 4.6.10)

and

H = 0 if
$$t_3 t_4 > 0$$
 or if
 $t_3 t_4 = 0$ and $(t_3 + t_4) \ge 0$
= 0.5 otherwise
(eq. 4.6.11)

The function $T(t_j, \Delta_j)$ for j = 3,4 is tabled as Annex 4.2 (a)-(d) for coarse groupings on Δ_j and fine groupings on t_j , and as Annex 4.3 (a)-(d) for fine groupings on Δ_j and coarse groupings on t_j . In the tables, make the identification $h = t_j$ and $a = \Delta_j$. Ordinary linear interpolation should be satisfactory in most applications; if refined calculations are to be made, detailed interpolation procedures are given in [4.12]. The T-function is tabulated only for $0 \le \Delta_j \le 1$ and ∞ ; for values of Δ_j between 1 and ∞ , use the following equation

$$T(t_{j}, \Delta_{j}) = 0.5[Q(t_{j})+Q(t_{j}\Delta_{j})]-Q(t_{j})Q(t_{j}\Delta_{j})-T(t_{j}\Delta_{j}, 1/\Delta_{j})$$
(eq. 4.6.12)

where Q(t) is the area under the standardized normal curve from $-\infty$ to t. To account for negative values of t_i or Δ_i , use

$$T(t_{j}, -\Delta_{j}) = -T(t_{j}, \Delta_{j}), \text{ and}$$
 (eq. 4.6.13)

$$T(-t_j, \Delta_j) = T(t_j, \Delta_j)$$
 (eq. 4.6.14)

Approach 2: Computer Calculations

Evaluation of $L(t_3, t_4, \rho)$ by table look-up involves a fair amount of effort. It is far simpler to use an existing computer subroutine that computes $L(t_3, t_4, \rho)$ directly, and with greater precision. Subroutine MDBWOR from the IMSL library of programs (International Mathematical and Statistical Libraries), is one example of a computer subroutine that is easily applied.

Having calculated Q⁻, trial and error calculations in which a_2 and a_3 (and hence a_4) are varied must be performed to find Q⁻_{max}. This exercise is not as straightforward as for determing Q_{max} because in that instance, the optimum value of a_3 (from a diverter's viewpoint) was known for given a_2 ; this is not true for determining Q⁻_{max}. Thus, two parameters must be varied, and not just the one.

Basis

For approach 1, the basis for (eq. 4.6.6) - (eq. 4.6.12) is given in pages 184-186 of [4.12].

Examples

EXAMPLE 4.9 (a)

For example 4.8 (a), Q_{max} was found to be 0.0695 occurring at $a_2 = 0.7$, $a_3 = 0$, and $a_4 = 0.3$. Find Q⁻ for these values of a_2 , a_3 , and a_4 . In order for the comparison to be more valid from a false alarm viewpoint, initially set

 $\alpha = 1 - \sqrt{0.95} = 0.0253$

for the \hat{D} and MUF tests, since α was 0.05 for the (MUF- \hat{D}) test.

From example 4.3 (a),

 $\theta = (1.75)^{-1} = 0.5714$

Also, m = 1500/296 = 5.0676

 $t_{\alpha} = 1.955$

and

so that from (eq. 4.5.10),

$$t_3 = \frac{1.955 \sqrt{1.5714} -5.0676 a_3}{\sqrt{1+0.5714} C_1^2}$$

From (eq. 4.5.13) and the data of example 4.7 (a),

 $t_4 = 1.955 - 1500 a_4 / \sqrt{45,010}$

 $= 1.955 - 7.0703 a_4$

From (eq. 4.4.23), (eq. 4.6.3), and (eq. 4.6.4), and the data of example 4.7 (a),

 $k_2 = 45,010/87,675 = 0.513$; $k_3 = 0$

$$\rho = \frac{-0.513}{\sqrt{(1+0.5714C_1^2)(0.513)}} = \frac{-0.716}{\sqrt{(1+0.5714C_1^2)}}$$

In the expressions for t_3 and ρ ,

 $C_1^2 = \min(4, 1+5.0676 a_3)$

First, use approach 1, (table look-up), to compute Q⁻¹ for $a_2 = 0.7$, $a_3 = 0$, and $a_4 = 0.3$.

$$t_3 = 1.955$$

$$t_4 = -0.166$$

$$\rho = -0.571$$

From (eq. 4.5.12) and (eq. 4.5.14),

$$Q_3 = 0.9747 , \quad Q_4 = 0.4341$$

From (eq. 4.6.9) and (eq. 4.6.10),

$$\Delta_3 = 0.592 , \quad \Delta_4 = -13.65$$

From Annex 4.3 (b) and 4.3 (c),

T(1.955, 0.592) = 0.0106

To evaluate T(-0.166, -13.65), use (eq. 4.6.13) and (eq. 4.6.14) to eliminate the negative values.

T(-0.166, -13.65) = T(0.166, -13.65) = -T(0.166, 13.65)

Then use (eq. 4.6.12) since ${\scriptstyle \Delta_4}$ >1.

Finally, H of (eq. 4.6.8) is 0.5 so that, from (eq. 4.6.8)

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L(1.955, -0.166, -0.571) = 0.5 (0.9747 + 0.4341) - 0.0106 + 0.2169 - 0.5= 0.4107

Then, from (eq. 4.6.2),

 $Q^{-} = (0.05)^{0.7} (0.4107) = 0.0504$

Using the MDBNOR subroutine, $L(t_3, t_4, \rho)$ is calculated to be 0.4109, in good agreement with the table look-up value.

Note that at this combination of values of a_2 , a_3 , and a_4 , Q⁻ is smaller than Q; this does not mean, however, that Q⁻ max is smaller than Q_{max} since Q and Q⁻ may not reach their respective maximum values at the same combination of values for a_2 , a_3 , and a_4 . Further calculations are needed to determine Q⁻ max.

Before proceeding with these additional calculations, the optimal choices for α_3 and α_4 are used in place of $\alpha_3 = \alpha_4 = 0.0253$, where these optimal choices are given by Annex 4.4. In using Annex 4.4, the value of ρ is, of course, that calculated under the null hypothesis, i.e., corresponding to $C_1^2 = 1$. This is

 $\rho = -0.716/\sqrt{1.5714} = -0.571$

Thus, from Annex 4.4, by graphical interpolation, chose

 $\alpha_3 = 0.035$ $\alpha_4 = 0.021$ $t_{\alpha_3} = 1.811$ $t_{\alpha_4} = 2.034$

The example calculation is now performed with these values used instead of 1.955 in the expressions for t_3 and t_4 . At $a_2 = 0.7$, $a_3 = 0$, and $a_4 = 0.3$,

 $t_3 = 1.811$ $t_4 = -0.087$ $\rho = -0.571$

From (eq. 4.5.12) and (eq. 4.5.14),

 $Q_3 = 0.965$ $Q_4 = 0.465$

From (eq. 4.6.9) and (eq. 4.6.10),

 $\Delta_3 = 0.637$ $\Delta_4 = -24.66$

From Annex 4.3 (c),

T(1.811, 0.637) = 0.0148

To evaluate T(-0.087, -24.66), use (eq. 4.6.13) and (eq. 4.6.14) to eliminate the negative values.

T(-0.087, -24.66) = T(0.087, -24.66) = -T(0.087, 24.66)

Then, since $\Delta_4 > 1$, use (eq. 4.6.12),

T(0.087, 24.66) = 0.5 (0.535 + 0.984) - (0.535)(0.984) - 0.0007

= 0.2324

Finally, since H of (eq. 4.6.8) is 0.5, the result is

$$L(1.811, -0.087, -0.571) = 0.5 (0.965 + 0.465) - 0.0148 + 0.2324 - 0.5$$

= 0.4327

This compares with the value of 0.4107 for the case $\alpha_3 = \alpha_4 = 0.0253$. The Q' value is $(0.05)^{0.7}(0.4327) = 0.0531$, compared with the earlier value, 0.0504.

The further calculations are now made to investigate the relationship between Q' and diversion strategy, and also determine an approximate value for Q'_{max} . The table gives values of Q' for various sets of values of a_2 , a_3 , and a_4 . The $L(t_3, t_4, \rho)$ values are calculated using the MDBNOR subroutine. Two sets of values for $L(t_3, t_4, \rho)$ and Q' are given. Those with subscript 1 are based on $\alpha_3 = \alpha_4 = 0.0253$ while for $\alpha_3 = 0.035$ and $\alpha_4 = 0.021$, the subscript 2 values are calculated.

<u>a</u> 2	<u>a</u> 3	<u>a</u> 4	<u>C12</u>	β ^{a2}	$L_1(t_3, t_4, \rho)$	$L_2(t_3,t_4,\rho)$	Q1	Q2
0	0	1	1	1	0.0000	0.0000	0.0000	0.0000
0	0.25	0.75	2.267	1	0.0001	0.0001	0.0001	0.0001
0	0.50	0.50	3.534	1	0.0098	0.0101	0.0098	0.0101
0	0.75	0.25	4	1	0.0822	0.0757	0.0822	0.0757
0	1	0	4	1	0.0671	0.0559	0.0671	0.0559
0.25	0	0.75	1	0.4729	0.0002	0.0002	0.0001	0.0001
0.25	0.25	0.50	2.267	0.4729	0.0243	0.0259	0.0115	0.0122
0.25	0.50	0.25	3.534	0.4729	0.2097	0.2010	0.0992	0.0951
0.25	0.75	0	4	0.4729	0.2136	0.1879	0.1010	0.0889
0.50	0	0.50	1	0.2236	0.0474	0.0531	0.0106	0.0119
0.50	0.25	0.25	2.267	0.2236	0.3963	0.3946	0.0886	0.0882
0.50	0.50	0	3.534	0.2236	0.4596	0.4224	0.1028	0.0944
0.75	0	0.25	1	0.1057	0.5498	0.5710	0.0581	0.0604
0.75	0.25	0	2.267	0.1057	0.7577	0.7255	0.0801	0.0767
1	0	0	1	0.0500	0.9494	0.9440	0.0475	0.0472
0.333	0.333	0.333	2.688	0.3684	0.1718	0.1733	0.0633	0.0638

Note from this table that the Q_1 and the Q_2 values are quite comparable. It is recommended that in application the Q_2 values be used, i.e., the nondetection probabilities be based on the optimal assignment of values for α_3 and α_4 . It is very simple to determine this optimal assignment using Annex 4.4.

For the values in this table, $Q_2^{'}$ max is 0.0951, considerably larger than the Q_{max} value of 0.0695. (The actual value of $Q_2^{'}$ max over the entire space will be greater than 0.0951 by some amount which could be determined by performing additional runs in the region of the maximum.) The $Q_2^{'}$ max value of 0.0951 occurs when

375 kg U is diverted into large and medium data falsifications, 750 kg U is diverted into small falsifications, and 375 kg U is diverted into MUF. Note that this region is quite far removed from the region of Q_{max} illustrating that the two test combinations react differently to different diversion strategies.

EXAMPLE 4.9 (b)

In example 4.8 (b), Q was found to be 0.3413 at $a_2 = 0.6$, $a_3 = 0$, and $a_4 = 0.4$. Find the corresponding value of Q⁻. In order for the comparison to be more valid, initially set $\alpha = 0.0126$ for the D and MUF tests, where $\alpha = 1 - \sqrt{0.975}$.

Since the sample sizes in this example are implementation sample sizes rather than planning sample sizes, t_3 , t_4 , and ρ are expressed in terms of $V(\hat{D}^{-})|H_0$, $V(\hat{D}^{-})|H_1$, V(MUF), and V_0 rather than k_2 , k_3 , and θ .

From (eq. 4.5.6) and the data of example 4.7 (c), $C_1^2 = \min (4, 1 + 8a_3 / \sqrt{23.978453})$ $= \min (4, 1 + 1.634a_3)$

where, in applying (eq. 4.5.6), a_1 is replaced by a_3 and \hat{D}_k by $\hat{D}^{\,\prime}.$ From (eq. 4.5.7), again applied to $\hat{D}^{\,\prime}$ rather than to \hat{D}_k ,

$$t_{3} = \frac{2.238 \sqrt{27.303719} - 8a_{3}}{\sqrt{23.978453} + 3.325266 C_{1}^{2}}$$
$$= \frac{11.6942 - 8a_{3}}{\sqrt{23.978453} + 3.325266 C_{1}^{2}}$$

From (eq. 4.5.13),

$$t_{4} = 2.238 - 8a_{4}/\sqrt{10.729310}$$
$$= 2.238 - 2.4423a_{4}$$

From (eq. 4.6.5),

$$\rho = \frac{-10.729310 + 2.230517}{\sqrt{(23.978453 + 3.325266C_1^2)(10.729310)}}$$
$$= \frac{-2.5946}{-2.5946}$$

 $\sqrt{(23.978453 + 3.325266C_1^2)}$

First, use the table look-up approach 1 to compute Q⁻ for $a_2 = 0.6$, $a_3 = 0$, $a_4 = 0.4$. Since $a_3 = 0$, $C_1^2 = 1$ so $t_3 = 2.238$ t₄ = 1.261 $\rho = -0.497$ From (eq. 4.5.12) and (eq. 4.5.14), $Q_3 = 0.9874$ $Q_{L} = 0.8964$ From (eq. 4.6.9) and (eq. 4.6.10), $\Delta_3 = 1.222$ $\Delta_4 = 2.618$ From Annex 4.3 (d), T(2.230, 1.222) = 0.0063To evaluate T(1.261, 2.618), apply (eq. 4.6.12), T(1.261, 2.618) = 0.5 (0.8964+0.9995) - (0.8964)(0.9995) - 0.0002= 0.0518Finally, since H of (eq. 4.6.8) is 0, L(2.238, 1.261, -0.497) = 0.5 (0.9874+0.8964) - 0.0063 - 0.0518= 0.8838Then, from (eq. 4.6.2), $0^{-} = (0.20)^{0.6}(0.8838) = 0.3365$

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Using the MDBNOR subroutine, $L(t_3, t_4, \rho)$ is calculated to be 0.8838, in agreement with the table look-up value.

Before performing further calculations at other combinations of diversion strategies, use the optimal values of α_3 and α_4 in place of $\alpha_3 = \alpha_4 = 0.0126$. These are found from Annex 4.4 where the values for α_3 and α_4 read from the graph must be divided by 2 since $\alpha = 0.025$ instead of 0.05. The value for ρ at $C_1^2 = 1$ is $\rho = -0.497$. Then, from graphical interpolation in Annex 4.4,

> $\alpha_3 = 0.5(0.036) = 0.018$ $\alpha_4 = 0.5(0.018) = 0.009$ $t_{\alpha_3} = 2.098$ $t_{\alpha_{11}} = 2.365$

The example calculations are now performed with these values used instead of 2.238 in the expressions for t_3 and t_4 . At $a_2 = 0.6$, $a_3 = 0$, and $a_4 = 0.4$,

> $t_3 = 2.098$ $t_{11} = 1.388$ o = -0.497

From (eq. 4.5.12) and (eq. 4.5.14),

 $Q_3 = 0.982$ $Q_{i_{\rm H}} = 0.917$ From (eq. 4.6.9) and (eq. 4.6.10),

 $\Delta_3 = 1.335$ $\Delta_4 = 2.315$

From Annex 4.3 (d),

T(2.098, 1.335) = 0.0093

To evaluate T(1.388, 2.315), apply (eq. 4.6.12),

$$T(1.388, 2.315) = 0.5(0.917+0.999) - (0.917)(0.999) - 0.0003$$

= 0.0416

Finally, since H of (eq. 4.6.8) is 0,

L(2.098, 1.388, -0.497) = 0.5 (0.982+0.917)-0.0093-0.0416

= 0.8986

This compares with the value of 0.8838 for the case $\alpha_3 = \alpha_4 = 0.0126$. The Q⁻ value is $(0.20)^{0.6}(0.8986) = 0.3421$, compared with the earlier value, 0.3365.

The further calculations are now made to investigate the relationship between Q' and diversion strategy, and also to determine an approximate value for Q'max. The table gives values of Q' for various combinations of values of a_2 , a_3 , and a_4 . The L(t_3 , t_4 , ρ) values are calculated using the MDBNOR subroutine. Two sets of values for L(t_3 , t_4 , ρ) and Q' are given. Those with subscript 1 are based on $\alpha_3 = \alpha_4 = 0.0126$ while for $\alpha_3 = 0.018$ and $\alpha_4 = 0.009$, the subscript 2 values are calculated.

a 2	<u>a</u> 3	<u>a</u> 4	<u>C1²</u>	β ^{d2}	$L_1(t_3, t_4, \rho)$	$L_2(t_3, t_4, \rho)$	Qí	Q2
0	0	1	1	1	0.4080	0.4531	0.4080	0.4531
0	0.25	0.75	1.409	1	0.6243	0.6579	0.6243	0.6579
0	0.50	0.50	1.817	1	0.7666	0.7733	0.7666	0.7733
0	0.75	0.25	2.226	1	0.7941	0.7732	0.7941	0.7732
0	1	0	2.634	1	0.7285	0.6890	0.7285	0.6890
0.25	0	0.75	1	0.6687	0.6454	0.6854	0.4316	0.4583
0.25	0.25	0.50	1.409	0.6687	0.8107	0.8270	0.5421	0.5530
0.25	0.50	0.25	1.817	0.6687	0.8682	0.8586	0.5806	0.5741
0.25	0.75	0	2.226	0.6687	0.8327	0.8033	0.5568	0.5372
0.50	0	0.50	1	0.4472	0.8329	0.8558	0.3725	0.3827
0.50	0.25	0.25	1.409	0.4472	0.9131	0.9133	0.4083	0.4084
0.50	0.50	0	1.817	0.4472	0.9072	0.8891	0.4057	0.3976
0.75	0	0.25	1	0.2991	0.9355	0.9423	0.2798	0.2818
0.75	0.25	0	1.409	0.2991	0.9523	0.9439	0.2848	0.2823
1	0	0	1	0.2000	0.9748	0.9730	0.1950	0.1946
0.333	0.333	0.333	1.545	0.5848	0.8758	0.8776	0.5122	0.5132

For the values in this table, Q_2^{-} max is 0.7733. The Q max value was 0.5855 from example 4.8 (b). As in the prior example, Q_2^{-} max is much larger than Qmax.

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 $\frac{1}{2}$ VERSUS M/ σ_s FOR DIFFERENT PROBABILITIES OF DETECTION (1- β)

Annex 4.1 (b)



4-65

Annex 4.2 (a)

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A Function for Computing Bivariate Normal Probabilities [162] Table A of T(h, a)

h	0.25	0.50	0.75	1.00
0.00 0.01 0.02 0.03 0.04	0.038990 0.038988 0.038982 0.038982 0.038972 0.038958	0.073792 0.073788 0.073776 0.073756 0.073728	0.102416 0.102410 0.102393 0.102363 0.102321	0.125000 0.124992 0.124968 0.124928 0.124873
0.05	0.038940	0.073692	0.102267	0 • 124801
0.06	0.038918	0.073649	0.102202	0 • 124714
0.07	0.038892	0.073597	0.102124	0 • 124611
0.08	0.038862	0.073538	0.102035	0 • 124492
0.09	0.038862	0.07357	0.101934	0 • 124357
0.10	0.038791	0.073395	0.101821	0.124207
0.11	0.038750	0.073312	0.101697	0.124041
0.12	0.038704	0.073221	0.101561	0.123860
0.13	0.038655	0.073122	0.101413	0.123663
0.14	0.038602	0.073016	0.101253	0.123450
0.15	0.03854 5	0.072902	0.101082	0 • 123223
0.16	0.038484	0.072780	0.100900	0 • 122980
0.17	0.038419	0.072651	0.100706	0 • 122722
0.18	0.038350	0.072514	0.100501	0 • 122449
0.19	0.038278	0.072369	0.100285	0 • 122162
0.20	0.038202	0.072217	0 • 100057	0 • 121859
0.21	0.038122	0.072058	0 • 099819	0 • 121542
0.22	0.038038	0.071891	0 • 099569	0 • 121210
0.23	0.037951	0.071717	0 • 099308	0 • 120864
0.24	0.037860	0.071535	0 • 099037	0 • 120503
0.25	0.037766	0.071347	0.098755	0.120129
0.26	0.037668	0.071151	0.098462	0.119740
0.27	C.037566	0.070948	0.098158	0.119337
0.28	0.037461	0.070738	0.097844	0.118921
0.29	0.037352	0.070521	0.097520	0.118492
0.30	0.037240	0.070297	0.097186	0.118048
0.31	0.037124	0.070066	0.096841	0.117592
0.32	0.037005	0.069828	0.096487	0.117123
0.33	0.036882	0.069584	0.096122	0.116641
0.34	0.036756	0.069333	0.095748	0.116146
0.35	0.036627	0.069076	0.095365	0.115639
0.36	0.036495	0.068812	0.094971	0.115119
0.37	0.036359	0.068542	0.094569	0.114587
0.38	0.036220	0.068265	0.094157	0.114044
0.39	0.036078	0.06798 3	0.093736	0.113489
0.40	0.035933	0.067694	0.093306	0.112922
0.41	0.035785	0.067399	0.092868	0.112344
0.42	0.035634	0.067098	0.092421	0.111755
0.43	0.035479	0.066791	0.091965	0.111155
0.44	0.035479	0.066479	0.091501	0.110545
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		Table A of T(h, a)				Table A of T(h	1, a)	
1_	0.25	0.50	0.75	1.00	1_	0.25	0, 50	0.75	1.00
1 4 5	0-035162	191990-0	0.00100		06-0	0.025791	0-047700	0.064013	0.0750.0
	0.034999	0.065837	0.090548	0.109763	16-0	0.025554	0.047237	0.063347	0-074251
0.47	0.034834	0.065508	0.090060	0.108652	0.92	0.025316	0.046775	0.062681	0.073411
0.48	0.034665	0.065173	0.089564	0.108001	0.93	0.025079	0.046311	0.062015	0.072572
C•49	0.034494	0.064834	0.089060	0.107341	0.94	0.024840	0.045848	0.061349	0.071734
0.50	0.034320	0-064489	0.088549	0.106671	0,05	0.03460.0	0.025364	0.0604040	0.070808
C.51	0.034144	0.064139	0.088031	0.105003	40.00	0.024363		0-060015	5400L0*0
0.52	0.033965	0.063784	0.087506	0.105305	0.97	0.024125	0-044456	0.059554	0.000000
0.53	0.033783	0-063474	0.086074						
0.54	0.033599	0.063059	0.086435	0.103905	66°0	0.023647	0.043528	0.058090 0.058027	0.067369
1 1 1	0 033/12		000000000000000000000000000000000000000						
	0.033774	0.0602090	0.0050307	647601°0	1.00	0.023408	0.043065	0.057365	0.066742
	0-044044	0-041038			101	0.023169	0.042602	40194040	0.065917
- a - a - a	078280-0	0-41010-0	0-084179	0.101010	1.02	0.022931	0.042139	0.056044	0.065095
	0-032645	0-041148	0.004645		1.03	0+022692	0.0416//	0.025386	0.064276
		001100-0	6+0500+0	0.1UZ08	1•04	0.022454	0.041216	0.054729	0.063459
C.60	0.032447	0.060778	0.083069	0.09919	1,05	0.022216	0-01.0755	0.050.75	0 062646
C.61	0.032247	0.060383	0.082487	0.098764	1.05	0.071078		0.05260	0.061836
C.62	0.032046	0.059984	0.081901	0.0980.02		0.7130.0			
0.63	0.031842	0.059581	0.081309			0.01120.0	0+07070		670T00.0
19.0	0.031636	0.059175	0.080712	0.096460		0.02120.0	0.0380.0	0.051474	0,000,000
				9 4 4 4 4		0 · · · · · · · · · · · · · · · · · · ·	*****		
C. 65	0.031429	0.058765	0.080110	0.095681	1.10	0.021030	0.038466	0.050830	0.058630
0.66	0.031219	0.058352	0.079504	0.094896		0.020794	0.038012	0.050188	0.057839
0.67	0.031008	0.057936	0.078893	0.094106	· !</td <td>0.020559</td> <td>0.037559</td> <td>0-10-0-0</td> <td>0.057051</td>	0.020559	0.037559	0-10-0-0	0.057051
0.68	0.030795	0.057516	0+078278	0.093312	4 C	0.000305			
0.69	0.030581	0.057093	0.077658	0.092512	1.14	0.020091	0.036657	0.048277	0.055489
1									•
0• 10	0.030365	0.056667	0.077035	0.091709	1.15	0.019857	0.036209	0.047646	0.054714
- r - r - r		0.000255	0.016408	106060-0	1.16	0.019625	0+035762	0.047018	0.053945
	0.0297070	0.056373	111610.0	0.090089	1.17	0.019393	0.035317	0.046393	0.053180
	0.029485	0.054937	0.074506	0.088455	1.18	0.019162	0.034874	0.045771	0-052420
					1.19	0.018931	0.034432	0.045152	0.051664
0.75	0.029262	0.054498	0.073866	0.087634	02 - 1	0.018702	0.033003	0-046537	0.050014
0.16	0.029038	0.054056	0.073223	0.086809	12.1	0-018473	0.033556	0.043075	0.050160
	0.028812	0.053613	0.072577	0.085982	1.22	0.018246	0.033120	0.043317	0.049430
		191660.0	8767/0.0	241480.0	1.23	0.018319	0.032687	0.042712	0-048696
61.0	1 6 6 8 7 0 • 0	071740.0	0.071278	0.084320	1.24	0.017794	0.032256	0.042112	0-047967
0.80	0.028128	0.052270	0.070625	0.083486	ас г а	017520			
0.81	0.027898	0.051819	0.069970	0.082651	77 T	0077707	0.031460		
0.82	0.027667	0.051367	0.069313	0.081814	1 - 2 7	C+C 10 0	0.020078	0.0404232	1 700000
0.83	0.027435	0.050912	0.068655	0.080975		0.014000		1 1 1 0 0 0 - 0	
0.84	0.027202	0.050457	0.067995	0.080136	1.29	0.016682	0.030138	0.039167	0*044408
0.85	0.026968	0.050000	0.067333	0.079296	1.30	0.016463	0.029721	0.038590	0.043715
0.85 1	0.026/34	0.049542	0.066671	0.078455	1.31	0.016245	0.029308	0.038018	0.043027
. 8 .	0.026499	0.049083	0.066007	0.077614	1.32	0.016028	0.028857	0.037450	0.042345
9 Q 9 Q	0.026264	0.048622	0.065343	0.076773	1.33	0.015813	0.028488	0.036386	0.041670
1• a v	120020-0	101040.0	0.0646/8	0.015932	1.34	0.015599	0.028083	0.035327	0.041000

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Annex 4.2 (b)

abilities (cont.)		1.00	0.017320	0.016956	0.016549	0.015901	1 - - -	0.015561	0.015227	C.C.14898	0.014575	0.014258	9 213675				0.012752	1	0.012467	0.012187	116110.0	0.011641	0.011376		0.011116	0.010861	0.010611	0.010365	0.010124		0.009887	0.009656	0.009428			0.008773	0.008563	0.008357	0.008155	0.007958		0.007764	0 00100 0	0.007307	0.007020		0.006855	0.006684	0.006517		** T 0 0 0 * 0
Normal Prob	h, a)	0.75	0.015492	6.015069	0.010200 0.00500 0.00500	0.014731	1	0.014425	C.014130	C.013836	C.013547	C.C13263	00000 V	0-01-202	0.012437				0.011652	C.011399	0.011150	0.010905	0.010665		0.010429	0.010197	0.009970	0.009746	0.009527		0.009311	660600.0	0.008891		0+000000	0.008291	0.008098	0.007909	0.007724	0.007542		0.007363	0.0000	110100.0	0.006684		C.006523	0.006364	C.006209		××××××
ing Bivariate	Table A of T(0.50	0.612449	0.012701	0.0124210	0.011976		0.011744	0.011514	0.011236	0.011062	0.013841							0.009535	0.029357	0.005152	0,009000	0.008811		0.005625	0.008442	0.008263	0.008086	0.007512		0.00/741	E/ 4/00 0	0.007408		00000000	0.006929	0.006775	0.006524	0.006476	0.006330		0.006187			0.005639		0.005509	0.005381	0.005255		
n for Comput		0.25	0.007467	0.007331	0.007064	0.006933		0.006804	0.006676	0.006550	0.006426	0.006304	0,000,02	Color0400.0	0-005947		112200.00		0.005605	0.005495	0.005386	0.005278	0.005172		0.005068	0.004966	0.004865	0.004765	0.004667		1/4400.0	0.004476	0.004383			0.004112	0.004025	0.003939	0.003854	0.003771		0.003690		1000000	0.003377		0.003303	0.003229	0.003157		1 1 2 0 0 0 0
A Functio	ſ	/ 4	1.80	1.81	1 • 3 × 4			1.85	1.86	1.87	1.88	1.89	00 5		1.02	0.2	70.1		1.95	1.96	1.97	1.98	1.99		2.00	2.01	2.02	2.03	2•04		2.05	2 0 6	2.07	200 r	60.03	2.10	2.11	2.12	2.13	2.14		2,15	01.0	2.18	2.19	4	2.20	2.21	2•22	67•4 7 C C	t 7 • 7
abilities (cont.)			1.00	0.040337	0.039030	0.038386	0.037749		0.037118	0.036493	0.035875	0.035264		0.034061	0.033470	0.032885	0.032308	0.031736		0.031172	0.030614	0.030063	0.029519	0 • 0 2 8 9 8 2	13/0/0/0	U+070707	0.02410		0.02520F	C & C & C & C & C & C & C & C & C & C &	0 0 7 F P O 0	0.025/08	0.024024	0-024447	0.023976		0.023512	0.023055	0.022604	0.022159	77177000	0.021290	0.020865	0.020446	0.020033	0.019627	7 2 2 9 1 9 9	0.018833	0.018446	0.018064	0.017689
Normal Prob	h, a)		0.75	0.035773	0.034578	0.034137	0.033601		0.033070	0.032543	0.032022	0.031500	+**000 *D	0.030487	0.029985	0.029489	0.028997	0.028511		0.028029	0.027553	0.027082	0.026616	0.026155	005300	0,0257.0		0.0044004		676570.0			0,022666	0.022242	0.021833		0.021430	0.021032	0.020638	0.020250	0.017000	0.019490		0.018750	0.018388	0.018030	957510 0	0.012120.0	0-016989	0.016651	0.016319
ting Bivariate	Table A of T(0.50	0.027680	0.026884	0.026490	0.026099		0.025711	0.025326	0.024944	0.024566	0.004140	0.023818	0.023449	0.023084	0.022721	0.022362		0.022006	0.021654	0.021305	0.020959	0.020617		6/2020.0		119610 0	0000000	846810*0			0.010005	700210-0	0.017387		0.017083	0.016783	0.016486	0.016193	5065T0•0	0.0.5617	11011090	0.015055	0.014780	0.014508		0.013074	612810-0	0.013454	0.013200
n for Comput	-		0.25	0.015387	C.014966	0.014757	C.C14550		C.014345	0,014140	C.C13938	0.013737	166610.0	0.013339	0.013142	0-012947	0.0:2754	0.012562		0.012372	0.012184	0.011997	0.011812	0.011628		0.011446	007110-0	0,011088	116010.0	0.010736		0°010°0	145010.0		0.009887		0.009723	0.009560	0.009399	0.009240	0.009082	70800 V		0.008621	0.008470	0.008322		0.008030	788700.0	0.007745	0.007605
A Functio		e	2/a	• • • •	0 h 9 (f • •		0 01 • 1		, • •		:++2	, t) t -	. • 4 1		1		- 5			:•50	1.51	1.52	1.53	1.54				~~	1.58	1.59			101	70 • T			1.65	1.66	1.67	1.68	1.69	<u>,</u>	- + - - + -	1.72	1.73	1 • 74	, ,	1. 15		1.78	1.79

-I Probabilitie inte No. Bivo 1 i ù 2 4

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Annex 4.2 (c)

A Function for Computing Bivariate Normal Probabilities (cont.) A Function for Computing Bivariate Normal Probabilities (cont.)

(n, a) 0.75
0.006038 (.005884
0.005735
0.005445
0.005305
0.005167
0.00000
0.004774
0,004640
0.004527
0.004407
0.004291
0.004177
0.004045
0.004460 0.00446
0.003850
0.003746
0.003645
0.00000
648800•0 0
0.003173
1 T & 7 O O P O
0.002756
0.002679
0.002603
0.002530
0.002458 0.002388
0.002320
0.002200
0.002134
0-002220
0.002064
0.002004
0.001946
0.001889
0.001834
0.001780

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Annex 4.2 (d)

A	Function for (Computing Bi	variate Norm	al Probabiliti	es (cont.)	ΑF	unction for C	omputing Biv	ariate Normo	al Probabilitie	is (cont.)
		Table	: B of T(h, a)					Table E	3 of T(h, a)		
*/ c	0.00	10.0	0.02	0.03	0 • 0 4	₽/4	0.15	0.16	C.17	0.18	0.19
0.0000 0.0000 0.00000	000000 000000 000000 000000 000000 00000	0.001591 0.001543 0.001404 0.0001201 0.000965	0.003183 0.003085 0.002085 0.002402 0.002402	0.004773 0.004626 0.004212 0.003603 0.002895	0.006363 0.006167 0.005615 0.005615 0.004802 0.003855	0 0 0 0 0 0 0 0 0 0 0 0 0	0.023697 0.022962 0.020893 0.017850 0.014319	C.025251 0.024467 0.0224467 0.022260 0.019015 C.015251	C • C26600 0 • C26600 0 • C259660 0 • C259660 0 • C229623 0 • C22023 0 • C2203 0 • C220	C.028344 C.027463 C.027463 C.024980 C.021331 O.017100	0.029583 0.026953 0.0269333 0.022482 0.016018
	000000000000000000000000000000000000000	0.000729 0.000517 0.000344 0.000345 0.000127	0.001457 0.001033 0.000688 0.000688 0.000431 0.000253	0.002185 0.001549 0.001032 0.000646 0.000379	0.002912 0.002364 0.001375 0.000360 0.000566	000000 00100 00100 00100 00100	0.01C786 0.5C7629 0.5C7629 0.5C95067 0.03160 0.031850	0.011485 0.008120 0.005391 0.003360 0.003360	0.012179 0.006608 0.0055712 0.003559 0.003559	0.012869 0.0059092 0.006031 0.003755 0.002195	C.013555 0.005573 0.006347 0.002308 0.002308
() (C.000000 C.CCCC00 C.CCCC00 C.CCCC00 C.CCCCC0	0.000070 0.0000136 0.000018 0.000008 0.000008	0.000140 0.000073 0.000035 0.00016 0.0016	0.000210 0.000109 0.000053 0.00024 0.08	0.000279 0.000145 0.000071 0.000032 0.00032	N (N M M • • • • O U O U	0.001017 0.000255 0.000255 0.000116 0.20	0.001081 0.000558 0.000270 0.006123 0.21	C.001143 C.005590 C.00285 C.00150 C.22	0.001205 0.000621 0.000136 0.23	0.0001266 0.000652 0.000315 0.000143 0.24
10000 1000 1000 1000 1000 1000 1000 10	0.007951 0.007706 0.007016 0.006000 0.004821	0.009538 0.009244 0.008416 0.008416 0.007197	0.011123 0.010780 0.009814 0.008392 0.006741	0.012705 0.012314 0.011209 0.009585 0.007698	0.014285 0.013845 0.012603 0.010775 0.008653	0.25 0.55 0.55 1.00	0.031416 0.030437 0.027679 0.023627 0.023627	0.032944 0.031916 0.029020 0.024766 0.019837	C.C.C.2.4.465 C.C.2.3.3.388 C.C.2.3.555 C.C.2.5555 C.C.2.5559 C.2.2.3559 C.2.2.35599 C.2.2.3399	0.035580 0.034854 0.031683 0.027027 0.027027	0.037488 0.036313 0.036313 0.033005 0.028148 0.022525
2.00 2.00 2.00 2.00 2.00 2.00 2.00 2.00	0.003638 0.002579 0.001717 0.001074	0.004363 0.003092 0.002059 0.001288 0.001288	0.005086 0.003604 0.002399 0.001500 0.001500	0.005807 0.004115 0.002739 0.001712 0.001005	0.006527 0.004624 0.003077 0.001923 0.001129	1 • 50 • 1 • 50 • 20 • 20	0.014237 0.010050 0.006659 0.004142 0.002418	0.014913 0.010523 0.006969 0.0064332 0.002528	0.C15585 0.010592 0.007276 0.004520 0.002635	0.016252 0.016252 0.007579 0.004705 0.002741	0.016913 0.011917 0.007879 0.004888 0.002846
2 • 50 2 • 75 2 • 75 2 • 25	C.000348 C.000181 O.0000588 O.0000588 C.10	0,000417 0,000216 0,000105 0,000105 0,000048	0.000486 0.000252 0.000123 0.000123 0.00056	0.000555 0.000287 0.000140 0.000140 0.00064	0.000622 0.000322 0.000157 0.000157 0.14	2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	0.001325 0.000682 0.000329 0.000149 0.25	0.001384 0.000712 0.000343 0.000156 0.26	0.001442 0.000741 0.000357 0.000357 0.000162 C.27	C.001499 C.000769 0.000371 0.000371 0.00167 0.28	0.001555 0.000797 0.000384 0.000173 0.29
0.25 0.450 0.450 0.450 0.450	0.015863 C.015373 0.013993 0.011963 0.011963 0.009605	0.017437 0.016898 0.015380 0.0153847 0.013147 0.013147	0.019008 0.018420 0.016764 0.014328 0.014328	0.020575 0.019938 0.018144 0.015506 0.015506	0.022138 0.021452 0.019521 0.013680 0.013384	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	0.038990 0.037766 0.034320 0.029262 0.023408	0.040484 0.039211 0.035628 0.030370 0.030370	0.041971 0.040649 0.036529 0.031470 0.031470	0.043451 0.042080 0.038223 0.038223 0.032564	0.044923 0.043503 0.039509 0.0335509 0.033650
1.55 1.55 2.00 2.25	0.037244 0.035131 0.033413 0.002133 0.001251	0.007958 0.005635 0.003748 0.002341 0.001373	0.008670 0.006138 0.004081 0.002548 0.001494	0.009379 0.006638 0.004412 0.002754 0.001614	0.010084 0.007135 0.004740 0.002958 0.001733	1	0.017569 0.012372 0.008175 0.002968 0.002948	<pre>C.018219 O.012823 C.0012823 C.0052467 C.005246 C.003049</pre>	0.012864 0.013269 0.008756 0.008756 0.005421	0.019502 0.013710 0.009041 0.005593 0.003245	0.020135 0.014147 0.005322 0.005762 0.003341
9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9	0.000690 0.000357 0.000357 0.000174 0.000079	C. 000757 C. 000391 D. 000190 O. 000087	7.000823 0.000426 0.000207 0.000207	0.000888 0.000459 0.000223 0.000102	0.000953 0.000492 0.000239 0.000109	8 8 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9	0.001609 0.000824 0.000396 0.000396	0.001663 v.000851 c.000409 c.000184	0.001716 C.000877 0.000421 0.000421	0.001767 0.000902 0.000432 0.000432	0.001817 0.000927 0.000444 0.000444

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s (cont.)		0.49	0.072513 0.072117 0.063395 0.0533597 0.053597	C.C31345 O.C21691 O.O14049 O.O08519 O.O04838	0.002574 0.001284 0.000600 0.000263	0 • 54	0.078803 0.076163 0.068764 0.058003 0.045720	0.033685 0.023207 0.014956 0.009020 0.005094	0.002695 0.001337 0.006622 0.000271	0.59	0.084835 0.081951 0.073879 0.062165 0.048839	0.035838 0.024574 0.015756 0.009451 0.005308	0.002793 0.001378 0.000638
l Probabilitie		0.48	0.071225 C.068877 C.062897 C.052290 C.052687 C.052687 C.041684	0.020854 0.021355 0.013855 0.005410 0.005410	0.002547 0.001272 0.001272 0.0002595 0.000262	0.53	0.077566 0.074974 0.067710 0.057141 0.057141	0.033232 0.022916 0.014783 0.008926 0.005046	0.002673 0.001327 0.000618 0.000270	0.58	0.083649 C.080814 C.072876 0.061353 0.061353	C.035422 C.024312 C.015604 O.009370 O.005268	0.002775 C.001370 C.000635 0.000635
ariate Norma	3 of T(h, a)	0.47	C+C55926 C+C67628 C+C67628 C+C67628 C+C6725 C+C6726 C+C7275 C+C7527 C+C7527 C+C7527 C+C7527 C+C7527 C+C7527 C+C7527 C+C7527 C+C7527 C+C7527 C+C7527 C+C5577 C+C5577 C+C5577 C+C75777 C+C75777 C+C75777 C+C75777 C+C75777 C+C757777 C+C757777 C+C7577777 C+C757777777777	0000 000 000 000 000 000 000 000 00 000 0000	6 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	0.52	0.076318 0.073775 0.055547 0.055647 0.055270 0.044410	0.032772 0.022619 0.014656 0.006828 0.004997	0.002650 0.001317 0.000514 0.000614	0.57	0.082453 0.079567 0.0718667 0.071864 0.060530	0.034999 6.024045 0.015448 0.009267 0.009227	0.002756 0.000632 0.000632 0.000275
omputing Biv	Table [0•46	C. 068618 C. C66368 C. 060052 O. 050837 C. 040268	C.029849 C.02710 C.02710 C.013453 C.005183 C.005183	C. 002490 C. 001246 C. 001246 C. 000585 C. 000257	0•51	0.075060 0.072566 0.065573 0.065573 0.055389 0.043742	C.032304 0.022315 0.014425 0.014425 0.008728 C.004946	0.002626 0.001306 0.000510 0.000267	0.56	C.081247 0.078509 C.070841 C.059697 0.046994	0.034569 C.023771 C.015288 U.009201 C.005184	0.002737 0.001354 1.000229 0.000274
unction for Co		C•45	0.067299 0.065098 0.058918 0.0498918 0.049898	0.029336 0.0203336 0.013245 0.013245 0.0013245 0.0013245 0.0013245	0.002459 0.001232 0.000579 0.000255	0.50	0.073792 0.071347 0.064489 0.054498 0.054498	0.031828 0.022006 0.014239 0.005625 0.004693	0.002600 0.001295 0.00605 0.000265	C.55	0.080030 0.077341 0.058807 0.058855 0.068855	0.034131 0.023492 0.015124 0.005140	0.002716 0.001346 0.00025 0.000273
A Fu		°/_	00000 •••• ••••0 ••••0		00000 00000 00000		0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	1111 1111 1111 1111 1111 1111 1111 1111 1111	2 2 2 2 5 2 5 2 5 2 5 5 5 5 5 5 5 5 5 5		1 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	2	0.000 0.000 0.000 0.000
s (cont.)		0.34	0.052161 0.050457 0.045815 0.036963 0.036963	0.023201 0.016248 0.016647 0.0066565 0.003735	0.002050 0.001040 0.000495 0.000221	0.39	0.059153 0.057275 0.051912 0.044068 0.035040	0.026098 0.016210 0.011905 0.007293 0.004188	0.002254 0.001137 0.000538 0.000239	0•44	0.065971 0.063818 0.057775 0.048950 0.048950	0.028815 0.020026 0.013033 0.007944 0.004537	0.002428 0.001218 0.000573 0.000253
al Probabilitie		0.33	0.050730 0.049115 0.044573 0.037916 0.030235	0.022601 C.015839 O.0104839 0.010496 0.006411	0.002006 0.001019 0.000486 0.000217	0•38	0.057797 0.055937 0.0550311 0.050711 0.043065 0.034259	0.025533 0.017829 0.011666 0.007154 0.007154	0.002215 0.001119 0.000530 0.000236	0•43	0.064633 0.062529 0.056621 0.047992 0.038079	C.028286 0.019675 0.012816 0.007820 0.007820	0.002395 0.001203 0.000567 0.000250
variate Norm	B ot 1(h, α)	0.32	0.049291 0.047725 0.043319 0.036862 0.036862	0.621994 0.015424 0.010142 0.006253 0.006253	0.001961 0.000977 0.000476 0.000213	0 •.3 7	0.056401 0.054591 0.049501 0.042052 0.033470	0.024961 0.017443 0.011423 0.0011423 0.007011	0.002176 0.001101 0.000522 0.000232	0.42	0.063284 0.061230 0.055458 0.047025 0.037332	0.U27750 0.019318 0.012595 0.012595 0.007693 0.007693	0.002362 0.001188 0.000560 0.000248
Computing Bi	Table	0.31	C.047843 C.046326 C.046326 O.042057 O.035799 O.028571	0.021381 0.015003 0.009873 0.006092 0.003526	C.001914 0.000974 0.000465 0.000209	0•36	0.054997 0.053235 0.048282 0.041031 0.041031	0.024381 0.017050 0.011175 0.006866 0.003954	0.002135 0.001081 0.000513 0.000513	0.41	C.061927 0.059921 0.054285 0.046048 0.036576	0.027207 0.018954 0.012370 0.012370 0.012370 0.012333	C.002327 0.001171 0.00553 0.000245
unction for C		0.30	C・C46387 C - C46387 C - C46377 C - C46377 C - C463777 C - C463777 C - C463777777777777777777777777777777777777	0000 0000 0000 0000 0000 0000 0000 000	0.001866 0.001866 0.000455 0.000455	C • 35	0,053583 0,051871 0,047054 0,047054 0,040001 0,031568	C.C23795 0.C16652 C.O10923 C.OU0717 C.O03872	0.002093 0.001061 0.000505 0.030225	0.40	C.060559 0.058602 0.053103 0.045063 C.035812	C. C26656 C. C18585 C. C121240 C. CC7430 C. CC7430 O. VC4261	0.002291 0.001155 0.000546 0.000242
Ą	r	1/2	0 11 3 11 11 0 11 11 11 11 0 11 11 11 11 0 11 11 11 11 11 11 11 11 11 11 11 11 11	16 X + 3 + 6 Y < 7 + 6 Y (0 00 0 00 10 12 03 (3 * * * * 13 14 03 04		0 0 0 0 0 0 0 0 0 0 0 • • • • • • • • • •	000000 00000	0 C O A 0 C		0 / 0 / 0 / 0 0 - 4 / 1 / 1 0 1 - 5 - 5 - 5	らいらい in こうでいう * * * * * * * * * * * * * * * * * * *	00000

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Annex 4.3 (b)

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unction for Con	Сол	Iputing Bi Table	variate Norm B of T(h_a)	al Probabilitie	ss (cont.)	AF	unction for C	computing Bir Table	variate Norme B of T(h_a)	al Probabiliti	es (cont.)
0.60 0.61 0.62	0.61 0.62	0.62		0.63	0 • 64	8/4	0.75	0.76	C.77	0.78	C.79
C.C86010 0.087176 0.088330 C.C83078 0.084194 0.085300 C.075871 C.075854 0.076826 0.062969 0.063762 0.064546 C.049436 C.050024 0.050604	0.087176 0.088330 0.084194 0.085300 0.075854 0.076826 0.063762 0.064546 0.063762 0.056664	0.088330 0.085300 0.085300 0.064546 0.064546 0.050604		0.089475 0.086396 0.077788 0.065320 0.065320	0.090609 0.067482 0.078739 0.066084 0.051738	10000 1000 0000 00000	0.102416 0.098755 0.088549 0.073866 0.073866	C.1C3430 0.099720 C.039362 C.074518 C.074518	00000000000000000000000000000000000000	C.105428 C.101521 L.C91020 C.C75794 C.058728	0.106413 0.102557 0.091824 0.076420 0.059167
C.036246 C.036646 0.03704C C.0224831 0.025081 0.0255326 0.015904 C.016048 0.016188 C.009530 C.009606 0.009679 C.005346 U.005383 0.005418	C.036646 0.03704C 0.025081 0.225326 C.016048 0.016188 C.009606 0.009679 C.005383 0.005418	0.03704C 0.025326 0.016188 0.009679 0.009679		0.037426 0.025566 0.016324 0.009750 0.005452	0.037805 0.0258800 0.016456 0.009818 0.009818	1 4 4 8 8 8 9 4 4 8 9 8 9 9 4 9 9 8 9 9 9 9 9 8 9 9 9 9 9 8 9 9 9 9 9	0.041515 0.028C29 0.028C29 0.010429 0.0C5763	C.041812 C.0218203 C.017770 C.017770 C.01C473 C.01C473	6,78600 0,76640 766840 767000 0,766470 0,0000 0,76440 0,0000 0,76440 0,0000 0,76400 0,000000	0.042388 0.0242388 0.028536 0.017944 0.010556 0.005818	0.042666 0.028695 0.018027 0.018027 0.0180295 0.005834
C.CC2810 C.002826 0.C02842 5.CC1385 0.001391 0.C01398 0.CC0640 C.000643 0.000645 0.000278 C.0C0279 0.000280	C.002826 0.002842 0.001391 0.001398 C.000643 0.000645 C.000279 0.000280	0.002842 0.001398 0.000645 0.000280		0.002857 0.001404 0.000647 0.000280	0.002871 0.001409 0.000649 0.000281	9009 9009 9999 9999 9999 9999 9999 999	0.002987 0.001453 0.000665 0.000286	C.CC2994 C.O1456 V.O00665 C.O0286	0000 000 000 000 000 00 00 00 00 00 00	C.003008 C.001461 C.0C0667 C.000287	0.00301 0.001463 0.0005668 0.000287
0.052291 0.052836 0.053373 0.052847 0.093950 0.079681 0.089622 0.090677 0.066839 0.067584 0.068320 0.052291 0.052836 0.053373	0.00 0.092847 0.089622 0.099677 0.089612 0.061584 0.068320 0.052836 0.053373	0.093950 0.093950 0.090677 0.081534 0.068320 0.053373		0.095044 0.095044 0.082445 0.082445 0.053901	0.096127 0.096127 0.092756 0.063347 0.069762 0.054421	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	0.80 0.107388 0.103484 0.022620 0.077036	0.81 0.108354 0.108354 0.093406 0.077643 0.060022	0 • 8 4 0 • 9 9 9 0 • 1 0 9 9 9 0 • 1 0 9 9 9 0 • 1 0 9 9 9 0 • 0 9 9 8 0 • 0 9 0 4 3 8 0 0 6 0 4 3 8	0.83 C.110257 C.110257 C.094950 C.078832 C.060847	0.84 C.111195 O.107C97 0.095708 0.0579414
C.038177 0.038541 0.038899 C C.C26028 0.026251 0.026469 C C.016585 0.016709 0.016831 C 0.009885 0.009949 0.010010 C	0.038541 0.038899 C 0.026251 0.026469 C 0.016709 0.016831 C 0.009949 0.010010 C 0.005546 0.005574 C	0.038899 0.026469 0.016831 0.010010 0.005574	000000	039250 026682 0016948 0010070	0.039594 0.026889 0.017063 0.010127 0.010127	1.25 1.50 2.005 2.20 2.50	0.042939 0.028851 0.018107 0.010632 0.010632	C.043205 0.029002 0.018184 0.010668 0.010668	C+C+3+66 C+C29149 C+C29149 C+C2916259 C+C28259 C+C28762 C+C2877762 C+C287777 C+C28777777 C+C2877777777777777777777777777777777777	C.043721 C.025292 C.018331 O.C1C735 O.005892	C.043970 0.029431 0.018401 0.018401 0.015766
0.002884 v.002897 0.002909 0. 0.001415 c.001420 0.001424 0. 0.000651 0.000653 0.000655 0. 0.00282 0.000283 0. 0.020282 0.000283 0.	v.002897 0.002909 0. c.001420 0.001424 0. 0.000653 0.000655 0. c.000282 0.000283 0. 0.72	0.002909 0.001424 0.000655 0.000283 0.72	0000	002921 001429 000656 000283 0.73	0.002932 0.001433 0.000658 0.000284 0.74	N N N N N N N N N N N N N N N N N N N	0.003020 0.001465 0.000668 0.000287 0.85	2.003026 2.001467 2.0005669 2.000287 0.86	C. CC3031 C. 0C1465 C. 00C1465 C. 00C1465 C. 00C287 D. 87	0.003036 0.001470 0.000670 0.88	0.003041 0.001472 0.0006570 0.006270 0.006287
0. C97200 C.098263 0.099316 0. 0.093781 0.094796 0.095800 0. 0.084239 0.085120 0.085992 0. C.070469 0.071167 0.071856 0. C.054932 C.055435 0.055929 0.	C.098263 0.099316 0. 0.094796 0.095800 0. 0.085120 0.085992 0. 0.071167 0.071856 0. C.055435 0.055929 0.	0.099316 0.095800 0.085992 0.071856 0.071856 0.055929	00000	100360 096795 086854 072535 056416	0.101393 0.097780 0.087787 0.073205 0.073205	0.00 0.50 0.50 0.75 1.00	0.112124 0.107977 0.096458 0.079988 0.079988	0.113043 C.108848 C.097198 0.080553 0.062029	00000000000000000000000000000000000000	0.114855 0.110563 C.098653 C.088653 C.081658 C.062782	0.115747 0.111407 0.099367 0.082199 0.063148
C.039930 C.040261 0.040584 0 0.027091 0.027289 0.027481 0 5.017173 0.017281 0.017385 0 C.010182 C.010236 0.010287 0 C.0102853005700 0	C. 040261 0.040584 0 C.027289 0.C27481 0 C.017281 0.017385 0 C.010236 0.C10287 0 C.010236 0.C10287 0	0.040584 0.027481 0.017385 0.017385 0.017385 0.001287	00000	.040901 .027669 .017486 .010336	0.041211 0.027851 0.017583 0.010384 0.005743	v c v v v v v v v v v v v v v v v v v v	0.044213 0.029566 0.018469 0.010796	064451 0.029697 0.018533 0.018533 0.018255 0.00825	 In 0 0 0 0, In 0 0 0 0, In 0 0 0 0, In 0 0 0, In 0 0, In 0 0, In 0 0, In 0, <li< td=""><td>0.044910 0.024948 0.018656 0.018656 0.010879 0.005950</td><td>0.045132 0.03C068 C.018715 0.010905 0.005960</td></li<>	0.044910 0.024948 0.018656 0.018656 0.010879 0.005950	0.045132 0.03C068 C.018715 0.010905 0.005960
0.002942 0.002952 0.002961 0 0.001437 0.001441 0.001444 0 0.000659 0.00666 0.000662 0 0.000284 0.000285 0.000285 0	0.002952 0.002961 0 C.001441 0.001444 0 C.00669 0.000662 0 C.00285 0.00285 0	0.002961 0.001444 0.000662 0.000285 0	00 00	.002970 .001447 .000 663	0.02979 0.001450 0.000664 0.000286	8 8 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9 9	0.003045 0.001473 0.000671 0.000288	0.003049 0.001475 0.000671 0.000288	0.000000000000000000000000000000000000	C.003057 C.001477 C.00672 C.00288	C. C03060 0. 001478 0. 00C672 0. 00C588

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- 250 -Annex 4.3 (c)

Annex 4.3 (d)

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A Function for Computing Bivariate Normal Probabilities (cont.) Table B of T(h, a)

h	0.90	0.91	0.92	0.93	0.94
0.00	0 • 116631	0.117506	0.118372	0.119230	0•120079
0.25	0 • 112243	0.113069	0.113887	0.114696	0•115497
0.50	0 • 100073	0.100770	0.101458	0.102138	0•102810
0.75	0 • 082731	0.083256	0.083772	0.084281	0•084783
1.00	0 • 063507	0.063859	0.064205	0.064544	0•064877
1.25	0.045348	0.045559	0.045766	0.045967	0.046163
1.50	0.030185	0.030298	0.030408	0.030514	0.030617
1.75	0.018771	0.018825	0.018877	0.018927	0.018975
2.00	0.010929	0.010952	0.010974	0.010995	0.011015
2.25	0.005969	0.005978	0.005986	0.005994	0.006001
2.50	0.003063	0.003066	0.003069	0.003072	0.003074
2.75	0.001479	0.001480	0.001481	0.001482	0.001482
3.00	0.000672	0.000673	0.000673	0.000673	0.000673
3.25	0.000288	0.000288	0.000288	0.000288	0.000288
	0.95	0.96	0.97	0.98	0 • 99
0.00	0 • 120920	D.121752	0.122576	0:123392	0•124200
0.25	0 • 116290	O.117074	0.117850	0:118617	0•119377
0.50	0 • 103474	O.104129	0.104777	0:105416	0•106047
0.75	0 • 085276	O.085762	0.086241	0:086713	0•087177
1.00	0 • 065203	O.065523	0.065837	0:066145	0•066446
1.25	0.046355	0.046542	0.046724	0.046902	0.047075
1.50	0.030717	0.030814	0.030908	0.030999	0.031087
1.75	0.019021	0.019066	0.019109	0.019150	0.019189
2.00	0.011034	0.011052	0.011069	0.011086	0.011101
2.25	0.006008	0.006015	0.006021	0.006027	0.006032
2.50	0.003076	U.003078	0.003080	0.003082	0.003084
2.75	0.001483	0.001483	0.001484	0.001485	0.001485
3.00	0.000673	0.000674	0.000674	0.000674	0.000674
3.25	0.000288	0.000288	0.000288	0.000288	0.000288
	1.00	1.25	1.50	2.00	80
0.00	0.125000	0.142612	0.156416	0 • 176208	0.250000
0.25	0.120129	0.136540	0.149156	0 • 166613	0.200647
0.50	0.106671	0.119952	0.129584	0 • 141581	0.154269
0.75	0.087634	0.096973	0.103119	0 • 109570	0.113314
1.00	0.066742	0.072452	0.075735	0 • 078468	0.079328
1.25	0.047244	0.050283	0.051753	0.052673	0.052825
1.50	0.031172	0.032582	0.033134	0.033383	0.033404
1.75	0.019227	0.019798	0.019973	0.020028	0.020030
2.00	0.011116	0.011318	0.011365	0.011375	0.011375
2.25	0.006038	0.006100	0.006111	0.006112	0.006112
2.50	0.003086	0.003103	0.003105	0.003105	0.003105
2.75	0.001485	0.001490	0.001490	0.001490	0.001490
3.00	0.000674	0.000675	0.000675	0.000675	0.000675
3.25	0.000288	0.000289	0.000289	0.000289	0.000289

.



Optional Values for Significance Levels in $\, \widehat{D} \,$ and MUF Tests



Chapter 5

IMPLEMENTING INSPECTION PLANS

5.1 ON-SITE ACTIVITIES

The activities that are statistical in nature and that are performed on site, i.e., at the facility, are those activities that relate to attributes inspection, using both the attributes and variables tester, and to variables inspection. A detailed description of the kinds of activities involved is given in Section 4.2. The discussion in Section 4.2 does not address specific problems in implementation however. Such problems include the procedure for drawing a random sample, and the means of establishing defect criteria. These topics are now addressed in Sections 5.1.1 and 5.1.2 respectively. A third topic dealing with on-site inspection activities is the construction of confidence intervals based on data derived from the attributes inspection. This topic is covered in Section 5.1.3.

5.1.1 Drawing a Random Sample

It is important that items selected for measurement during an inspection be selected in a random fashion. Clearly, it is unacceptable to select only those items that are easily accessible, for then the diverter would falsify only the items that are not readily accessible. Nor should one rely on his own ability to select a random sample; this is difficult to do without introducing some nonrandom features into the selection process. In order to combat the possibility that the diverter might anticipate which items are likely to be inspected, the sample should be selected by some random process. Some means for doing this are set forth in the next three sections. In each case, it is necessary that the items in the population be numbered serially from 1 to N, and the problem is to randomly select n from these N items.

5.1.1.1 Random Number Table

Random number tables may be used to supply random numbers. Annex 5.1 (a)-(e) gives 5,000 four digit random numbers taken from [5.1]. More extensive tables are available [5.2].

Random number tables are simple to use. The procedure for using the Annex 5.1 tables is given as Method 5.1. Clearly, Method 5.1 may be applied to any set of such random numbers.

Method 5.1

Notation

N = number of items in population to be sampled

n = number of sampled items, with n < N

Mode1

In Annex 5.1, each four digit number from 0000 to 9999 is equally likely to occur, i.e., will occur with probability 0.0001 at each entry. This probability is independent of entries preceding the entry in question so that movement in the table may be in any direction (down, up, left, right). A similar statement applies if one uses only the first or last three, two, or one digits.

Results

Arbitrarily select a starting point in the random number tables of Annex 5.1, and decide upon a method of moving in the tables to select successive entries.

Determine the number of digits to use. If $1 \leq N \leq 9$, use either the first, second, third, or fourth digit of each number; if $10 \leq N \leq 99$, use either the first two, middle two, or last two digits; if $100 \leq N \leq 999$, use either the first three or last three digits. For N>9999, use all 4 digits plus the first digit in the next column, etc.

Examine each tabled value in turn and write down all numbers between 1 and N until the n items are identified. Do not duplicate numbers already listed and ignore any numbers in the table that exceed N.

Basis

The numbers tabled in Annex 5.1 meet the criteria for randomness suggested by the model. Numbers selected from this table in the fashion indicated will likewise meet these criteria.

Examples

EXAMPLE 5.1 (a)

From example 4.1 (b), 48 items are to be inspected from the total of 360 items in the stratum. For n=48 and N=360, use Method 5.1 to select the items to be inspected.

Arbitrarily start with the four digit number, 3501, in column 4 row 12 of Annex 5.1 (b). Select the numbers by moving downward in the table. Arbitrarily use the last three digits of each four digit number, since N=360 is a three digit number. The 48 three digit numbers between 001 and 360 are as follows.

183	177	216	170	256	68	9	66
29	341	53	160	100	183	178	339
279	125	93	8	237	22	148	
202	126	82	131	107	144	60	
166	354	156	-53-	1	293	297	
270	33	12	274	-156 -	116	123	
347	38	284	295	340	306	223	

Note that 51 numbers had to be selected to obtain the 48 distinct numbers since the numbers 53, 156, and 183 were duplicates, as indicated.

Many of the pocket calculators available to the inspector either have builtin random number generators or else they can be programmed very easily to generate random numbers. Further, the problem illustrated in Example 5.1 (a) where so many numbers had to be ignored because they exceeded N=360 can be circumvented quite easily so that virtually all of the numbers generated are useable. (A modification may be made to Method 5.1 to accomplish this also, but it is usually simpler when using random number tables to simply ignore the unwanted numbers.)

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Method 5.2 indicates how a pocket calculator may be used to generate random numbers.

Method 5.2

Notation

N and n are defined as in Method 5.1.

d = number of digits in N

Mode1

The numbers generated by this method are uniformly distributed on the interval 0 to 1. By using the first d digits and ignoring the decimal point, random numbers from 1 to N are created.

Results

Assume initially that the pocket calculator is not programmable. Then, the random numbers from 1 to N may be generated as follows.

Calculate $m = 10^{d}/N$, rounded down to integer (eq. 5.1.1)

Select an arbitrary "seed number" between 0 and 1 and containing d digits. Call this number f_0 , and enter it in the calculator.

Calculate $g_1 = 997 f_0$ (eq. 5.1.2) Define $f_1 =$ fractional part of g_1

Calculate $h_1 = f_1/m$

Ignore the decimal in h_1 . The first d digits is the first random number from 1 to N. If this number should exceed N, ignore it. To find the next number, repeat the above steps, replacing f_0 by f_1 , f_1 by f_2 , g_1 by g_2 , and h_1 by h_2 .

If the pocket calculator is programmable, the above procedure may be programmed very easily to generate random numbers. This is illustrated for the HP-67 pocket calculator. The specific programming steps will depend on which calculator is available.

(eq. 5.1.3)

Programming Steps: RCL 2 RCL 0 x g frac STO 2 RCL 1 $\frac{1}{2}$ h rtn To execute the program, make the following entries. DSP d 997 STO 0 m STO 1 f_0 STO 2 (The arbitrary seed)

Then, repeatedly initiate the program to generate the numbers, ignoring the decimal. If a given number exceeds N, ignore it. Also, as with Method 5.1, numbers that are duplicates of numbers previously generated must be ignored.

Basis

The algorithm used for generating the random numbers is adapted from the algorithm of Reference [5.3]. The adaptation consists of dividing by m to reduce the number of generated numbers that exceed N. As stated in [5.3], the generator in question passes the chi-square frequency test for uniformity, and the serial and run tests for randomness. Of course, with each application, a different seed number, f_0 , must be used. This is true also if the calculator in question has a built-in random number generator.

Examples

EXAMPLE 5.2 (a)

Redo Example 5.1 (a) using Method 5.2. The parameter values are

N = 360 d = 3m = integral part of $10^3/360 = 2$

Choose the arbitrary seed number

 $f_0 = 0.298$ (contains d=3 digits)

In applying Method 5.2, all numbers generated by the algorithm are listed below. Those that are deleted either because they exceed 360 or because they are duplicated are crossed out until the n=48 useable numbers are generated.

53	233	213	493	73	4 53	133	113	393
341	301	- 361	21	281	141	101	161	321
477	97	-417	437	157	77	197	17	37
69	209	249	189	29	269	409	449	
293	373	253	433	413	193	273	153	
121	381	241	201	261	421-	181	41	
137	357	277	-397 -	217	237	457	377	
89	429	169	309	349	289	129	369 -	

- 25% -

5.1.1.3 Computer

The Agency has computer programs available that facilitate the drawing of random samples. These are especially useful if the inspector has good knowledge of his inspection parameters, N and n, prior to leaving for the facility. In this event, he can request that he be supplied with a listing of randomly selected items in advance.

Available computer programs are of two types. In the first type, one inputs values for n and N, and the n items to be inspected are printed out. These are listed in numerical order to facilitate inspection. An example of computer output for n=65 and N=1200 is shown

			18	31	39	70	91	97	98
100	104	129	139	146	155	161	237	262	280
281	285	297	306	309	330	335	336	339	349
362	365	383	385	392	461	488	515	533	597
645	689	696	700	709	729	740	757	781	815
829	835	865	902	911	920	923	944	970	978
1011	1032	1048	1057	1073	1080	1162	1179		

In some inspection situations, a different kind of sample selection process may be simpler to implement. For example, if the population items are stacked in some sort of array, a skip-sampling procedure may be used conveniently. With skip sampling, the sampling scheme indicates how many items are skipped, then how many are inspected, then how many are skipped, etc. A computer program for this time of inspection sampling is also available and may be used, again if the inspector has advance information on the inspection parameters, N and n.

An example of computer output for skip sampling with N=1200 and n=65 is shown. If this specific plan were implemented, the inspector would decide on how he would order the array of items. Then, he would skip 2 items, sample 1, skip 12, sample 1, skip 16, sample 1, etc.

For either type of random sample selection, once a set of computer-generated random numbers have been used on an inspection, they should not be reused at the same facility. A new computer request should be made for each application.

Population: 1200

Sample	Skip	Sample	Skip	Sample	Skip
A = 1 A = 1	B = 2 B = 12 B = 16 B = 15 B = 18 B = 33 B = 13 B = 13 B = 13 B = 10 B = 19 B = 2 B = 8 B = 60 B = 11 B = 25 B = 19 B = 23 B = 7 B = 5 B = 12 B = 3	C = 1 C = 1	D = 25 D = 16 D = 81 D = 23 D = 23 D = 23 D = 48 D = 33 D = 24 D = 52 D = 7 D = 3 D = 4 D = 52 D = 15 D = 27 D = 8	$E = 1 \\ E = $	F = 2 F = 23 F = 15 F = 32 F = 23 F = 23 F = 23 F = 23 F = 23 F = 35 F = 74 F = 10 F = 10 F = 10 F = 10 F = 20 F = 20
н — I	D - Z	ι – 1	U - 1/		

5.1.2. Attributes Inspection Defect Criteria

In Section 4.2, the concept of attributes inspection was discussed, and it was pointed out there that in attributes inspection, each item inspected is classified as being either acceptable or a defect. Attributes inspection activities were described in Section 4.2.1. Three inspection activities described there, activities 3, 5 and 6 require that a defect be defined, i.e., that defect criteria be established. Activity 3 deals with inspection to detect recording and/or calculational mistakes, and the problem of defining defect criteria for this activity and the effect of such mistakes on MUF are considered in Section 5.1.2.1. Section 5.1.3.1 considers the confidence interval for the number of mistakes. The effect of defects observed in connection with activity 5 and 6 of Section 4.2.1 are treated in exactly the same way in Sections 5.1.2.1 and 5.1.3.1, except, the basis for the defect criteria are different as described in Section 5.1.2.2 for attributes inspection and Section 5.1.2.3 for variables inspection.

5.1.2.1 Effects of Mistakes (Defects) on MUF

Defects observed in checking source data for recording and/or calculation mistakes and the large or medium defects observed during attributes and variables inspection are treated in this section in order to determine their effect on MUF. It may be impossible to detect and eliminate all mistakes in recording or measurement when there are thousands of entries in a material balance period. One hundred percent inspection may also be impossible. Therefore it is desirable to require that the net effect of mistakes and defects on the facility MUF be evaluated. Method 5.3 to follow provides a procedure to determine the quantitative effect of medium and large defects on MUF. Small mistakes in records are also considered by this method, however Method 5.3 will tolerate many more of the small defects than it will medium or large defects. When a mistake is found, the records for that item should be corrected. However, since only a sample of items are checked, the likelihood (or at least the possibility) exists that other mistakes still exist that will affect the facility MUF. In Method 5.3, the random variable Z is introduced. This is the adjusted sum of defects as they affect MUF in their combined effects. The mean and variance of Z are calculated under specific assumptions about the probability distribution of defects. A confidence interval may then be constructed about the true mean of Z to assess the overall impact of the defects on MUF in a probabilistic sense. The evaluation of defects is made to combat the diversion strategy in which "mistakes" are made to conceal diversion.

Method 5.3

Notation

- N_k = number of items in stratum k
- n_{ak} = sample size for attributes inspection in stratum k
- n_{dk} = observed number of defects in stratum k
- - U_k = largest value for d_{ki} in stratum k
- L_k = smallest value for d_{ki} in stratum k
- a_k = a constant, equal to +1 if stratum k is an input or beginning inventory stratum and equal to -1 otherwise.

Model

Under the assumption that mistakes are unintentional, it is assumed that d_{ki} is uniformly distributed in the interval from $x_{0k}-\theta_k$ to $x_{0k}+\theta_k$. Estimates are found for x_{0k} and for θ_k for each stratum in which defects are found in the inspection.

Results

Estimate x_{0k} and θ_k by the following equations.

$$x_{ok} = (L_k + U_k)/2$$
(eq. 5.1.4)

$$\theta_k = (U_k - L_k)/2(0.05)^{1/n} dk$$
(eq. 5.1.5)

These equations apply for $n_{dk} \ge 2$. For $n_{dk} = 1$, set $x_{0k} = d_{k1}$ and θ_k is given by (eq. 5.1.5) with $(U_k - L_k)$ replaced by $|d_{k1}|$. For $n_{dk} = 0$, the stratum is not included in further calculations.

The quantity Z is given by

$$Z = \sum_{k=1}^{K} a_k h_k n_{dk} x_{ok}$$
 (eq. 5.1.6)

where

$$h_k = (N_k - n_{ak})/n_{ak}$$
 (eq. 5.1.7)

if the n_{dk} mistakes are corrected for, or

$$h_{k} = N_{k}/n_{ak}$$
 (eq. 5.1.7a)

if the n_{ck} mistakes are not corrected for.

The variance of Z is

$$V(Z) = 1/3 \sum_{k=1}^{K} h_k^2 \theta_k^2 n_{dk}$$
 (eq. 5.1.8)

A two-standard deviation confidence interval on Z is given by

 $Z \pm 2 \sqrt{V(Z)}$

If Z is approximately normally distributed, which will occur in a limiting sense as a result of the central limit theorem, then the above confidence interval is an approximate 95 % interval. The interpretation of this interval is very similar to that for MUF or D as described in Section 5.2.3.1. In fact, the intervals for MUF, Z and D should be compared with each other. Z represents the result of the Agency's attribute verification of MUF and D is the result of the variables verification. If Z is much larger than MUF or D then one might conclude that the effect of mistakes (defects) is much greater than normal measurement errors. Under such circumstances the evaluation of MUF may not be meaningful until the frequency and magnitude of such defects can be brought under control at the facility level by improvements in accounting practices and measurement control programs. Of course, the Agency must also make sure that the observed mistakes (defects) are not caused by misapplication of their own verification procedures.

Basis

First, consider the basis for (eq. 5.1.4) and (eq. 5.1.5). Dropping the k subscript for simplicity, it is assumed that the size of a mistake is uniformly distributed between $x_0 - \theta$ and $x_0 + \theta$. The mean of this distribution is x_0 , and it is estimated by the mid-range, (eq. 5.1.4). To estimate θ , equate the probability that all nd observations will fall between L and U, given $\beta=0.05$, and solve for θ . The quantity θ is then the solution of the equation:

$$\left(\frac{U-L}{2\theta}\right)^{nd} = 0.05$$
 (eq. 5.1.9)

The solution is given by (eq. 5.1.5).

Given x_0 , which represents the average difference per mistake in the stratum, the average difference per inspected item is

 $n_d x_o / n_a$

The total number of uninspected items is $(N-n_a)$, so the extrapolated net effect on MUF of the mistakes in the stratum is given by

a $(N-n_a)n_d x_o/n_a$

if the observed mistakes n_d were corrected for.

Upon replacing $(N-n_a)/n_a$ by h and summing over the strata, the result is (eq. 5.1.6). However, h should be replaced by N/n_a if the observed mistakes n_d were not corrected for.

To compute the variance of Z, use the fact that the variance of d_{i} is, from reference [5.4].

 $V(d_i) = (2\theta)^2/12 = \theta^2/3$

The variance of $n_{\rm d}$ such values is simply $n_{\rm d}$ times V(d_i), and (eq. 5.1.8) follows immediately.

Examples

EXAMPLE 5.3 (a)

In the low enriched uranium fuel fabrication facility of Example 3.3 (a), say that the attribute sample sizes for the 7 strata are 470, 470, 3, 15, 8, 15, and 8 respectively. Review the following calculational mistakes detected during the inspection and make a judgement as to their acceptability.

Stratum	<u>Facility</u>	Inspector	_a _{ki}
1	20.116 19.853 20.231 21.021 19.899 20.072 19.847 20.128	20.143 21.356 20.328 22.021 19.987 19.514 19.184 20.170	-0.027 -1.503 -0.097 -1.000 -0.088 0.558 0.663 -0.042
2	20.019 5.015 5.133 4.978 5.024 4.961	20.103 4.599 5.142 4.993 4.712 4.950	-0.084 0.416 -0.009 -0.015 0.312 0.011
4	4.120	4.348	-0.228
7	5.013	5.103	-0.090

The following values are found for L_{μ} and U_{μ} $U_1 = 0.663$ $L_1 = -1.503$ $L_2 = -0.015$ $U_2 = 0.416$ From (eq. 5.1.4) and (eq. 5.1.5), $x_{01} = -0.420$ $\theta_1 = 1.511$ $\theta_2 = 0.392$ $x_{0,2} = 0.201$ For strata 4 and 7, $x_{04} = -0.228$ $x_{0.7} = -0.090$ θμ = 2.280 $\theta_7 = 0.900$ Then, by (eq. 5.1.7), $h_1 = (12,000 - 470)/470 = 24.532$ $h_2 = (47,760 - 470)/470 = 100.617$ $h_4 = (1800 - 15)/15 = 119.000$ $h_7 = (800 - 8)/8 = 99.000$ Z is calculated by (eq. 5.1.6) Z = (24.532)(9)(-0.420) + (100.617)(5)(0.201) + (119.000)(1)(-0.228) ++ (99.000)(1)(-0.090) = -212 kg U(Note that Z is negative, a direction favorable to a diverter). The variance of Z is calculated from (eq. 5.1.8) $V(Z) = \frac{1}{3} [(24.532)^2 (1.511)^2 (9) + \dots + (99.000)^2 (0.900)^2 (1)]$ $= 101,698/3 = 33,899 \text{ kg}^2 \text{ U}$

The two-standard deviation confidence interval is

$$-212 + 2\sqrt{33}, \overline{899} = -212 + 368 \text{ kg U}$$

or (-580, 156)

Note that:

- (1) The confidence interval embraces zero, i.e., there is no reason to believe that the net effect on MUF due to these mistakes differs from zero. Note, however, that $\sqrt{V(Z)}$ is larger than $\sqrt{V(MUF)} = 212 \text{ kg U from Example 3.5(a)}$.
- (2) The lower limit (-580), is smaller than the goal quantity for this type facility. Thus, these small mistakes in recording do not have a large effect on MUF.

5.1.2.2 Large Defects--Attributes Tester

For planning purposes, a gross or large defect was defined in Section 4.3.1 to be of size equal to the average element weight in the stratum, this weight being denoted by \bar{x}_k . However, for many attributes testers, a discrepancy need not be as large as \bar{x}_k to be detected, since detection simply implies that the tester has determined that the facility value associated with the item in question is incorrect, with high probability. As an illustration, if the attributes test involves tipping a container to see if it has the listed amount of material in it, then quite clearly the defect need not be of size \bar{x}_k (i.e., empty container) to be detected. Quite likely, if the weight were off by, say, 50% or more, this would be detected as a significant discrepancy, i.e., it would be classified as a defect.

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The foregoing discussion leads to the following definition of a large defect.

Definition: In attributes inspection with the attributes tester, a defect is a discrepancy between the facility and the inspector values that is larger than $\gamma_k \ \bar{x}_k$ in absolute value.

To further explain this definition, if the tester in question has an associated error of measurement, then γ_k may be a multiple of the measurement error standard deviation. On a relative basis, let δ_k be the standard deviation of the attributes tester. Then, $\gamma_k = 4\delta_k$ would be a reasonable value for γ_k since any discrepancy larger than 4 measurement error standard deviations is almost certainly a real discrepancy, one that cannot be explained as being due to measurement errors. This relationship between δ_k and γ_k assumes that the facility error of measurement is negligible in size compared with the inspector measurement error for the attributes tester. If this is not the case, then δ_k would be the standard deviation of the difference between the facility and the inspector value, i.e., would be the square root of the sum of the squared standard deviations for both parties.

This discussion may be summarized as Method 5.4, the procedure for defining a defect in attributes inspection with the attributes tester.

Method 5.4

Notation

- \bar{x}_{ν} = average element weight for an item in stratum k
- γ_k = a fractional value which, when multiplied by \bar{x}_k , defines a dispancy that is larger in absolute value than can be explained by errors of measurement
- δ_{k_1} = relative random error standard deviation for facility measurement
- δ_{k2} = relative random error standard deviation for inspector measurement

Note: The definition for \bar{x}_k implies that the characteristic being measured is the element weight. More generally, \bar{x}_k relates to any measured characteristic being checked by the inspector, e.g., the enrichment being verified by a stabilized assay meter (SAM).

Model

When relating γ_k to δ_{k1} and δ_{k2} , it is implicitly assumed that a discrepancy due to measurement errors is normally distributed.

However, this is not an important assumption since the factor of 4 used in (eq. 5.1.10) has significance for distribution functions other than the normal distribution, i.e., it is quite unlikely that an observation will differ from the mean by more than 4 standard deviations even for non-normal populations that might occur.

Results

Assuming that the attributes tester in question has an associated measurement error, calculate

$$\gamma_{k} = 4(\delta_{k1}^{2} + \delta_{k2}^{2})^{1/2}$$
 (eq. 5.1.10)

Calculate the product ${}^{\gamma}k\bar{k}k$. If a discrepancy exceeds this product in absolute value, it is labeled a defect. If a zero-acceptance sampling plan is being utilized, then discovery of at least one defect leads to "rejection" of the stratum in question, and whatever action such rejection implies (see Section 4.3.1). Procedures for evaluation of the effect of discrepancies on the material balance are given in Section 5.1.3, Confidence Interval for Defects and Section 5.1.2.1, Effect of Mistakes (Defects) on MUF.

If the particular attributes tester cannot be characterized as having an error of measurement in the strict sense of the word, assign a value to γ_k such that there is little question but that a discrepancy larger in absolute value than $\gamma_k \bar{x}_k$ is unexplainable as being due to errors in measurement.

Basis

For γ_k defined by (eq. 5.1.10), and assuming measurement errors to be normally distributed, a discrepancy as large as $\gamma_k x_k$ would occur due to chance alone less than 7 times out of 100,000. Thus, a discrepancy larger in absolute value is correctly labeled a defect with very high probability.

Examples

EXAMPLE 5.4 (a)

With reference to example 4.1 (a), a total of 470 items (containers of UO_2 powder) are to be inspected. Suppose that the attributes inspection consists of verifying the enrichment with a stabilized assay meter (SAM), which has a relative error standard deviation of 0.025 (2.5% relative). The problem is to define a defect.

In applying (eq. 5.1.10), $\delta_{k^2} = 0.025$. The value for δ_{k^1} is negligibly small and may be ignored since the facility value is based on a mass spectrometer measurement. Therefore,

$$\gamma_{k} = (4)(0.025) = 0.10$$

To assign a value to \bar{x}_k , note from Example 3.6 (a) that the UO₂ powder is at 3 enrichments: 3.25%, 2.67%, and 1.52%. Therefore, 3 different defect criteria are established.

For the 3.25% containers, $\gamma_k \bar{x}_k = 0.325\%$ U-235 For the 2.67% containers, $\gamma_k \bar{x}_k = 0.267\%$ U-235 For the 1.52% containers, $\gamma_k \bar{x}_k = 0.152\%$ U-235

5.1.2.3 Medium Defects--Variables Tester

The discussion in this section perhaps more logically belongs in Section 5.2 dealing with post-inspection activities as opposed to on-site activities because the final data analysis will probably have to depend on awaiting the results from the laboratory. However, the statistical aspects of this problem are closely related to those discussed in Section 5.1.2.2, and on that basis, it is reasonable to consider the subject at this time. Further, variables measurements may, in fact, be performed nondestructively so that in some cases, the evaluation discussed here could be performed on site.

As was the case with gross defects, there is a distinction between a medium defect as defined for inspection planning purposes and a medium defect defined in implementation. In planning, the inspector wants assurance that his sample size is large enough to combat the diverter's best strategy, that of falsifying given containers as much as feasible to escape detection with the attributes tester. From this viewpoint, defect size was related to the measurement error of the <u>attributes</u> tester. On the other hand, in implementation, any discrepancy that cannot be explained as being due to the measurement errors of the <u>variables</u> tester, and of the facility measurement, is labeled a defect.

Previous results may be used in defining a defect specifically for a given stratum. The computational formulas given by Methods 3.8, 3.9, and 3.10 are adapted to apply to a single item. Method 5.5 gives the procedure for defining a defect when the variables tester is used in the attributes mode.

Method 5.5

Notation

The notation is given in Sections 3.4.3.2 and 3.5.3.2. Further notation is as follows:

- d_{ki} = facility value minus inspector value for element weight of item i in stratum k
- x ikqpt = facility value for element weight of item i in stratum k based on facility measurement method q for the bulk measurement, p for sampling, and t for analytical
- y_{ikapt} = defined as x_{ikapt}, except it is an inspector value

Model

Under the hypothesis that discrepancies are due to measurement errors, it is implicitly assumed that a given discrepancy is normally distributed inasmuch as a discrepancy larger than four standard deviations is concluded to occur with very small probability due to chance alone. If the assumption is valid, then this probability can be calculated exactly. There is little reason to question the validity of this assumption in most applications but, in any event, it is not an important assumption. For any reasonable probability distribution likely to be encountered in this application, a four standard deviation discrepancy will occur with very low probability if measurement error is the only cause of the discrepancy. The actual value of this "low" probability is not really important.

Results

Calculate the following quantities:

$$V_{rx}(d_{ki}) = x_{ikqpt}^{2} \left(\delta_{rq \cdot \cdot x}^{2} + \delta_{r \cdot p \cdot x}^{2} / r_{k} + \delta_{r \cdot \cdot tx}^{2} / c_{k} r_{k} \right) \qquad (eq. 5.1.11)$$

$$V_{ry}(d_{ki}) = y_{ikqpt}^{2} \left(\delta_{rq \cdot \cdot y}^{2} + \delta_{r \cdot p \cdot y}^{2} / v_{k} + \delta_{r \cdot \cdot ty}^{2} / a_{k} v_{k} \right) \qquad (eq. 5.1.12)$$

$$V_{r}(d_{ki}) = V_{rx}(d_{ki}) + V_{ry}(d_{ki})$$
 (eq. 5.1.13)

$$V_{gx}(d_{ki}) = x_{ikqpt}^{2} \left(\delta_{gq \cdot \cdot x}^{2} + \delta_{g \cdot \cdot tx}^{2} \right) \qquad (eq. 5.1.14)$$

$$V_{gy}(d_{ki}) = y_{ikqpt}^{2} \left(\delta_{gq \cdots y}^{2} + \delta_{g \cdots ty}^{2} \right)$$
 (eq. 5.1.15)

$$V_{g}(d_{ki}) = V_{gx}(d_{ki}) + V_{gy}(d_{ki})$$
 (eq. 5.1.16)

$$V_{sx}(d_{ki}) = x_{ikqpt}^{2} \left(\delta_{sq \cdot \cdot x}^{2} + \delta_{s \cdot \cdot tx}^{2} \right) \qquad (eq. 5.1.17)$$

$$V_{sy}(d_{ki}) = y_{ikqpt}^{2} \left(\delta_{sq \cdot \cdot y}^{2} + \delta_{s \cdot \cdot ty}^{2} \right) \qquad (eq. 5.1.18)$$

$$V_{s}(d_{ki}) = V_{sx}(d_{ki}) + V_{sy}(d_{ki})$$
 (eq. 5.1.19)

$$V(d_{ki}) = V_{r}(d_{ki}) + V_{g}(d_{ki}) + V_{s}(d_{ki})$$
 (eq. 5.1.20)

If a discrepancy, d_{ki} , exceeds $4\sqrt{V(d_{ki})}$ in absolute value, it is labeled a defect. (Physically, $\sqrt{V(d_{ki})}$ is the standard deviation of a given difference. In view of the dominance of certain type errors, it may not be necessary to calculate all the above components; some may be ignored in practice). Procedures for the evaluation of the effect of discrepancies on the material balance are given in Section 5.1.3, Confidence Intervals for Defects and Section 5.1.2.1, Effect of Mistakes (Defects) on MUF. If the assumption of normality is valid, then a discrepancy as large as $4\sqrt{V(d_{kj})}$ would occur due to chance alone less than 7 times out of 100,000. Thus, a discrepancy larger in absolute value is correctly labeled a defect with very high probability.

It is noted that the results were given on the basis that the item characteristic in question is the element weight. It is simple to modify the key equations should another characteristic be under investigation. Only those measurement operations that affect the difference statistic are, of course, included in the calculations. It may be that additional terms would be required, e.g., if the item characteristic is isotope weight rather than element weight. The results in Section 3.5.4, appropriately modified to apply to the single item, are pertinent in this event.

The calculations indicated by the equations seem quite involved. However, they may be applied quite easily by noting that: (1) for error propagation purposes, Xikqpt and Yikqpt are essentially identical so that various pairs of equations may be combined; (2) some error variances are zero and will hence not appear in the equations; and (3) the calculations for $V_r(d_{ki})$, $V_g(d_{ki})$, and $V_s(d_{ki})$ need not actually be performed; they are intermediate values leading up to the final (5.1.20).

Examples

EXAMPLE 5.5 (a)

The low enriched uranium fuel fabrication facility of example 3.3 (a) is inspected. In the UO_2 powder stratum, 36 measurements are made of item element weight, using the data of example 3.8 (a) (12 batches sampled with 3 items weighed per batch). Determine the defect criterion for the variables tester in the attributes mode. Use the nominal value of 20 kg U for x_{ikqpt} and y_{ikqpt} for all items.

The following parameter values are given in prior example. From example 3.3 (a), for the facility:

q = 1 p = 1 t = 1 k = 1 $r_1 = 5$ $c_1 = 1$ $\delta_{r_1 \cdots x} = 0.000658$ $\delta_{r_1 \cdots x} = 0.000531$ $\delta_{r \cdots 1x} = 0.000433$

From example 3.5 (a)

$$\delta_{s_1 \cdots s_n} = 0.000439$$
 $\delta_{s_1 \cdots s_n} = 0.000571$

From example 3.8 (a), for the inspector

q = 1	p = 1	t = 1
$v_1 = 2$	$a_1 = 2$	
$\delta_{r1 \cdots y} = 0.000658$	$\delta_{r \cdot 1 \cdot y} = 0.000531$	$\delta_{r \cdot \cdot 1y} = 0.000433$

From example 3.9 (a), $\delta_{g \cdot 1y} = 0.000544$ From example 3.10 (a), $\delta_{s1 \cdot y} = 0.000439$ $\delta_{s \cdot 1y} = 0.000172$

The equations, (eq. 5.1.11) - (eq. 5.1.20) are now applied to give the following results.

 $V_{rx}(d_{1i}) = 0.000211 \qquad V_{ry}(d_{1i}) = 0.000248 \qquad V_{r}(d_{1i}) = 0.000459$ $V_{gx}(d_{1i}) = 0 \qquad V_{gy}(d_{1i}) = 0.000118 \qquad V_{g}(d_{1i}) = 0.000118$ $V_{sx}(d_{1i}) = 0.000208 \qquad V_{sy}(d_{1i}) = 0.000089 \qquad V_{s}(d_{1i}) = 0.000297$

 $V(d_{1i}) = 0.000874$

4
$$\sqrt{V(d_{1j})}$$
 = 0.118 kg U, defect criterion

5.1.3 Confidence Intervals for Defects

5.1.3.1 Numbers of Defects

Upon completion of the attributes inspection, a confidence interval may be calculated for the number of defects in the population, (or, in the case of mistakes, the number of mistakes). This interval may be helpful in reaching a decision as to the need for further inspection in a given stratum. A procedure for estimating the effect of the defects on MUF is given in Section 5.1.2.1.

The methods for constructing a confidence interval are given. Method 5.6 applies when zero defects are observed. Method 5.7 is applicable for ≥ 1 observed defects.

Method 5.6

Notation

- N = number of items in population
- n = sample size
- $1-\beta$ = confidence coefficient
 - U = upper limit of confidence interval

Mode1

The random variable is the number of defects found in a sample of n items selected at random from a population of N items containing a given number of defects. It is well known that this random variable follows a hypergeometric density function [5.5].

Results

With $100(1-\beta)$ % confidence, the upper limit on the number of defects in the population, given that no defects are observed in the sample, is

$$U = 0.5(1-\beta^{1/n})(2N-n+1)$$
 (eq. 5.1.21)

Basis

If U is the number of defects in the population of N items, find that value for U such that the probability of observing zero defects in the sample of size n is β . This defines the $100(1-\beta)\%$ upper confidence limit on the number of defects.

The appropriate value for U is the solution of the equation:

$$\frac{\begin{pmatrix} U \\ 0 \end{pmatrix} \begin{pmatrix} N-U \\ n \end{pmatrix}}{\begin{pmatrix} N \\ n \end{pmatrix}} = \beta$$
 (eq. 5.1.22)

The left hand side is

$$\frac{(N-U)!}{(N-U-n)!} \frac{(N-n)!}{N!} = \frac{(N-U)(N-U-1)\cdots(N-U-n+1)}{N(N-1)\cdots(N-n+1)}$$
$$= (1 - \frac{U}{N})(1 - \frac{U}{N-1})\cdots(1 - \frac{U}{N-n+1})$$

These are n factors in this expression. The "middle" factor is

$$(1 - \frac{2U}{2N-n+1})$$

so that the approximate value for β is

$$\beta \approx (1 - \frac{2U}{2N - n + 1})^n$$
 (eq. 5.1.23)

Solving this for U gives (eq. 5.1.21).

EXAMPLE 5.6 (a)

With reference to example 4.1 (b), in the mixed oxide powder stratum of the mixed oxide fuel fabrication facility, 48 items out of the 360 total items were inspected in attributes sampling. No defects were found. What is the 95% upper confidence limit on the number of defects in the remaining 312 items?

The parameter values are: N = 360 n = 48 $\beta = 0.05$ By (eq. 5.1.21), the limit is $U = 0.5 (1-0.05^{1/48})(720-48+1)$ = 20.4, or 21 items

Method 5.7 is applicable when ≥ 1 defects are observed in the sample.

Method 5.7

Notation

N, n, $(1-\beta)$, and U as in Method 5.6

d = number of defects observed in the sample

Model

See Method 5.6

Results

Define $t_{1-\beta}$ by

$$\frac{1}{\sqrt{2\pi}} \int_{-\infty}^{t_{1-\beta}} e^{-z^2/2} dz = 1-\beta \qquad (eq. 5.1.24)$$

That is, the area under the standardized normal curve from -- ∞ to t is (1-_b).

Calculate the quantities z, x, A, B, C, and p using the following equations.

z = d+0.5 (eq. 5.1.25) x = 1 - (n-1)/(N-1) (eq. 5.1.26) $A = n^{2} + t_{1-\beta}^{2} nx$ (eq. 5.1.27)

$$B = nz + 0.5t_{1-\beta}^2 nx \qquad (eq. 5.1.28)$$

$$C = z^2$$
 (eq. 5.1.29)

$$p = (B + \sqrt{B^2 - AC})/A$$
 (eq. 5.1.30)

Then, the upper limit, U, is given by

$$U = [pN + 0.5] - 1$$
 (eq. 5.1.31)

where the brackets indicate that the largest integer contained in (pN+0.5) should be used. Note that since U is the limit on the number of defects in the lot, then (U-d) is the limit for the (N-n) uninspected items.

Basis

The normal approximation to the hypergeometric distribution forms the basis for this result. See reference [5.6].

Examples

EXAMPLE 5.7 (a)

With reference to example 5.6 (a), suppose that 2 defects were found in the sample of 48 items. What is the 95% upper limit on the number of defects in the remaining 312 items?

N = 360 n = 48 β = 0.05 d = 2 t_{1-\beta} = 1.645 z = 2.5 x = 0.8691 A = 2416.8867 B = 176.4434 C = 6.25 p = 0.1254 U = 45.14 -1 = 44 defects, including those found in the sample. U-d = 42, required limit

5.2 POST-INSPECTION ACTIVITIES

Generally speaking, the statistical activities discussed in Section 5.1 are those that would be performed on-site during the course of an inspection. In Section 5.2, further statistical analyses are described, those that would normally be performed after the physical inspection has been completed and the appropriate inspection data accumulated.

Not all of the statistical techniques described need be performed on any given inspection. The collection of techniques are those available to the inspector for his use in evaluating the data, and include those techniques most likely to be utilized, if not in connection with each phase of each inspection, certainly frequently enough to warrant inclusion here.

In Section 5.2.1, supplemental statistical tests of hypotheses are described (see Section 4.5.1 for the distinction between supplemental and primary tests). These tests include the test for normality, tests for randomness, variance tests, and the test for the significance of \hat{D}_k , the difference statistic in stratum k. The principal statistical tests are described in Section 5.2.2. These include the test on \hat{D}_k , the test on (MUF- \hat{D}). Finally, the construction of confidence intervals for the facility MUF and for the inspector's estimate of the facility MUF, (MUF- \hat{D}), are treated in Section 5.2.3.

5.2.1 Supplemental Tests of Hypotheses

5.2.1.1 Normality Tests

Various statistical procedures to be applied in the analyses of variables data are based on the assumption of normality. The effect of a failure in this assumption on the validity of the procedure depends on the nature and degree of nonnormality and on the specific statistical procedure involved. Tests for normality are given in Methods 5.8 and 5.9. One of these tests may be applied whenever there is a question on the validity of this assumption. If the test results indicate that the assumption is of questionable validity, then guidance should be sought from a statistical expert to determine the effects of the non-normality on the statistical procedures to be applied. Guidance can also be given on the need to modify the procedures to account for the non-normality. Further, non-normality of the data in question may be indicative of unindentified variables affecting the results, and may therefore provide valuable insight into the structure of the data. For example, data falsifications introduced by a diverter, if not carefully and thoughtfully introduced, could perhaps be detected by a test of normality. Of course, it doesn't necessarily follow that detection of non-normality in the data signals diversion; it merely signals the need to perform a more careful investigation of the data in order to uncover the reasons for the departure from normality.

There are a number of statistical tests of normality that have been suggested. Some require large sample sizes and are therefore generally inappropriate for most situations likely to be encountered by the inspector. In the absence of knowledge about the alternative hypothesis, i.e., about the particular type of non-normality likely to exist, it is advisable to apply a statistical test that is generally sensitive to all kinds of non-normality. The so called W-test for normality is such a test. It is applicable for sample sizes up to 50, and is described in Method 5.8. For sample sizes larger than 50, a related test referred to as the D⁻ test may be applied. Method 5.9 describes this test.

Method 5.8

Notation

 $x_1, x_2, \dots, x_n =$ sample values for some random variable, ordered such that $x_1 < x_2 < \dots < x_n$

Model

Under the null hypothesis, the data are normally distributed. The distribution under the alternative hypothesis is not specified.

Results

Using the coefficients a_{n-i+1} given in Annex 5.2, calculate

$$b = a_{n}(x_{n}-x_{1})+a_{n-1}(x_{n-1}-x_{2})+\cdots+a_{n-k+1}(x_{n-k+1}-x_{k}) \quad (eq. 5.2.1)$$

where k = n/2 for even n
= (n-1)/2 for odd n

Calculate

$$S^{2} = \sum_{i=1}^{n} x_{i}^{2} - \left(\sum_{i=1}^{n} x_{i}\right)^{2}/n$$
 (eq. 5.2.2)

(Note that S^2 is simply (n-1) times the calculated variance of the x_i values.)

Calculate

$$w = b^2/S^2$$
 (eq. 5.2.3)

A small value for W is indicative of non-normality. If W is less than the critical value given in Annex 5.3 for a given significance level, α , conclude that the data are not normally distributed.

Basis

The W-test for normality is covered in [5.7].

Examples

EXAMPLE 5.8 (a)

In the low enriched uranium fuel fabrication plant treated in previous examples, $19 UO_2$ powder cans in stratum 1 are measured for total uranium by the inspector. His results are compared item by item with the facility values by noting the difference in uranium weights. These facility-minus-inspector values are given in grams

uranium. Test the hypothesis that the differences are normally distributed, using a significance level α of 0.01.

-32	32	-31	-4
-10	-71	-20	-1
-72	40	42	0
8	33	12	-22
40	25	13	

The first step is to arrange the differences in descending order, i.e., from the largest to the smallest.

42	25	-1	-31
40	13	-4	-32
40	12	-10	-71
33	8	-20	-72
32	0	-22	

The a_{n-i-1} values are taken from Annex 5.2, and (eq. 5.2.1) is applied.

 $b = 0.4808(114) + 0.3232(111) + \cdots + 0.0303(9)$

= 140.28

 S^2 is then calculated using (eq. 5.2.2).

 $\begin{array}{rcl}
19 \\
\Sigma \\
i=1
\end{array} \\
x_i = -18 \\
x_i^2 = 21272.95
\end{array}$ $\begin{array}{rcl}
19 \\
\Sigma \\
i=1
\end{array} \\
x_i^2 = 21290
\end{array}$

From (eq. 5.2.3),

W = 0.925

From Annex 5.3, for n = 19 and α = 0.01, the critical value is 0.863. Since 0.925 is greater than 0.863, do not reject the hypothesis that the differences are normally distributed.

For sample sizes greater than 50, the D' test of Method 5.9 may be applied.

Method 5.9

Notation

The x_i are defined as for Method 5.8.

Model

See Method 5.8.

Results

Calculate

$$T = \sum_{i=1}^{n} [i-0.5(n+1)] \times_{i}$$
 (eq. 5.2.4)

Calculate S^2 from (eq. 5.2.2)

Compute

 $D^{-} = T/S$

If D' lies between the critical values given in Annex 5.4, <u>do not</u> reject the hypothesis that the data have been sampled from a normal population. For an α - level of significance, the two critical values are in columns P = $\alpha/2$ and P = $1-\alpha/2$.

(eq. 5.2.5)

<u>Basis</u>

The D⁻ test for normality is given in reference [5.8].

Examples

EXAMPLE 5.9 (a)

In the same context as in example 5.8 (a), 59 differences in amounts of uranium are recorded. The values, ordered from smallest to largest, are given below. Apply the D^{\prime} test for normality with the significance level α = 0.01.

-100	-29	18	69	142	186
-95	-26	29	71	146	190
-76	-22	31	86	147	215
-69	-12	34	95	155	218
-68	-5	39	100	156	220
-62	-1	42	103	159	268
-50	2	45	107	163	298
-48	4	50	108	169	301
-39	5	50	116	180	344
-30	14	60	128	182	

From (eq. 5.2.4),

$$T = -29(-100) -28(-95) - \cdots + 29(344)$$

= 104,398

From (eq. 5.2.2),

$$\sum_{i=1}^{59} x_i = 4513$$

$$\sum_{i=1}^{59} x_i^2 = 1,004,439$$

$$S^2 = 659,232.75$$

$$S = 811.93$$

From (eq. 5.2.5),

 $D^{-} = 104,398/811.93 = 128.56$

For $\alpha = 0.01$, and n = 59, the lower critical value in the P = 0.005 column is 121.0 by interpolation. In the P = 0.995 column, the upper critical value is 130.1. Since D' falls between these two critical values, <u>do not</u> reject the hypothesis that the data have been sampled from a normal population.

5.2.1.2 Randomness Tests

Testing for randomness of a set of data is difficult because randomness is a characteristic that is difficult to define. It is simpler to approach the problem from the alternative viewpoint, i.e., to consider different types of non-randomness that may characterize the data. In the context of inspection, certain kinds of diversion strategies that include data falsification could create some types of non-randomness, e.g., the creation of sub-populations of falsified and non-falsified items. Further, tests for randomness could uncover assignable causes in the data, i.e., could lead to a better understanding of the data structure that would aid the statistical analysis.

The tests for normality discussed in Section 5.2.1.1 may be regarded as tests of randomness in the specific instance in which randomness is equated to normality. This equivalence between randomness and normality is often present with measurements data, and so the normality tests could have wide application here.

As another special case especially relevant to inspection, inspection of a flow stratum may take place over a period of time. Bias shifts in either the facility's or inspector's data could create non-randomness in the data. A similar statement applies to shipper-receiver data. Thus, a particular type of non-randomness that the inspector should be aware of is shifts in the population parameter values when data are ordered in time. This is the particular type of non-randomness addressed in this section.

Two methods are given to address this type of non-randomness. The first method is simple to apply and is very effective in providing a good visual impression of the data. It detects bias shifts very effectively but is partly subjective in that a quantitative measure of non-randomness is not produced. Often, this first method, involving a CUSUM (cumulative sum) plot is sufficient in detecting non-randomness due to bias shifts. If a more objective measure of non-randomness is needed, then the second method, involving an analysis of variance, may be applied. Collectively, these two methods plus the test for normality provide the tests needed to test for the most important types of non-randomness likely to characterize inspection data.

Method 5.10

Notation

x_i = observed value for the random variable, ordered in time or with respect to some other factor

Model

For the CUSUM plot as presented here, the inferences are made on the basis of a visual impression from the plot. This impression is generally adequate in making conclusions about the presence of parameter shifts. There are objective means for making inferences from CUSUM plots. These involve the use of V-masks and are not considered further here [5.9]. Such decision-making tools assume a certain structure in the data, commonly, that the observations are drawn at random from a normal distribution. When the plot is made just to create a visual impression, this assumption about the data structure is not required.

Results

From an inspection of the data, as based on some other considerations, select some central value for the data. In the case of difference data, this central value would be zero. The purpose of this central value selection is to force the plot to be nearly horizontal in the absence of shifts in the parameter value. Call the central value μ .

Calculate the difference values:

$$d_i = (x_i^{-\mu})$$
 (eq. 5.2.6)

Calculate the CUSUM values

$s_i = s_{i-1} + d_i$	(eq. 5.2.7)
$s_0 = 0$. Thus,	
$s_1 = d_1$	

where

 $s_1 - u_1$ $s_2 = s_1 + d_2$ $s_3 = s_2 + d_3$, etc.

Using an equal spacing along the abscissa, plot the s_i values. Observe the plot to determine if more than one line segment is needed to connect the plotted points. If so, conclude that there is non-randomness exhibited by the data in the sense that the parameter describing central tendency is not constant (bias shift).

Basis

As long as the mean of the x_i values remains constant, all the plotted points may be connected visually by a straight line segment. If there is a shift in the mean, then this straight line will change direction, or, stated alternately, more than one line segment will be needed. If the central value, μ , is wisely chosen, and if there are no shifts in the parameter value (i.e., in the mean of the x_i values), the slope will be zero.

Examples

EXAMPLE 5.10 (a)

Percents uranium in cans of dirty UO_2 scrap powder are listed below in container number order. Construct a CUSUM plot for these data. (Data ordered by columns.)

73.33	85.41	81.10	84.41
77.63	86.31	79.62	83.26
75.18	86.24	83.76	83.33
83.55	76.03	81.36	74.79
81.93	85.45	85.64	82.96
71.93	82.08	74.95	75.87
79.49	82.92	76.44	77.45
83.52	76.76	70.76	75.45
78.92	83.25	81.39	73.32
68.24	66.24	70.35	73.35
82.42	83.31	76.26	76.40
84.84	79.92	81.40	77.65
72.73	74.46	74.28	83.06
75.47	87.02	76.14	83.23
88.17	77.44	80.98	72.07
81.04	84.02	82.32	84.64
71.26	67.99	87.64	79.46
85.70	82.30	73.04	76.38
85.25	80.69	82.26	75.39
75.84	69.91	74.49	82.73
74.74	79.07	67.08	
76.45	72.34	81.96	

Upon inspection of the data, a reasonable central value, μ , is 78. The table below lists the d_i values for the first few observations using (eq. 5.2.6), and all the s_i values, using (eq. 5.2.7)

<u> </u>	i	si	i	s _i	i
73.33	-4.67	-4.67	19.04	47.89	58.42
77.63	37	-5.04	27.35	49.51	63.68
75.18	-2.82	-7.86	35.59	55.27	69.01
83.55	5.55	-2.31	33.62	58.63	65.80
81.93	3.93	1.62	41.07	66.27	70.76
		-4.45	45.15	63.22	68.63
		-2.96	50.07	61.66	68.08
		2.56	48.83	54.42	65.53
		3.48	54.08	57.81	60.85
		-6.28	42.32	50.16	56.20
		-1.86	47.63	48.42	54.60
		4.98	49.55	51.82	54.25
		-0.29	46.01	48.10	59.31
		-2.82	55.03	46.24	64.54
		7.35	54.47	49.22	58.61
		10.39	60.49	53.54	65.25
		3.65	50.48	63.18	66.71
		11.35	54.78	58.22	65.09
		18.60	5/.4/	62.48	62.48
		16.44	49.38	58.97	67.21
		13.18	50.45	48.05	
		11.63	44./9	52.01	



The data plot suggests quite strongly that the data divide into at least three groups. There is also some indication of cyclic behavior in the plotted points within the last grouping, but this is not as evident; objective tests would be required to determine if the non-randomness that appears to exist within the last group is real in a statistical sense.

Having detected this apparent non-randomness in the data, one would try to find an explanation for it. Perhaps the samples are taken and then stored for a brief time prior to performing the analyses on a campaign basis. Any analytical shifts could explain the non-randomness detected. It is the results of the investigation triggered by the CUSUM plot that are of primary interest, and not merely the fact that such non-randomness was detected. The aim, of course, is to determine if data falsification is the explanation, or if there are more innocent assignable causes that should be identified and corrected if possible.

When the data are grouped according to some criteria external to the data themselves, the analysis of variance previously given as Method 2.4 may be applied to determine if there are significant differences among the group means. In Method 2.4, the analysis of variance was presented as a method of estimating measurement error variance components. In the current problem situation, the analysis of variance is given from point of view of testing for significant differences among group means. The problem solution is presented as Method 5.11.

Method 5.11

Notation

The notation is consistent with that of Method 2.4 but is repeated here in part and redefined to meet the present problem situation.

> x_{ij} = value for j-th observation in group i; i=1, 2, ..., m n; = number of observations in group i

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Mode1

 x_{ij} is normally distributed about μ_i , the mean for group i, and with variance σ^2 , constant for all groups. Under the hypothesis, μ_i is the same for all i.

Results

Following Method 2.4, calculate the quantities:

 T_i , T, S₀, S₁, S₂, M_B, and M_W

Form the F ratio:

 $F = M_B / M_W$ (eq. 5.2.8)

Select a value for α , the significance level of the test. For $\alpha = 0.05$, 0.025, and 0.01, enter the table in Annex 5.5 (a), 5.5 (b), or 5.5 (c) respectively. If F exceeds the tabled value for degrees of freedom for the numerator, (m-1), and degrees of freedom for the denominator, (n-m), conclude that $\mu_{i} \neq \mu$ for all i, i.e., reject the hypothesis that the group means are the same.

Basis

The statistical technique that forms the basis for this method is the one way analysis of variance which is described in many texts. See, for example, [5.10].

Examples

EXAMPLE 5.11 (a)

In Example 5.10 (a), say that the percent uranium values were determined in four analytical compaigns, i.e., during four distinct periods of operation in the laboratory. The data are divided into groups as follows:

Group	1:	73.33	-	71.26	(n ₁ -	=	17)
Group	2:	85.70	-	83.25	(n ₂	=	14)
Group	3:	66.24	-	81.96	(n ₃	=	35)
Group	4:	84.41	-	82.73	(n4	=	20)

Following Method 2.4:

T ₁ =	1329.65	S ₀	Ξ	533761.2853
$T_2 =$	1142.43	S_1	=	533902.8742
T ₃ =	2727.93	S_2	=	536132.4325
T ₄ =	1575.20	M _B	=	47.1963
T =	6775.21	MW	=	27.1897
From (eq. 5.2.8),

F = 47.1963/27.1897 = 1.736

Choose $\alpha = 0.05$ and enter the table of Annex 5.5 (a). The tabled value for 3 degrees of freedom in the numerator and 82 degrees of freedom in the denominator is 2.74, by interpolation. Since the F value of 1.736 does not exceed this tabled value, do not reject the hypothesis that the group means are equal.

Some further comments are in order because this conclusion seems to conflict with that reached in Example 5.10 (a) on the basis of the CUSUM plot. First, it was pointed out that the CUSUM plot provide a visual impression of the data, and in this particular example, is quite suggestive of a real difference in group means. However, the statistical significance of that conclusion is not stated. On the basis of this current example, it appears that the conclusion of a significant difference is not warranted at the $\alpha = 0.05$ significance level; the actual value for α , it turns out, would be slightly larger than $\alpha = 0.10$. The up-and-down pattern of the data plot is an indication of a large random error variance or in this case, of a rapidly shifting bias, which tends to obscure the differences in the group means.

Further, from the data plot, in observing the slopes of the line segments, it is apparent that group means 1, 3, and 4 are nearly equal whereas group mean 2 is relatively high. The analysis of variance tests the global hypothesis that all group means are equal; if three are in fact equal while one differs somewhat, the analysis of variance may not detect this fact so readily. In fact, had groups 1, 3, and 4 been combined and tested against group 2, then M_B and M_W would have been

$$M_{\rm p} = 133.0415$$
 $M_{\rm hl} = 26.6441$

and F with 1 and 84 degrees of freedom is 4.993, a significant result at $\alpha = 0.05$. Here is an example in which the CUSUM plot was perhaps more sensitive in detecting the <u>particular alternative hypothesis</u> that apparently exists; with the analysis of variance, the alternative hypothesis is not specified.

By way of summary, the four group means are

\bar{x}_1	=	78.21	x ₃	=	77.94
$\bar{\mathbf{x}}_2$	=	81.60	\bar{x}_4	E	78.76

5.2.1.3 Variance Tests

In advance of an inspection, the facility provides values for its random and systematic error variances. These values are used in planning the inspection and also in the data analysis if, in fact, the inspection data substantiate the stated values. This section addresses the problem of verifying that the facility's stated values for the random error variances are valid. The method makes use of the facility minus inspection data.

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Method 5.12

Notation

- d = difference between facility and inspector values for specified characteristic and stratum
- n = number of d_i values
- σ_0^2 = facility's stated random error variance for given characteristic and stratum
- σ_1^2 = corresponding inspector's value

Model

The quantity d_i is normally distributed with arbitrary mean and variance equal to $(\sigma_0^2 + \sigma_1^2)$ under the null hypothesis that σ_0^2 and σ_1^2 are correctly stated.

Results

Calculate

$$S_d^2 = \sum_{i=1}^n d_i^2 - \left(\sum_{i=1}^n d_i\right)^2 / n$$
 (eq. 5.2.9)

Calculate the chi-square statistic

$$\chi^{2}_{n-1} = S_{d}^{2} / (\sigma_{0}^{2} + \sigma_{1}^{2})$$
 (eq. 5.2.10)

Select a value for α , the significance level of the test. Enter the table in Annex 5.6 under the columns headed $\chi^2_{\alpha/2}$ and $\chi^2_{1-\alpha/2}$, and for degrees of freedom (df) equal to (n-1). If χ^2_{n-1} of (eq. 5.2.10)falls between the two tabled values, do not reject the hypothesis, i.e., conclude that the sum, $(\sigma^2_0 + \sigma^2_1)$, is correct.

In the event the hypothesis is rejected, conclude that σ_0^2 misrepresents the actual variance for the facility. This conclusion assumes that the inspector can properly assign the σ_1^2 value.

Basis

The statistical technique that forms the basis for this method is the chisquare test on the variance which is described in many texts (see, for example, [5.11]).

Of underlying importance to this test is the validity of the assumption that the inspector's value, σ_1^2 , is correct. This should pose no problem because of the wide base of experience upon which the σ_1^2 value will generally be based. However, the problem can be circumvented under some circumstances, i.e., it is possible to test the hypothesis about the validity of σ_0^2 irrespective of the value for σ_1^2 .

The procedure for making this test, and the conditions under which the alternate test is preferred, are given in reference [5.12].

Example

EXAMPLE 5.12 (a)

Consider the data of Example 5.8 (a). These data represent differences between facility and inspector measurements of total uranium in containers of low enriched UO_2 powder.

From example 3.3 (a),

 $\sigma_0^2 = [(.000950)(20000)]^2 = 361.00 \text{ g}^2 \text{U}$

From example 3.8 (a),

 $\sigma_1^2 = 361.00 \text{ g}^2 \text{U}$

Then, again from example 5.8 (a),

 $s_d^2 = 21272.95$

From (eq. 5.2.10), the chi-square value is

 $\chi_{18}^2 = 21272.95/722.00 = 29.46$

At α = 0.05, from Annex 5.6, the tabled critical values are 8.23 and 31.53. Since 29.46 lies between these two numbers, do not reject the hypothesis that $(\sigma_0^2 + \sigma_1^2) = 722.00$.

5.2.1.4 Test on \hat{D}_k and on Shipper/Receiver Differences

The final supplemental test to be considered is the test on \hat{D}_k , the difference statistic in stratum k. Although primary emphasis in the analysis of the variable inspection data is on the difference statistic appropriately summed over all strata, there are occasions when one might wish to test for the significance of \hat{D}_k in a given stratum. As a prime example of this, it was pointed out in Section 4.5.3 that a shipper-receiver difference test is formally equivalent to a test on \hat{D}_k , and one is interested in routinely performing such tests on shipper-receiver differences.

The \hat{D}_k test was considered in Section 4.5.3 from point of view of its probability of detection. In this current section, emphasis is on how the significance test is performed.

Method 5.13

Notation

The notation is consistent with that given in Methods 3.8 - 3.10.

Mode1

The random variable, \hat{D}_k , is assumed to be normally distributed with variance $V(\hat{D}_k)$ and with mean zero under the null hypothesis.

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Results

Calculate $V(\hat{D}_k)$ as the sum of three variance components

$$V(\hat{D}_{k}) = V_{r}(\hat{D}_{k}) + V_{g}(\hat{D}_{k}) + V_{s}(\hat{D}_{k})$$
 (eq. 5.2.11)

where $V_r(\hat{D}_k)$ is given by (eq. 3.5.5), and where $V_g(\hat{D}_k)$ and $V_s(\hat{D}_k)$ are given respectively by (eq. 3.5.14) and (eq. 3.5.21), in each case the calculations being performed for only the single stratum.

Having observed \hat{D}_k , compute the statistic

$$t = \hat{D}_{k} / \sqrt{V(\hat{D}_{k})}$$
 (eq. 5.2.12)

Select a value for α , the significance level of the test, and find the corresponding critical value, t_{α} , from Annex 5.7. Then,

- (a) if stratum k is an input or beginning inventory stratum, reject the hypothesis that the mean of \hat{D}_k is zero if $t < -t_{\alpha}$;
- (b) if stratum k is an output or ending inventory stratum, reject the hypothesis if $t > t_{\alpha}$.

Basis

This is the standard test on the mean of a normally distributed random variable with known variance [5.13]. The test is constructed as a one-sided test because from a diversion viewpoint, only those values of \hat{D}_k that differ from zero in one direction favor the diverter. Of course, a large value of \hat{D}_k in the opposite direction would also be called to the attention of the facility as evidence of a malfunctioning measurement system.

Examples

EXAMPLE 5.13 (a)

In example 3.8 (b), the inspection sample sizes are given for the mixed oxide fuel fabrication facility. In the PuO_2 powder stratum, 16 of the 24 strata are randomly selected with 6 items weighed per batch and with 3 samples drawn per batch to determine percent plutonium. Duplicate analytical determinations are made. For the resulting 96 paired differences, say that

 $d_1 = -0.00468$ kg Pu, so that, from (eq. 3.5.1) $\hat{D}_1 = -(768)(0.00468) = -3.594$ At a significance level, $\alpha = 0.010$, does this represent a significant difference?

From the cited example,

 $V_{r}(\hat{D}_{1}) = 0.296817 + 0.621036 = 0.917853 \text{ kg}^{2}\text{Pu}$

From example 3.9 (b), the calculations for the short term systematic error variance are performed for stratum 1. Example 3.9 (b) made use of earlier calculations performed in Example 3.4 (a). In the expression for $V_{\rm g}(\hat{\rm D}_1)$ given below, the first two terms come from example 3.4 (a) and the last term from example 3.9 (b).

 $V_{g}(\hat{D}_{1}) = 0.012124 + 1.329070 + (0.0016)^{2}[2(768)^{2}]$ = 4.361093 kg²Pu

From example 3.10 (b), the calculations for the long term systematic error variance are performed for stratum 1. Example 3.10 (b) made use of earlier results from example 3.5 (b). In the expression for $V_S(\hat{D}_1)$ given below, the first two terms come from example 3.5 (b) and the last two from example 3.10 (b).

 $V_{s}(\hat{D}_{1}) = 0.094372 + 1.156055 + (1656.6)^{2}(0.00030)^{2} + (1536)^{2}(0.0012)^{2}$ = 4.894802 kg²Pu

The (eq. 5.2.11) may now be applied

 $V(\hat{D}_1) = 0.917853+4.361093+4.894802 = 10.173748 \text{ kg}^2\text{Pu}$

From (eq. 5.2.12),

 $t = -3.594/\sqrt{10.173748} = -1.127$

At α = 0.010, t $_{\alpha}$ = 3.090. Since -1.127 is not less than -3.090, conclude that the facility measurements of plutonium are not significantly smaller than the inspector measurements for this input stratum, i.e., there is no reason to conclude that the input values are understated.

5.2.1.5 International Standards of Accountancy [5.15]

In Section 3.4 the variance of MUF, V (MUF), is used to test the hypothesis that the true MUF is equal to some stated value (e.g., zero). V (MUF) may be calculated from the operator's design information data on his random and systematic random error variances. The inspector may verify these error estimates using inspection results, estimation methods described in Chapter 2 and the Chi-square test of Section 5.2.1.3. Depending on the outcome of these many possible tests the inspector may calculate his own estimate of V (MUF) in order to determine whether the operator's system of measurements conform to international standards or be equivalent in quality to such standards.

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Standards do not exist for each measurement method and material combination. Instead the Agency has defined such standards for V (MUF) which are considered achievable in practice at bulk facilities of each identified type. For example, at uranium fabrication facilities the international standard of accountancy for σ_{MUF} is 0.3 %, expressed as a percentage of the larger of inventory or throughput. This represents a maximum expected value for σ_{MUF} that is easily achievable by the majority of facilities using well known measurement methods that are widely used in the industry.

EXAMPLE 5.13(a)

From example 3.3(a) we see that the outputs of 238800 + 1200 = 240000 kg U are much larger than beginning or ending inventory. In this case, the standard of accountancy would be

 σ_{MUF} = (0.003) (240000) = 720 kg U

and the calculated value of \sqrt{V} (MUF) from Example 3.5(a) is

$$\sqrt{V}$$
 (MUF) = $\sqrt{45010}$ = 212 kg U.

Since 212 < 719 kg U we conclude that the operator's system of measurements is well within this international standard. In the event that \sqrt{V} (MUF) is greater than the standard the test of MUF in Section 11.9 should be based on the standard value rather than the calculated value and the state should be informed that the system of measurements does not meet the maximum expected values for σ_{MUF} .

A similar approach can be used for testing the quality of the inspector's system of measurements as represented by V (\hat{D}) . In fact this may be more important than checking V (MUF) since V (\hat{D}) is the primary measure of the Agency's verification accuracy. Safeguards effectiveness based on nuclear material accountancy will be limited by this verification accuracy as the size and throughput of bulk handling facilities increase.

5.2.2 Principal Tests of Hypotheses

In assessing the safeguards performance of a facility, the key measures are D, MUF, and MUF-D. The observed values of these quantities and their calculated variances form the basis for both the principal tests of hypotheses discussed in Section 4.5.1 and the estimation of the true MUF. This section describes the performance of significance tests, and the next section describes the construction of confidence intervals estimates.

5.2.2.1 Test on D

The D test was considered in Section 4.5.4 from point of view of its detection probability. In this current section, emphasis is on how the significant test is performed.

Method 5.14

Notation

The notation is that used in Methods 3.8 to 3.10.

Mode]

The random variable, \hat{D} , is assumed to be normally distributed with zero mean and with variance V(\hat{D}) under the null hypothesis.

Results

Calculate $V(\hat{D})$ as the sum of three variance components:

$$V(\hat{D}) = V_r(\hat{D}) + V_q(\hat{D}) + V_s(\hat{D})$$
 (eq. 5.2.13)

where $V_r(\hat{D})$, $V_g(\hat{D})$, and $V_s(\hat{D})$ are given in (eq. 3.5.6), (eq. 3.5.14), and (eq. 3.5.21) respectively.

Compute

t

$$= \hat{D} / \sqrt{V(\hat{D})}$$
 (eq. 5.2.14)

Select a value for α , the significance level of the test. If t<-t $_{\alpha}$, conclude that there is a significant difference between the facility and inspector results. The value for t $_{\alpha}$ comes from Annex 5.7.

<u>Basis</u>

The basis is the same as for the $\hat{\rm D}_k$ test of Method 5.13. For $\hat{\rm D}$, a large negative value favors the diverter and so the test is a one-sided test against that alternative.

Examples

EXAMPLE 5.14 (a)

Continue with the mixed oxide facility of example 5.13 (a). This relates to the inspection described in example 3.8 (b). At α = 0.025, how large must \hat{D} be in a negative direction in order to reject the hypothesis that its mean is zero?

From (eq. 5.2.14) and Annex 5.7, the hypothesis in question is rejected if

 $\hat{D} < -1.960 \sqrt{V(\hat{D})}$

The quantity $V(\hat{D})$ for this example was calculated in example 3.10 (b).

 $V(\hat{D}) = 27.303719 \text{ kg}^2\text{Pu}$

Therefore, the hypothesis will be rejected if

 \hat{D} <-1.960 $\sqrt{27.303719}$, or if

D<-10.242 kg Pu

5.2.2.2 Test on MUF

The test on MUF was considered in Section 4.5.5 from point of view of its detection probability. In this current section, emphasis is on how the significance test is performed.

Method 5.15

Notation

The notation is given in Section 3.4.3.2.

Mode1

The random variable, MUF, is assumed to be normally distributed with zero mean and with variance V(MUF) under the null hypothesis.

<u>Results</u>

Calculate V(MUF) as the sum of three variance components.

$$V(MUF) = V_{r}(MUF) + V_{g}(MUF) + V_{s}(MUF)$$
 (eq. 5.2.15)

where $V_r(MUF)$, $V_g(MUF)$, and $V_s(MUF)$ are given in (eq. 3.4.3), (eq. 3.4.7), and (eq. 3.4.11) respectively.

Compute

$$t = MUF / \sqrt{V(MUF)}$$
 (eq. 5.2.16)

Select a value for $\alpha,$ the significance level of the test. If t exceeds t_α from Annex 5.7, reject the hypothesis that the mean of MUF is zero.

Basis

The basis is the same as for the \hat{D}_k test of Method 5.13. For MUF, a large positive value is an indication of diversion and so the test is one-sided against that alternative.

Examples

EXAMPLE 5.15 (a)

Consider the MUF for the mixed oxide fuel fabrication facility. Values for $V_{r}(MUF)$, $V_{q}(MUF)$, and $V_{s}(MUF)$ were calculated in Examples 3.3 (b), 3.4 (a), and

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From the cited examples, as summarized in example 3.5 (b),

√V(MUF) = 3.276 kg Pu

For α = 0.050, t_{α} = 1.645 so that the hypothesis is rejected if MUF exceeds

(1.645)(3.276) = 5.389 kg Pu

5.2.2.3 Test on (MUF-D)

The test on $(MUF-\hat{D})$ was considered in Section 4.5.6 from point of view of its probability of detection. In this current section, emphasis is on how the significance test is performed.

Method 5.16

Notation

The notation is that of Method 3.13.

Mode1

The random variable, (MUF- \hat{D}), is assumed to be normally distributed with zero mean and with variance V(MUF- \hat{D}) under the null hypothesis.

Results

Calculate V(MUF- \hat{D}) from (eq. 3.6.5). Compute

 $t = (MUF-\hat{D})/\sqrt{V(MUF-\hat{D})}$ (eq. 5.2.17)

Select a value for α , the significance level of the test. If t exceeds t_{α} from Annex 5.7, reject the hypothesis that the mean of (MUF-D) is zero.

Basis

The basis is the same as for the \hat{D}_k test of Method 5.13. For (MUF- \hat{D}), a large positive value is an indication of diversion and so the test is one-sided against that alternative.

Examples

EXAMPLE 5.16 (a)

Consider the low enriched uranium fuel fabrication facility of example 3.13 (a). At α = 0.050, how large must (MUF-D) be in order to reject the hypothesis that its mean is zero?

From the cited example,

 $V(MUF-\hat{D}) = 40,983 \text{ kg}^2 U$

For α = 0.050, t $_{\alpha}$ = 1.645 so that the hypothesis is rejected if (MUF-D̂) exceeds

 $(1.645)\sqrt{40,983} = 333 \text{ kg U}$

EXAMPLE 5.16 (b)

Suppose that in the previous example, (MUF- \hat{D}) were calculated for U-235 rather than for uranium. Then, since

 $V*(MUF-\hat{D}) = 33.6843 \text{ kg}^2U-235$

from Example 3.13 (a), the critical value is

 $1.645 \sqrt{33.6843} = 9.547 \text{ kg U-}235$

This example illustrates how Methods 5.13-5.16, written in terms of element weights, may easily be adapted to relate to isotope weights. The changes in calculations are obvious.

EXAMPLE 5.16 (c)

Consider the mixed oxide fuel fabrication facility of example 3.13 (b). At α = 0.050, how large must (MUF-D) be in order to reject the hypothesis that its mean is zero?

From the cited example,

 $V(MUF-\hat{D}) = 21.035443 \text{ kg}^2\text{Pu}$

For α = 0.050, t $_{\alpha}$ = 1.645 so that the hypothesis is rejected if (MUF-D) exceeds

 $1.645 \sqrt{21.035443} = 7.545 \text{ kg Pu}$

This completes the discussion on tests of hypothesis for the various statistics derived from the inspection data. The final topic on the analysis of inspection data is the construction of confidence intervals.

5.2.3 Confidence Intervals on Material Unaccounted For

The values of MUF and MUF- \hat{D} are estimates of the true material unaccounted for calculated from facility data and facility data plus inspection data, respectively. These observed values and their calculated variances contain all the information about

the magnitude of the true MUF available to the inspector. In addition to the specific tests of the hypothesis of no diversion (true MUF equal to zero) described in the preceding section, it is revealing to display the total information about material unaccounted for upon completion of the analysis of facility and inspection data. In particular, the estimated magnitude of a significant diversion relative to the goal quantity M used as a basis for inspection planning may be of interest.

A convenient way to convey this information is through the determination of a confidence interval estimate of the true MUF and a graphical presentation of this interval as it relates to both the absence of any diversion (true MUF equal 0) and the diversion of a significant quantity (true MUF equal M). In Section 5.2.3.1 the facility MUF forms the basis for construction of the confidence interval while in Section 5.2.3.2 the basis is the adjusted estimate MUF- \hat{D} based on inspection data.

5.2.3.1 Confidence Interval Based on MUF

Method 5.17

Notation

The notation is given in Section 3.4.3.2. Further, M is the goal amount.

Model

The random variable, MUF, is assumed to be normally distributed with variance V(MUF). The observed MUF is assumed to be the estimate of the true unknown MUF in the sense that its expected value is the true MUF. (No small biases or data fal-sifications.)

Results

Calculate V(MUF) by (eq. 5.2.15). Choose a value for the confidence coefficient $(1-\alpha)$ and compute

$$L = MUF - t_{1-\alpha/2} \sqrt{V(MUF)}$$
 (eq. 5.2.18)

(eq. 5.2.19)

and

where $t_{1-\alpha/2}$ is read from Annex 5.8 for given $(1-\alpha)$.

 $U = MUF + t_{1-\alpha/2} \sqrt{V(MUF)}$

To display the results graphically, draw a horizontal line scaled in amounts of element. Let the smallest value on the left be min (0,L) and the largest value on the right be max (M,U). Indicate the values for 0, L, U, and M on this line by appropriately marking the line, and connect the L and U marks.

There are six possible ways in which the O, L, U, and M marks may be ordered. (Note that L must be less than U and O is less than M.) These possibilities are listed below along with a narrative description of their interpretations. In the first three cases the test of the hypothesis of a true MUF less than or equal to zero would be rejected.

Case	Ordering	Description
1	0-L-U-M	The true MUF is greater than zero, but is less than the goal amount.
2	0-L-M-U	The true MUF is greater than zero but not greater than the goal amount.
3	0-M-L-U	The true MUF is greater than the goal amount.
4	L-0-M-U	The uncertainty in the estimate of MUF is large and little de- finitive can be said about the true MUF relative to zero or to the goal amount.
5	L-0-U-M	The true MUF is less than the goal amount and not greater than zero.
6	L-U-0-M	The true MUF is less than zero.

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<u>Basis</u>

The method is based on the construction of confidence limits on the mean of a normally distributed random variable with known variance [5.14].

Examples

EXAMPLE 5.17 (a)

Suppose that for the mixed oxide fuel fabrication facility of example 5.15 (a), the MUF were 4.212 kg Pu and the goal quantity were 8 kg Pu. Then, from the cited example,

 $\sqrt{V(MUF)}$ = 3.276 kg Pu

The limits, L and U, are calculated from (eq. 5.2.18) and (eq. 5.2.19) for $(1-\alpha) = 0.95$.

L = 4.212 - (1.960)(3.276) = -2.209 kg Pu U = 4.212 + (1.960)(3.276) = 10.633 kg Pu

The horizontal line is drawn extending from -2.209 kg Pu to 10.633 kg Pu, and O, L, U, and M are indicated on this line.



This is case 4; little definitive can be said about the true MUF relative to zero or to the goal amount.

5.2.3.2 Confidence Interval Based on (MUF-D)

Method 5.18

Notation

The notation is that of Method 3.13. M is the goal amount.

Mode1

The random variable $(MUF-\hat{D})$ is assumed to be normally distributed with variance $V(MUF-\hat{D})$. The observed $(MUF-\hat{D})$ is assumed to be the estimate of the true unknown MUF in the sense that its expected value is the true MUF (facility MUF corrected for biases or data falsifications).

Results

Calculate V(MUF- \hat{D}) from (eq. 3.6.5). Choose a value for the confidence coefficient $(1-\alpha)$ and compute the lower and upper confidence limits:

$$L = (MUF-\hat{D}) - t_{1-\alpha/2} \sqrt{V(MUF-\hat{D})}$$
(eq. 5.2.20)
$$U = (MUF-\hat{D}) + t_{1-\alpha/2} \sqrt{V(MUF-\hat{D})}$$
(eq. 5.2.21)

where $t_{1-\alpha/2}$ is read from Annex 5.8 for given $(1-\alpha)$.

Proceed as in Method 5.17 to display the results graphically.

<u>Basis</u>

The basis is the same as for Method 5.17.

Examples

EXAMPLE 5.18 (a)

Suppose that for the mixed oxide fuel fabrication facility of example 5.17 (a), D = -3.617 kg Pu. Then,

 $(MUF-\hat{D}) = 4.212 + 3.617 = 7.829 \text{ kg Pu}$

For this facility, from example 5.16 (c),

 $V(MUF-\hat{D}) = 21.035443 \text{ kg}^2\text{Pu}$

From (eq. 5.2.20) and (eq. 5.2.21), for $(1-\alpha) = 0.90$,

$$L = 7.829 - 1.645 \sqrt{21.035443} = 0.284 \text{ kg Pu}$$

The horizontal line is drawn extending from 0 to 15.374 kg Pu, and O, L, U, and M are indicated on this line.



This is case 2. The true MUF is greater than zero but the uncertainty in the estimate of the MUF is very large and precludes making a definitive statement about the relationship of the true MUF to the goal amount.

EXAMPLE 5.18 (b)

In the low enriched uranium fuel fabrication facility of example 5.16 (b), the goal amount is 75 kg U-235. Method 5.18 is adapted to apply to isotope rather than element MUF.

Say that the value for MUF is 21.224 kg U-235 while $\hat{\rm D}$ = -11.355 kg U-235. Then,

 $(MUF-\hat{D}) = 32.579 \text{ kg } U-235$

From example 5.16 (b),

 $V*(MUF-\hat{D}) = 33.6843 \text{ kg } U-235$

Applying (eq. 5.2.20) and (eq. 5.2.21) for $(1-\alpha) = 0.95$,

L = $32.579 - 1.960 \sqrt{33.6843} = 21.204 \text{ kg U} - 235$

 $U = 32.579 + 1.960 \sqrt{33.6843} = 43.954 \text{ kg } U-235$

The horizontal line is drawn extending from 0 to 75 kg U-235, and 0, L, U, and M are indicated on this line.



This is case 1. The true MUF is estimated quite precisely and is both greater than zero and considerably less than the goal amount.

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cont.)	3171 5563 4846 5263 7132	9644 5923 7101 9700 5499	4083 0433 9028 5945 8528	5451 0950 3623 0198 2774	2330 1901 7577 0830 8830	6807 1822 1392 0964 2257	6332 0075 8601 0310 4326	5658 5110 9465 7252 1708	3335 6201 8690 2031 2734	1942 5192 4538 1038 3096
nbers (o	3208 2355 5271 6534 0393	7582 2991 6288 7428 0953	4707 0426 0465 4875 8102	2461 7008 9808 2259 2413	7549 3743 7632 5589 6466	7811 8806 5563 1757 2831	4839 5189 5650 5920	6450 0294 4276 6379 9278	0222 8043 2661 1832 4191	1716 9983 0967 5612 5295
om Nur	8818 1281 0294 6235 9764	4262 5295 1840 7133 7881	3695 8894 7202 3106 0612	3 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	6509 2660 64564 1535 1535 1535	8482 4455 9104 1062 3979	2209 7651 2677 4620 9069	7583 6043 4118 7068 1664	8676 6942 9433 8036 3222	4757 5055 0546 2183
Rand	4890 8932 6983 1044 1256	2914 0206 7141 9117 7479	0500 1457 8139 9063 5307	4988 6939 66339 45634 4583	7720 1489 4223 0812 8997	0586 1077 1521 8252 3298	3590 8030 4143 5579 0741	1137 1859 9717 1815 7447	6677 5458 1931 7171 3194	7373 2123 3351 1231 3961
	3741 7544 6055 1168 9718	9473 3178 4044 1856 1136	2830 8090 7340 85 45 08 44	6636 5800 8006 5357 0134	7171 6858 4092 7236 3583	7880 7600 41 4 1 4612 7423	0377 2315 8204 3485	5933 3753 0163 5101 5068	0074 0255 6333 1815 7765	9362 5474 2106 7203 8974
	6731 8964 1288 3678 3383	1453 0446 6789 1976 0733	9561 1763 5868 5288 9022	5248 8184 4852 4998 4435	2492 6790 5289 2160 9870	3828 3382 0104 6348 0303	1629 5565 3973 9889 3900	7127 5323 4957 3781 0199	9512 4011 1690 5627 9677	6250 7385 1191 3365 7517
	2742 9112 0462 4616 4976	9852 7535 7469 1886 6268	2097 3735 9296 8527 7866	9954 2613 2668 3002 8422	3690 0813 6477 0772 5692	2080 1039 7227 8506 5086	0092 0935 2605 7277 5484	6905 8387 4094 4951 9047	7274 9192 0554 9231 3995	2402 5295 5177 7315 5775
	0270 9885 2290 0046	6971 7963 6509 3326	5772 6078 2920 7872 5054	7875 9161 0431 8449 8745	2185 7981 8577 7702 7702 3657	2490 7395 4418 9072 1570	7 8764 7155 659 659 2404	6484 3838 6736 7912 6736 7912 7946	0 9 9 0 5 7 3 1 8 9 9 1 8 9 9 1	9970 93603 93603 85789
	7599 5572 8536 5370 6572	2551 9909 3212 0020 5694	5509 5926 4551 3674	3148 1303 2492 8042 8042 8042	5149 0649 1982 5600 6681	9557 2251 0632 2264 8869	3165 3993 4505 2647 3681	4568 0787 8681 7041 0855	6920 1216 2057 1869 8878	7891 8674 4027 5759 3421
	3646 2234 2234 2538 15339	5628 4829 4238 4278 8244	1621 7873 8239 4668 5328	1336 4910 2848 1193 0188	7808 9456 2565 8733 2274	0869 2912 6272 7343 6944	7949 6917 0723 8726 1066	7435 8669 87558 8553 8553	6116 9417 5872 5409 2986	2632 7480 8688 9820 9064
cont.)	2822 4552 8060 1957 1297	6757 3679 5634 0948 3520	1387 0123 4454 1223 7066	9829 1339 1145 8216 4717	7787 2971 9189 4174 5114	2436 7361 8782 1143 2531	2904 2802 1937 5750 2781	0240 4696 3719 3388 9062	8245 8609 5951 7252 0096	6616 1662 7029 3462 6608
mbers (8256 4739 7709 8100 1626	5683 8819 6387 1547 8237	2107 1001 4156 3398 2340	9068 9829 9829 9744 9244 9244 9244 9244 9244 9244 92	6183 5629 1022 2823 3388	0934 7431 9881 3986	8293 4116 7511 2415 2306	7009 4680 6781 5533	1546 7778 9449 6931 3178	8772 3860 9481 8819 0148
om Nu	9033 9933 9951 4526 1915	8614 5702 6398 1038 8567	1053 1053 1053 1053	2789 4494 4093 6377 8520	8951 4082 5911 3156 8755	4012 8284 7775 0812 8609	4472 2915 7170 6572 6434	5910 2160 1492 1008 2736	1481 8131 9992 6053 6781	4673 2274 0434 1765 8295
Rand	3272 7792 3778 9043 6959	3250 2338 1141 6612 8377	5870 3501 1183 2378 0885	8999 4029 2542 6881 0577	0279 8422 4739 4715 4715	2692 7670 1905 9202 7390	9166 9588 1690 2684 0890	5270 5347 9177 4819 9614	5563 0341 3125 8770 2685	6810 3924 5126 0835 0354
	8665 5311 1011 6032 2340	1862 3028 2935 5020 8286	3851 2849 2962 2701 5997	1457 1457 2375 8554 9096	5569 9427 3389 3849 5611	6806 9378 7213 8674 8746	8020 8134 9702 3294 0950	7311 0599 6906 3849 6712	0004 9509 5321 6121 3899	1262 4925 3170 3242 5306
	2572 0788 6151 5799 0002	3381 6526 9879 8641 5596	6718 6727 2450 5783 9008	9739 3769 4641 2842 9301	9937 2074 7345 6718 9847	5984 2074 2461 4200 3033	9336 2841 2228 8860 3922	0765 1939 7658 7244 4441	0487 0512 8987 9690 5821	4974 6675 8213 1182 6600
	2271 3025 3382 7870 1697	3395 6081 3470 4952 4955	8246 6258 3235 2525	5852 0440 0820 4114 6558	0345 7430 8030 4894 4894	2676 9305 5138 8882 8882	1087 5666 3790 5250	5765 8408 8460 4198 9872	6485 2064 9927 4918 8099	1901 8273 2878 6088 5773

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	8522 9327 9119 3552	1553 8335 3600 8998 2922	5570 3461 1760 9780 0175	0490 7694 6104 3510	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	0682 2143 4495 5394 6195	7986 9714 0896 6139 7220	4264 4090 8318 0599 7238	9242 0423 7057 4156 7205	4224 3681 2703 4180 9376
	3974 6782 7404 2181 7153	6601 9938 8819 9683 4151	3573 9262 9814 1676 2784	8558 1816 25548 55548 5831	5751 4559 7970 3002 6198	0950 4275 7154 4927 4927	6953 6314 8234 7348 9733	9065 6438 9427 2064 1142	5788 4446 8310 8014 2742	7616 1467 4621 7679 3971
	0698 1969 2596 0708 1905	6848 7609 7914 4955 3901	5141 6074 7686 7818 7649	0098 1052 1579 3850 2301	5048 8205 3089 5149 1384	2113 7027 9840 1775 8739	8310 5029 6943 1699 8199	1767 8490 8226 9677 5009	1839 4400 1122 2919 5545	1545 9893 6380 8906 3502
cont.)	3795 9862 9306 4511 3905	0497 7414 1690 7760 5587	9954 1221 1988 1940 2113	6701 6399 9274 5644 7729	2608 2199 7258 7285 7532	6769 7342 7148 5739 7515	7299 6349 5864 6333 0203	2438 0438 1048 4217 6426	2967 2299 9577 1426 9884	7229 7404 2731 4546 8575
nbers (0778 1214 0842 9129 7515	7690 4637 4602 6631 0431 033	7456 6661 7125 9925 3380	5547 7657 7175 9048 4075	000 0745 2713 9128 8556	5375 7477 7477 9884 6536	4004 9763 9513 8957	5877 1335 8963 8975 6362	0311 4640 8789 6771 5200	9463 9670 7141 0757 1524
om Nur	3460 3896 7572 3809 3721	8837 4660 7216 3715 5306	8772 1724 0737 7238 7551	8271 6959 1559 9998	0770 6177 6904 6561 6493	4471 4262 6862 3125 0076	7841 3315 9856 6468 6992	7870 5716 5457 8517 3607	3767 3042 8557 5915 7891	6928 8697 6446 0705 6115
Rand	2028 3602 8683 0787 6256	6098 9747 7133 2324 3351	6647 3462 9398 3917 1143	7460 0756 8310 5037 0381	2192 1198 4632 1040 4322	7324 8814 8119 7921 2589	2904 9589 9032 9184 9359	7121 5273 4004 8785 5975	4707 5910 2380 2946 3684	1353 4084 8944 4628 6234
	9109 9109 6405 4158 4158	6861 4623 4634 7278 7378	5465 6962 8132 472C 4909	6300 6857 8748 0628 1385	5691 7972 6412 9112 3348	3291 0741 0845 8166 4578	4642 1060 5814 3478 1036	9118 0543 1836 2575 4377	9718 4838 3526 2758 5386	2486 7398 6074 6258 3369
	6903 2080 4197 2315 5578	4238 4628 5616 8822 3275	8339 6336 5338 5338 5338 5038 5038 5038 5038 5038	9046 5991 1958 9764 3753	4195 9635 3318 5751 8457	0874 3921 5449 9371 9371	5642 7727 6143 8697 4561	0688 0473 02473 0231 9868 4536	C238 7707 3738 9203 8923	7178 8225 7221 1007 0523
	9207 1886 1797 1797 6534	2325 6598 4592 1765 6139	3911 684 5572 23572 3138	1921 6735 6089 1767 1748	7529 9717 99063 0915 6456	8700 8050 6663 3648 4238	6015 1088 2027 1929 7651	1629 5650 0604 5913	9111 7787 5731 4827 1653	3561 8301 5658 4819 9239
	2137 7445 2086 4746 4983	4 6 6 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7 7	2605 6648 3771 6518 3905	6281 6462 8012 7058 9531	8995 115 117 141 141 15 15 15 15 15 15 15 15 15 15 15 15 15	4561 9489 7278 3106 7073	3089 6525 0814 2184 7707	2533 8512 55489 2866	46 56 0167 3292 5142 6281	5951 9973 0303 7655 5403
	3383 5994 4014 8057	0288 2800 2266 2953 9820	9651 0355 0415 9451 7615	1298 6054 9182 4787 5401	3331 8691 7138 4434 7053	3082 1664 1690 0837 3545	0964 2430 1295 9587 1433	8319 7069 9448 0045 1054	0134 7059 1160 7654 0672	9968 5693 5488 6118 0698
	0414 5270 5541 0578 7017	2589 7242 8472 4652 6712	6787 6575 4283 4283 9145 9145	9856 98163 98163 95163 1913 1915	7795 5161 1698 8948 0148	2358 5573 4267 9394 5848	8853 0618 1667 8134 0075	0803 3890 2179 6663 5985	9509 3626 1344 2986 5371	7867 2863 3107 0220 8418
cont.)	5306 8116 5092 9096 1263	5678 2647 6030 4247 8167	4956 9505 1895 4960 1970	3406 5176 0959 4901 5529	9363 6938 8328 4728 5895	4450 6226 9160 2418 3262	1896 9637 4014 0315 2615	1650 0042 5420 0175 9105	5212 1708 8434 9190 8090	0495 9203 2549 7227 0577
mbers (7000 8131 0262 7852 2999	3389 5411 1556 2963	0554 8636 4975 4031 4603	2080 8822 1630 2735 3261	1675 4400 4495 6414 6414	2426 8021 5480 5565 5766	1808 8352 2792 5869 4604	9288 4844 6256 9569 8197	0398 3027 9983 8705 6954	5190 3163 0320 3238 1750
lom Nu	1285 8567 2897 2660 3899	9204 2152 3252 5409 2758	2431 4853 1901 7445 8918	9061 8414 5192 2540 2015	3770 8613 4449 2580 1225	74C4 6736 2669 8181 8425	6922 7281 1888 5459 8795	0818 8612 9540 4276 3779	7599 5355 1214 2523 8310	5606 6871 1717 3501 7214
Rand	2346 2112 0874 4859 0721	1702 3380 9562 8552 7703	5846 2820 2194 2994 3646	4508 7299 2183 0375 8074	2632 0448 8577 8522 4050	4919 0981 7588 8844 8902	6516 3818 4296 1493 8787	8995 4893 3931 8975 1337	3846 6503 3270 8891 2199	8817 7875 6306 9313 8528
	6307 8843 2192 4247 6612	3464 7551 9691 3167 5457	0762 7332 5615 4769 6591	9755 2030 23335 2983 1944	3293 5869 5596 5596 0 939	5951 9892 9861 3251	3884 2850 5908 1329	2906 8941 2829 3817 8280	5021 8085 3746 1410 2922	2815 2393 8925 5698 0279
	2276 8902 1435 6130 8772	9396 7569 2854 8474 2086	5239 4019 1658 0105 4043	6036 4612 8973 6445 2693	4334 5174 5004 4294	8988 8456 2241 7226 1336	1863 9370 7865 6630 5450	2042 2815 4732 1435 7914	0044 1174 2669 1387 9529	4226 5936 2291 1384 6484
	5500 2550 2551 2553 2553 2553	5573 7478 3339 5505 6381	6975 7:85 4510 7752 4634	8866 6622 9622 5518 2705	1797 9448 3461 7392 5533	7252 5213 1158 9238 7711	2656 7980 1409 7657 2863	3988 4551 5772 9150 5764	5895 6857 2538 9983 5061	99999 4823 1232 1232

- 298 -Annex 5.1 (c)

	39 87 57 64 31 73 53 13 7542	2364 7024 8506 8506	8293 6078 9244 2444 0075	7755 8846 8327 7908 5098	2139 7908 2712 1997 0821	0425 2711 1547 0959 6737	3133 5813 8123 8989 7640	0426 4995 5725 8212 0397	6874 0797 4844 4399 9070	8563 4665 6919 8733 4544
	4989 2153 4690 4131	6742 8493 6124 8159 6850	7490 8300 8211 9279 5741	6672 2879 7106 1482 4320	3771 7505 3955 4975 3858	1459 9651 1871 3704 1822	0255 3543 6906 8478 1508	6421 9505 0844 8901 0794	7058 5606 3763 8885 4138	2598 1490 8367 5723 6847
	7962 4894 4745 8212 4153	3101 0650 5320 8430 8893	5286 4454 4780 3713 0762	085 085 05 05 05 05 05 05 05 05 05 05 05 05 05	9967 8991 4898 3011 0223	3593 6187 4512 3719 6726	7444 9499 3083 6710 7357	0455 6136 7534 2725 0181	4787 8733 0440 4826 7027	4731 4077 2816 1584 6761
cont.)	4113 3972 3642 1958 7027	9933 1756 2863 7628 2906	4402 2082 4990 3675 9036	3301 1968 5367 8475 8446	5137 4301 0171 1516 9440	0170 8105 7027 5429 6951	2468 6595 1208 2993 3827	4126 4223 1508 1861 8981	0415 4626 9922 0002 1942	4284 7679 4537 1831 6670
mbers (3068 0902 0087 2951 2993	3823 5255 5255 7298 3193		0349 9305 2326 2979 6516	6023 8078 7933 7495 5941	2652 3212 9642 9542 3735	6854 6854 2066 8818 1029	0197 5541 4231 6704 7173	8342 5732 2419 1936 7267	3503 3583 6795 0862 4495
om Nu	8076 8995 1166 8383 4295	7826 8147 2688 6055 1490	9742 8356 8356 6590 9949	8740 0974 1320 8485 9731	6325 9644 5045 9272 1821	1296 3438 6531 3964 3964	3391 2761 8100 5314 2548	7380 9141 2832 0447 8066	3367 3367 4514 1488 5718	8649 5921 5161 8406 7956
Rand	5595 5831 7101 2814 0473	3933 8663 7969 2737 4358	8352 0167 5566 5048 2201	3802 9411 3371 6275 2573	0334 6006 7400 6159 0708	6038 7922 2186 7479 6469	6155 2176 6773 6773 6773 6679	0892 5045 5361 1265	7115 2976 1402 9984 6668	5735 8245 8069 8260
	7878 7024 2123 9126 9175	5681 3096 9118 2640 9935	9897 2154 5581 4885	8858 8828 9855 9855 9855 9855 9855 9855	4701 7285 6491 8988 4187	5119 6418 6461 2836 1207	6632 7331 3454 1476 9759	3296 7608 4751 2461 9022	9207 4334 5282 1972 7228	0507 7697 5378 6739 0803
	2613 8618 4690 4609 0189	1540 2169 4981 3219 1369	4760 4369 5490 8238	7170 5444 6537 6863 6866	8360 7125 5242 7627 3259	0814 9604 5944 4732 3705	3056 1789 5232 3687 3687	8649 6761 9755 5538 6186	0.408 0.408 0.446 0.9546 0.3546 0.3564 0.3864	8432 4716 7193 7008 9775
	C43C 6095 6720 8948 3268	5473 5473 6051 7581 7581	1529 6640 5575 8575 8575	2274 7241 5975 5967 7751	53 51 9469 6303 86900 86900	3971 1458 15332 4758 4771	8320 0760 4070 5346 9998	3645 2557 1087 6355 8426	3513 8415 96615 9666 93893 04883	000 640 6430 6430 6450 6450 6450 6450 6450 6450 6450 645
	00700	N4045	4000	NNONN	10010	o n o ta o	o c a c c c	- n o n o n o n o n o n	~~~~	****
	00000 00000 000000 000000	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	00940 00040 00040	982 906 906 858 958	8 6 7 6 7 6 7 6 7 6 7 6 7 0 7 0 7 0 7 0 7	787 1987 1982 1582	000000 01440 01440	827 4627 9955 5233	7 6 6 6 7 1 1 8 0 8 0 8 0 8	771 372 894 124 093
	348 1445 1445 1895 33095 33095	6712 4600 2476 2493 8803	9328 4926 1959 9364 9364	4738 8610 3383 8746 8746	1892 2000 8126 8060 9877	7477 2623 8305 4756 8253	4995 5426 55236 3740 3740	5209 3658 5548 6019 6014	8075 3581 9880 0761 6442	1391 3080 19 5 9 8434 9638
	8108 1580 1934 3293 1554	5593 7744 1298 0682 5904	2482 6975 4163 7032 7210	2363 2624 1925 1329 0664	9612 5038 6387 9209 5214	4788 5909 1917 6321 0563	9167 2152 5460 9690	5272 1178 9816 7552 2864	4789 6872 4546 7214 1570	1588 5258 9151 6058
cont.)	1727 3642 6228 8084 3334	6849 9734 0616 6176 7400	3526 3932 4119 721 0854	5331 6435 2783 6329 7292	8389 5228 6605 8135 8135	4592 5989 7101 1134 8740	1996 3616 7253 5055 7609	1069 3008 7043 6603	1992 9032 9530 2049 2922	88 6021 5862 1468 1468
mbers (2911 2994 2994 2723 1273	4035 4399 6612 6612 2404	9064 4681 5267 0919 7509	9040 6914 7143 0975 1725	3270 1621 6516 9902 5892	4 4 4 4 4 4 4 7 6 2 8 5 9 8 0 2 8 0 2 8 0 2 8 0 2 8 0 2 8 0 2 8 0 2 8 0 2 8 0 2 8 7 8 7 8 7 8 7 8 7 8 7 8 7 8 7 8 7 8	6564 3080 8979 4964 1131	400 4640 34640 3400 3400	1270 8940 3207 1916 8600	4328 6180 6579 3697 2718
om Nu	4488 3079 8570 8619 7202	4182 8513 2620 0301 9804	6391 8640 4837 5111 3670	2444 5837 2695 8891 7511	0290 0862 4383 4982 4965	2055 5250 1402 8123 6692	7674 5111 3622 4773 5°31	3472 7064 8142 3213 4898	0427 8949 5257 5660	9193 4440 0563 2726 0656
Rand	3875 2758 7324 4469 0692	7679 9618 5909 8004 6737	4531 3032 8870 7309 1056	3654 7956 6372 8531 7696	3857 5727 7172 6475 3722	1198 6503 7882 9111 7068	6427 7309 7859 2205 3670	7116 1064 8956 1489 8397	8242 5496 4916 1690 2574	6582 6846 1295 0067 1461
	2107 8754 1481 0134 5280	9606 9342 7713 1247 5853	4963 1182 0987 5775 1848	4027 4109 4868 7158 2139	1505 6478 5992 0563 5603	5881 8867 9553 9837 234 0	1126 6037 1264 0220 6437	5684 5901 2920 8942	5328 1202 6881 8779 7631	4236 2186 2193 2833 6068
	6390 8812 4602 5460 7883	8623 5879 8918 2551 1333	2047 1191 7494 3586 8472	3476 3387 9026 4569 9650	4512 4512 4486 1295 5517	6696 2650 8415 5386 5546	4562 3914 6422 0292 4714	6939 4214 1426 7954 1061	6015 5282 6606 8877 2098	8366 5410 3091 1861 8924
	001010 0000 00000 00000	0.00111 0.0011 0.0000 0.0000 0.0000	0 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	8 8 4 1 1 9 8 1 9 4 4 1 9 1 1 1 1 1 1 1 1 9 1 1 1 1 1 1 1 1 1	66895 5013 5013 5015 505 505 505 505 505 505 505 505 50	2434 2625 2625 2008 2008 2008 2008 2008 2008 2008 20	00000 0000 0000 0000 0000 0000 0000 0000	8400 3260 2220 3138	4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4 4	7081 2300 4090 2656 9465

- 299 -Annex 5.1 (d)

- 300 -Annex 5.1 (e)

- 301 -Annex 5.2 A_{n-i+1} Coefficients

<u> </u>	(· · · · ·				
λ'	1	4	5	6	7	8	9	10	11	12	13	11	15	16	17	18
1	0 7071	0 6872	0 6646	0 6431	0 6233	0 6052	0 5888	0 57 39	0 5601	0 5475	() 5359	0.5251	0 1 1 50	0.5056	0 4968	0 4886
2		0 1677	0 2413	0 2806	0 3031	0 3164	0 3244	0 3291	0 3315	0 3325	0.3325	0 3318	0 3306	0 3290	0 3273	0 3253
٦				0 0875	0 1401	0 1743	0 1976	0 21 41	0.2260	0 2347	0.2412	0.24(0	0 2495	0.2521	0 2540	0 2553
4						0 0561	0 0947	01224	0 1429	0.1556	0 1707	0.1802	01878	0 [939	0 1988	0 2027
5								0 0399	0 0695	0.0922	0 1999	01240	01153	0 1447	0 1 5 2 4	0 1587
6										0 0303	0 0539	0 0727	0.0280	0.1005	0 1 1 0 9	0 1 197
7												0 0240	0 0433	0.0593	0 0725	0 0837
8														0 0196	0 0359	0 0496
9																0 0163
N																
, /	^{" 19}	20	21	22	23	24	25	26	27	25	29	30	31	32	33	34
1	0 4808	0 4734	0.4643	0.3500	0 4547	0 4393	0 4450	0 4407	1) 4366	0.4328	0 4291	0 4254	0.4220	0.4188	0 41 56	0 4127
;	0 1717	0 1211	0 3185	0 31 56	0 3176	0 3098	0 3069	0 3013	0.3018	0 29 12	0.2968	0 2914	0 2921	0.2898	0 2876	0 2854
ĩ	0 2561	0 2565	0 2578	0 2571	0 2563	0 2554	0 2543	0 2533	0 2522	0.2510	0 2 199	0 2 1 8 7	0 2475	0 2463	0.2451	0 2439
4	0 2059	0 2085	0 21 19	0 2131	0 2139	0 2145	0 21 48	02151	0 2152	0 21 51	0 2150	0.2148	0 2145	0.2141	0 21 37	0 2132
Ś	0 1641	0 1686	0 1736	0 1764	0 1787	0 1807	0 1822	0 1836	0 1848	01857	0 1864	0 1870	0 1874	0 1 9 7 8	0 1880	0 1882
6	0 1271	0 1334	0 1 3 9 9	0 1443	0 1 150	0 1512	0 153)	0 1 5 6 3	01584	0 1601	0 1616	0 630	0 [61]	0.1651	0 660	0 1667
7	0.0932	0 1013	0 1092	0 1150	0 1201	0 1245	0 1283	0 316	0 1346	0 1 3 7 2	01395	01415	01133	0 1 1 4 9	0 1463	0 1475
8	0.0612	0 0711	0 0804	0.0878	0 0941	0.09.)7	0 1046	0.1059	0.1128	0 1162	0 1492	0.1219	01213	0.1265	0.1284	0 1 3 0 1
9	0 0303	0.0122	0.0530	0.0618	0.06.16	0 0764	0.0523	0.0876	0.0023	0.0965	0.1002	0/036	0 1066	01033	0.1118	0 1140
10		0 0140	0 0263	0.0368	0 0459	0.0539	0.0610	0.0672	0.0728	0.0775	0.0522	0.0862	0 (1850	0.0871	0.0961	0.0955
-11				0.0122	0.0228	0.0321	0.0403	0.0476	(1.1)540	0.0595	0.0650	0.0697	0 073)	0 0777	0.0812	0.0844
12						0.0107	0.0200	0.0251	0.0355	0.0121	0.0181	0.0537	0.0585	0.0(29	0.0669	0 0706
11								0 8094	0.0178	0.0253	0.0320	0.0381	0 0 1 1 5	0.0485	0 0530	0 0572
14										0.0084	0 01 59	0 0227	0.0289	0.0344	0 0395	0 0441
15												0.0076	0 0144	0.0206	0 0262	0 0314
16														0.0068	0.0131	0.0187
17																0 0062

<u> </u>																
/"	15	36	37	38	39	40	41	42	43	44	45	46	47	48	49	5()
1	0 4096	0 4068	0 4040	0 4015	0 3989	0 3964	0 3940	0 3917	0 3894	0 3572	0 3850	0 3830	0 3808	0 3789	0 3770	0 3751
2	0 2834	0 2813	0 2794	0 2774	0 2755	0 2737	0 2719	0 2701	0 2684	0 2667	0 2051	0 2635	0 2620	0 2604	0 2589	0 2574
3	0 2427	0 2415	0 2403	0 2391	0 2380	0 2368	0 2357	0 2345	0 2334	0 2323	0 2313	0 2302	0 2291	0 2281	0 2271	0 2260
4	0 2127	0 2121	0 2116	02110	0 2104	0/2078	0 2091	0 2055	0 2078	0 2072	0 2965	0 2055	0 2052	0 2045	0 2038	0 2032
5	0 1553	0 1883	0 1583	01881	0 1850	0/1878	0 1876	0 1874	0 1871	0 1568	0 1865	0 1862	0 1859	0 1855	0 1851	0 1847
6	0 1673	0 1678	0 1653	01686	0 1659	0/1671	0 1693	0 1694	0 1695	0 1675	0 1695	0 1695	0 1695	0 1673	0 1692	0 1691
7	0 1487	0 1496	0 1505	0 1513	0 1520	0 1526	0 531	0 1535	0 1539	0 1542	0 1545	0 1545	0 1550	0 1551	0 1553	0 1554
8	0 1317	0 1331	0 1344	0 1356	0 1366	0 1376	0 384	0 1392	0 1398	0 1405	0 1410	0 1415	0 1420	0 1423	0 1427	0 1430
9	0 110	0 1179	0 1196	0 1211	0 1225	0 1237	0 249	0 1399	0 1269	0 1228	0 1286	0 1703	0 1300	0 1306	0 1312	0 1317
10	0 1013	0 1036	0 1056	0 1075	0.1002	0.1105	0 1123	0 1136	0 11 19	0 1470	0 1170	0 1150	0 1180	0.1191	0 1205	0 1212
11	0 0873	0 0 200	0 0924	0 0947	0.0067	0.0256	0 1004	0 1020	0 1035	0 1049	0 1062	0 10 3	0 1085	0.1035	0 1105	0 1113
12	0 0739	0 0 770	0 0798	0 0824	0.0848	0.0570	0 0801	0 0900	0 0 27	0 0943	0 0950	0 0072	0 0056	0.0335	0 1010	0 1020
13	0 0610	0 0645	0 0477	0 0706	0 0733	0 0759	0 0782	0 0504	0 0824	0 0842	0 0860	0 0876	0 0892	0 0206	0 0919	0 0932
14	0 0484	0 0523	0 0559	0 0592	0 0622	0 0651	0 0677	0 0701	0 0724	0 0745	0 0765	0 0783	0 0801	0 0517	0 0832	0 0846
15	0 0361	0 0404	0 0444	0 0481	0 0515	0 0546	0 1 575	0 0602	0 0628	0 0651	0 0673	0 0694	0 0713	0 0731	0 0748	0 0764
16 17 18	0 0239 0 0119	0 0287 0 0172 0 0057	0 0331 0 020 0 0110	0 0372 0 0264 0 0158	0 0409 0 0305 0 0203	0 0444 0 0343 0 0244	0 0476 0 0379 0 0283	0.0506 0.0411 0.0315	0 0534 0 0442 0 0352	0 0560 0 0471 0 0383	0 0584 0 0497 0 0412	0 0007 0 0522 0 0432	0 0625 0 0546 0 0465	0.0748 0.0568 0.0489	0-0667 0-0558 0-0511	0.0685 0.0608 0.0532
19 20 21				0.0053	0 0101	0 0146 0 0049	0 0158 0 0094	0 0227 0 0136 0 0045	0 0263 0 0175 0 0087	0 0296 0 0211 0 0126	0 0328 0 0245 0 0163	0 0357 0 0277 0 0107	0 0385 0 0307 0 0229	0 0411 0 0335 0 0259	0 0436 0 0361 0 0288	0 0459 0 0356 0 0314
22 23 24 25										0 0042	0 0081	0 0115 0 0039	0 0153 0 0076	0.0155 0.0111 0.0037	0 0215 0 0143 0 0071	0 0244 0 0174 0 0104 0 0035